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ELECTRONIC COMPONENTS AT 10,000 PSI

VICTOR C. ANDERSON, DANIEL K. GIBSON and ROY E. RAMEY

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ELECTRONIC COMPONENTS AT 10,000 PSI

Victor C. Anderson, Daniel K. Gibson and Roy E. Ramey

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ABSTRACT

This report presents the results of a component test program in which a series of commercial electronic components were immersed in oil and subjected to hydrostatic pressures ranging from 0 to 10,000 psig. Over 3000 components representing 163 manufacturer types were tested. Results are presented in graphic form for the reader's own interpretation.

INTRODUCTION

Electronic equipment used in deep submergence oceanographic work has generally been protected from pressure damage by encasing susceptible components and assemblies in a heavy pressure case designed to withstand the extreme pressures.

The inconvenience and high cost of large, high pressure cases has generated interest in investigating other means of protecting underwater electronic equipment from the deep-ocean environment. Some types of electronic components are capable of operating at the deep-ocean ambient pressures. For equipment constructed with these components, the package design is reduced to one of surrounding the electrical equipment with a lightweight housing filled with an insulating fluid maintained at ambient sea pressure through a pressure equalizing diaphragm. The only requirements imposed on the fluid are that it possess good electrical insulating properties and produce no harmful effects on the components. Sealing problems associated with mechanical and electrical penetrations through the package wall into the sea, or from the sea, are virtually eliminated since little or no pressure differential exists across the barrier.

The performance of a limited number of components under high pressure was reported by Buchanan and Flato in 1961. Since that time a number of articles and reports have appeared on the topic. The bibliography lists several which may be of interest to the reader.

As part of a program involving extensive use of ambient pressure electronics, a comprehensive testing program was undertaken at the Marine Physical Laboratory in the summer of 1964. Letters were sent to leading component manufacturers inviting submission of samples for testing in the program.

More than half of those manufacturers invited responded by submitting over 3000 parts for testing. The tests of those components and their results are the subject of this report. The test data are presented in the form of graphs with accompanying descriptions and photographs of physical damage for the individual reader's interpretation. All data have been presented without any attempt on the part of the laboratory to give opinions or form conclusions.

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 R62ELS-19, Feb. 1962.

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 Report #1, ER 12423, April 1962.

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 on Electronic Components
 General Electric Company, May 1, 1962.

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 Operation of Electronic Components under
 Severe Hydrostatic Pressures
 Progress Report #2, ER 12533, Aug. 1962.

TEST PROGRAM

Test Procedure

The test samples when received were catalogued and visually inspected for damage prior to being tested.

Sets of twenty components were used in each test wherever possible to obtain an adequate statistical sampling which would offer a more reasonable probability of failure or extreme deviation than a single component.

A maximum of seventy six components were installed in a pressure chamber containing a laboratory grade of light mineral oil. The chamber was sealed off and an initial set of readings taken at zero psig. The pressure was increased in 1000 psig increments to 10,000 psig and then varied between 0 and 10,000 psig for

a total of five cycles. A soak period at a prescribed pressure was conducted as time and conditions allowed. Pressure was then reduced to zero psig.

Electrical measurements of the components were made at the initial zero pressure conditions, at each of the 1000 psig increments, after the cycling period, at the end of the soak period and finally on return to zero pressure, making a total of fourteen readings per component. The test conditions corresponded to the respective manufacturers' specifications.

The components were then removed from the chamber, cleaned and visually inspected for physical damage.

Data Reduction

Data taken during the test, using instruments listed in "Description of Test Equipment," were recorded on prepared data sheets. This data was then transferred to punch cards for processing by a Control Data Corporation 3600 computer.

The computer was programmed to normalize each reading in a set sequence of a particular test component to that component's initial zero pressure reading. The results at each pressure station for a set of samples were averaged and the maximum and minimum values determined by the computer. Any component deviation of more than 50% from the initial zero pressure readings

was considered an incipient failure and deleted from the computations for that pressure. In some cases the apparent failures recovered at some subsequent pressure. These cases were then returned to the program at the recovery pressure.

The average, minimum and maximum values, number of components in a set, and pressures at which failures occurred are shown on individual graphs for each set of components tested. Additional descriptions and typical photographs are supplied of all visible mechanical damage. The presentation of this data is covered under "Data Format" in this report.

Description of Test Equipment

A schematic diagram of the test setup is given in Fig. 1. The hydraulic system is self explanatory. The chamber itself is a 192 cu. in. cylindrical pressure vessel. A screw-on, O-ring seal top contains six electrical bulkhead connectors and one hydraulic vent valve. Test

samples were attached to a mounting bracket on the removable chamber top. The various electrical testing configurations are shown schematically in Fig. 2. The major testing components are listed below.

Test Equipment List

Description	Manufacturer
Pressure Chamber	Marine Physical Laboratory
Pressure Gauge, 0-10,000 psig	Ashcroft
Pressure Regulator	Bastian-Blessing Co.
Air-to-Hydraulic Booster Pump	Scientific Engineering Corporation
System Oiler	Bastian-Blessing Co.
Stepping Relay	C. P. Clare
Isolation Trans.	Chicago-Stancor
Constant Voltage Trans.	Sola Corporation
Volt-Ohmmeter	Hewlett Packard
AC Voltmeter	Hewlett Packard
Impedance Bridge	Electro Scientific Corporation
Wide Range Oscillator	Hewlett Packard
Oscilloscope	Tektronix, Inc.
Transistor Curve Tracer	Tektronix, Inc.
Binocular Microscope	Bausch & Lomb

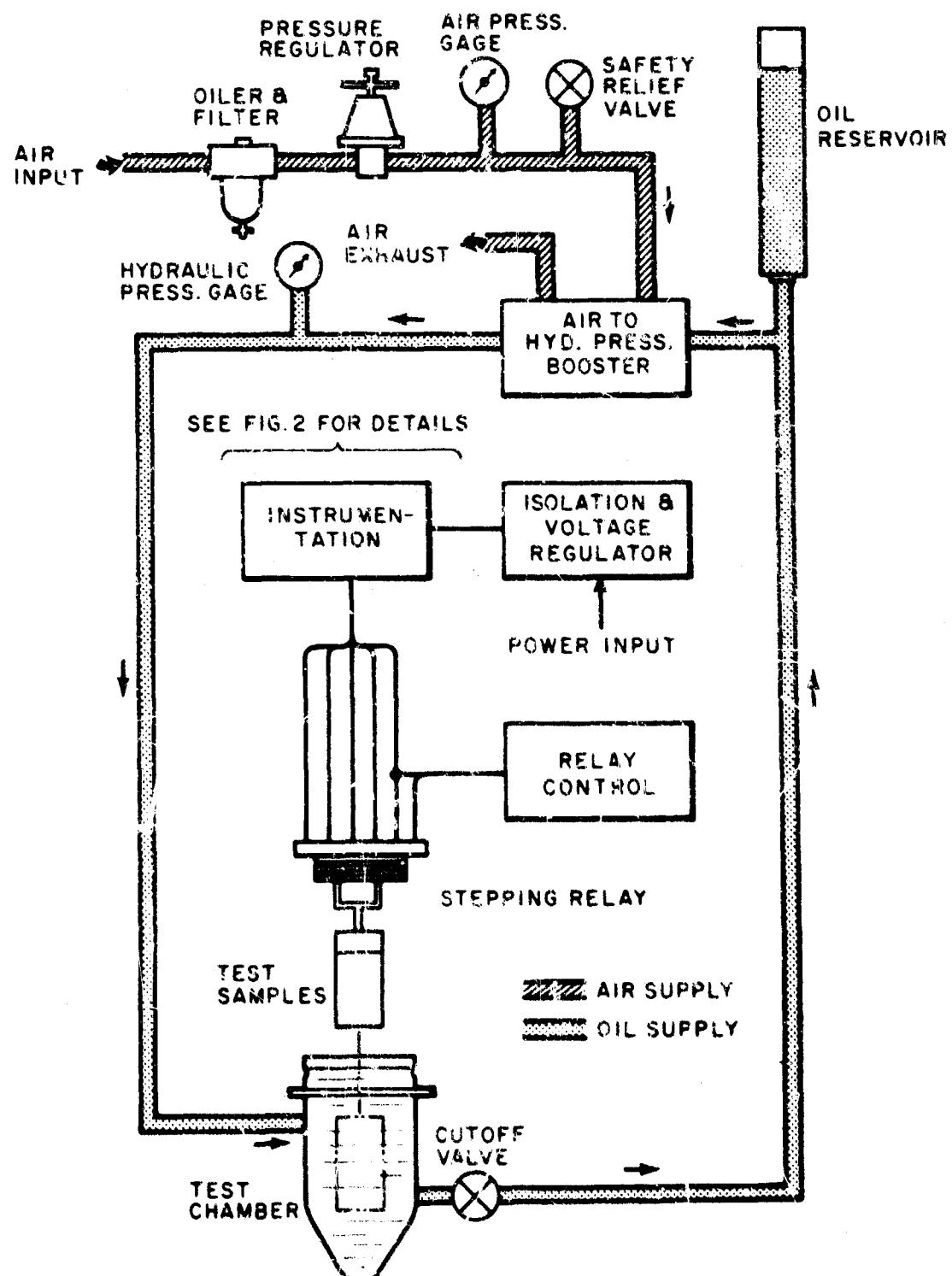


Fig. 1. Test Setup

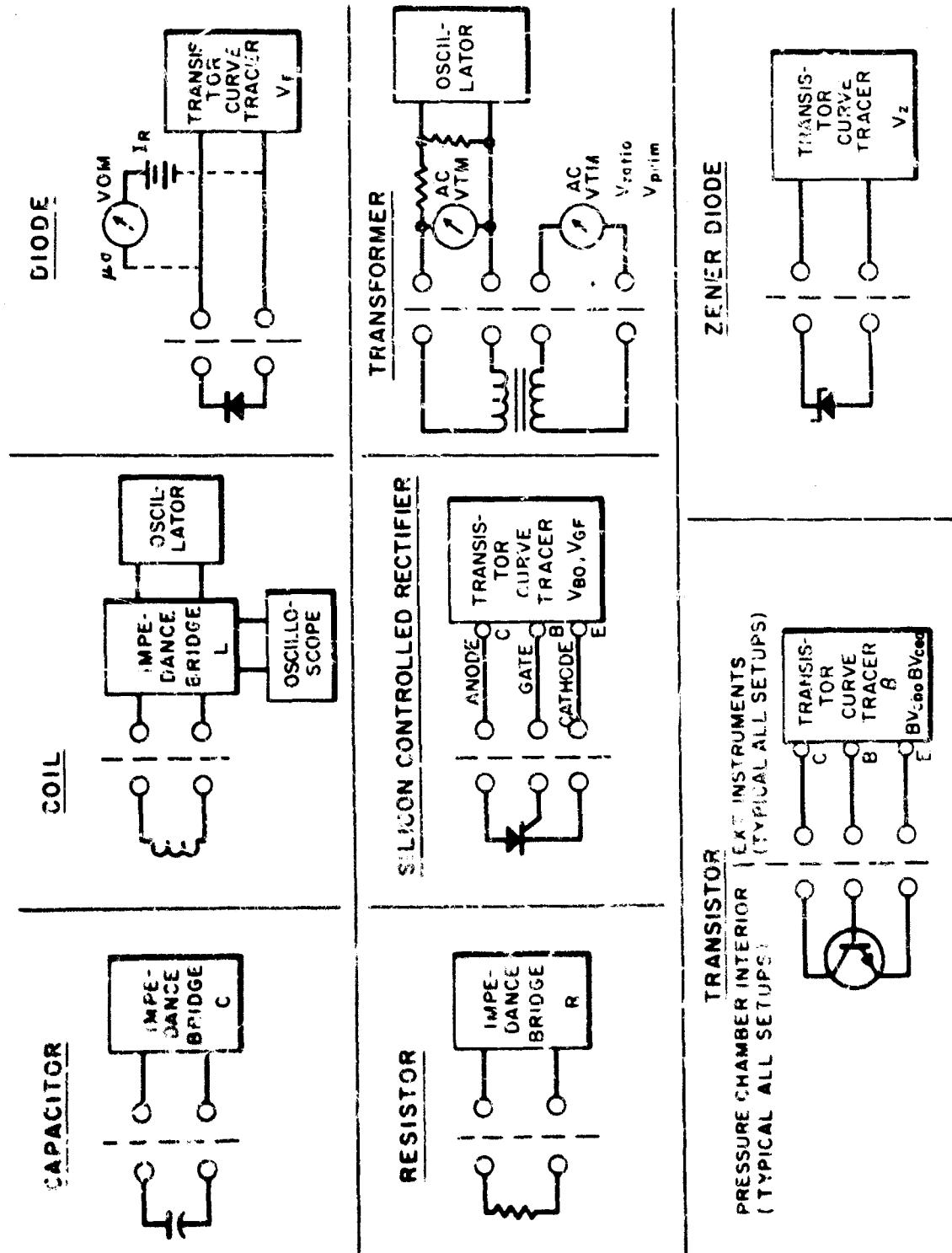


Fig. 2. Electrical Testing Configurations

TEST DATA

Index of Components by Manufacturer

			Page
Allen-Bradley Company	136 West Greenfield Avenue Milwaukee, Wisconsin	Resistors	110-131
Centralab	900 East Keefe Avenue Milwaukee, Wisconsin	Capacitors	10-17
Cornell-Dubilier Electronics	50 Paris Street Newark, New Jersey	Capacitors	18-53
Corning Glass Works	Electronic Products Division 3500 Electronics Drive Raleigh, North Carolina	Capacitors Resistors	54-61 130-137
Dale Electronics, Inc.	1370 28th Avenue Columbus, Ohio	Resistors	136-137
General Instrument Corp.	65 Gouverneur Street Newark 4, New Jersey	Diodes Resistors Transistors	78-87 138-139 170-173
Microtran Company, Inc.	145 East Mineola Avenue Valley Stream, New Jersey	Chokes Transformers	68-69 156-163
J. W. Miller Company	5917 So. Main Street Los Angeles, California	Chokes	70-77
Motorola	Semiconductor Products Div. 5005 E. McDonald Road Phoenix, Arizona	Diodes Transistors Integrated Networks	88-95 174-177 186-191
Omnite Manufacturing Co.	3635 Howard Street Skokie, Illinois	Diodes Resistors	98-101 140-151
The Potter Company	1424 So. Allec Street Anaheim, California	Capacitors	60-61
F. W. Sickles	Division of General Instrument Corporation P. O. Box 330 Chicopee, Massachusetts	Chokes Transformers	66-67 156-157

Index of Components by Manufacturer (Cont'd)

			Page
Sylvania	Semiconductor Division 100 Sylvan Road Woburn, Massachusetts	Diodes Transistors	101-105 178-183
Texas Instruments	Components Division 13500 N. Central Expressway Dallas, Texas	Capacitors Diodes Resistors Silicon Con- trolled Rect. Transistors	62-65 106-111 152-155 154-155 174-187
United Transformer Corp.	150 Varick Street New York 13, New York	Transformers	162-169

Index of Components by Type

Type	No. of Sets	No. of Components	Page
Capacitor	56	1060	10-65
Choke	12	211	66-77
Diode	17	400	78-111
Integrated Networks	4	80	158-191
Resistor	44	860	110-155
Silicon Controlled Rectifier	1	5	154-155
Transformer	14	190	155-169
Transistor	15	380	170-187
Totals	163	3186	

Data Format

The maximum, minimum and average electrical characteristics of each component type are plotted versus pressure. The graphs are normalized to unit initial values before application of pressure.

The ordinate of the graphs uses a composite of linear and log scales so that deviations of less than $\pm 10\%$ appear on a linear scale and deviations greater than $\pm 10\%$ are shown on a log scale. The exceptions to this form are the graphs for transistors and diodes. The accuracy of the readings for these components is of the order of $\pm 10\%$; therefore, the entire ordinate uses a log scale to avoid exaggerating inherent reading errors.

As previously stated, components having a relative value change greater than 50% were

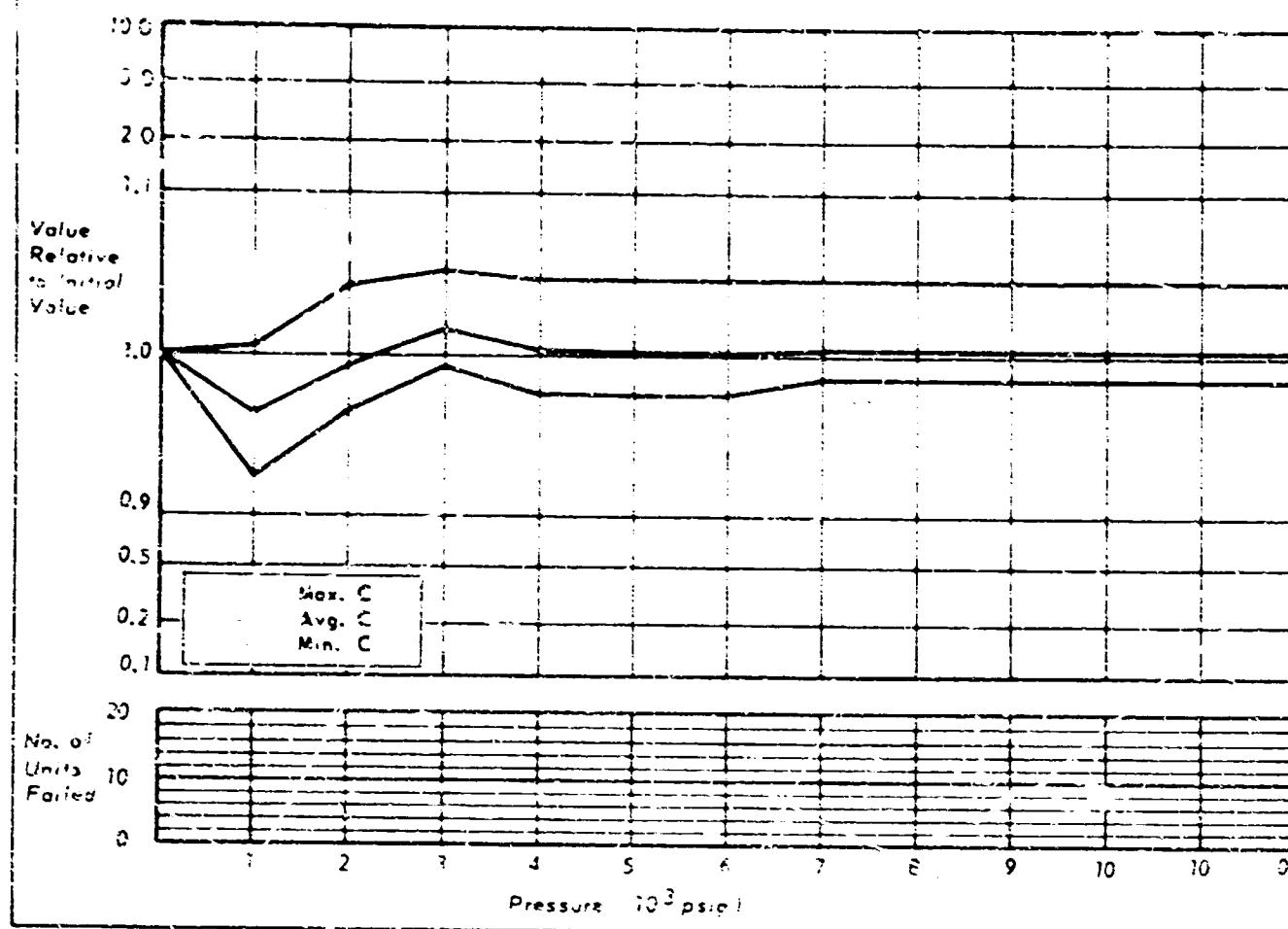
considered a failure and dropped from the set in computing values at that pressure.

The number of failures for each test set are shown in a bar graph for each 1000 psig pressure increment. This graph shows failures in the pressure interval in which they appear. The percentage of failures can be determined by reference to the total number of components tested given at the top of each graph.

Each graph is accompanied on the facing page by a complete description of the component tested, a summary of changes in relative value, a review of any physical damage and, where appropriate, a photograph of any visual physical evidence of mechanical damage.

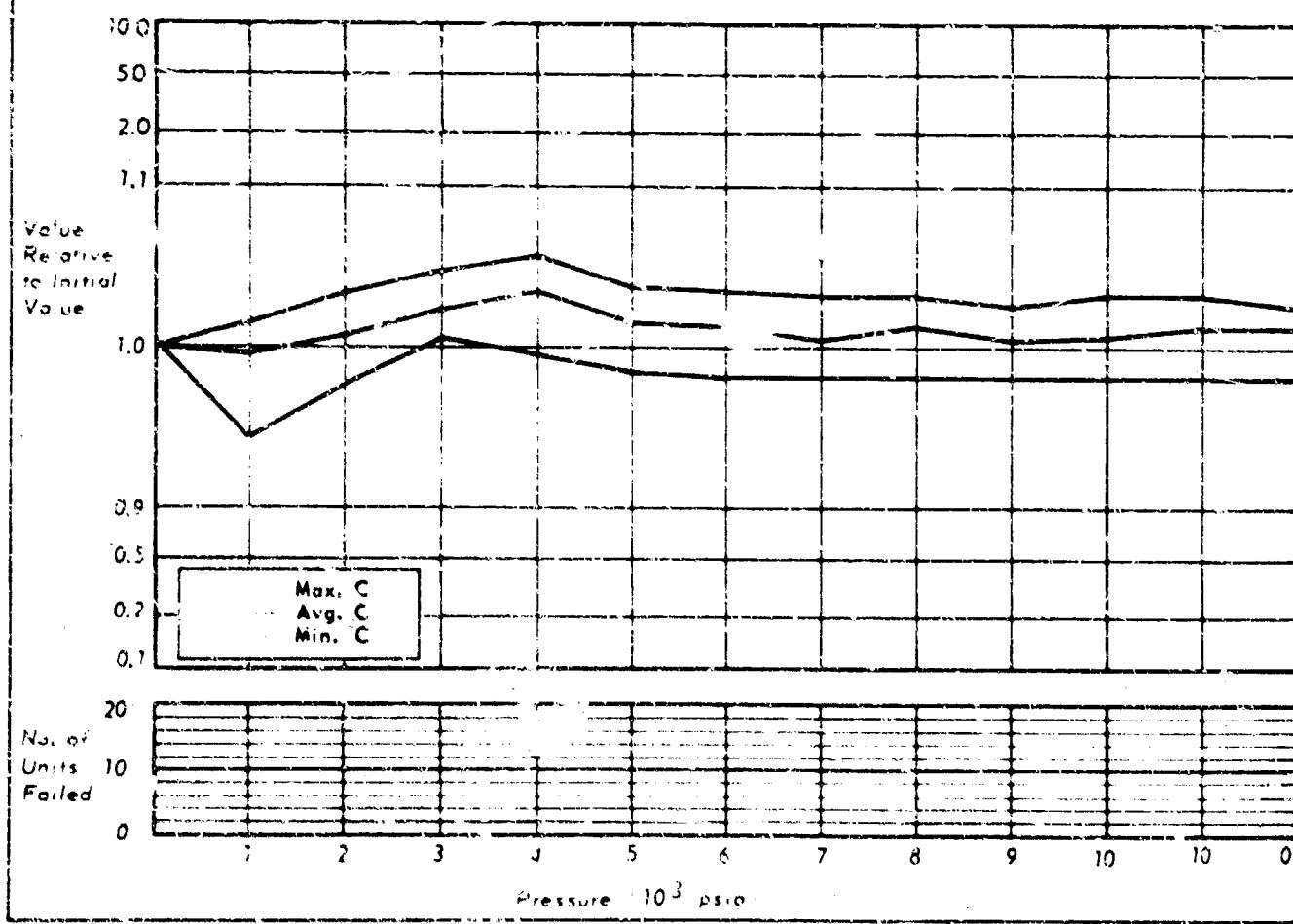
MFG. - CENTRALAB
TYPE - CAPACITOR
DESCRIPTION - DD-580

CHART NO. 1
NO. OF SAMPLES TESTED - 20



MFG. - CENTRALAB
TYPE - CAPACITOR
DESCRIPTION - 850

CHART NO. 2
NO. OF SAMPLES TESTED - 10



Centrofab
DD-560
Capacitor
SOAK PERIOD: 16 hours at 70,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

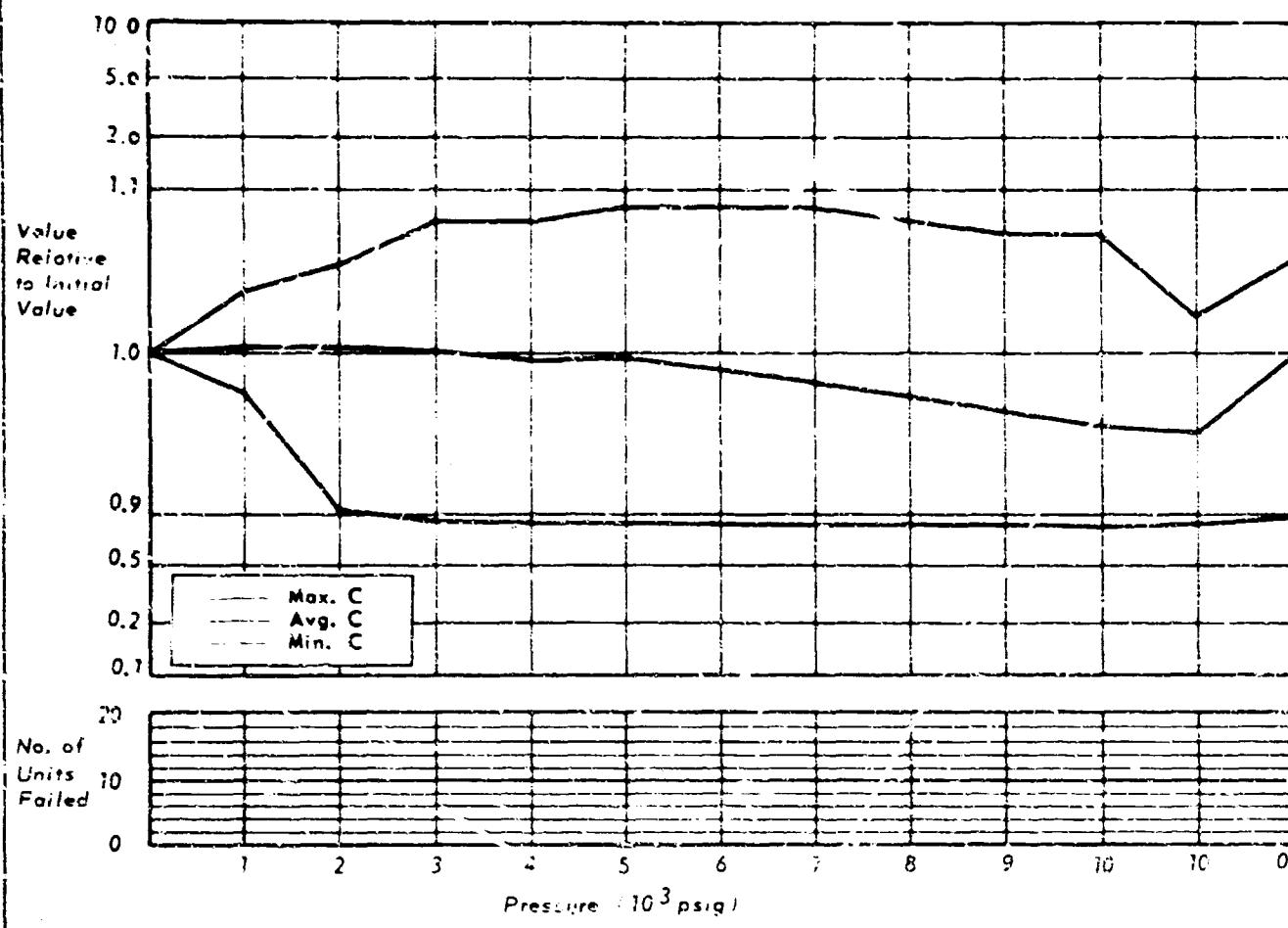
56 pF $\pm 10\%$
1000 VDCW
Ceramic, disc
Radial lead
 $0.12 \times 0.25''$ diam.

Centrofab
Type 550
Capacitor
SOAK PERIOD: 16 hours at 7,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

100 pF $\pm 10\%$
5000 VDCW
Metal case
Axial stud
 $0.65 \times 0.812''$ diam.

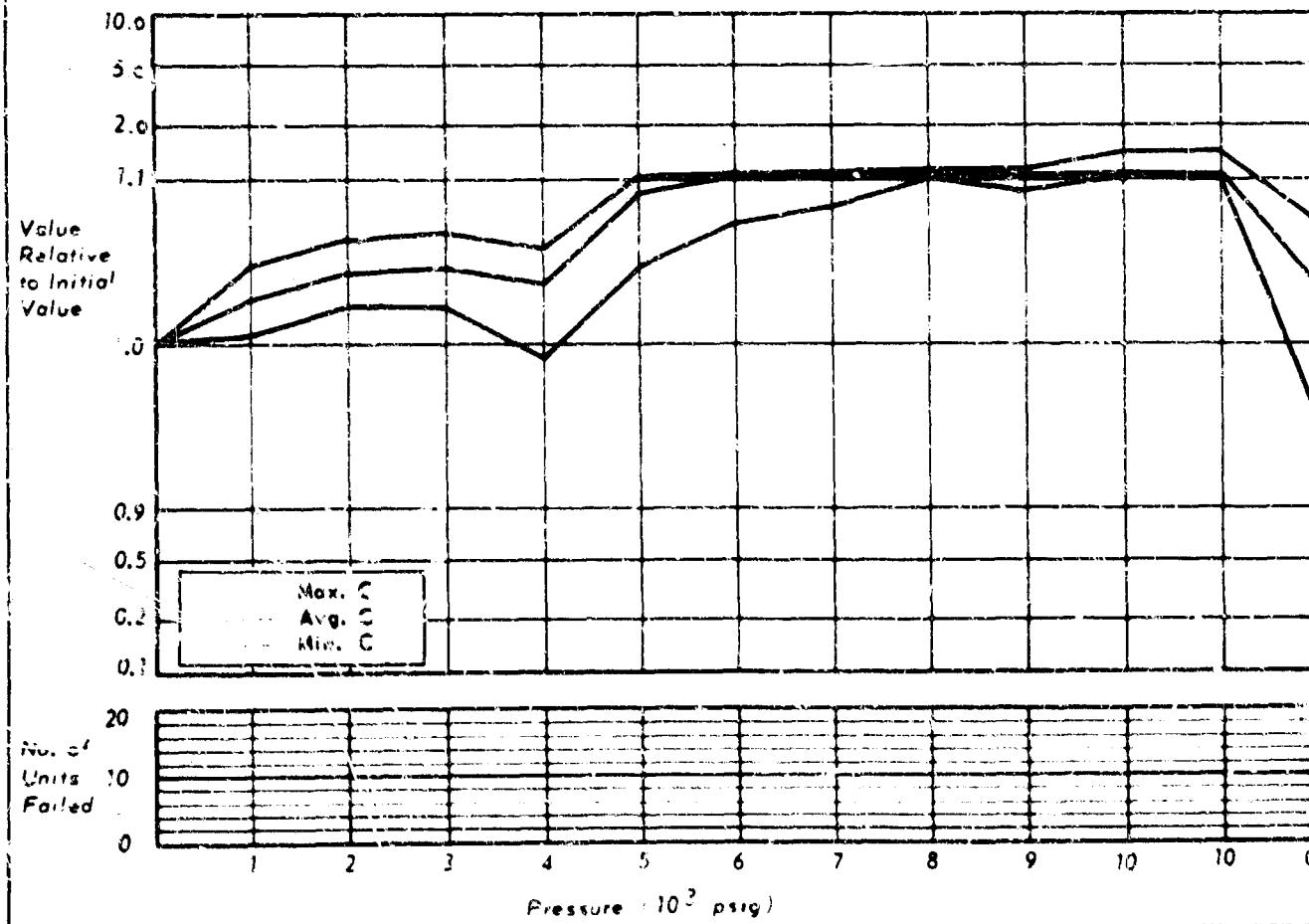
MFG. - CENTRALAB
TYPE - CAPACITOR, 741-0817, .001 MFD 6MV, 500 VDCW
DESCRIPTION - CERAMIC FEED THRU, AXIAL LEAD

CHART NO. 3
NO. OF SAMPLES TESTED - 20



MFG. - CENTRALAB
TYPE - CAPACITOR, 3A-203, .02 MFD $^{+100\%}$ $^{-20\%}$, .30 VDCW
DESCRIPTION - CERAMIC DISK, RADIAL LEAD

CHART NO. 4
NO. OF SAMPLES TESTED - 10



Centrelab 0.001 μ F GMV Ceramic, feed through
741-061Y 100 VDC# Tubular, axial lead
Capacitor 0.4 x 0.18" diam.

SOAK PERIOD: None

MECHANICAL: No apparent damage

ELECTRICAL: Seventeen components indicated less than 10% change.
Three components indicated a change greater than 10% and less than 50%.

Centrelab 0.02 μ F $^{+100\%}$ - 20% Ceramic, wafer
DA-203 30 VDCW Square, radial lead
Capacitor 0.57 x 0.57 x 0.12" th.

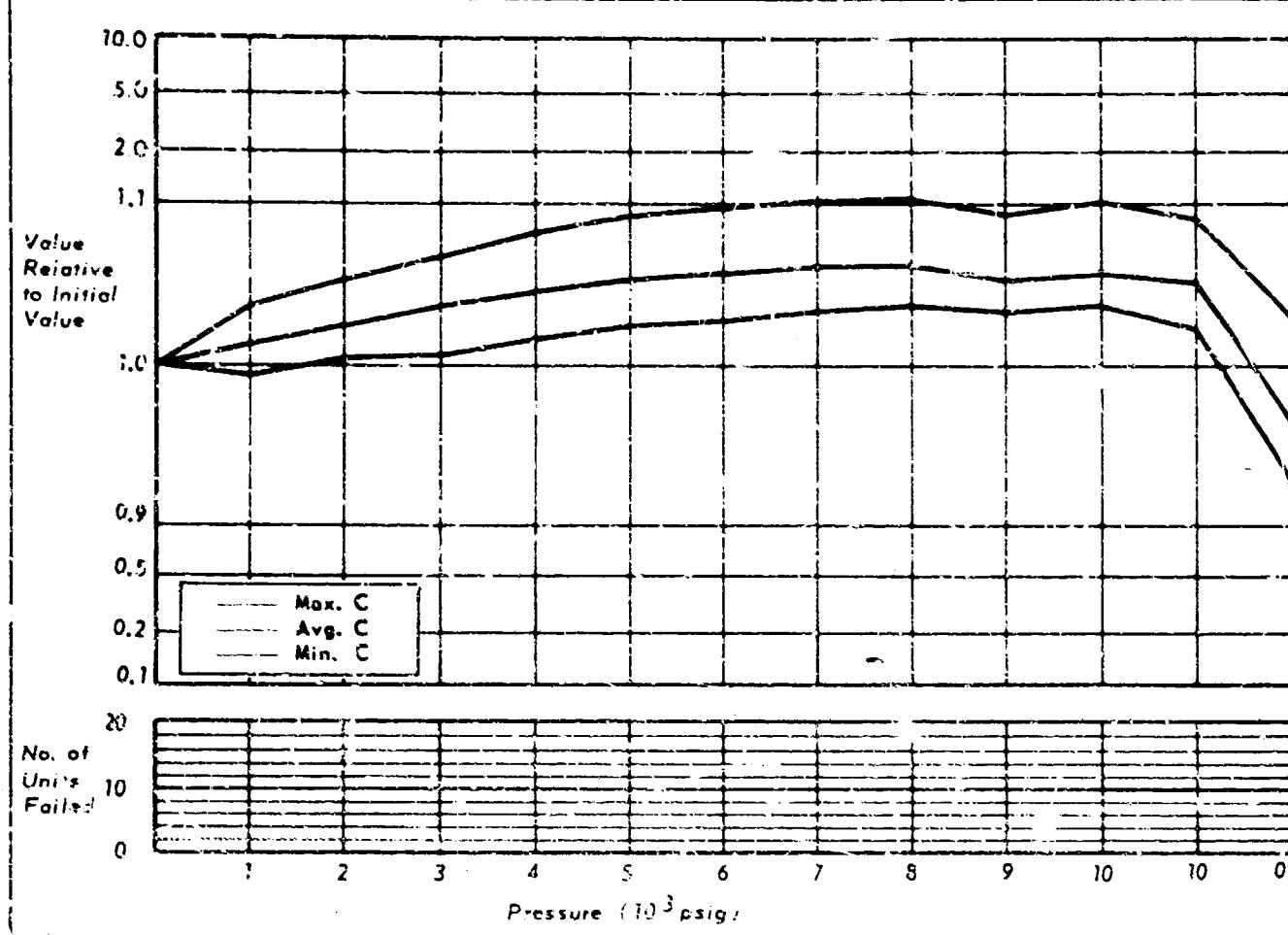
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage

ELECTRICAL: All components indicated a change greater than 10% and less than 50%.

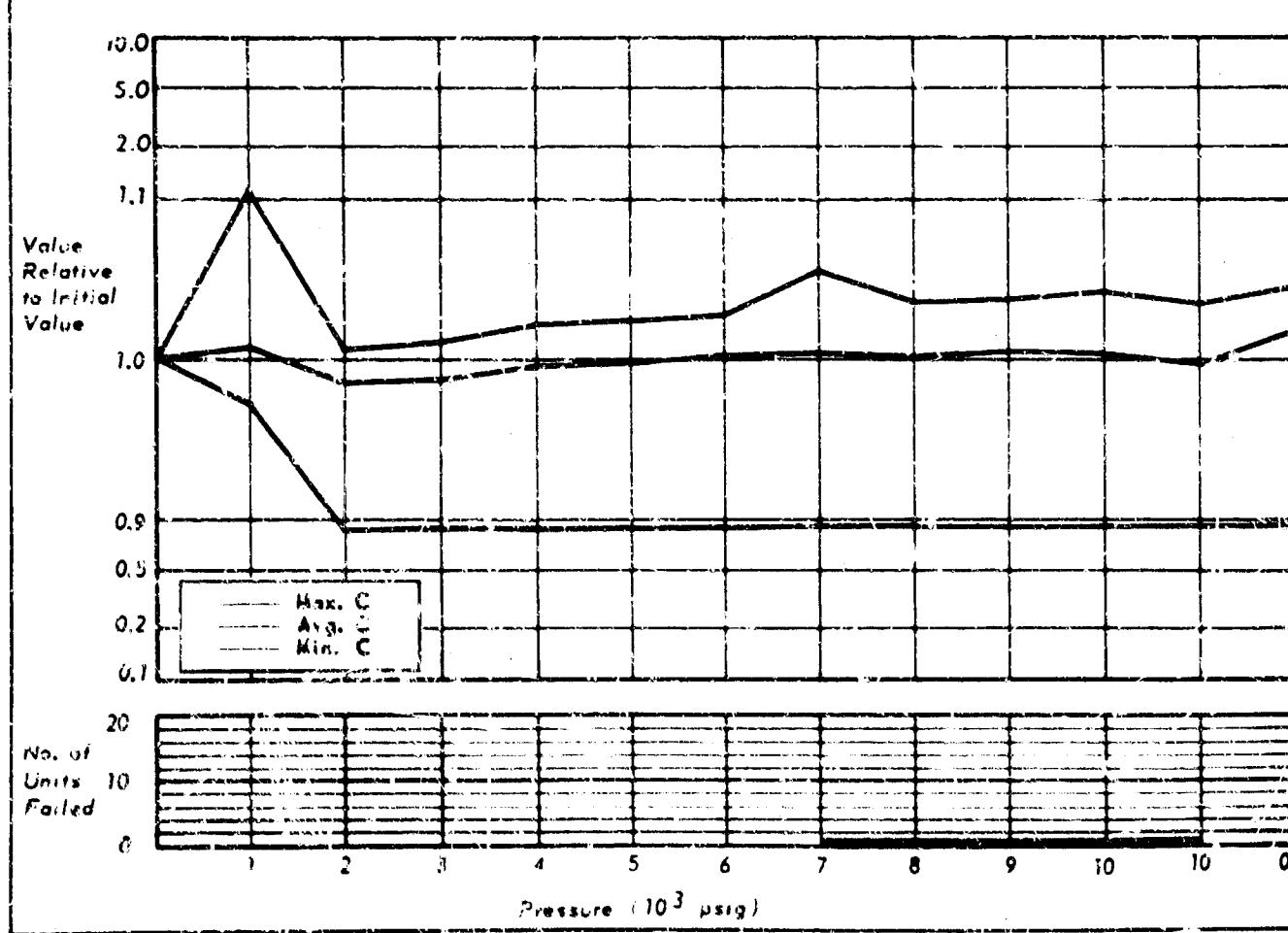
MFG.-CENTRALAB
TYPE-CAPACITOR, DO-203, .02 μ F \pm 20%, 600VDCW
DESCRIPTION-CERAMIC DISK, RADIAL LEADS

CHART NO. 5
NO. OF SAMPLES TESTED-20



MFG.-CENTRALAB
TYPE-CAPACITOR, DO-472, .0047 μ F \pm 20%, 75VDCW
DESCRIPTION-CERAMIC DISK, RADIAL LEADS

CHART NO. 6
NO. OF SAMPLES TESTED-20

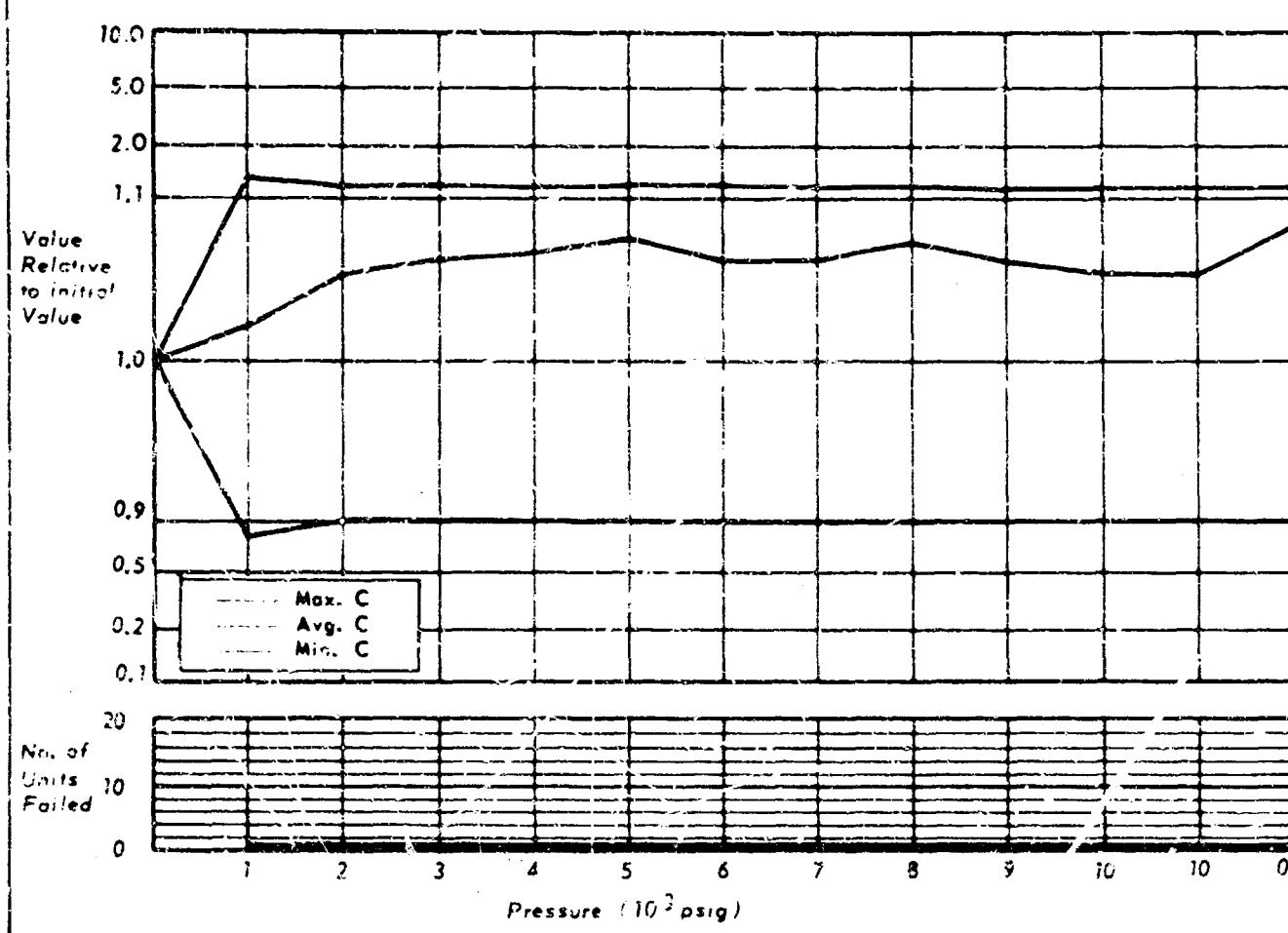


Centralab	$0.02 \mu F$ $^{+80\%}_{-20\%}$	Ceramic, disc
DD-203	600 VDCW	Radial lead
Capacitor		0.13 x 0.61" diam.
SOAK PERIOD: 16 hours at 3,000 psig.		
MECHANICAL: No apparent damage.		
ELECTRICAL: Nineteen components indicated less than 10% change.		
One component indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.		

Centralab	$0.0047 \mu F \pm 20\%$	Ceramic, disc
DD-472	75 VDCW	Radial lead
Capacitor		0.12 x 0.55" diam.
SOAK PERIOD: 16 hours at 3,000 psig.		
MECHANICAL: No apparent damage.		
ELECTRICAL: Nineteen components indicated less than 10% change.		
FAILURES: One component indicated a permanent change greater than 50% at the pressures shown on the failure graph on composite page.		

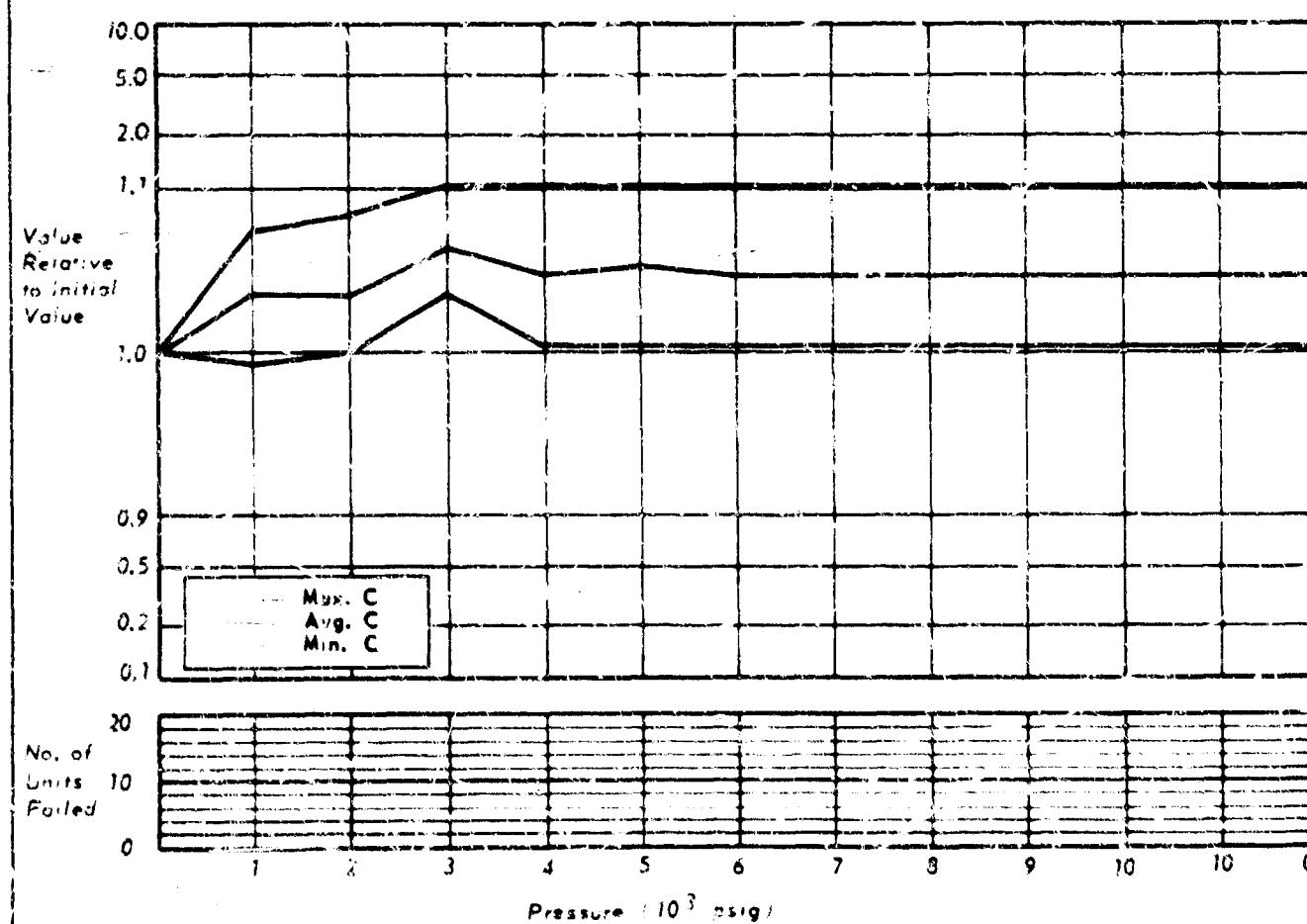
MFG. - CENTRALAB
TYPE - CAPACITOR
DESCRIPTION - DDA-104

CHART NO. 7
NO. OF SAMPLES TESTED - 20



MFG. - CENTRALAB
TYPE - CAPACITOR
DESCRIPTION - CVI10450

CHART NO. 8
NO. OF SAMPLES TESTED - 20



Centralab

0.1 μ F $^{+80\%}$
 -30%

DDA-104

75 VDCW

Capacitor

Ceramic, disc

Wax impreg

0.2 x 0.65" diam.

SOAK PERIOD: 15.5 hours at 3,000 psig.

MECHANICAL: One component was damaged as shown in accompanying photograph.

ELECTRICAL: Nineteen components indicated less than 10% change.

FAILURES: One component indicated a permanent change greater than 50% of the press ... shown on the failure graph on opposite page.



Centralab

7 to 45 pF

CV11D450

600 VDCW

Capacitor, variable

Ceramic, trimmer

Chassis mount, radial lug

SOAK PERIOD: 16 hours at 10,000 psig

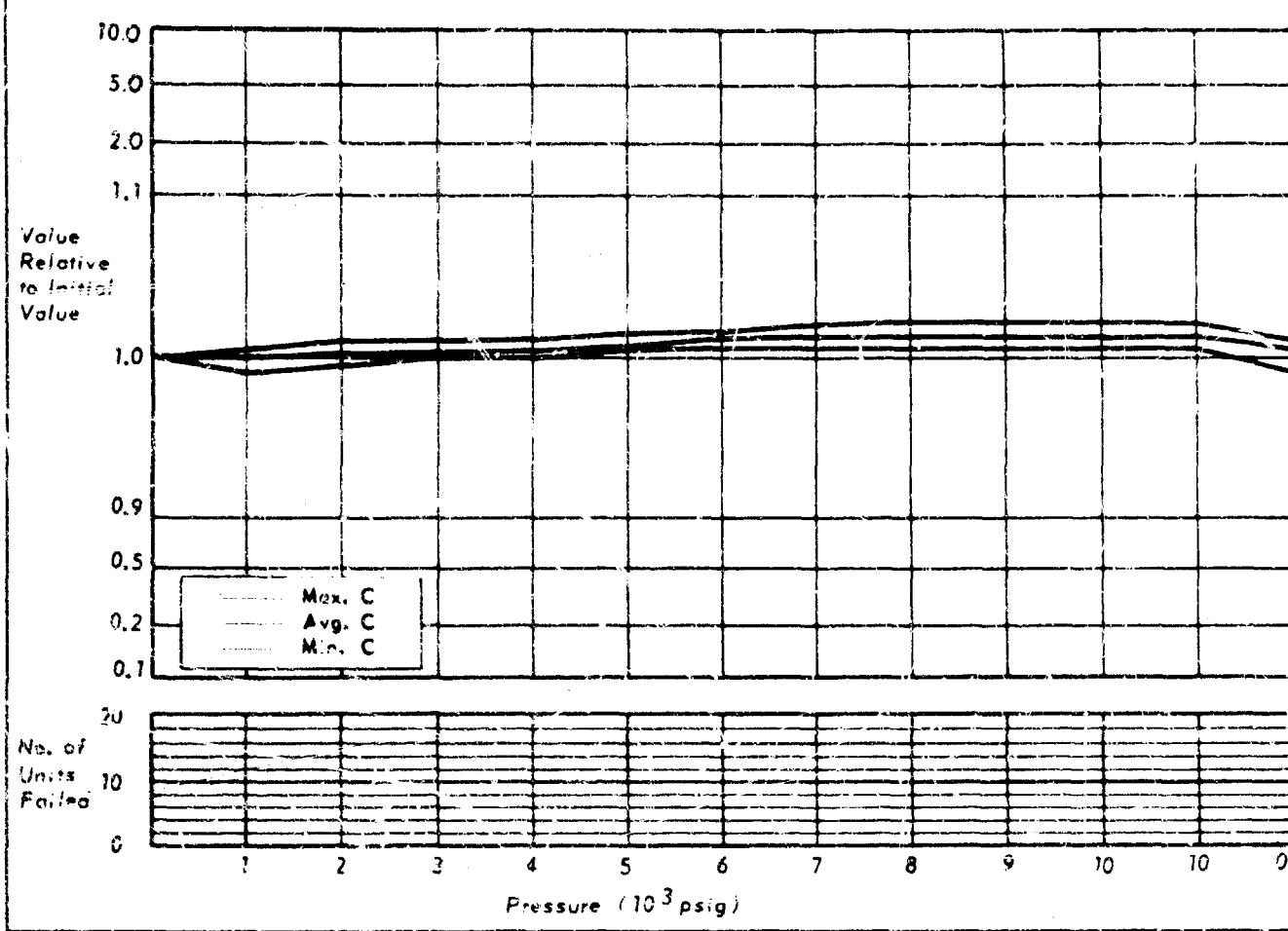
0.64 x 0.84" diam.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

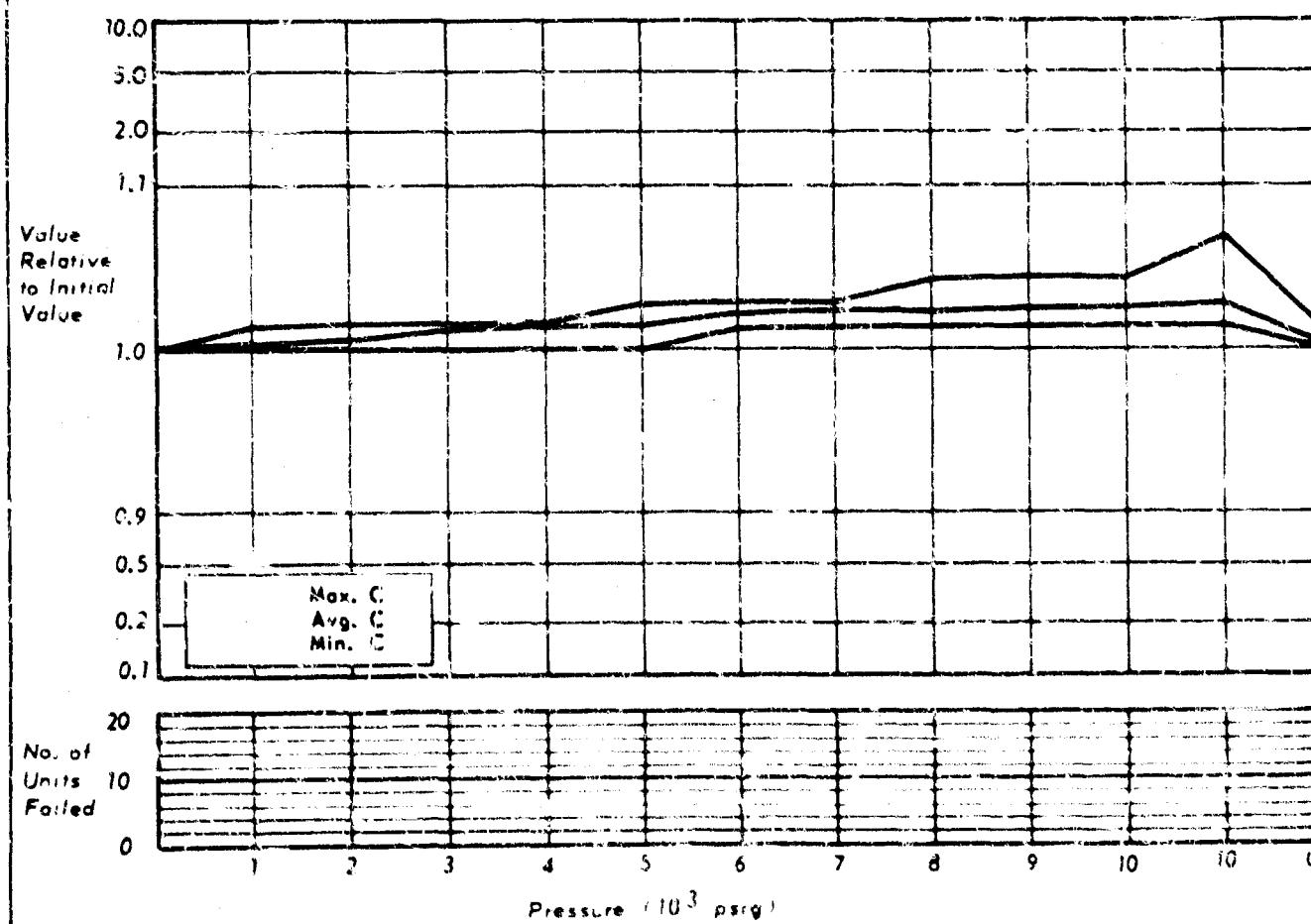
MFG. - CORNELL-DUBLIER
TYPE - CAPACITOR, DPMS 1522, .002 μ F \pm 20%, 100VDCW
DESCRIPTION - PAPER FILM, TUBULAR, RADIAL LEADS

CHART NO. 9
NO. OF SAMPLES TESTED - 18



MFG. - CORNELL-DUBLIER
TYPE - CAPACITOR, DPMS 606, .006 μ F \pm 20%, 600VDCW
DESCRIPTION - PAPER FILM, TUBULAR, RADIAL LEADS

CHART NO. 10
NO. OF SAMPLES TESTED - 18



Cornell-Dubilier	0.002 μ F \pm 20%	Paper, mylar
DPMS 1522	100 VDCW	Tubular, radial lead
Capacitor		Dipped casing
		0.63 x 0.37" diam.

SOAK PERIOD: 15 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier	0.006 μ F \pm 2%	Paper, mylar
DPMS 6D6	500 VDCW	Tubular, radial lead
Capacitor		Dipped casing
		0.69 x 0.34" diam.

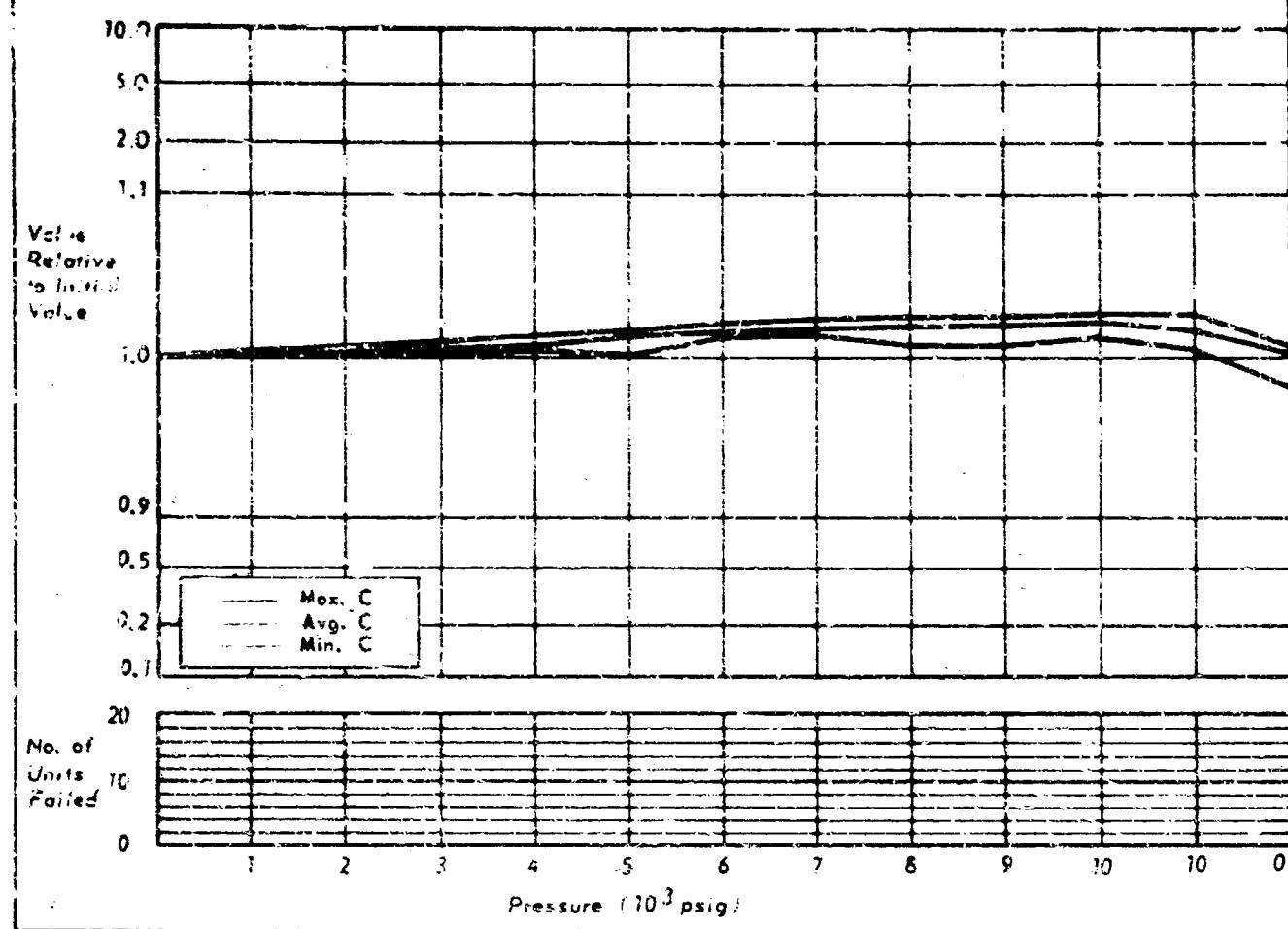
SOAK PERIOD: 16 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

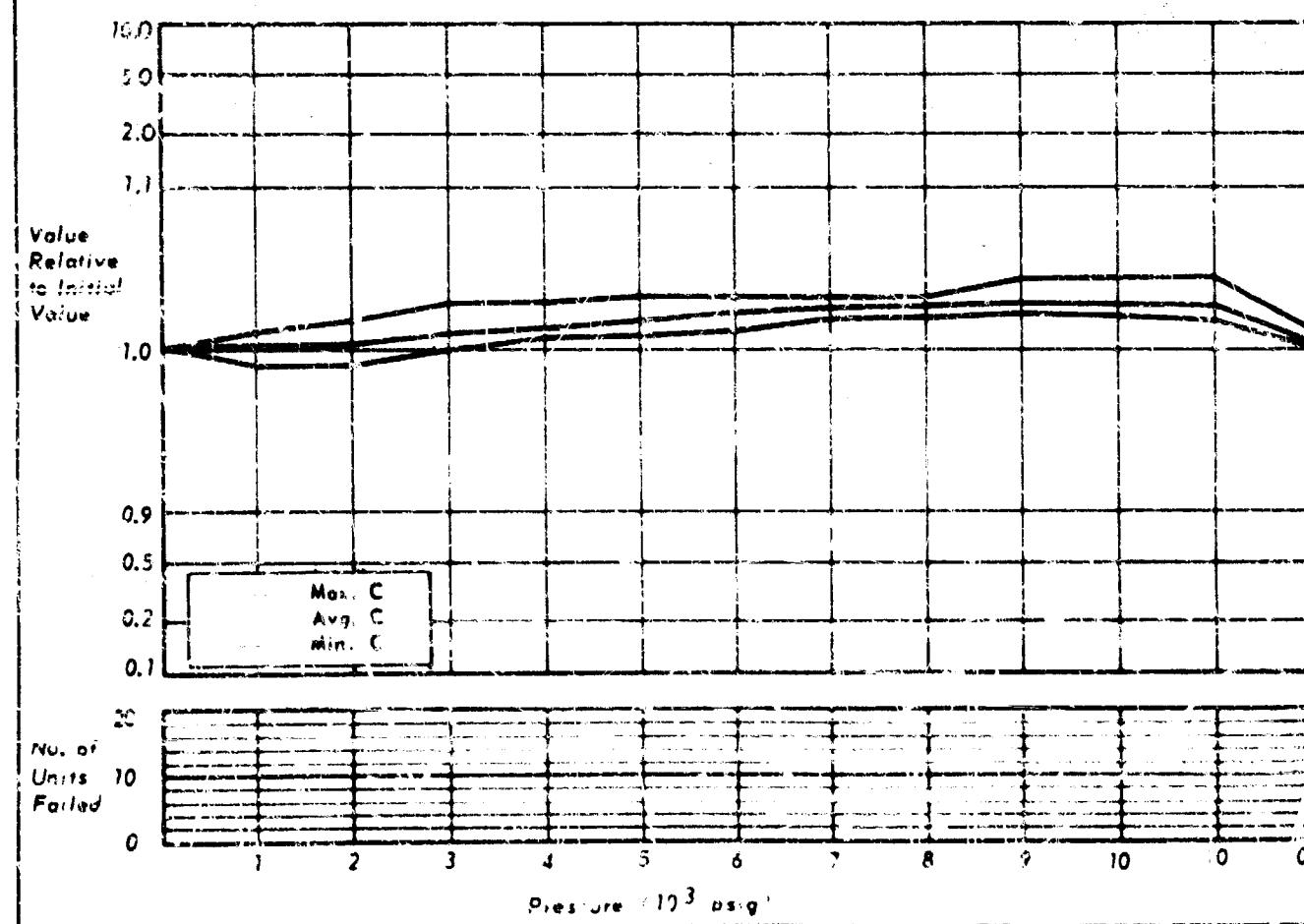
MFG. - CORNELL-DUBLIER
TYPE - CAPACITOR, DPMS 1833, .033 μ F $\pm 20\%$, 100 VDCW
DESCRIPTION - PAPER FILM, TUBULAR, RADIAL LEADS

CHART NO. 11
NO. OF SAMPLES TESTED - 20



MFG. - CORNELL-DUBLIER
TYPE - CAPACITOR, DPMS 4P1, .1 μ F $\pm 20\%$, 400 VDCW
DESCRIPTION - PAPER FILM, TUBULAR, RADIAL LEADS

CHART NO. 12
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier

0.033 μ F \pm 20%

DPMS 1533

500 VDCW

Capacitor

Paper, mylar

Tubular, radial lead

Dipped casing

0.63 x 0.37" diam.

SOAK PERIOD: 16 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier

0.1 μ F \pm 20%

DPMS 4P1

500 VDCW

Capacitor

Paper, mylar

Tubular, radial lead

Dipped casing

0.52 x 1.18" diam.

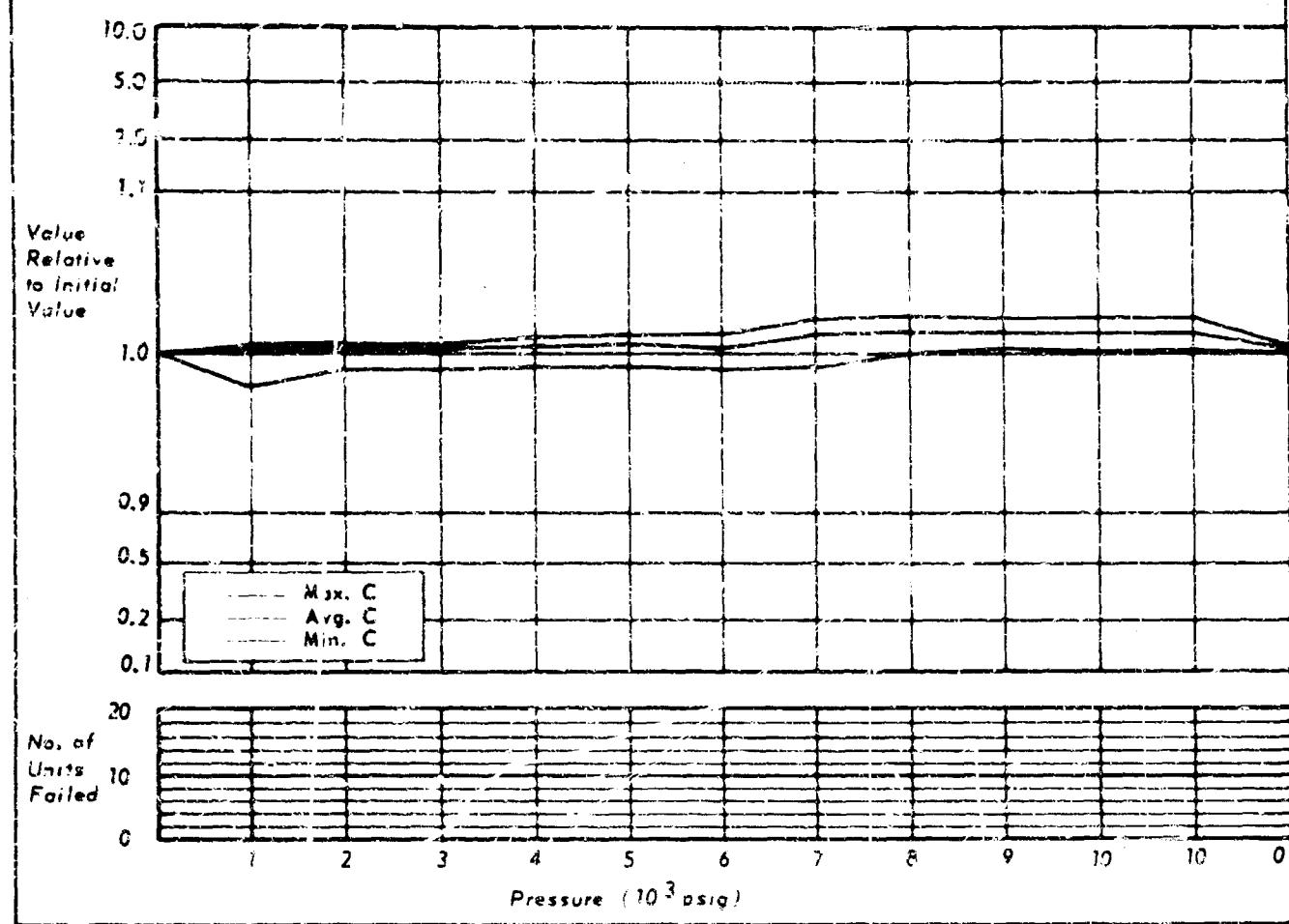
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

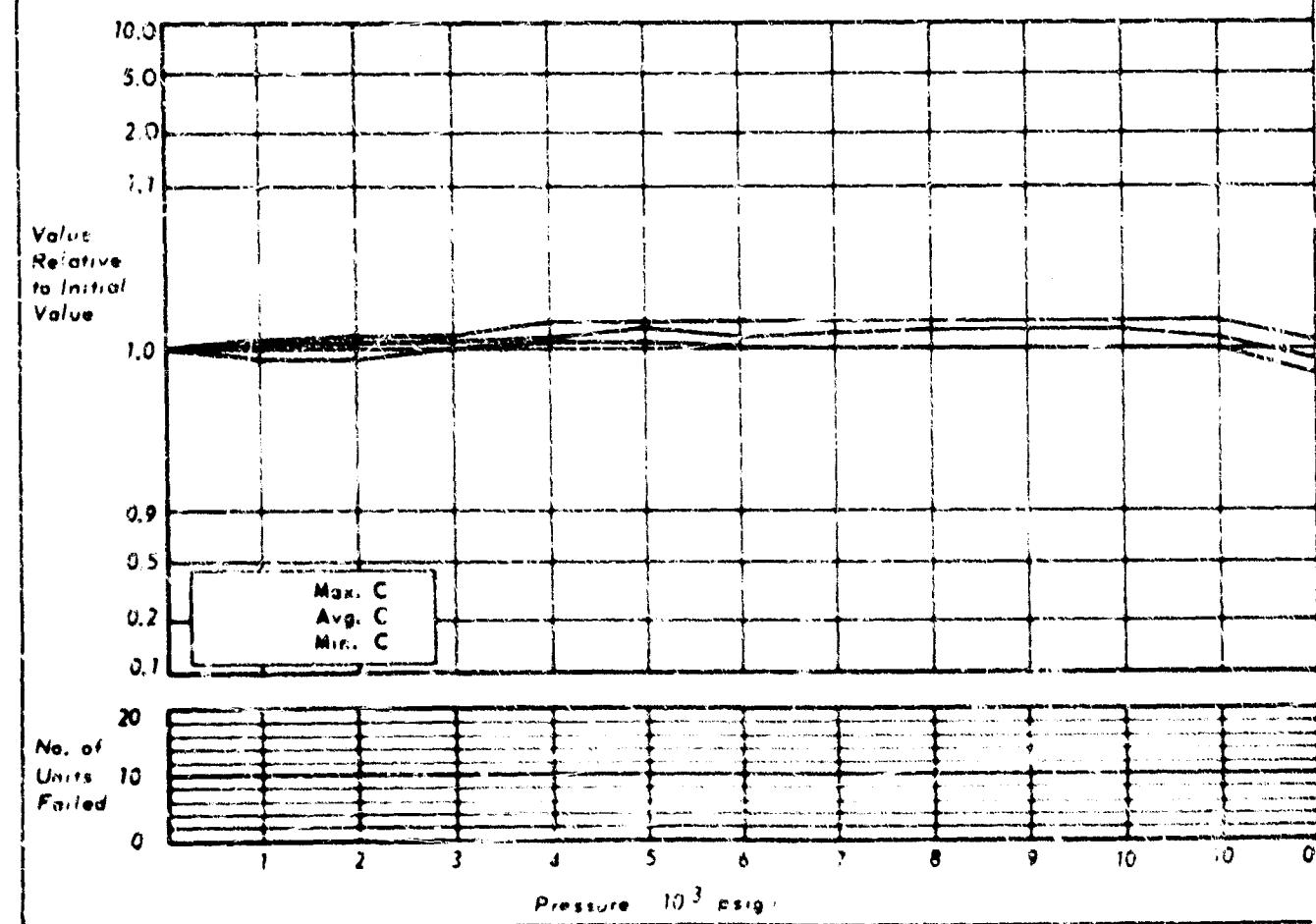
MFG. - CORMELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - DPMS 2P22

CHART NO. 13
NO. OF SAMPLES TESTED - 20



MFG. - CORMELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - DPMS 4P22

CHART NO. 14
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier	0.22 μ F \pm 20%	Paper, mylar
DPMS 2P22	200 VDCW	Tubular, radial lead
Capacitor		Dipped casing
		1.3 x 0.59" diam.

SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier	0.22 \pm μ F \pm 20%	Paper, mylar
DPMS 4P22	400 VDCW	Tubular, radial lead
Capacitor		Dipped casing
		1.56 x 0.62" diam.

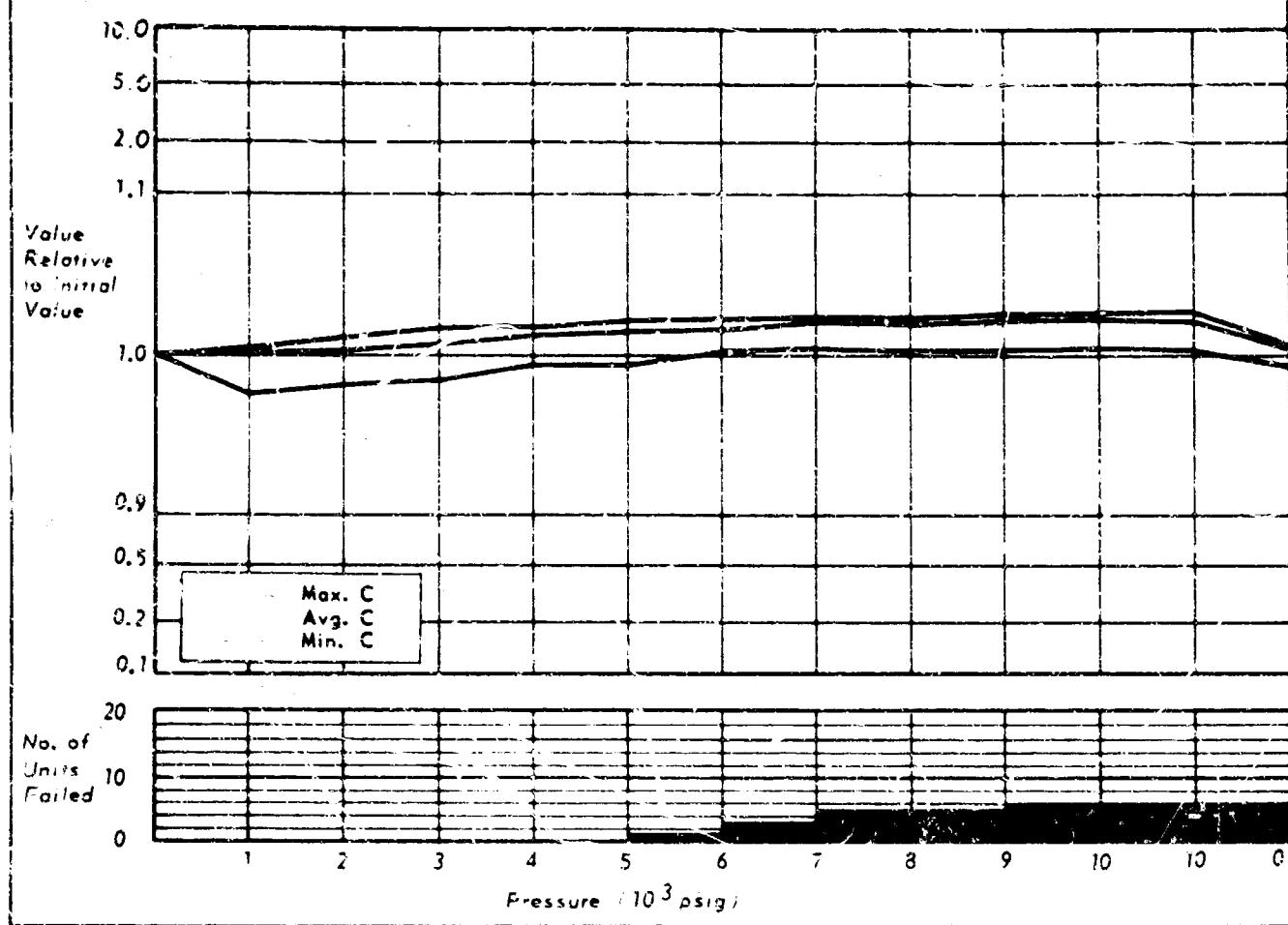
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

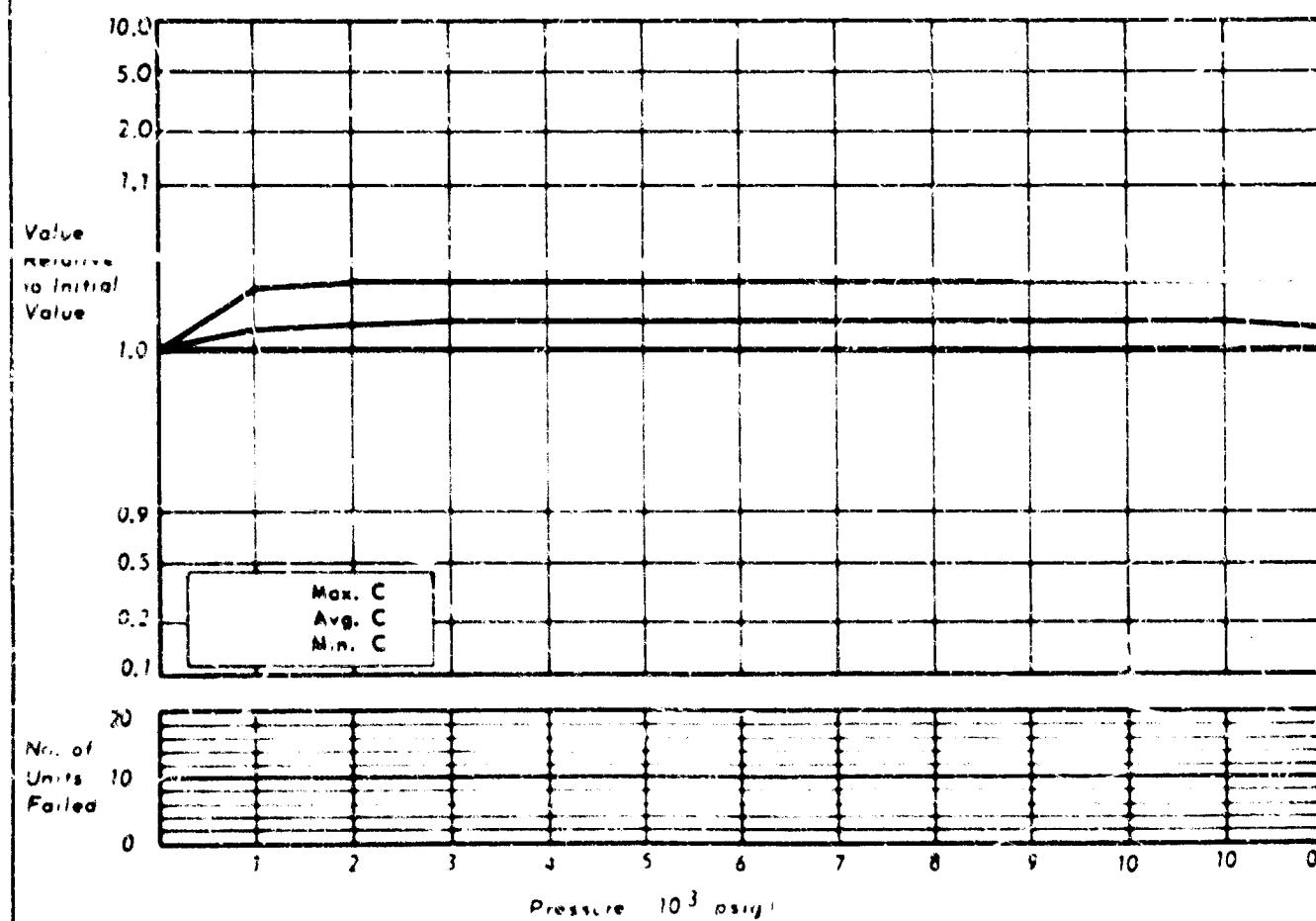
MFG. - CORNELL-DUBLIN
TYPE - CAPACITOR, DPM82P47, .47 μ F 120%, 200 VDCW
DESCRIPTION - PAPER FILM, TUBULAR, RADIAL LEADS

CHART NO. 15
NO. OF SAMPLES TESTED - 20



MFG. - CORNELL-DUBLIN
TYPE - CAPACITOR, PKM 402, .002 μ F 120%, 400 VDCW
DESCRIPTION - SOLID IMPREG, TUBULAR, AXIAL LEAD

CHART NO. 15
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier

0.47 μ F ± 20%

Paper, mylar

DPMS 2P47

200 VDCW

Tubular, radial lead

Capacitor

Dipped coating

1.6 x 0.73" diam

SOAK PERIOD: None

MECHANICAL: Visual inspection after completion of test showed hairline cracks in the casing of three units and a chipped casing on one unit.

ELECTRICAL: Fourteen components indicated less than 10% change.

One component indicated a change greater than 50% with subsequent recovery of pressures shown on failure graph on opposite page.

FAILURES: Five components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.



Cornell-Dubilier

0.002 μ F ± 20%

Solid impreg

PKM4D2

400 VDCW

Tubular, axial lead

Capacitor

Thermoset molded

1.0 x 0.38" diam

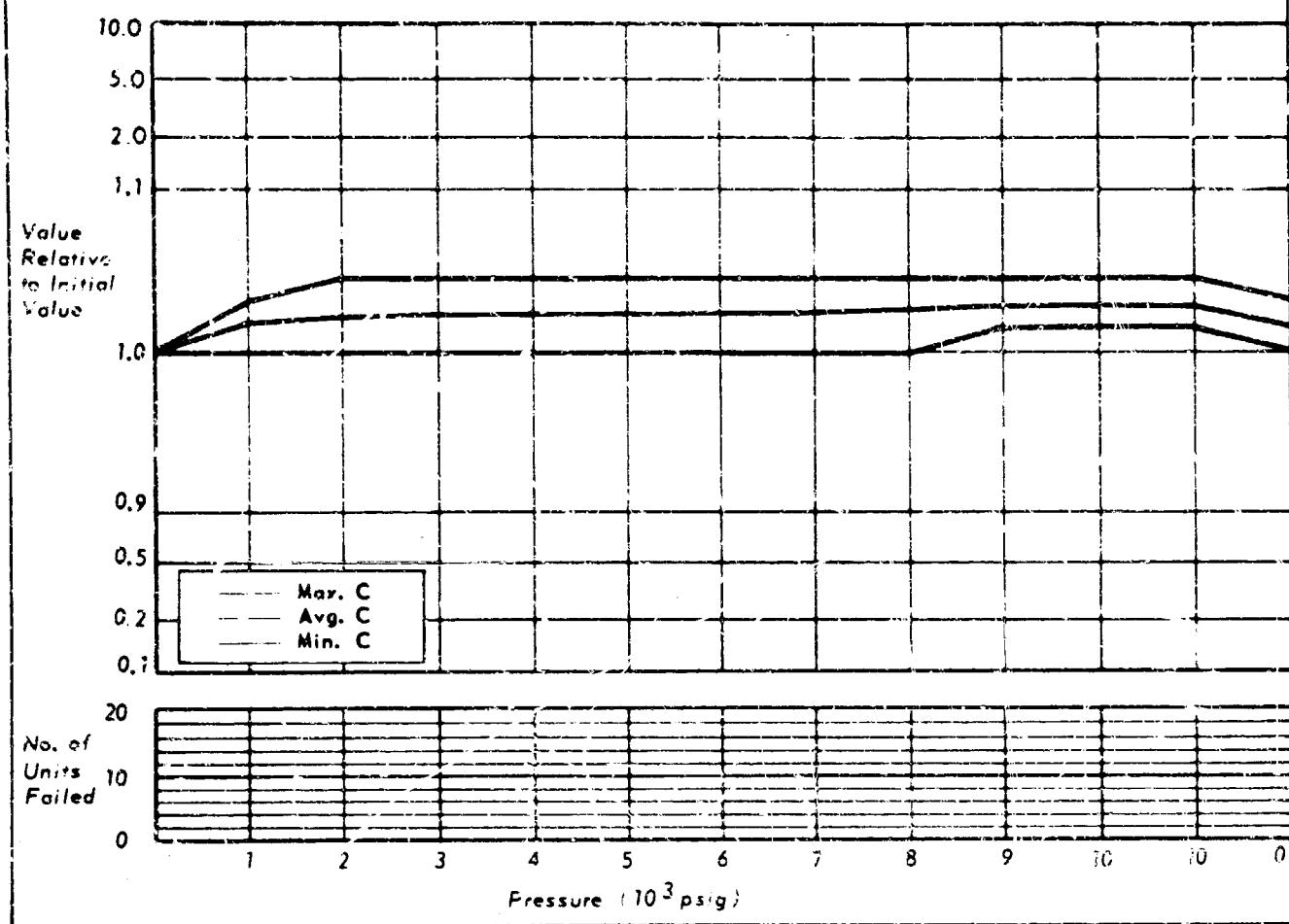
SOAK PERIOD: None

MECHANICAL: No apparent damage

ELECTRICAL: All components indicated less than 10% change.

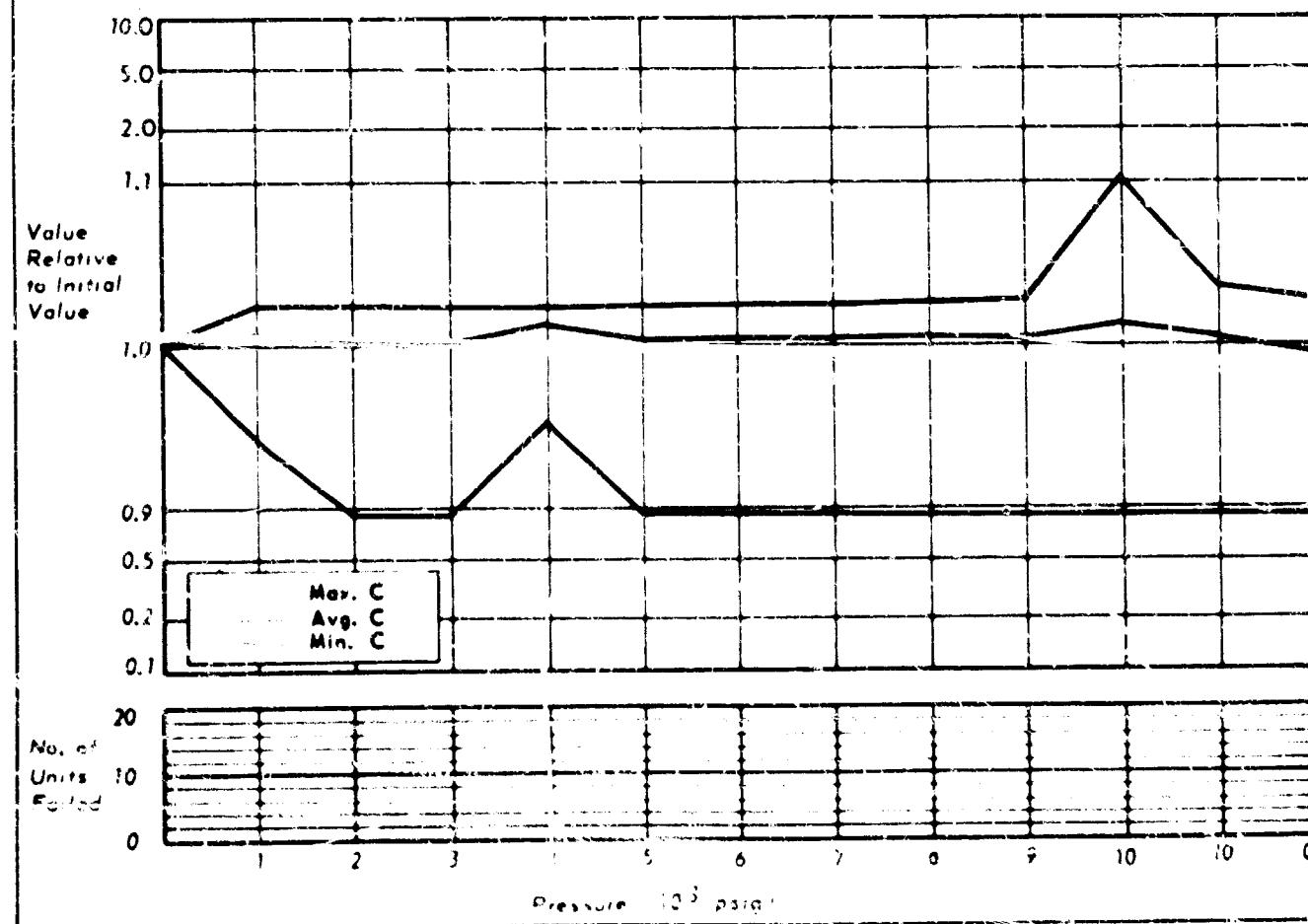
MFG. - CORNELL-DUBLINER
TYPE - CAPACITOR
DESCRIPTION - PKM606

CHART NO. 17
NO. OF SAMPLES TESTED-19



MFG. - CORNELL-DUBLINER
TYPE - CAPACITOR
DESCRIPTION - PKM485

CHART NO. 18
NO. OF SAMPLES TESTED-19



Cornell-Dubilier	0.006 μ F \pm 20%	Solid impreg
PKM 606	600 VDCW	Tubular, axial lead
Capacitor		Thermo et, molded
		1.9 x 0.32" diam.

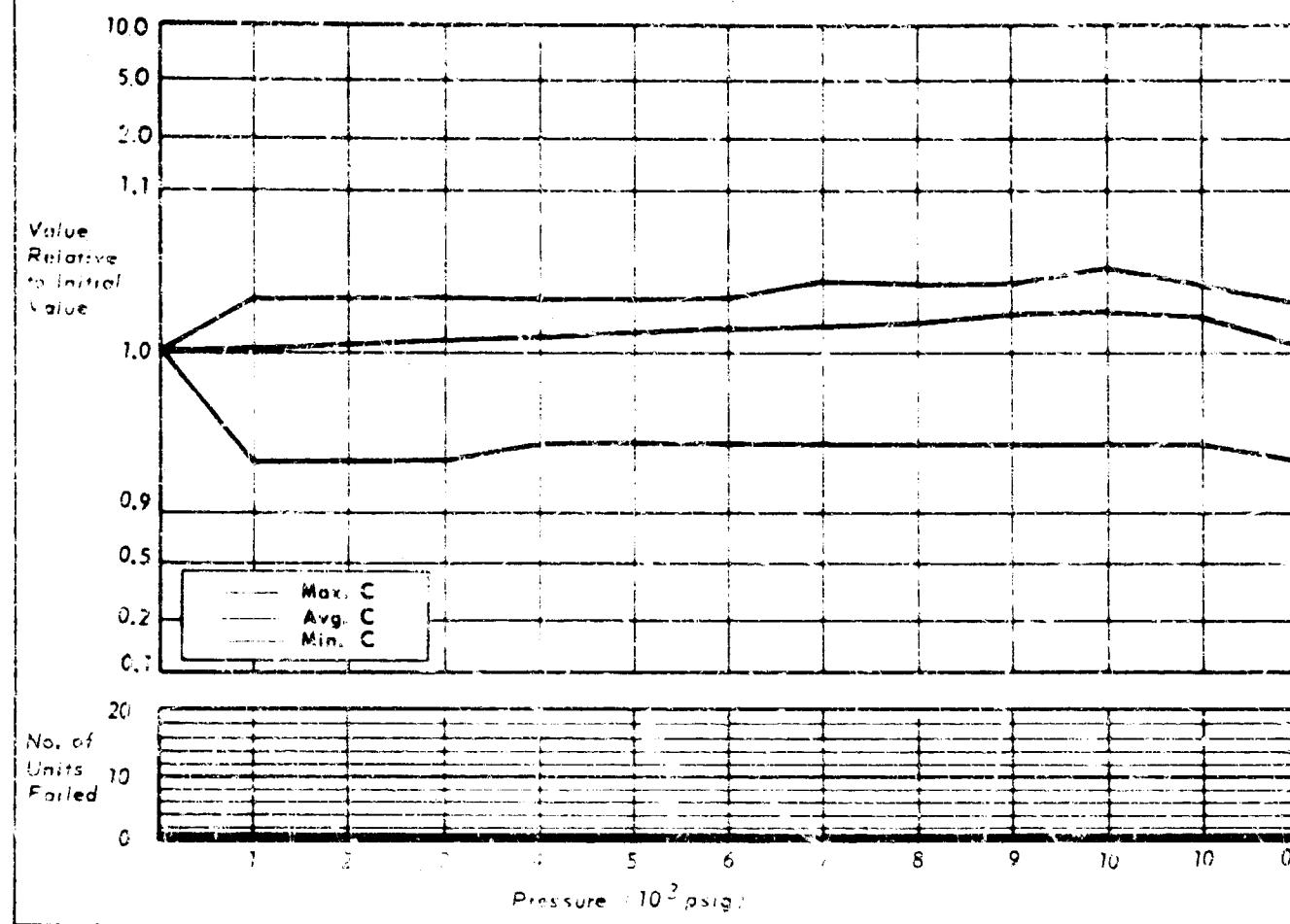
SOAK PERIOD: None
MECHANICAL: No apparent damage
ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier	0.05 μ F \pm 20%	Solid impreg
PKM 655	400 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		1.25 x 0.437" diam.

SOAK PERIOD: None
MECHANICAL: No apparent damage
ELECTRICAL: Eighteen components indicated less than 10% change.
One component indicated a change greater than 10% and less than 50%.

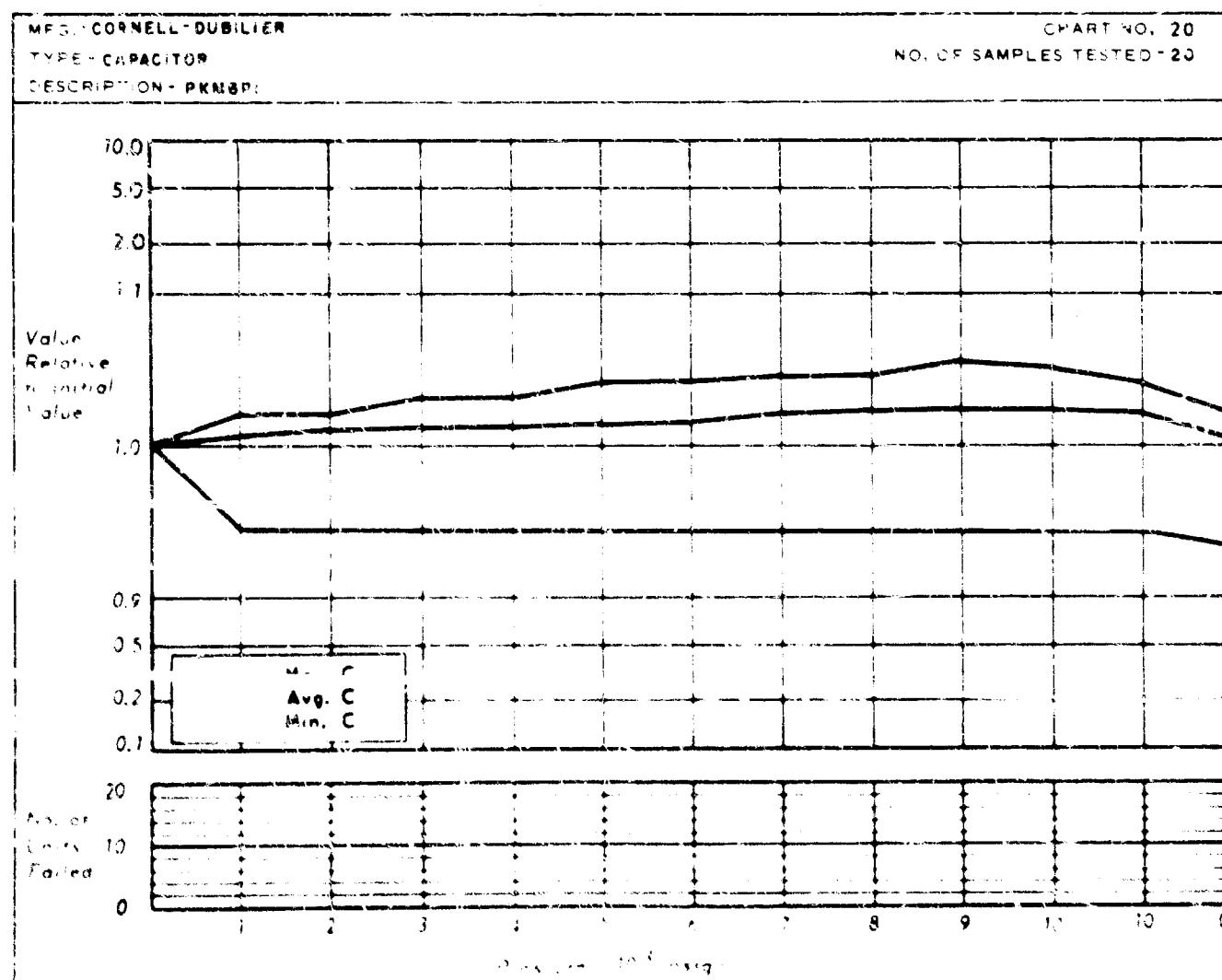
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - PKN281

CHART NO. 19
NO. OF SAMPLES TESTED - 19



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - PKN801

CHART NO. 20
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier	$0.1 \mu\text{F} \pm 20\%$	Solid impreg
PKM 2P1	600 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		1.3 x 0.5" diam.

SOAK PERIOD: 15 hours at 10,000 psig

MECHANICAL: No apparent damage

ELECTRICAL: Eighteen components indicated less than 10% change.

FAILURES: One component indicated a permanent change greater than 50% of the pressures shown on the failure graph on opposite page.

Cornell-Dubilier	$0.1 \mu\text{F} \pm 20\%$	Solid impreg
PKM 6P1	600 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		1.0 x 0.32" diam.

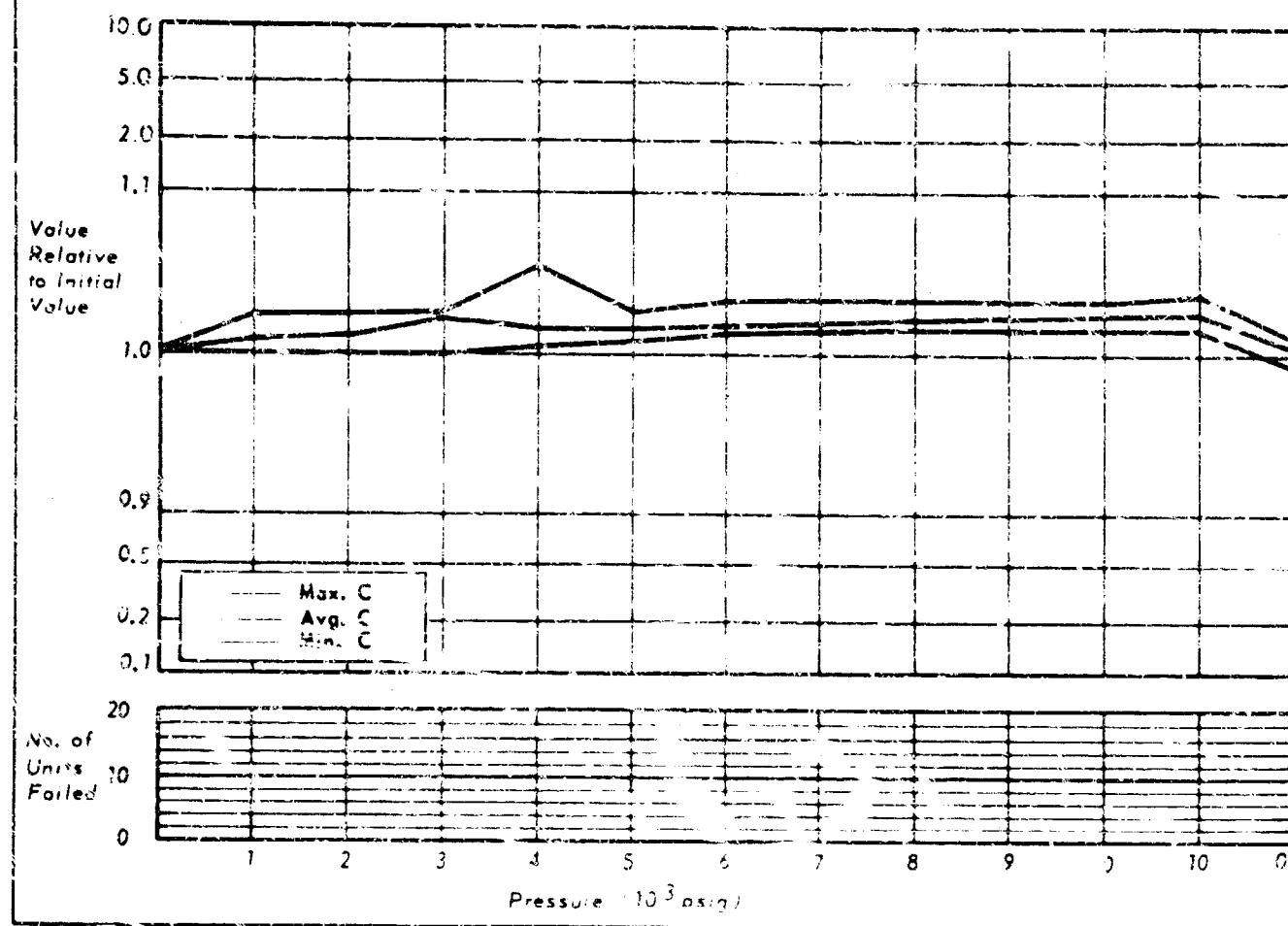
SOAK PERIOD: None

MECHANICAL: No apparent damage

ELECTRICAL: All components indicated less than 10% change.

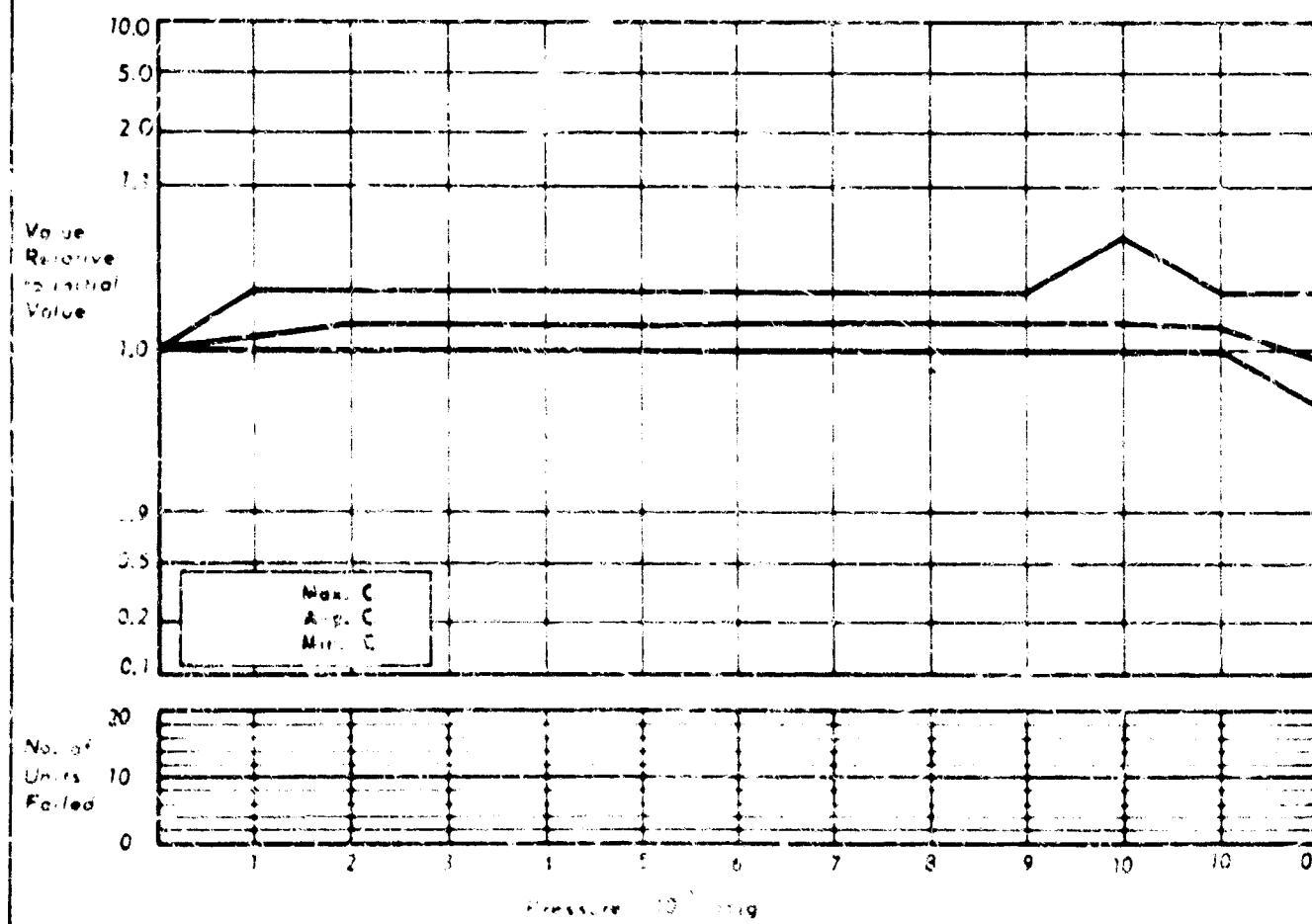
MFG.-CORNELL-DURACIER
TYPE-CAPACITOR
DESCRIPTION-PRM2P23

CHART NO. 21
NO. OF SAMPLES TESTED-20



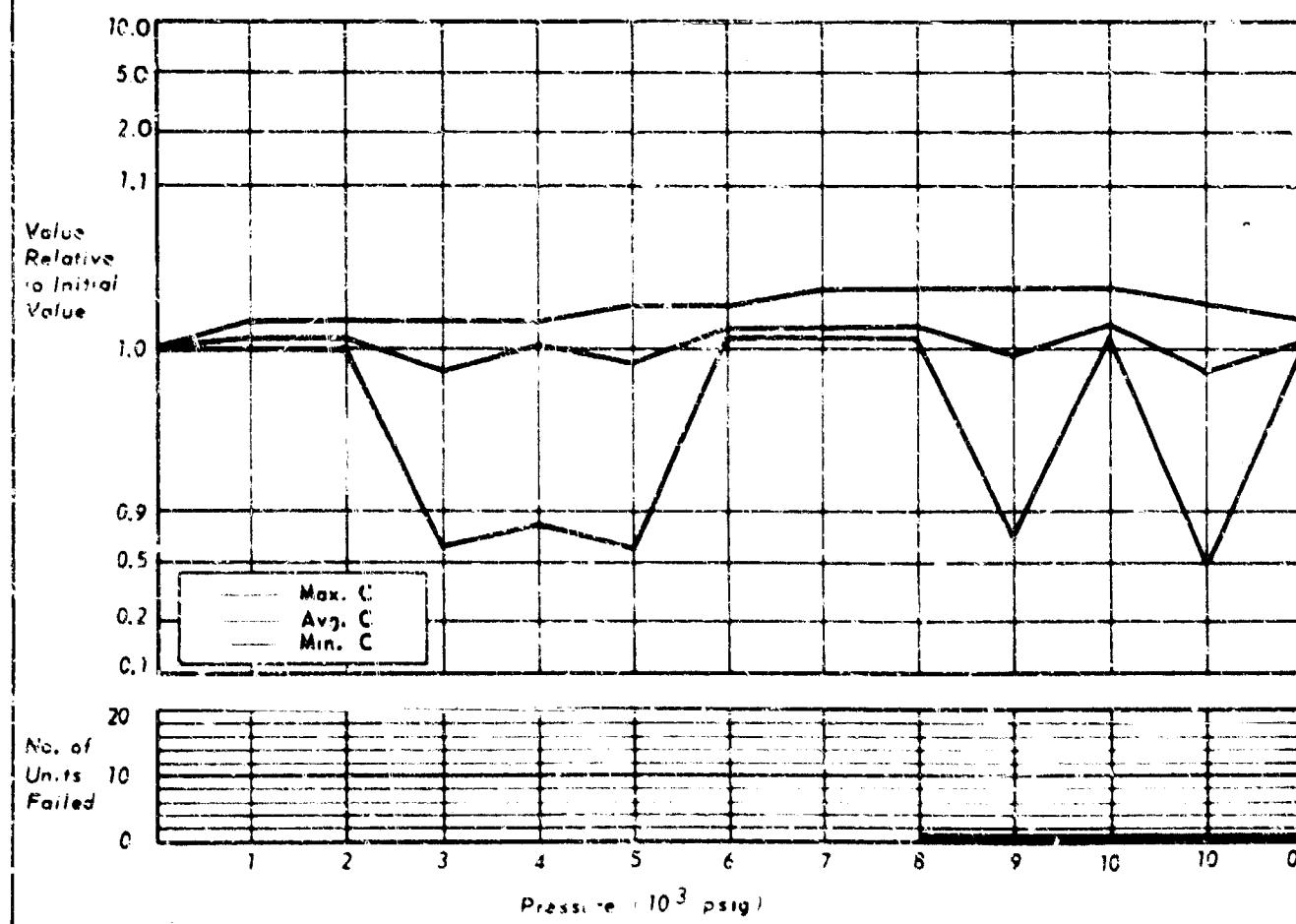
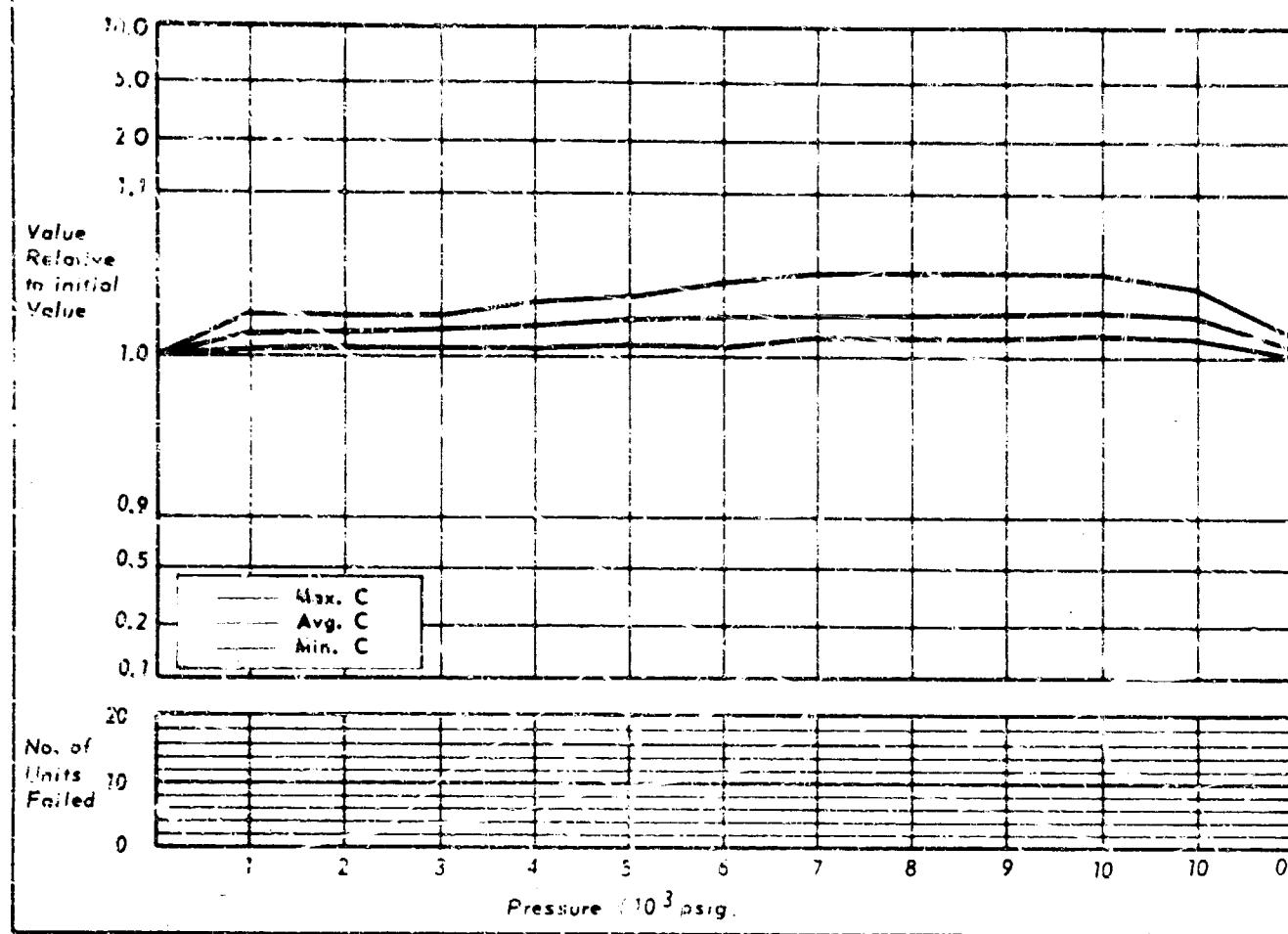
MFG.-CORNELL-DURACIER
TYPE-CAPACITOR
DESCRIPTION-PRM6P23

CHART NO. 22
NO. OF SAMPLES TESTED-19



Cornell-Dubilier	0.25 μ F \pm 20%	Solid impreg
PKM 2P25	200 VDCW	Tubular, axial lead
Capacitor		Thermoset incised
		1.87 \times 0.62" diam.
SOAK PERIOD:	16 hours at 8,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated less than 10% change.	

Cornell-Dubilier	0.3 μ F \pm 20%	Solid impreg
PKM 6P3	600 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		1.56 \times 0.56" diam.
SOAK PERIOD:	16 hours at 10,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated less than 10% change.	



Cornell-Dubilier	0.47 μ F \pm 20%	Solid impreg
PKM 4P47	400 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		1.94 x 0.68" diam.

SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10%

Cornell-Dubilier	1.0 μ F \pm 20%	Solid impreg
PKM 2W1	200 VDCW	Tubular, axial lead
Capacitor		Thermoset molded
		2.125 x 1.0" diam.

SOAK PERIOD: None

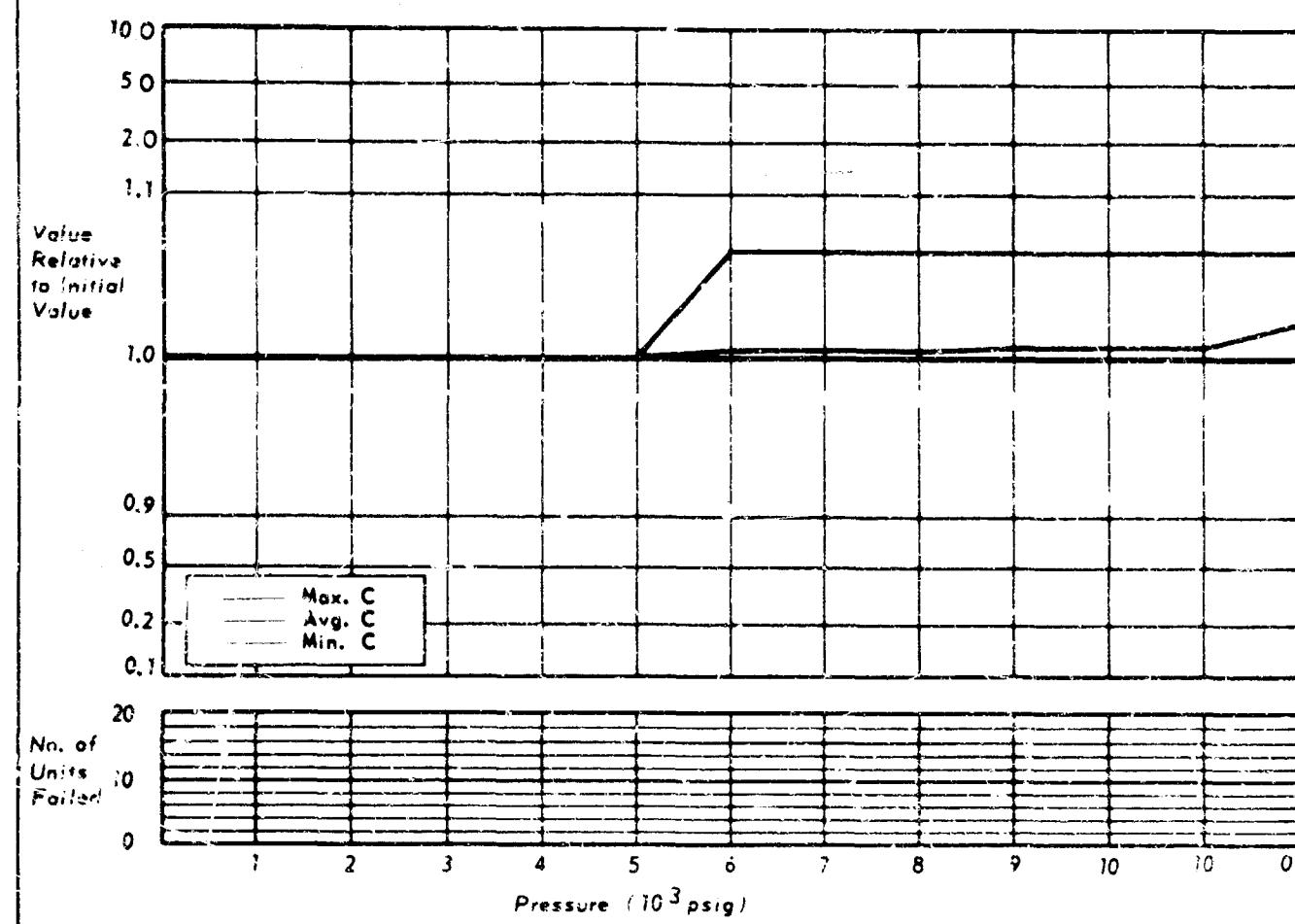
MECHANICAL: No apparent damage.

ELECTRICAL: Nineteen components indicated less than 10% change.

One component indicated a change greater than 50% with subsequent recovery at pressures shown on failure graph on opposite page. Recovery of the failing sample was on return to 0.

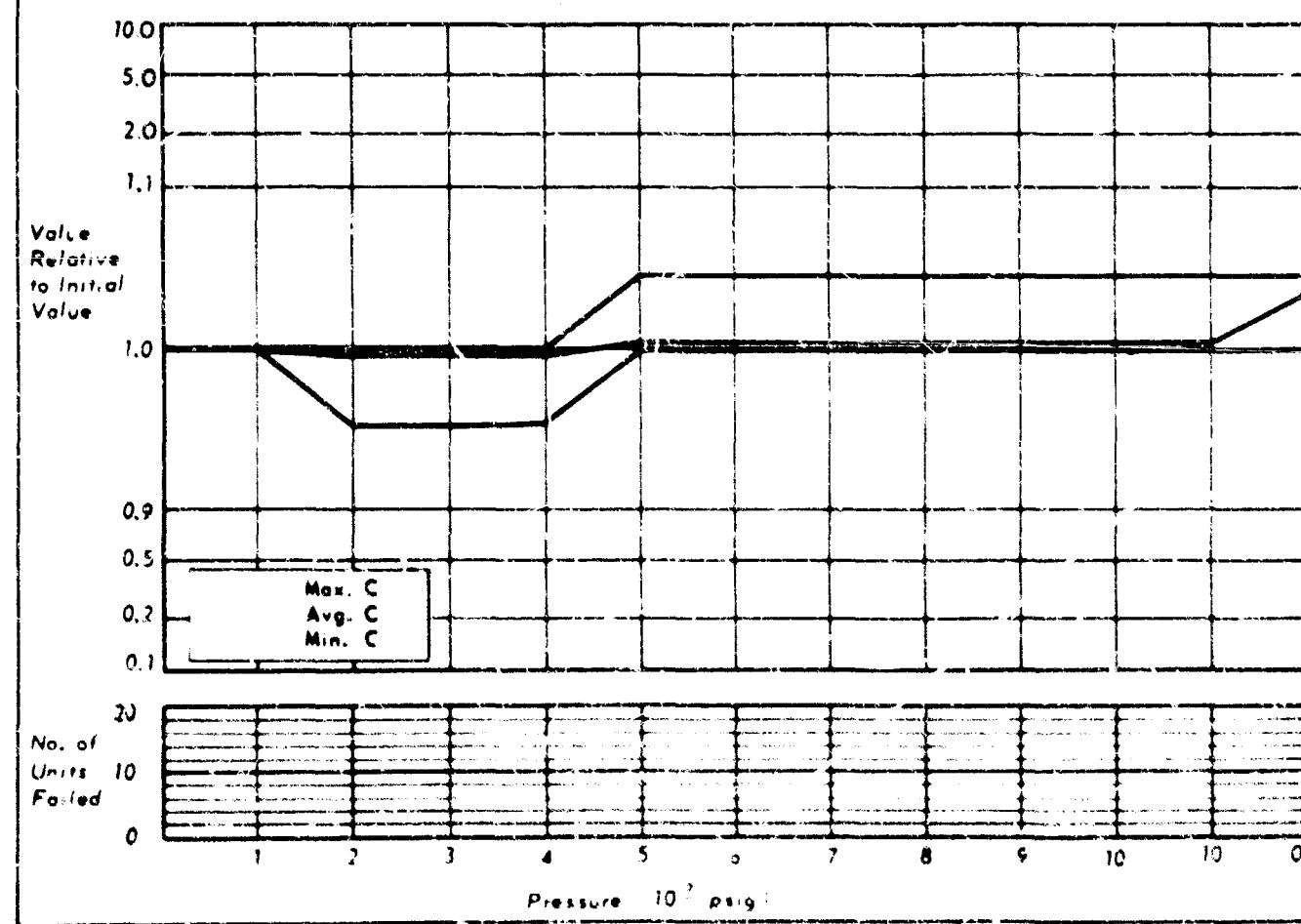
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - JB .001M-V

CHART NO. 25
NO. OF SAMPLES TESTED - 20



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - F8H602M

CHART NO. 26
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier	0.001 μ F \pm 20%	Ceramic, disc
JB	Voltage as requested	Florinated
Capacitor		Glass encap
		0.437" diam x 0.15" th.

SOAK PERIOD: None

MECHANICAL: No apparent damage

ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier	0.002 μ F \pm 15%	Ceramic, disc
FGH 6D2M	500 VDCW	Florinated
Capacitor		Glass encap
		0.29 diam x 0.18" th.

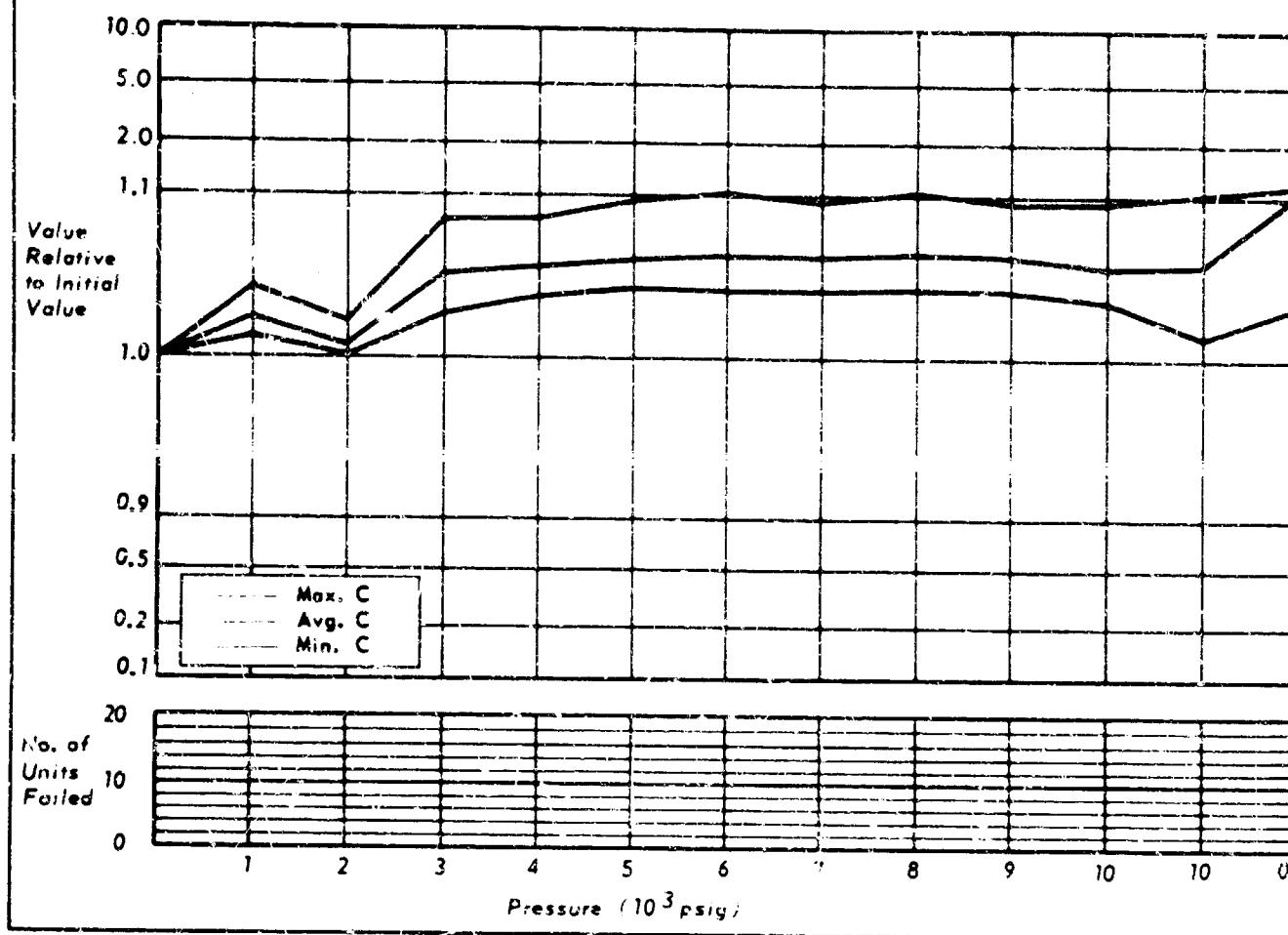
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

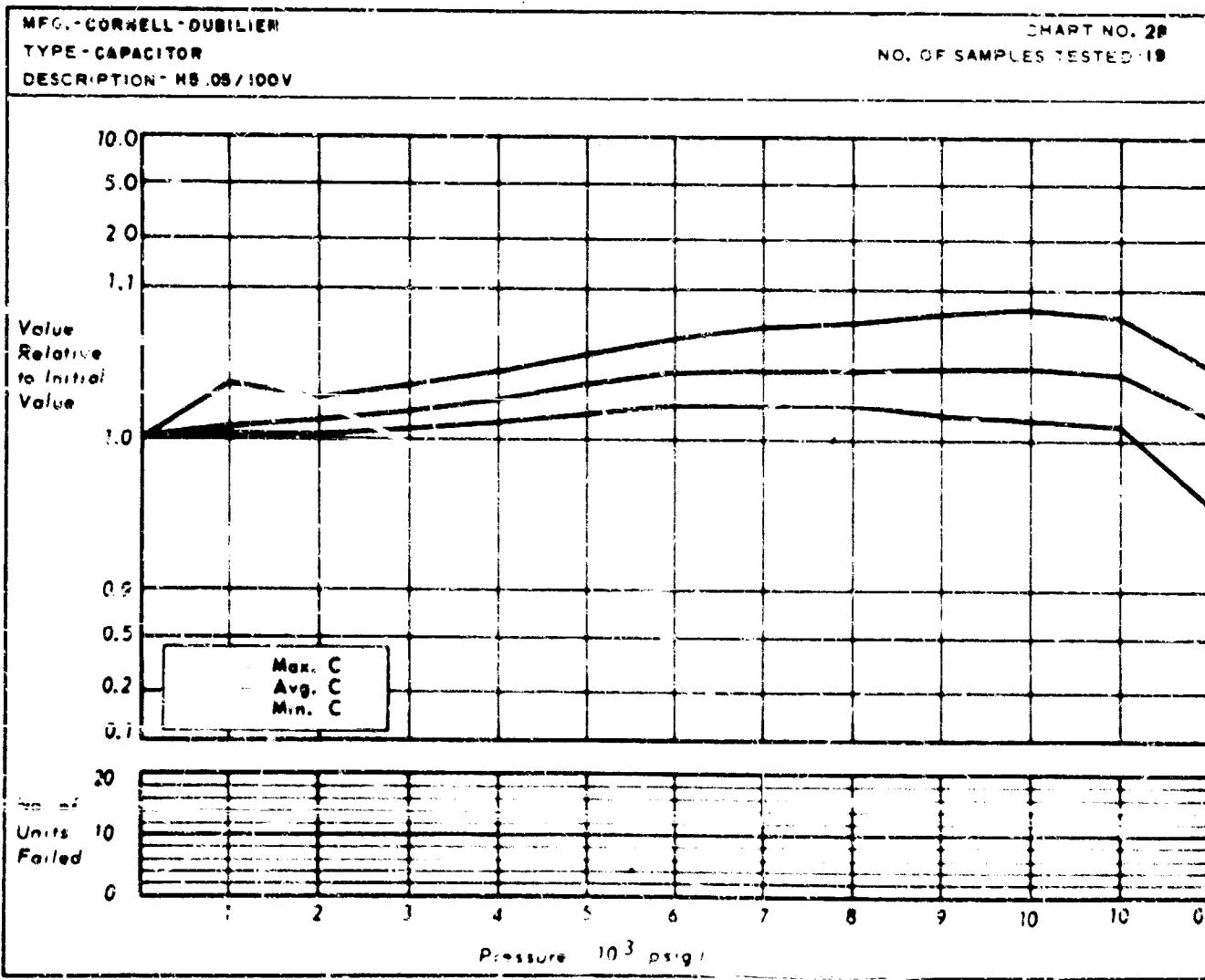
MFG.-CORNELL-DUBILIER
TYPE-CAPACITOR
DESCRIPTION-BYA.01 6KV

CHART NO. 27
NO. OF SAMPLES TESTED-18



MFG.-CORNELL-DUBILIER
TYPE-CAPACITOR
DESCRIPTION-HB.08/100V

CHART NO. 28
NO. OF SAMPLES TESTED-18



Cornell-Dubilier	0.01 μ F GMV	Ceramic, disc
BYA 651	600 VDCW	Wax impreg
Capacitor		Phenolic dip
		0.62 diam x 0.15" th.

SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: Eighteen components indicated less than 10% change.

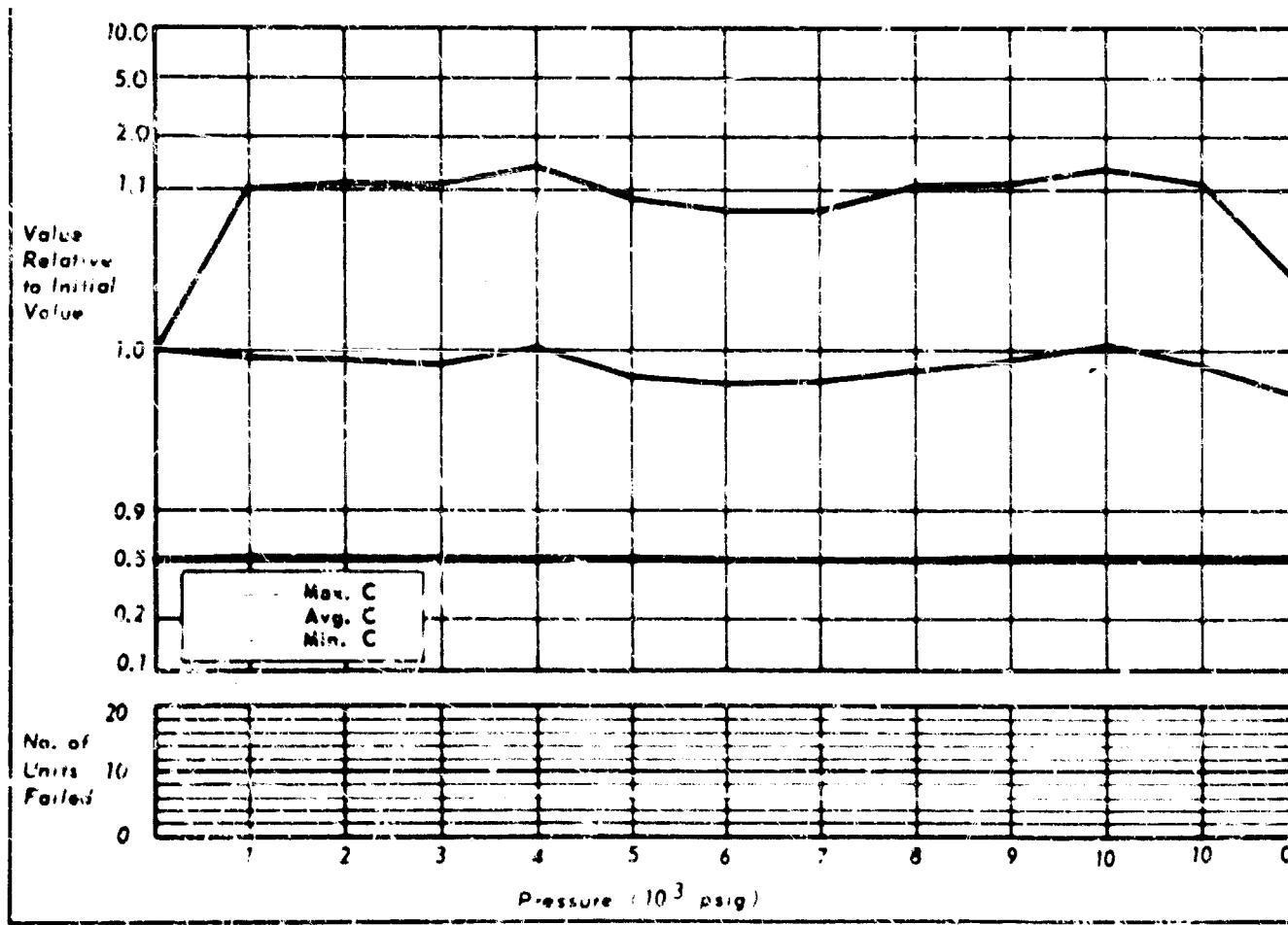
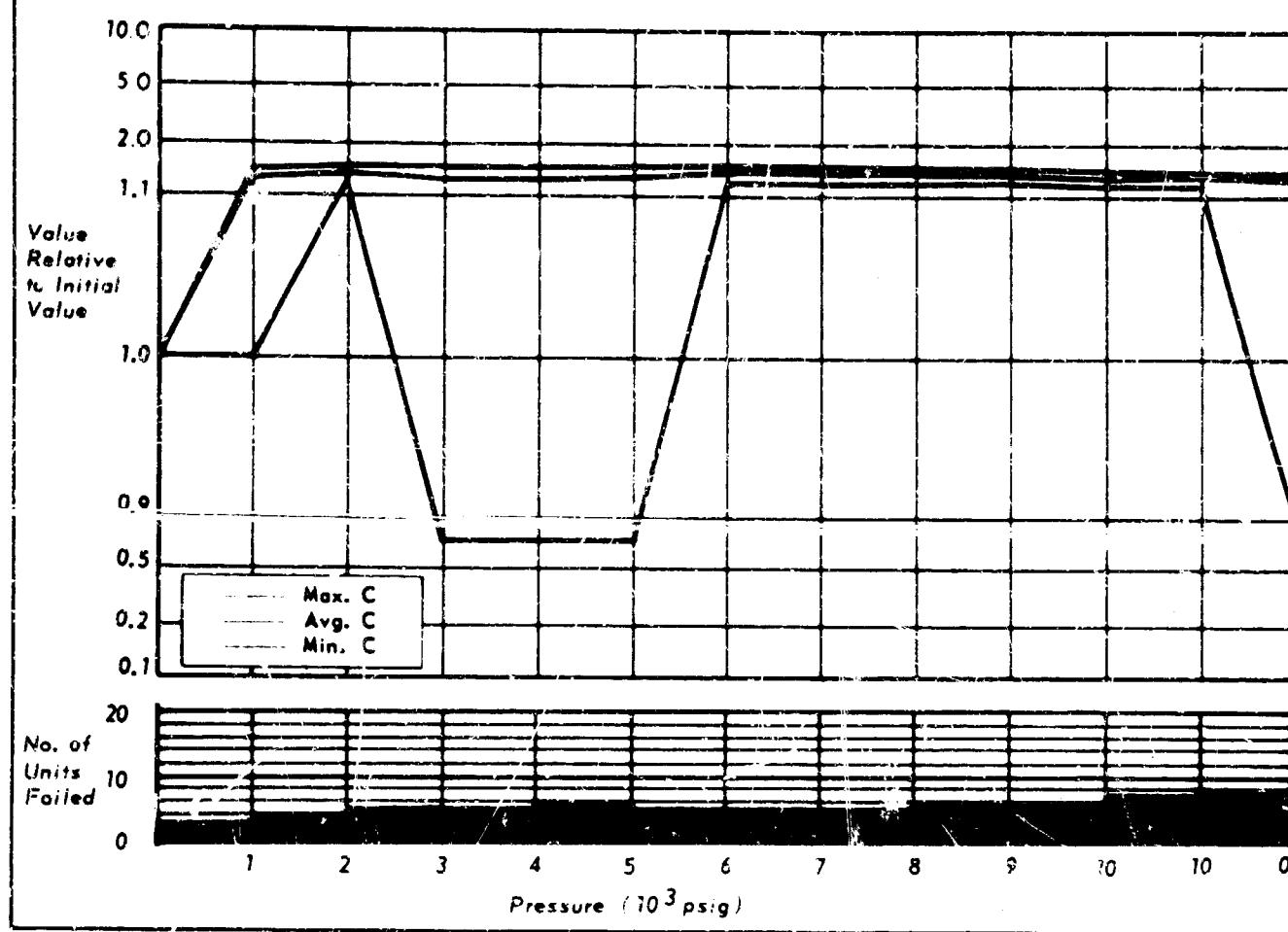
One component indicated a change greater than 10% and less than 50%.

Cornell-Dubilier	0.05 μ F ⁺⁸⁰ ₋₂₀ %	Ceramic disc
H5	100 VDCW	Wax impreg
Capacitor		Phenolic dip
		0.625 diam x 0.125" th.

SOAK PERIOD: None

MECHANICAL: No apparent damage

ELECTRICAL: All components indicated less than 10% change.



Cornell-Dubilier	5.0 μ F	Electrolytic
BWH 5-150	150 V	Tubular, axial lead
Capacitor		1.58 x 0.5" diam

SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: Visual inspection after completion of test showed deformation of the metal casing and displacement of end seals on eighteen components.

ELECTRICAL: Ten components indicated a change greater than 10% and less than 50%.

Five components indicated a change greater than 50% with subsequent recovery of pressures shown on failure graph on opposite page.

FAILURES: Five components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

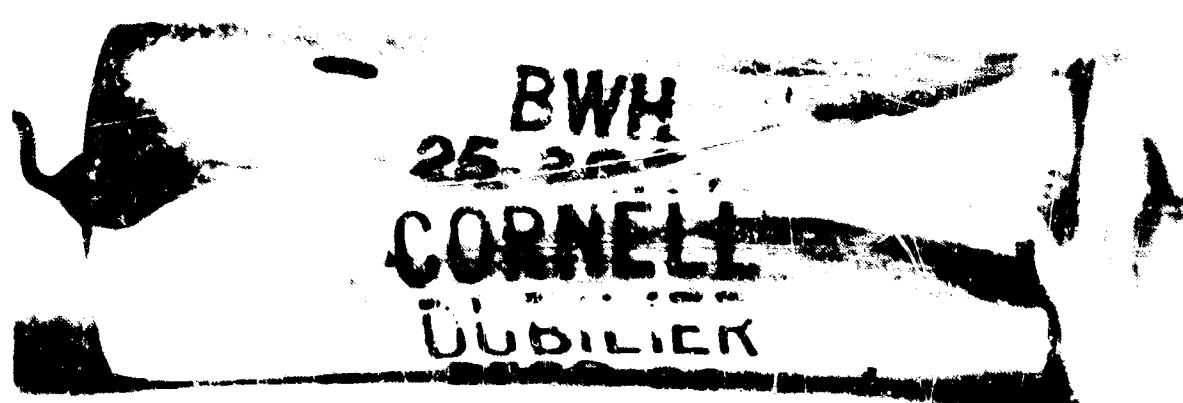


Cornell-Dubilier	25.0 μ F	Electrolytic
BWH 25-300	300 V	Tubular, axial lead
Capacitor		U1% purity foil
		2.125 x 0.75" diam

SOAK PERIOD: None

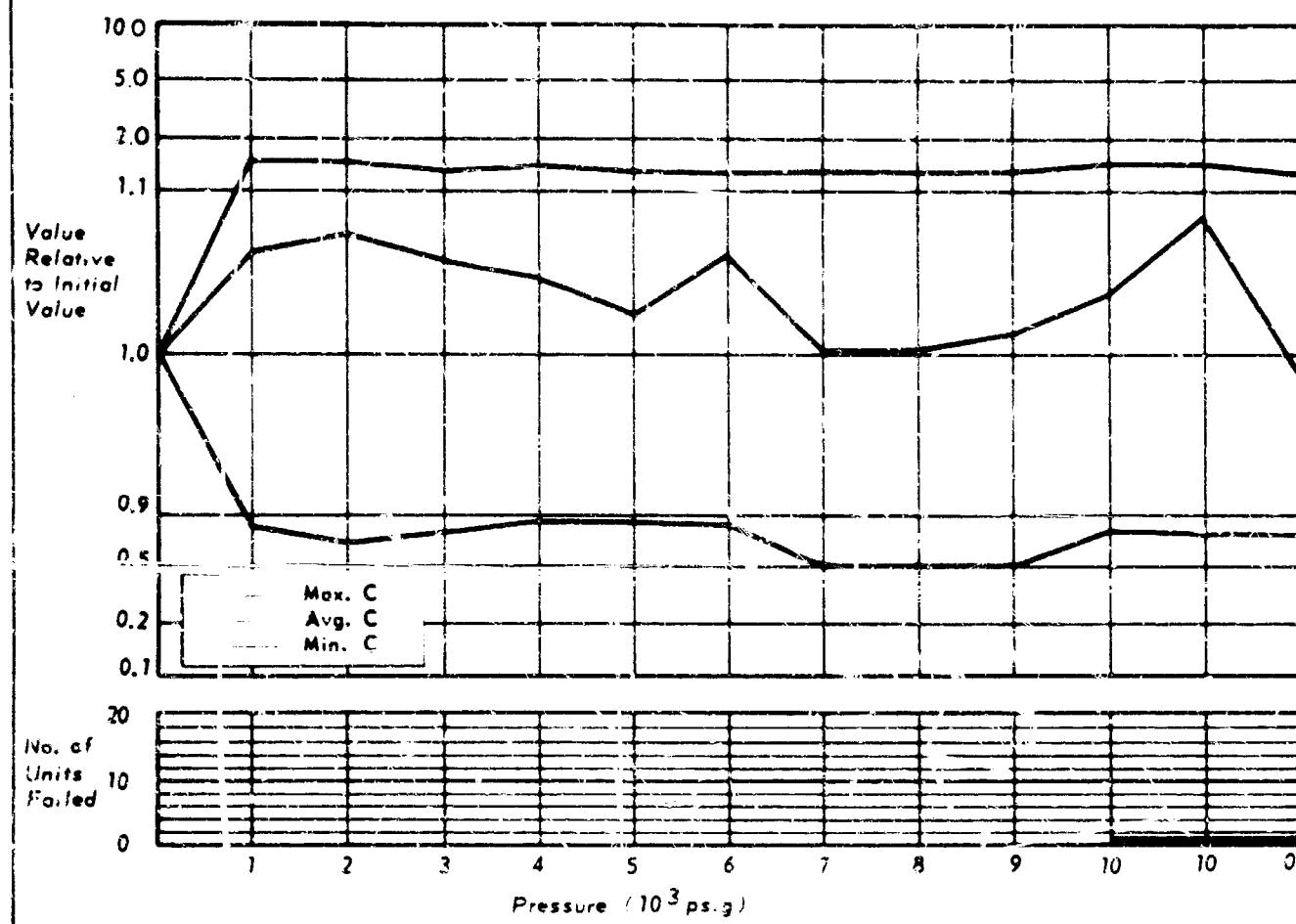
MECHANICAL: Visual inspection after completion of test showed slight deformation of all metal cases. One seal appeared ruptured as evidenced by an oil deposit in the external teflon case.

ELECTRICAL: All components indicated a change greater than 10% and less than 50%.



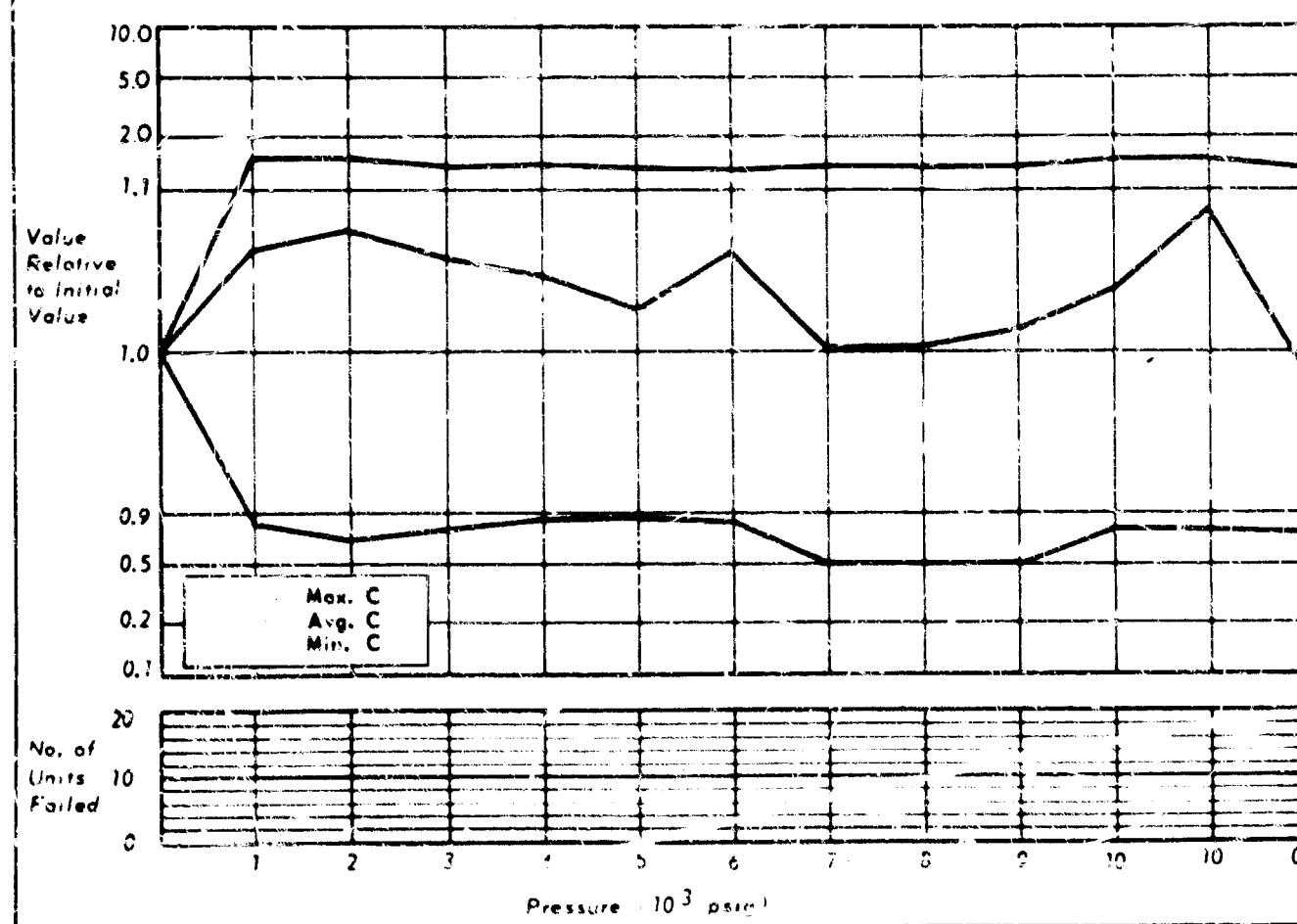
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - BWH 50-50

CHART NO. 31
NO. OF SAMPLES TESTED - 20



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - NEW 10-12

CHART NO. 32
NO. OF SAMPLES TESTED - 19



Cornell-Duhilier

50.1 μ F

Electrolytic

BWH 50-50

50 WV

Tubular, axial lead

Capacitor

Aluminum foil

1.62 x 0.62" diam

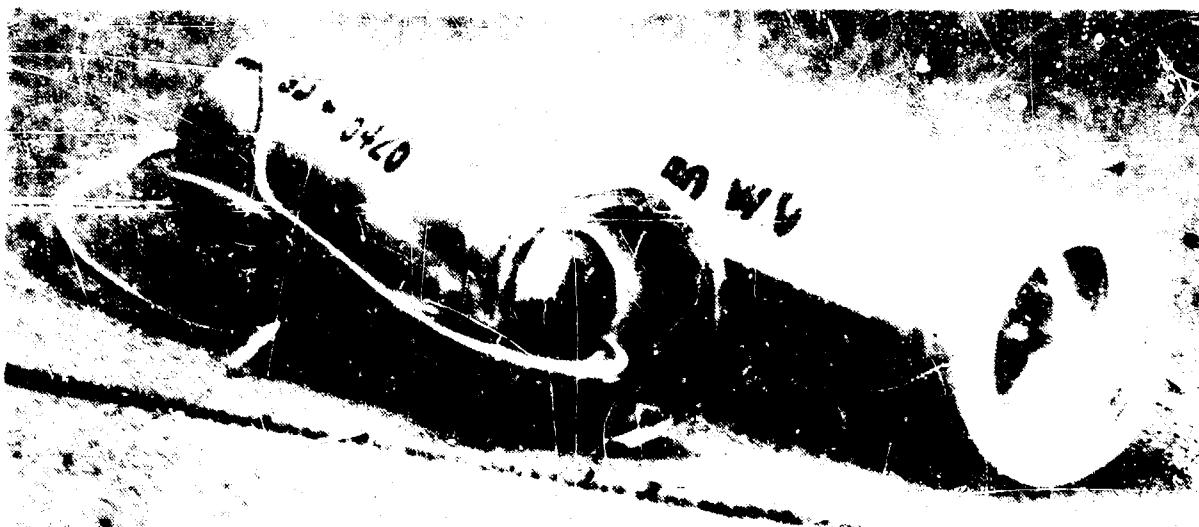
SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: Visual inspection after completion of test showed slight deformation of three metal cases, end seal displacement of five samples, and insulation extrusion of two samples.

ELECTRICAL: Nine components indicated less than 10% change.

Ten components indicated a change greater than 10% and less than 50%.

FAILURES: One component indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.



Cornell-Duhilier

10 μ F $^{+15}_{-10}$ %

Electrolytic

NLW 10-12

12 V

Tubular, axial lead

Capacitor

1.58 x 0.5" diam

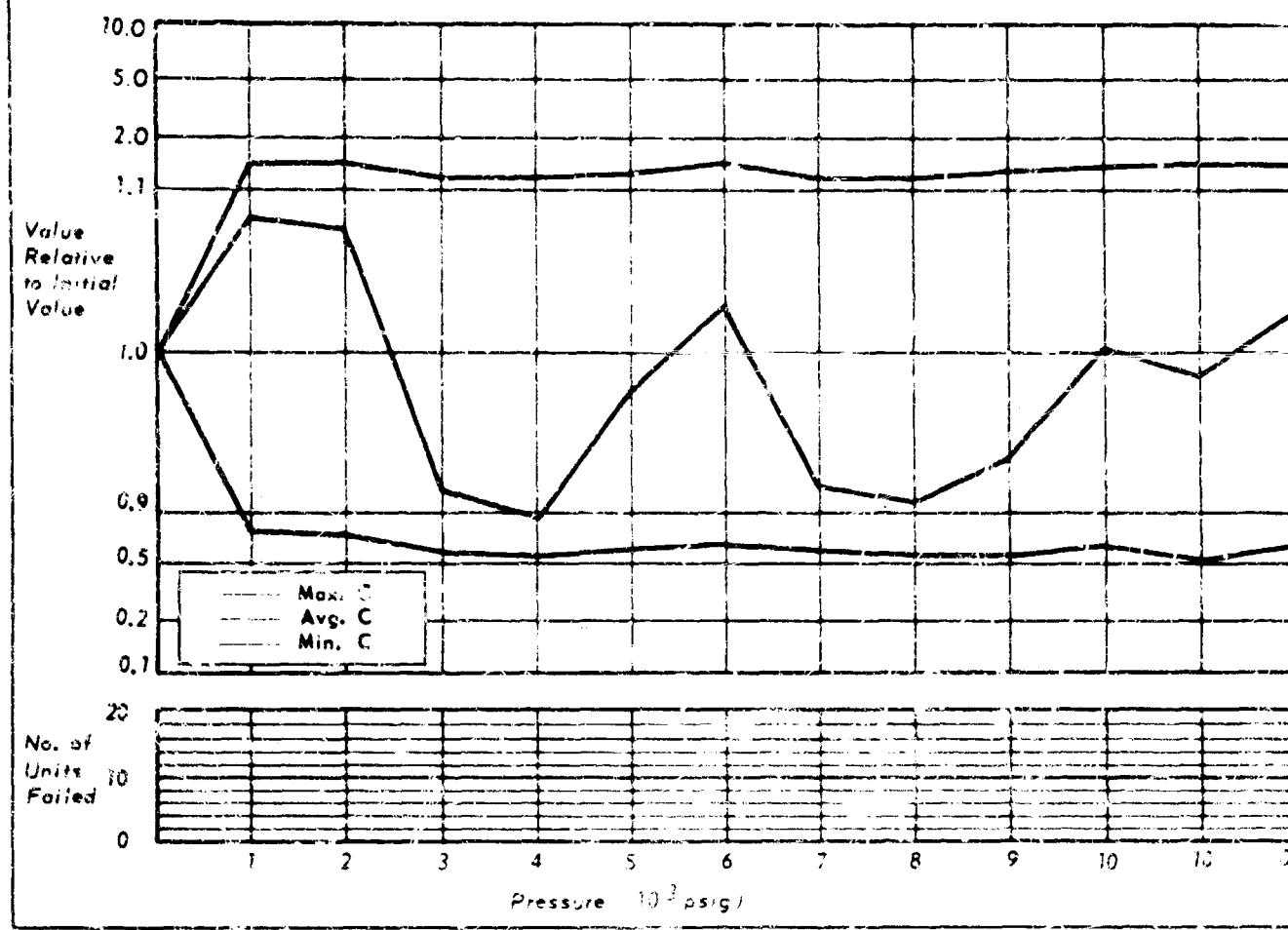
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: One component indicated a change greater than 10% and less than 50%.
All other components had less than 10% change.

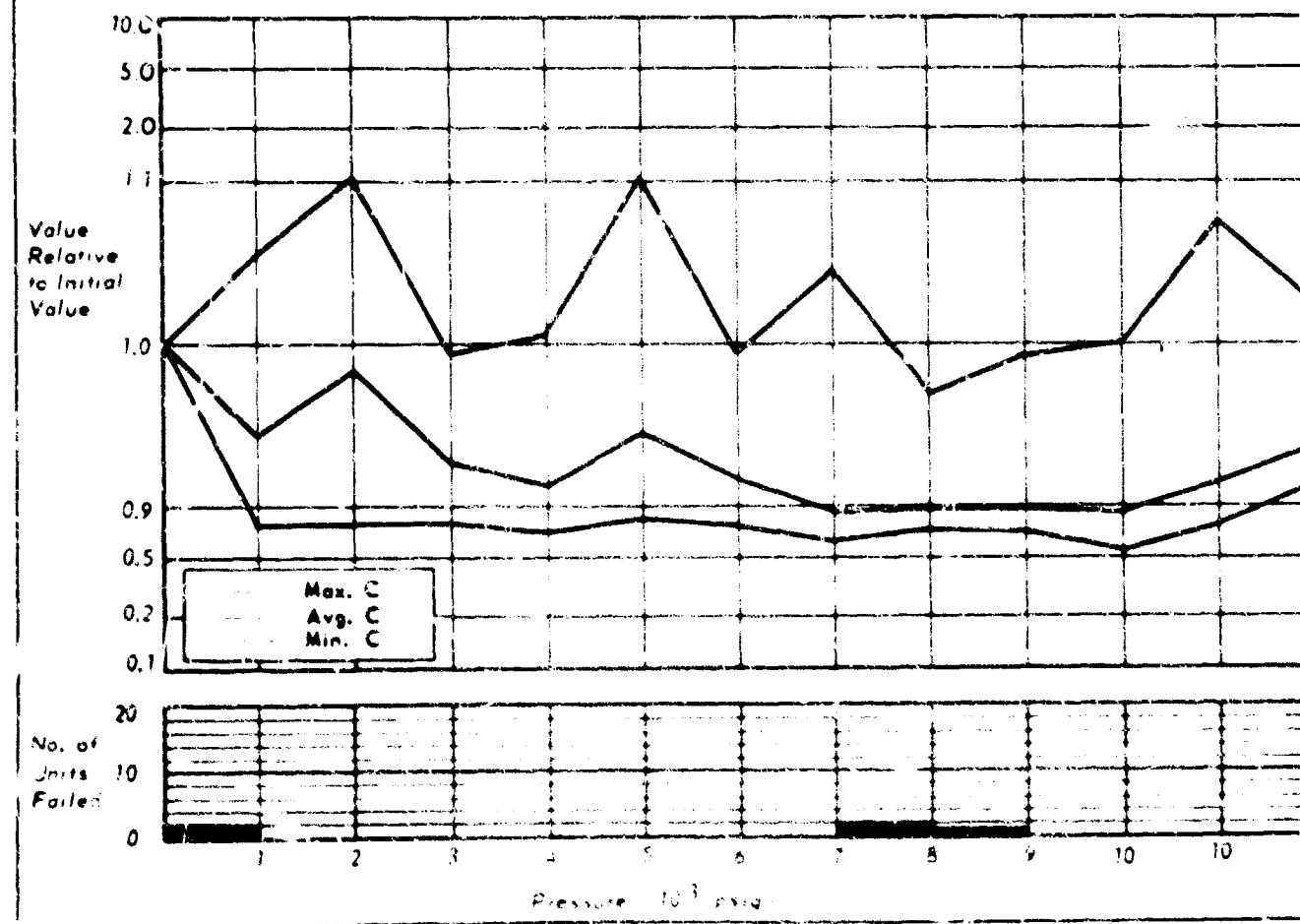
MFG.-CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - NLW-50-12

CHART NO. 33
NO. OF SAMPLES TESTED - 20



MFG.-CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - NLW-95-50

CHART NO. 34
NO. OF SAMPLES TESTED - 20



Cornell-Dubilier
NLW 50-12
Capacitor

50.0 μ F ± 150 %
12 V

Electrolytic
Tubular, axial lead
Aluminum foil
0.625 x 0.375" diam.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage

ELECTRICAL: Ten components indicated less than 10% change.
Ten components indicated a change greater than 10% and less than 50%.

Cornell-Dubilier
NLW 85-50
Capacitor

85.0 μ F
50 WV

Electrolytic
Tubular, axial lead
Aluminum foil
1.5 x 0.375" diam.

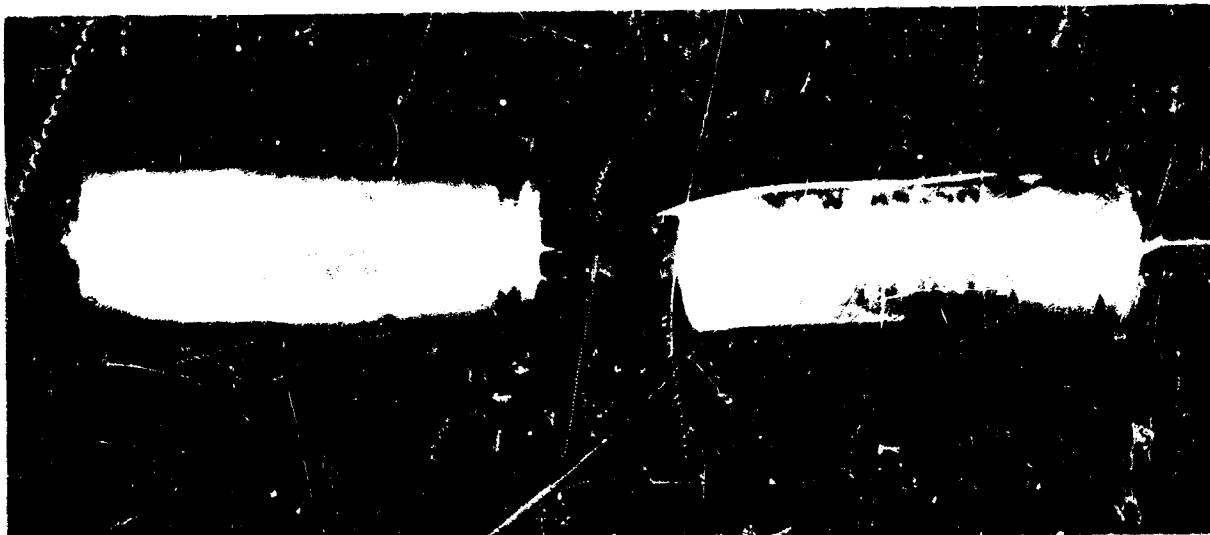
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: Visual inspection following completion of tests showed slight deformation of the metal cases of nine components. Seven of the damaged components remained functional throughout the entire test.

ELECTRICAL: Eleven components indicated less than 10% change.

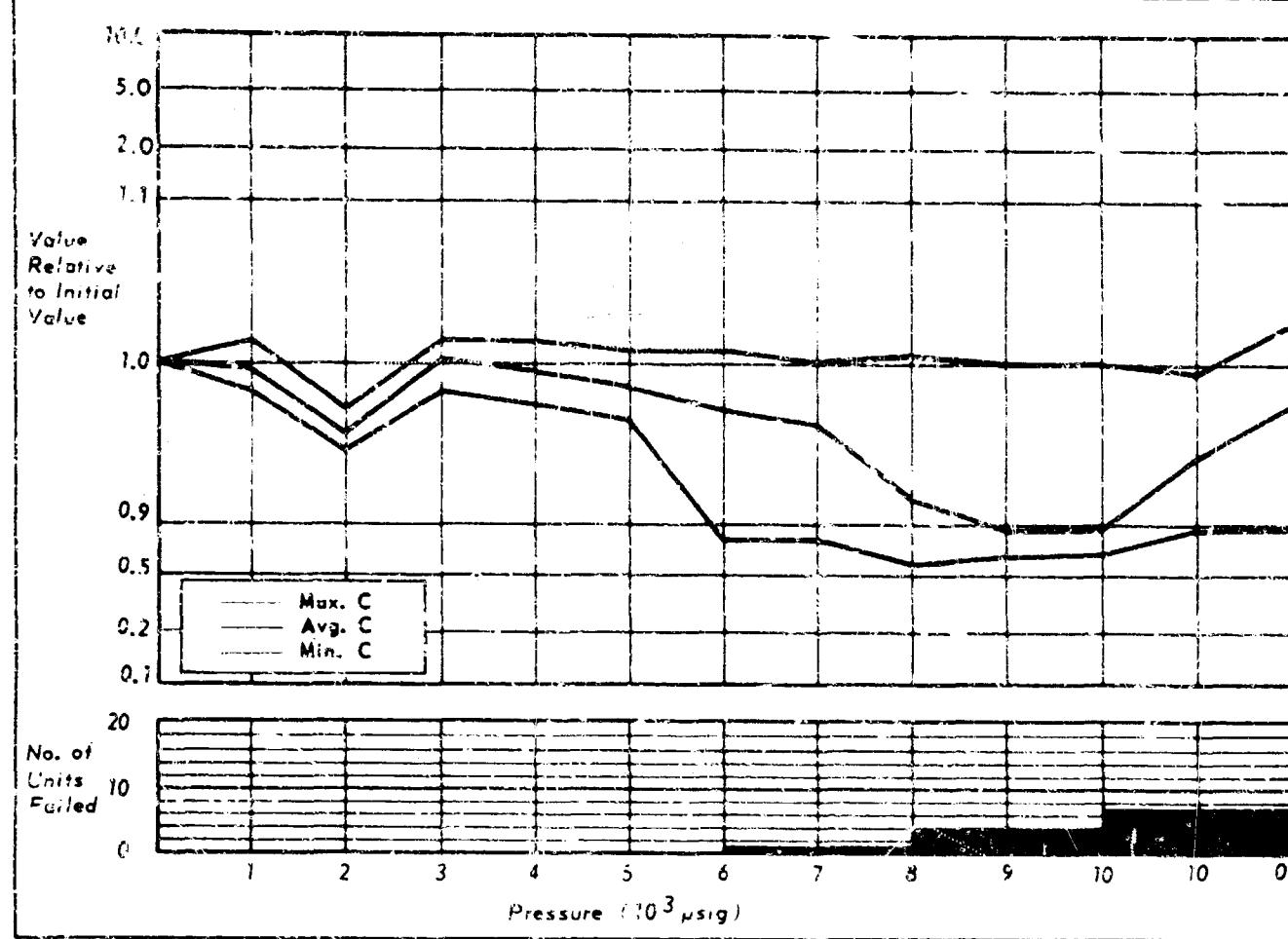
Seven components indicated a change greater than 10% and less than 50%.

Two components indicated a change greater than 50% with subsequent recovery of pressures shown on failure graph on opposite page.



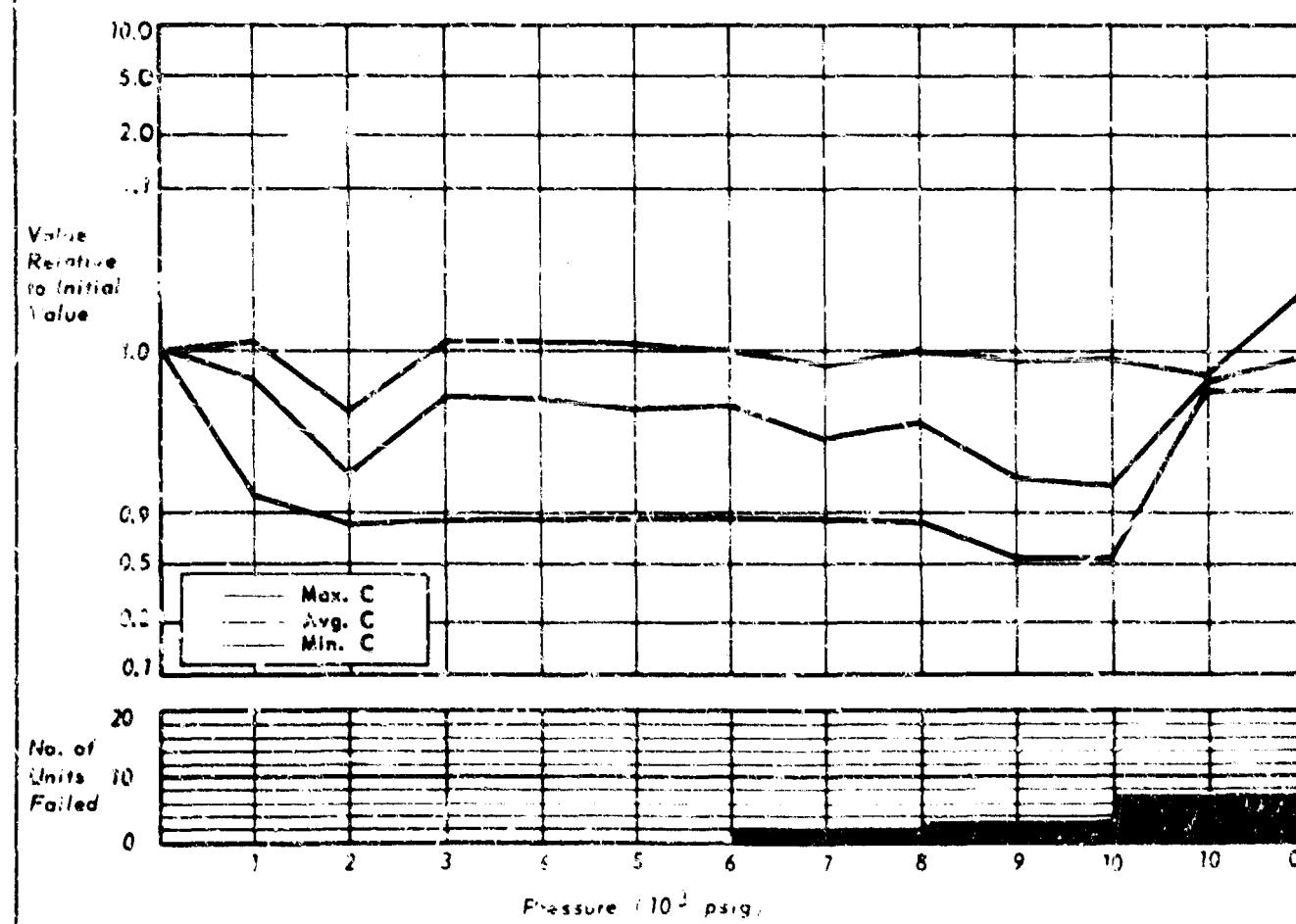
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - CK06 .0018 MFD

CHART NO. 35
NO. OF SAMPLES TESTED - 10



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - CK06 .0025 MFD

CHART NO. 36
NO. OF SAMPLES TESTED - 10



Cornell-Dubilier	0.0018 μ F + 10%	Ceramic
CK06	200 VDCW	Phenolic case
Capacitor		Square, radial lead
		0.3 x 0.03 x 0.1" th.

SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: Two components indicated less than 10% change.

One component indicated a change greater than 10% and less than 50%.

FAILURES: Six components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

Cornell-Dubilier	0.0022 μ F + 10%	Ceramic
CK06	200 VDCW	Phenolic case
Capacitor		Square, radial lead
		0.3 x 0.3 x 0.1" th.

SOAK PERIOD: 15.5 hours at 10,000 psig.

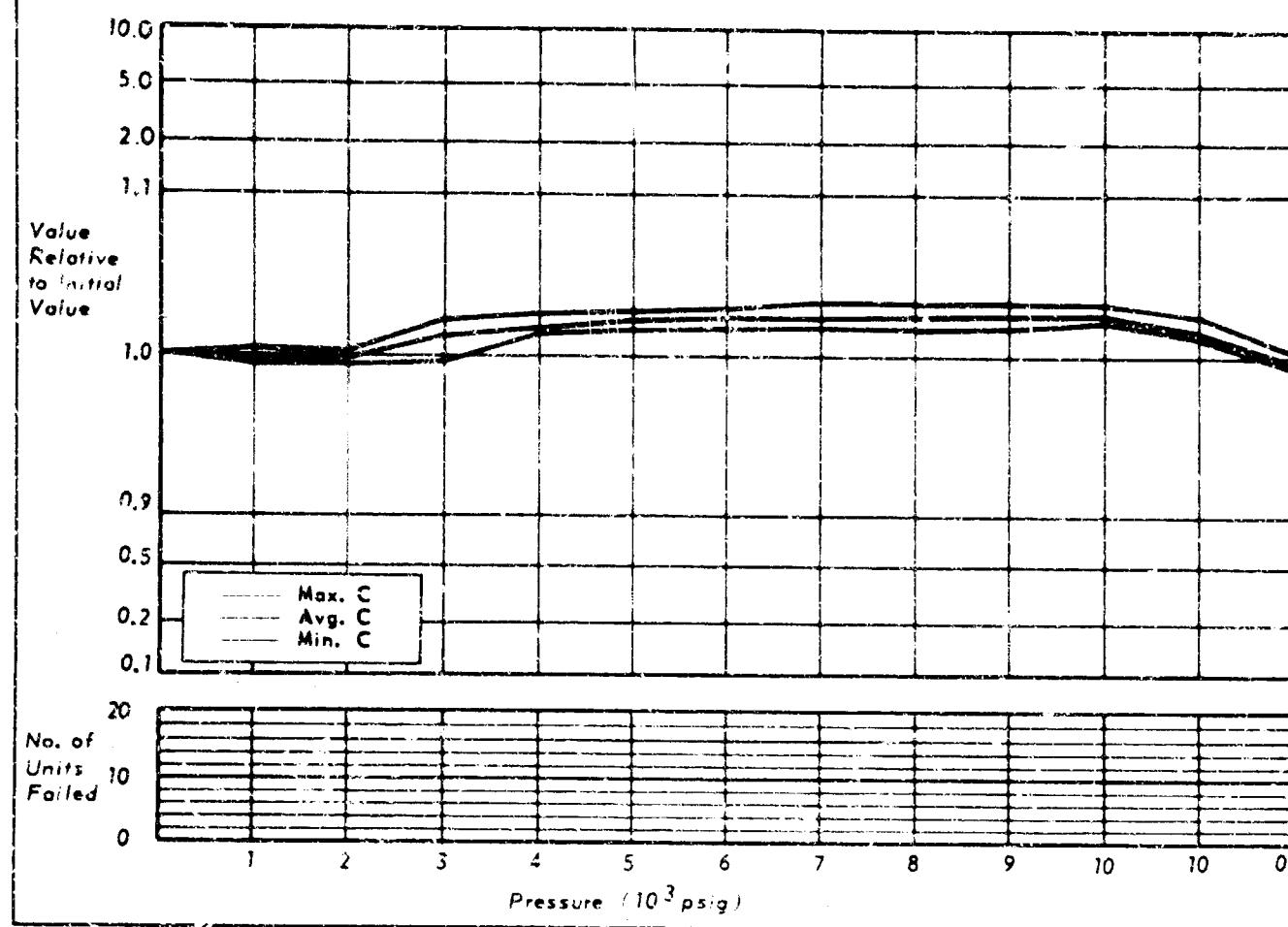
MECHANICAL: No apparent damage.

ELECTRICAL: Three components indicated less than 10% change.

FAILURES: Seven components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

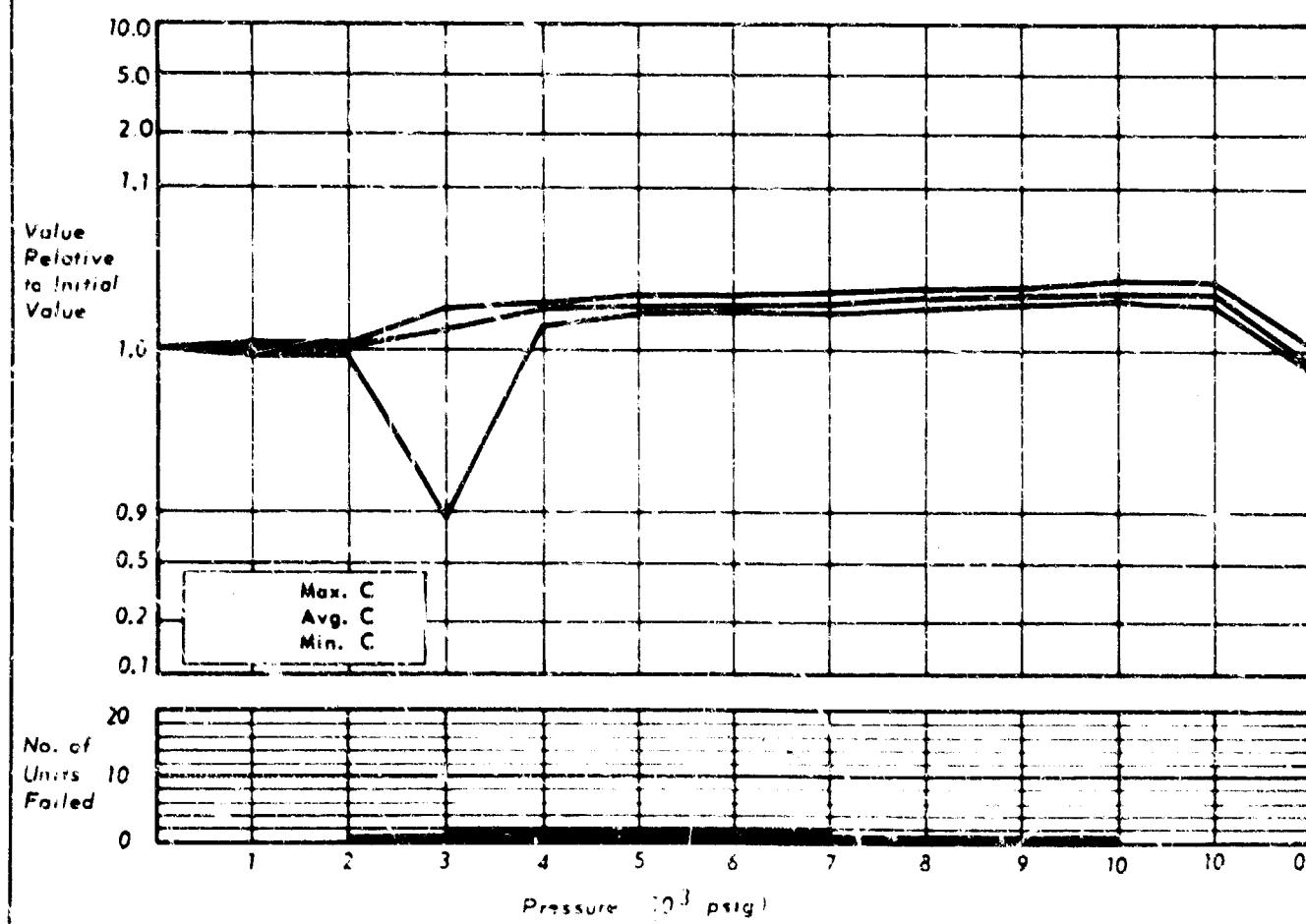
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - MTYXN1C043M

CHART NO. 37
NO. OF SAMPLES TESTED - 19



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - MTYN1A104M

CHART NO. 38
NO. OF SAMPLES TESTED - 19

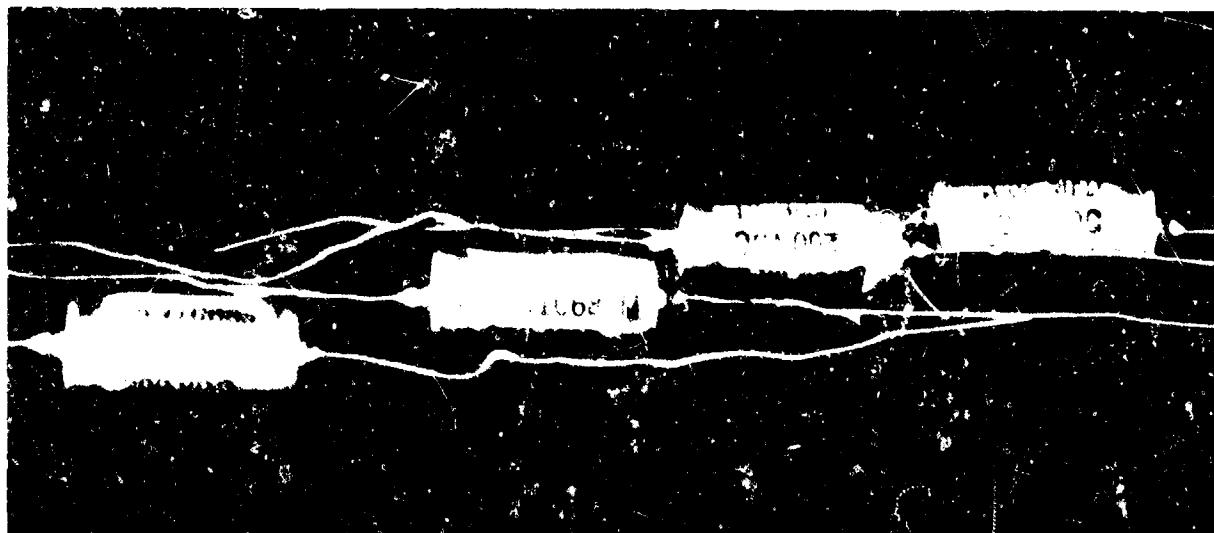


Cornell-Dubilier	0.068 μ F + 20%	Metallized paper, film
MTYKNIC 683M	200 VDCW	Tubular, axial lead
Capacitor		Glass end seal
		1.125 x 0.5" diam

SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: Visual inspection following completion of tests showed slight deformation of the metal cases of all components. All damaged components remained functional throughout the entire test.

ELECTRICAL: All components indicated less than 10% change.



Cornell-Dubilier	0.10 μ F + 20%	Metallized paper, film
MTYTNIA104M	200 VDCW	Tubular, axial lead
Capacitor		Glass end seal
		0.375 x 0.312" diam

SOAK PERIOD: None

MECHANICAL: Visual inspection following completion of tests showed deformation of metal cases of all components. Seventeen of the damaged components remained functional throughout the entire test.

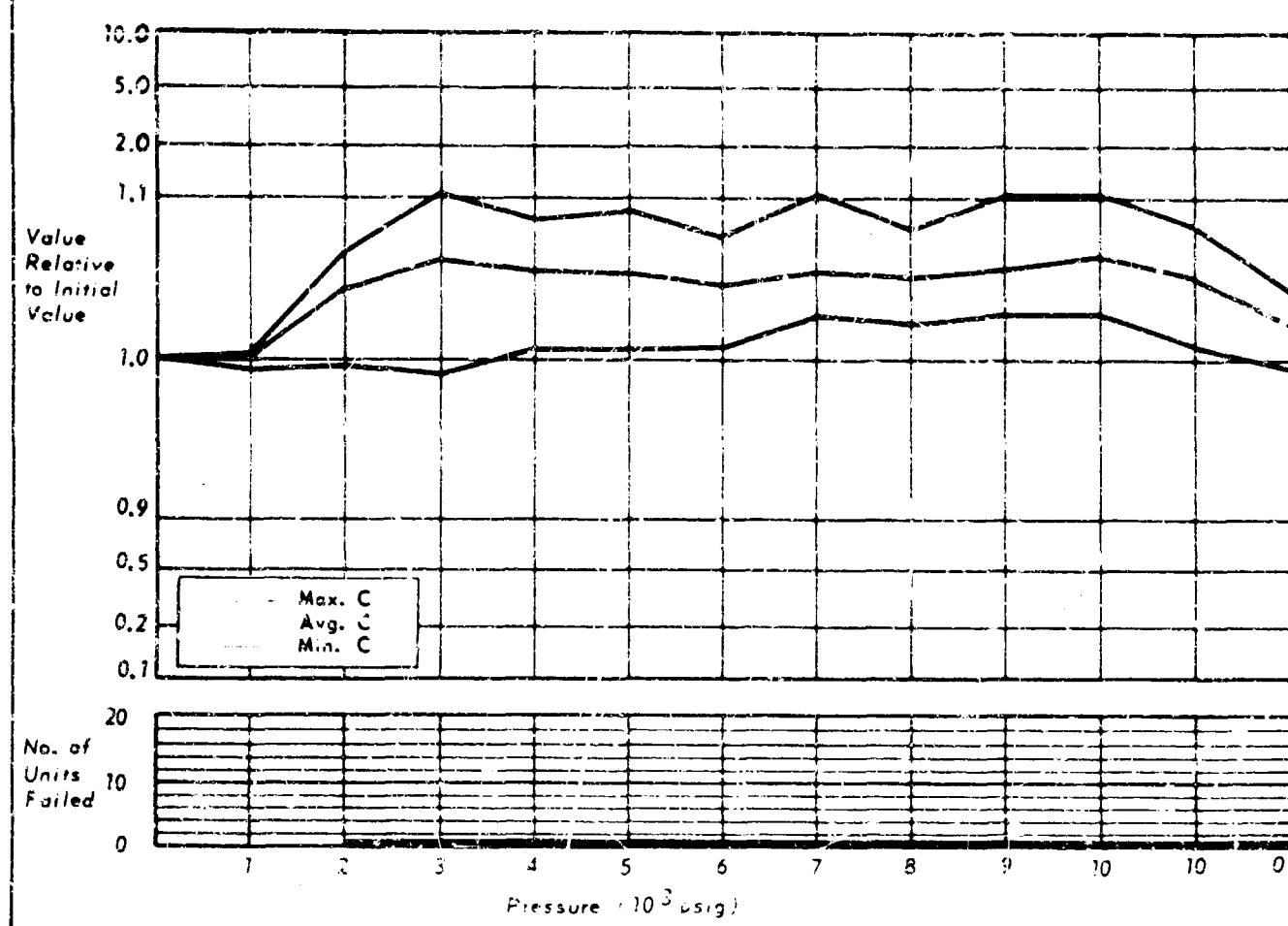
ELECTRICAL: Seventeen components indicated less than 10% change.

Two components indicated a change greater than 50% with subsequent recovery at pressures shown on failure graph on opposite page.



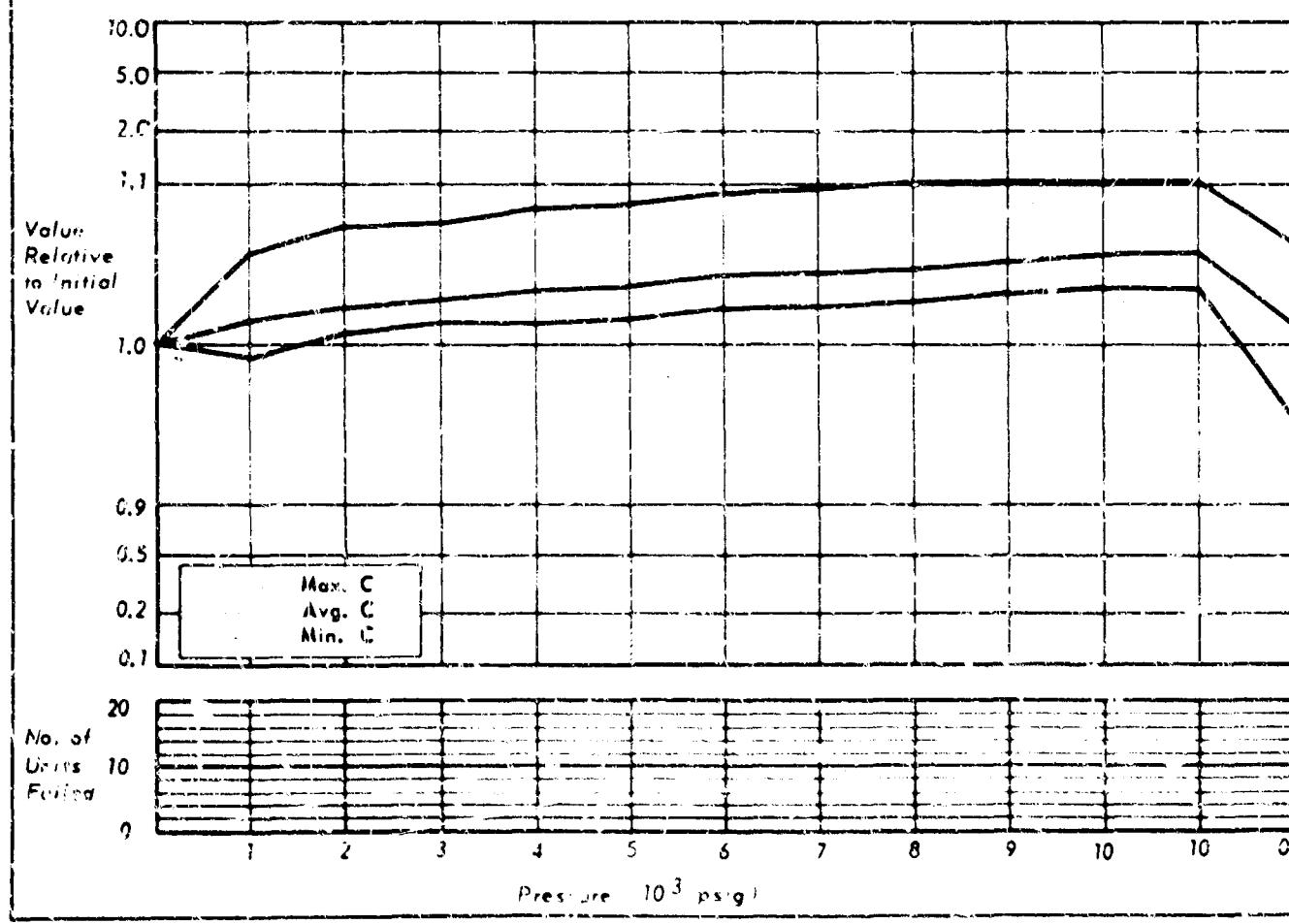
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - MTWKN1C104N

CHART NO. 39
NO. OF SAMPLES TESTED - 19



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - CP05A1KB224K3

CHART NO. 40
NO. OF SAMPLES TESTED - 19



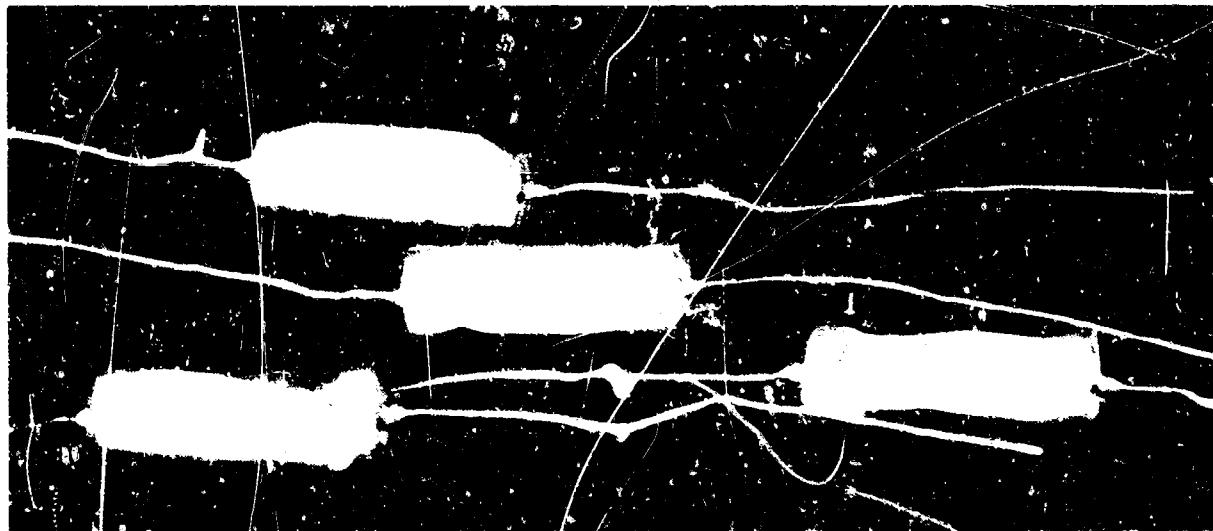
Cornell-Dubilier	0.10 μ F \pm 20%	Metalized paper, film
MTWKNIC104M	200 VDCW	Tubular, axial lead
Capacitor		Glass end seal
		0.87 x 0.312" diam

SOAK PERIOD: None

MECHANICAL: Visual inspection following completion of tests showed deformation of the metal cases of all components. Eighteen of the damaged components remained functional throughout the entire test.

ELECTRICAL: Eighteen components indicated less than 10% change.

FAILURES: One component* indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

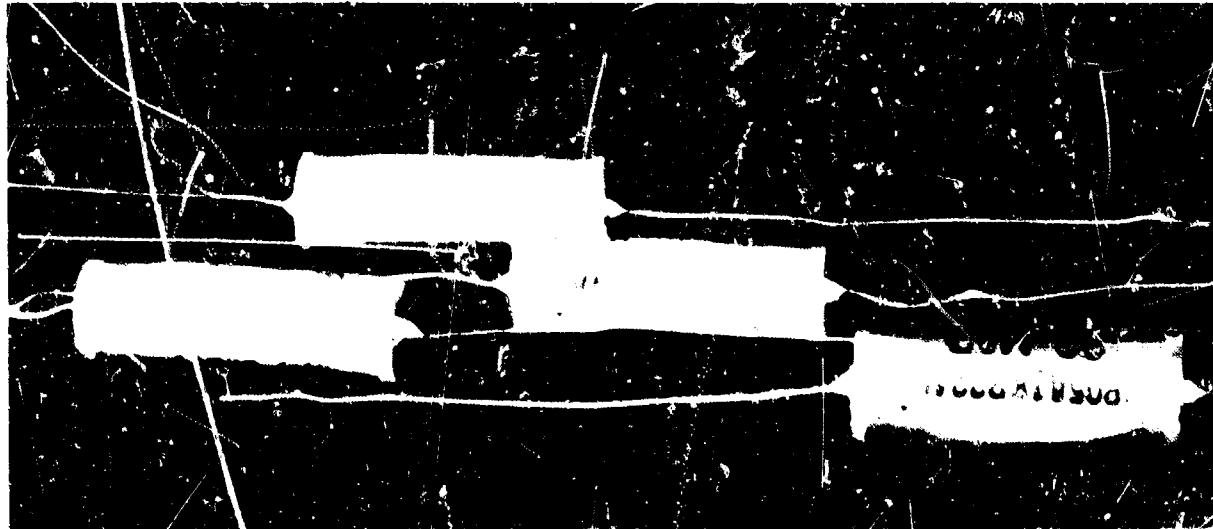


Cornell-Dubilier	0.22 μ F	Paper, oil
CP05AIKB22403	100 VDCW	Tubular, axial lead
Capacitor		Metal case
		1.125 x 0.49" diam

SOAK PERIOD: None

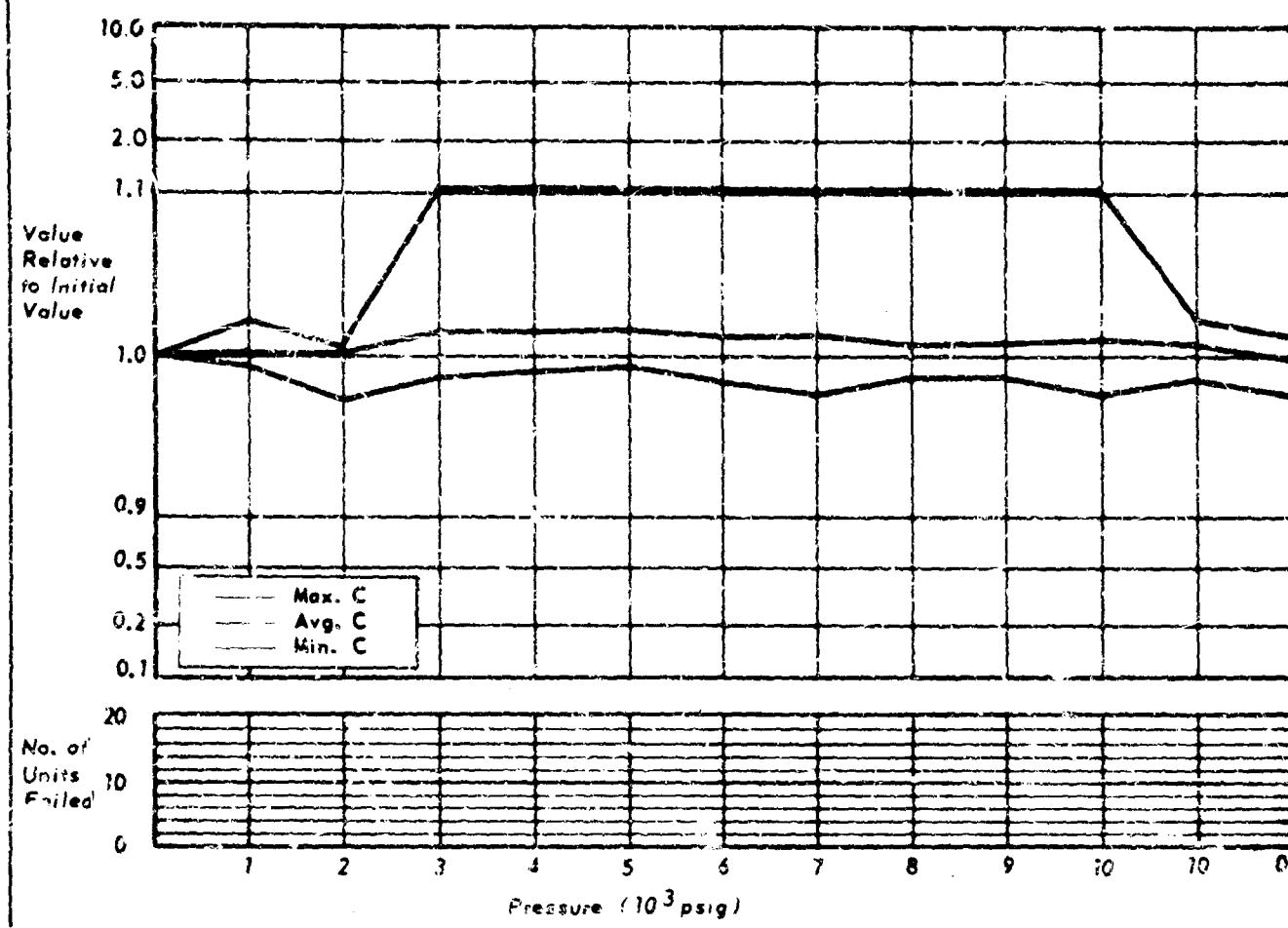
MECHANICAL: Visual inspection following completion of tests showed deformation of the metal cases of all components. All damaged components remained functional throughout the entire test.

ELECTRICAL: All components indicated less than 10% change.



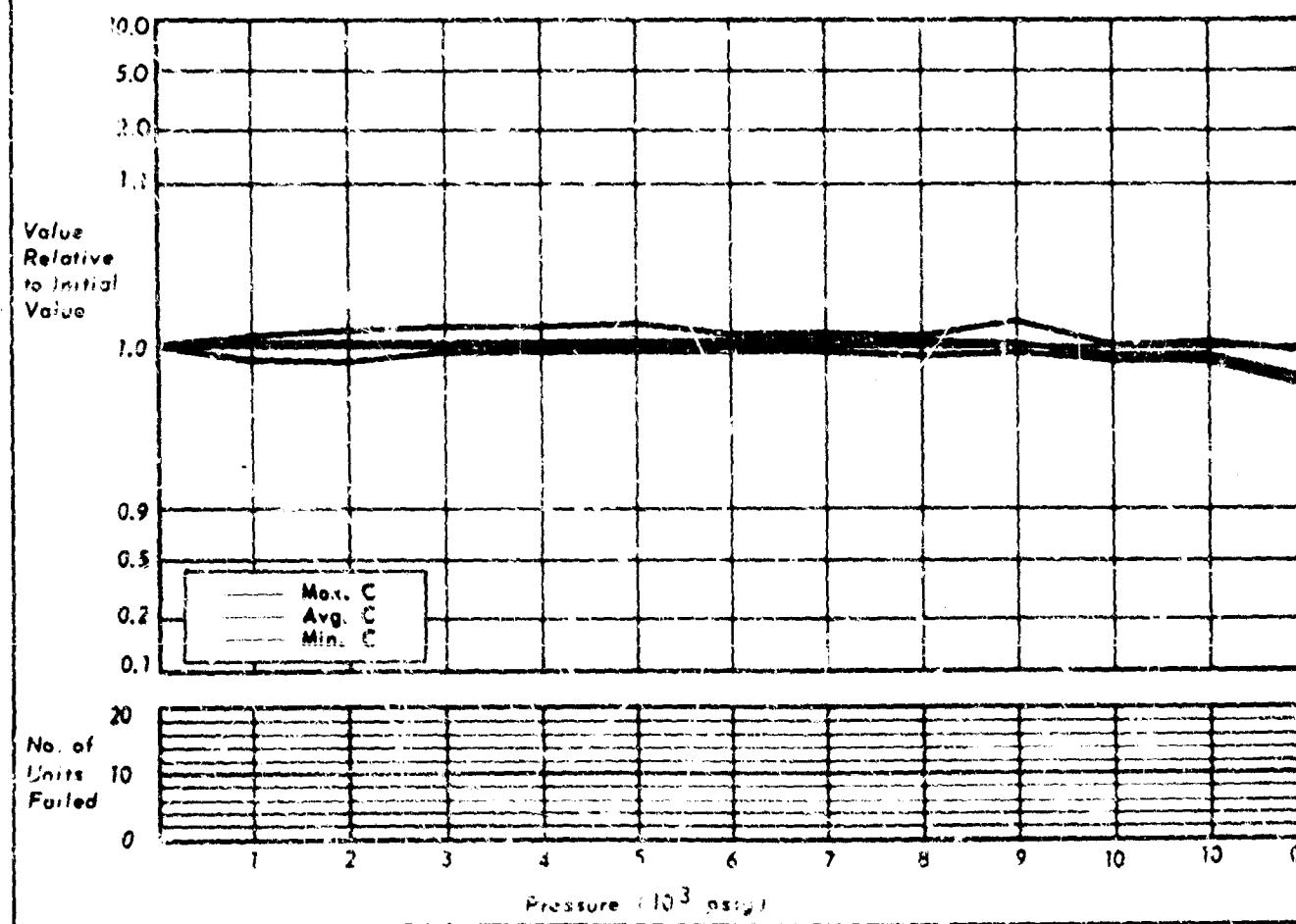
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - T1R128F82K

CHART NO. 41
NO. OF SAMPLES TESTED - 20



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - CD16F381J

CHART NO. 42
NO. OF SAMPLES TESTED - 20

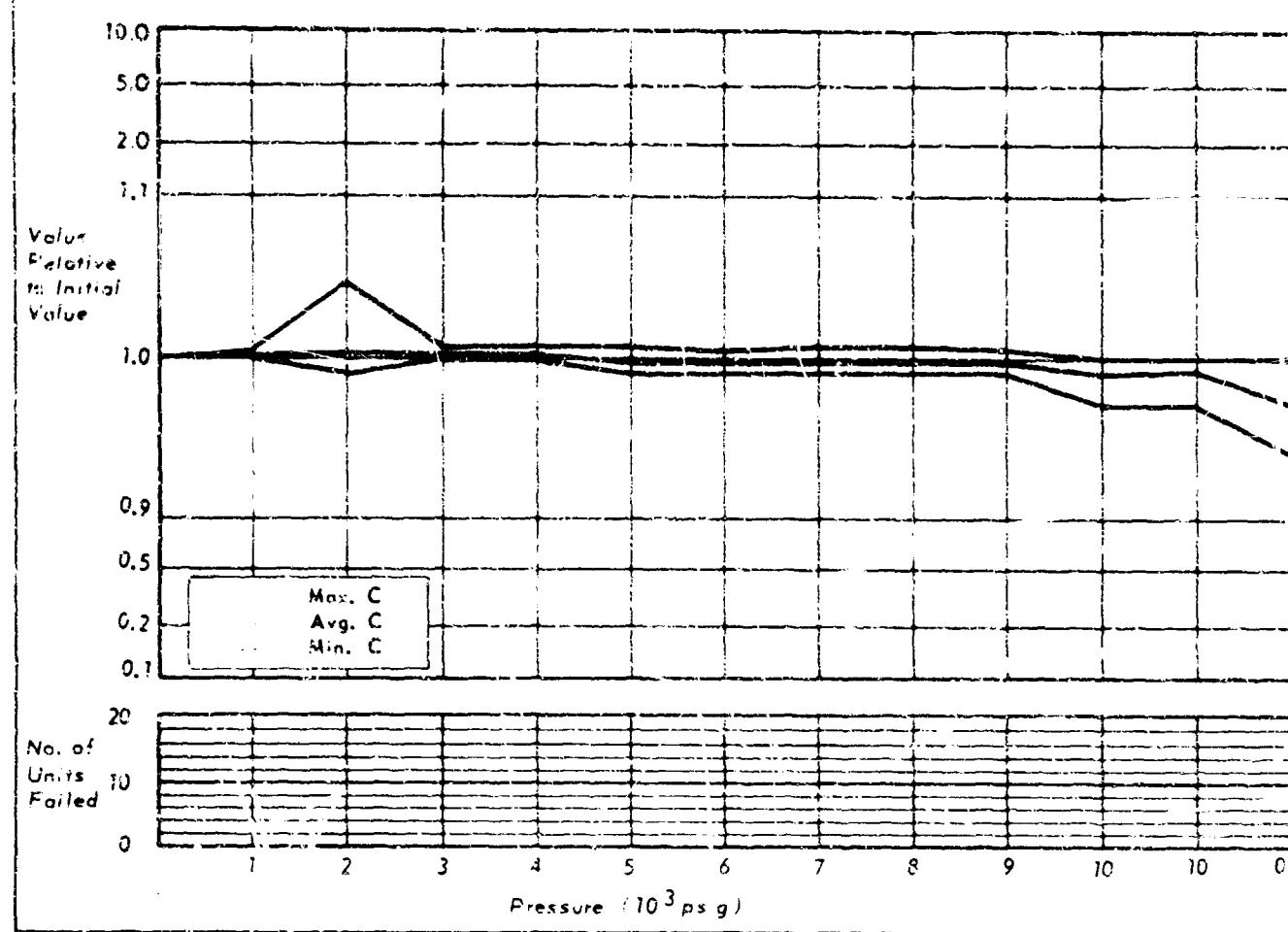


Cornell-Dubilier	0.82 μ F	Solid tantalum
TYR12BF62K	35 VDCW	Tubular, axial lead
Capacitor		0.438 x 0.175" diam.
SOAK PERIOD:	None	
MECHANICAL:	No apparent damage	
ELECTRICAL:	All components indicated less than 10% change.	

Cornell-Dubilier	390 μ F \pm 5%	Mica, dipped
CD15F391J	500 VDCW	Rectangular
Capacitor		Radial lead
		0.47 x 0.4 x 0.22" th.
SOAK PERIOD:	15.5 hours at 10,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated less than 10% change.	

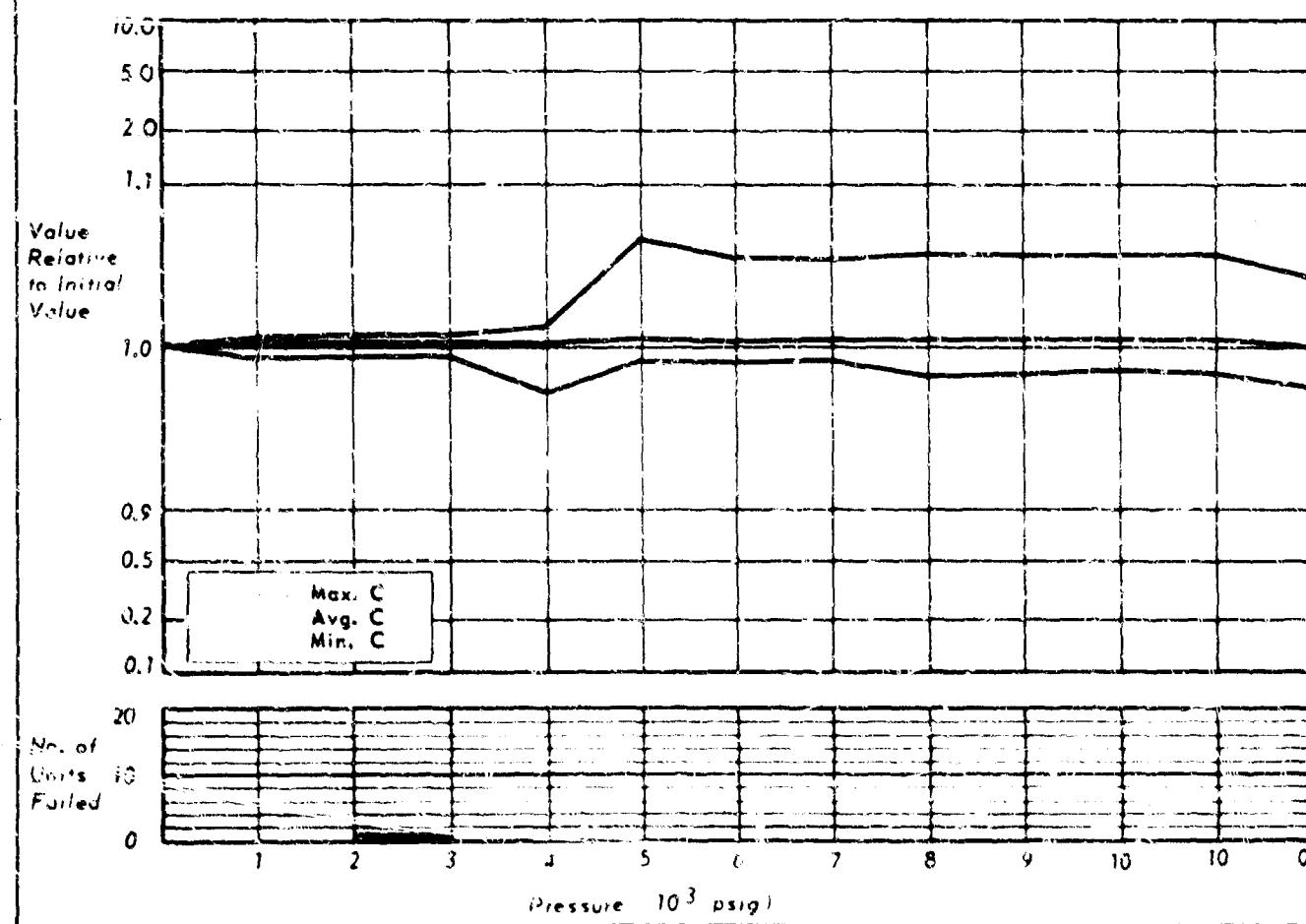
MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - 2030F103J

CHART NO. 43
NO. OF SAMPLES TESTED - 19



MFG. - CORNELL-DUBILIER
TYPE - CAPACITOR
DESCRIPTION - HCC3224P

CHART NO. 44
NO. OF SAMPLES TESTED - 20



SOAK PERIOD: 16 hours at 10 000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Cornell-Dubilier	0.22 μ F	Ceramic, tear drop
HCC3224P	3 VDCW	Phenolic coated
Capacitor		Wax impreg.

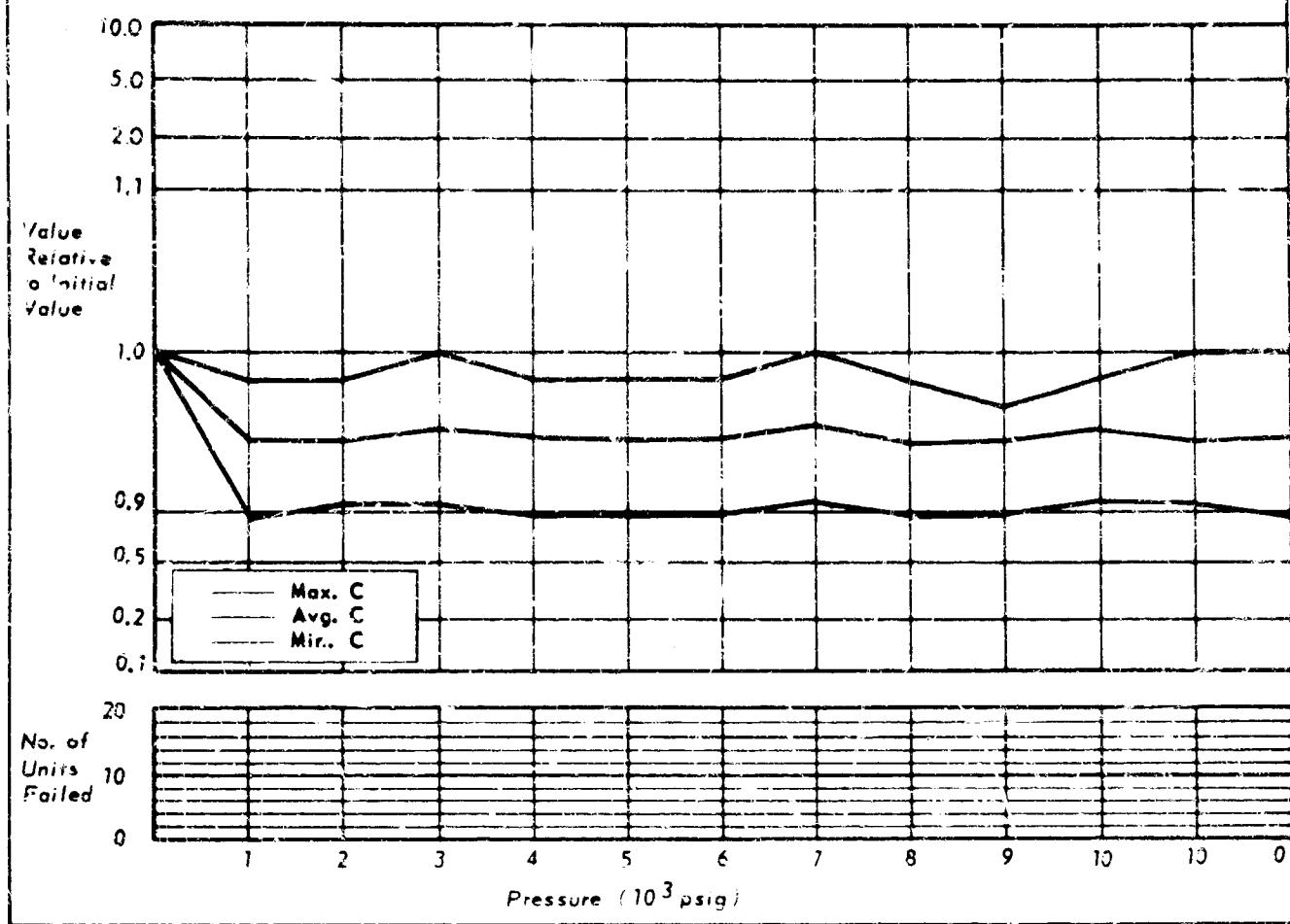
SOAK PERIOD: 14 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

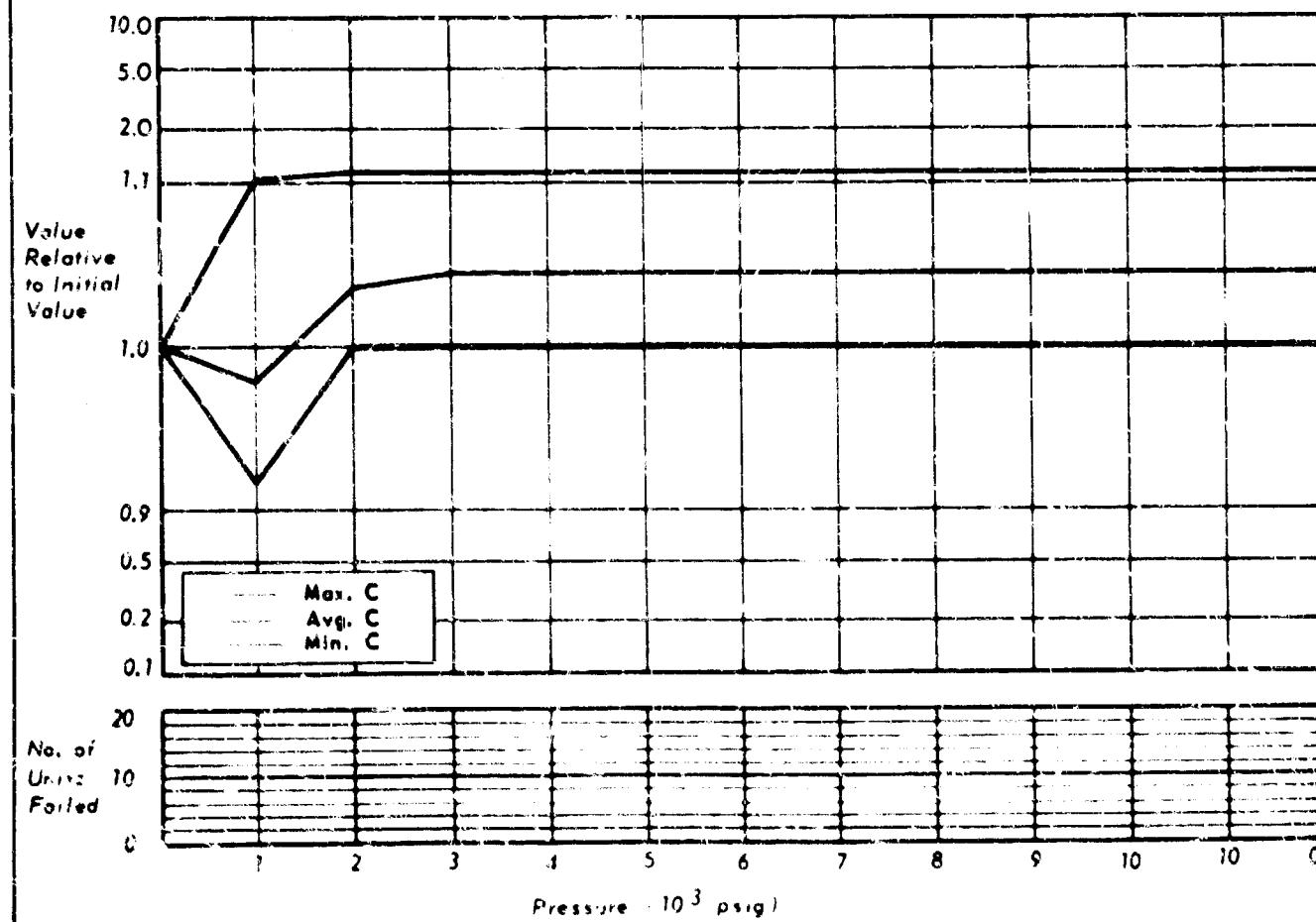
MFG.-CORNING
TYPE-CAPACITOR
DESCRIPTION-CYFM10

CHART NO. 45
NO. OF SAMPLES TESTED-20



MFG.-CORNING
TYPE-CAPACITOR
DESCRIPTION-CYFM15

CHART NO. 46
NO. OF SAMPLES TESTED-19

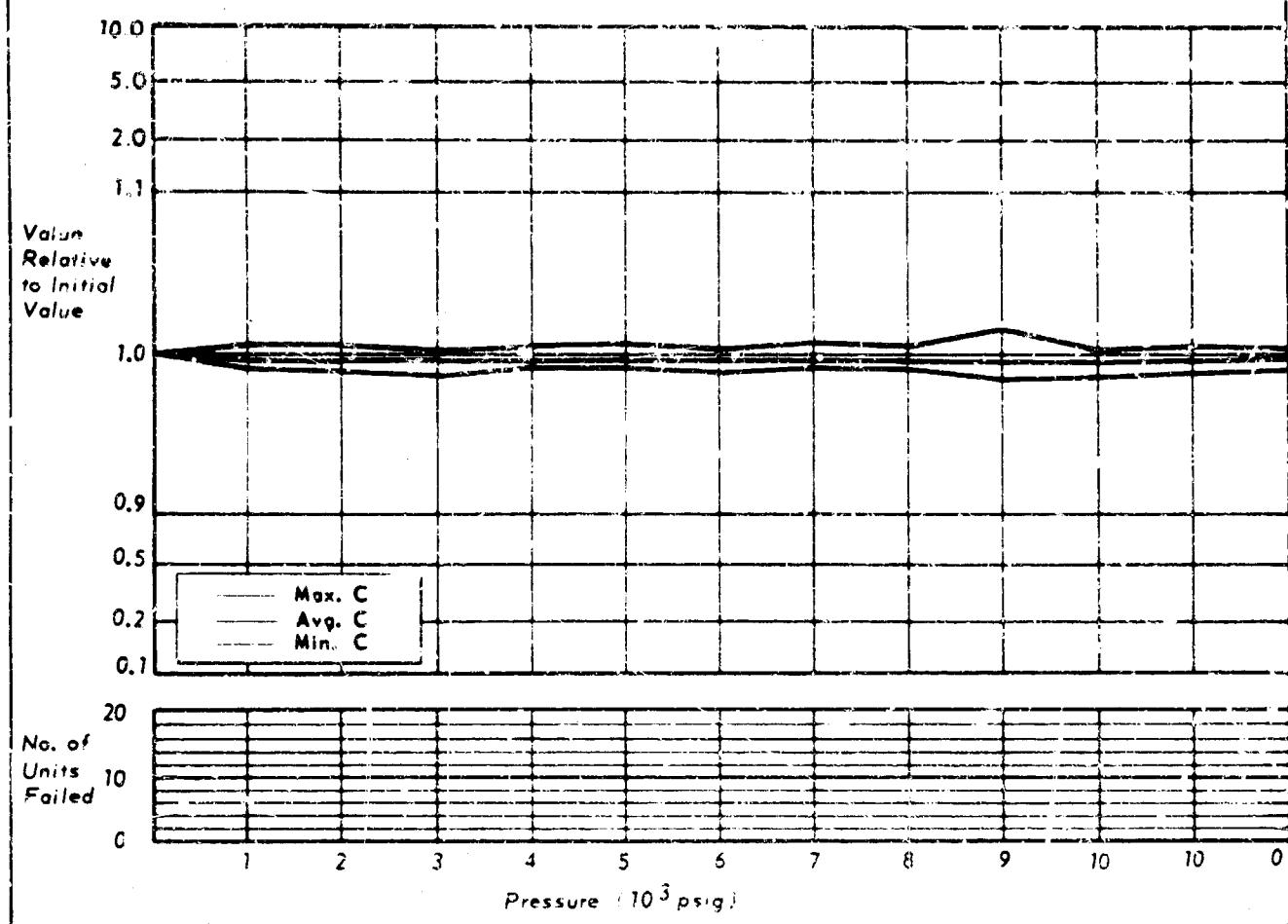


Corning 100 pF \pm 10% Glass, foil
CYMF 10 300 VDCW Rectangular, axial lead
Capacitor 0.406 x 0.203 x 0.78" th.
SOAK PERIOD: 16 hours at 10,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: Nineteen components indicated less than 10% change.
One component indicated a change greater than 10% and less than 50%

Corning 680 pF \pm 5% Glass, foil
CYFM 15 300 VDCW Rectangular, axial lead
Capacitor 0.468 x 0.265 x 0.11" th.
SOAK PERIOD: 15.5 hours at 10,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: Nineteen components indicated less than 10% change. One component indicated a change greater than 10% and less than 50%.
55

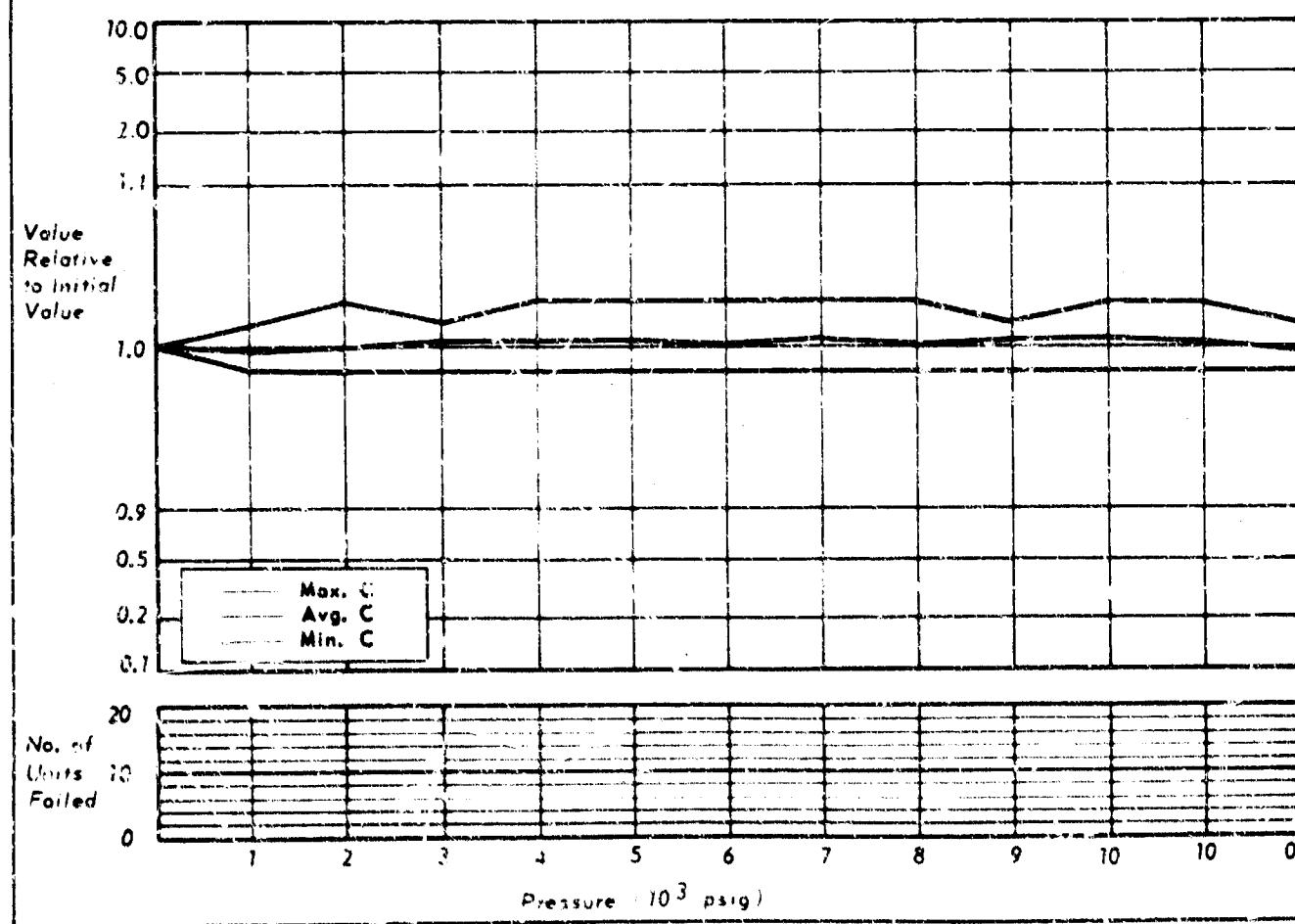
MFG. - CORNING
TYPE - CAPACITOR
DESCRIPTION - CYFM30

CHART NO. 47
NO. OF SAMPLES TESTED - 20



MFG. - CORNING
TYPE - CAPACITOR
DESCRIPTION - CYFM30

CHART NO. 48
NO. OF SAMPLES TESTED - 20



Corning	4700 pF \pm 5%	Glass, foil
CYFM 20	300 VDCW	Rectangular, axial lead
Cap. other		0.468 x 0.235 x 0.11" th.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Corning	6800 pF \pm 5%	Glass, foil
CYFM 30	500 V	Rectangular, axial lead
Capacitor		0.76 x 0.76 x 0.16" th.

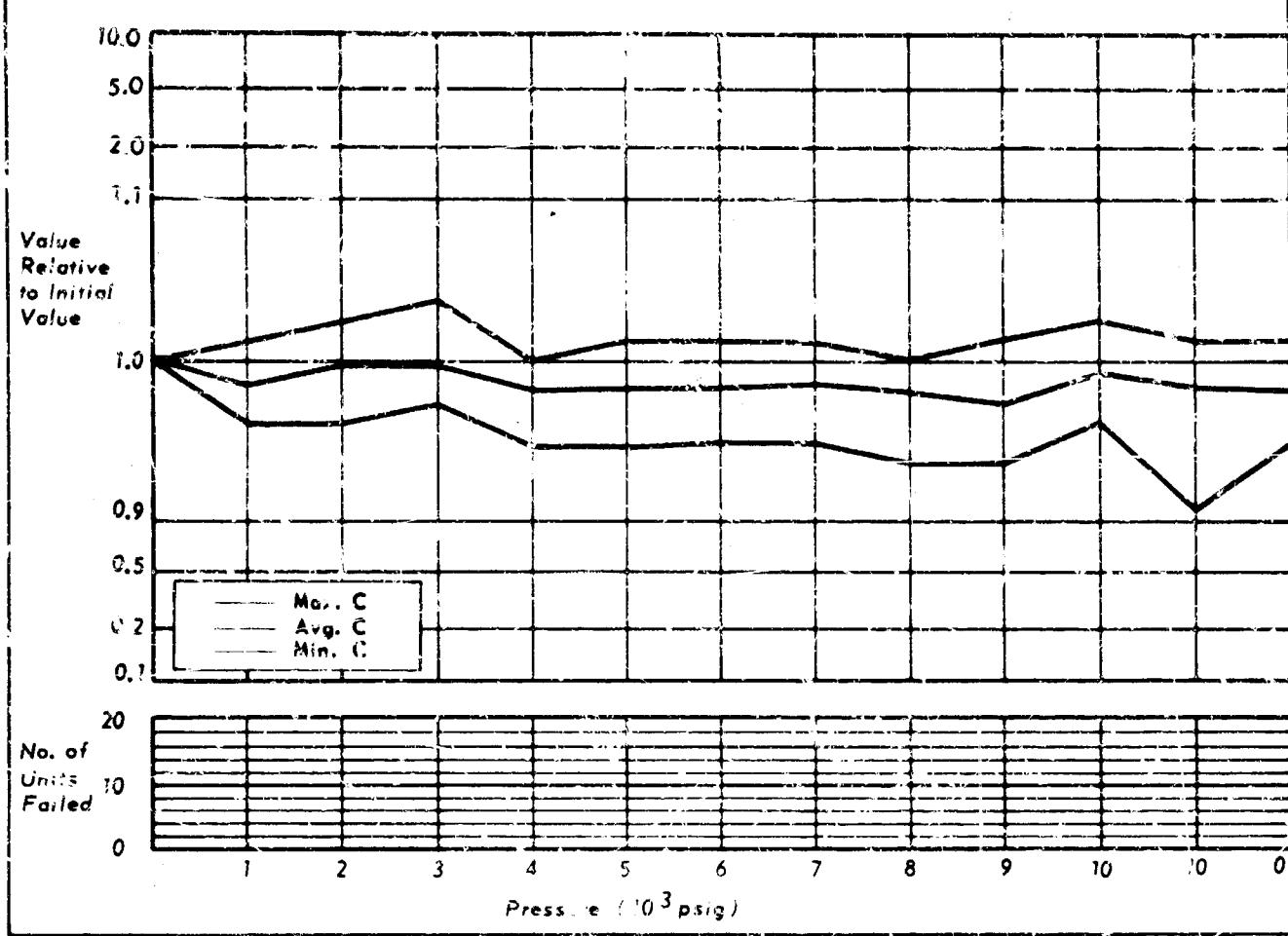
SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

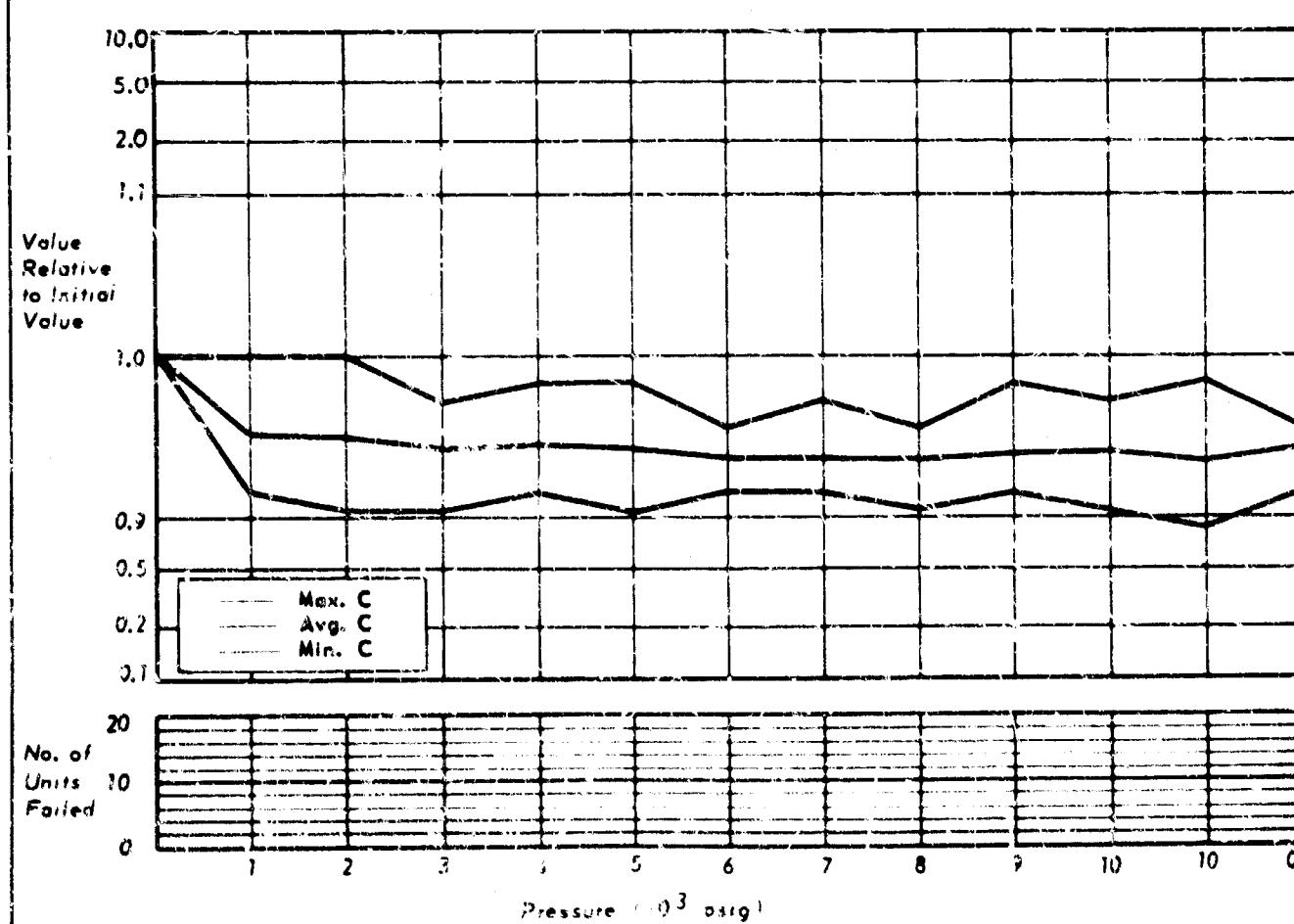
MFG. - CORNING
TYPE - CAPACITOR
DESCRIPTION - TY06

CHART NO. 49
NO. OF SAMPLES TESTED - 21



MFG. - CORNING
TYPE - CAPACITOR
DESCRIPTION - TY07

CHART NO. 50
NO. OF SAMPLES TESTED - 19



Corning	300 pF \pm 2%	Glass, foil
TY 06	300 VDCW	Rectangular, radial lead
Capacitor		Molded case
		0.3 x 0.2 x 0.115" th.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Corning	600 pF \pm 5%	Glass, foil
TY07	300 VDCW	Rectangular, radial lead
Capacitor		Molded case
		0.3 x 0.3 x 0.11" th.

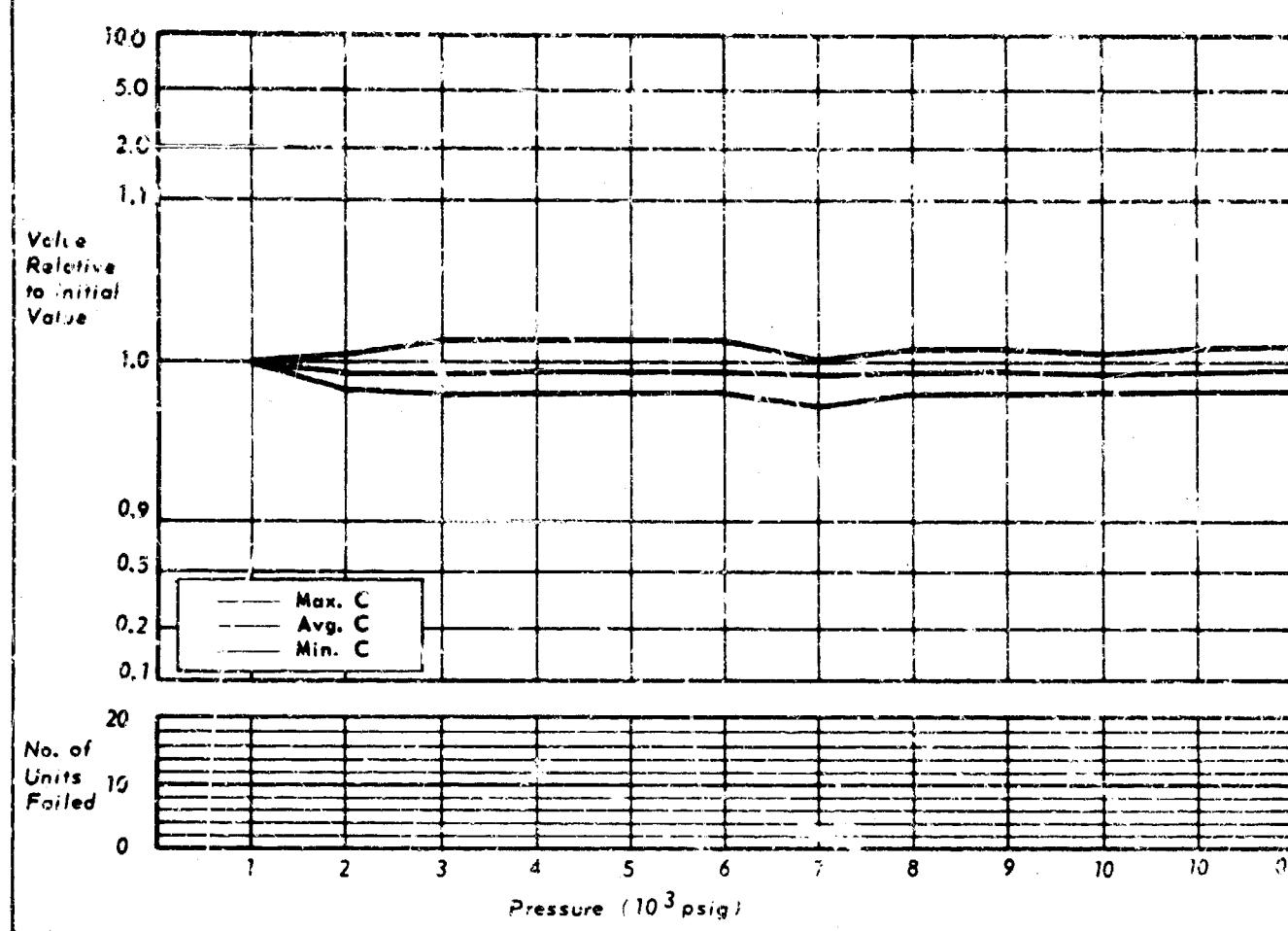
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

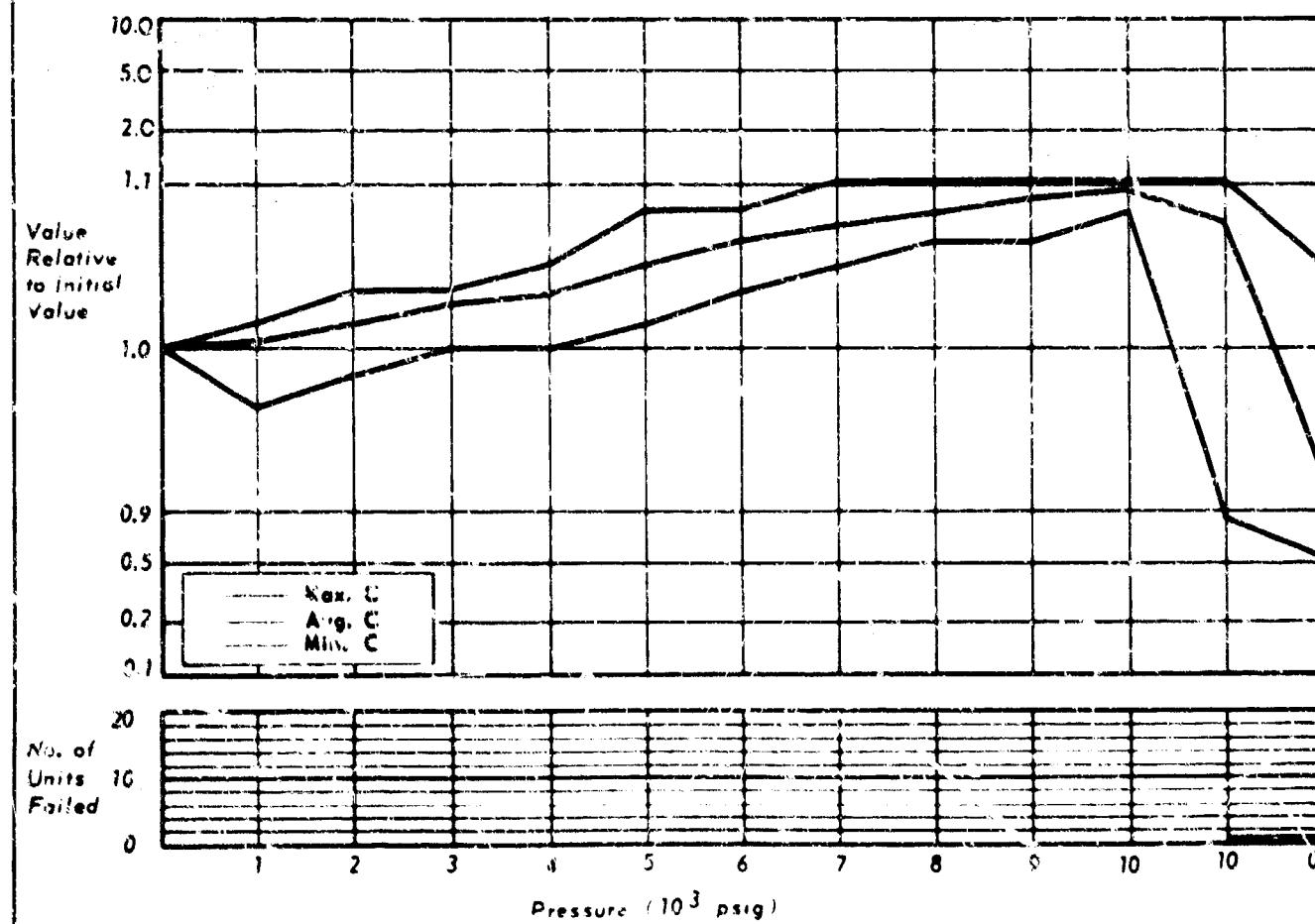
MFG. - CORNING
TYPE - CAPACITOR
DESCRIPTION - YYCB

CHART NO. 51
NO. OF SAMPLES TESTED - 23



MFG. - POTTER
TYPE - CAPACITOR
DESCRIPTION - 2002-621J

CHART NO. 52
NO. OF SAMPLES TESTED - 19



Corning 2060 pF \pm 1% Glass, foil
TY08 300 VDCW Rectangular, radial lead
Capacitor Molded case
0.5 x 0.3 x 0.115" th.

SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Potter 620 pF \pm 5% Ceramic, dice
2002-621J 200 VDCW Tubular, axial lead
Capacitor 0.25 x 0.1" diam.

SOAK PERIOD: None

MECHANICAL: No apparent damage.

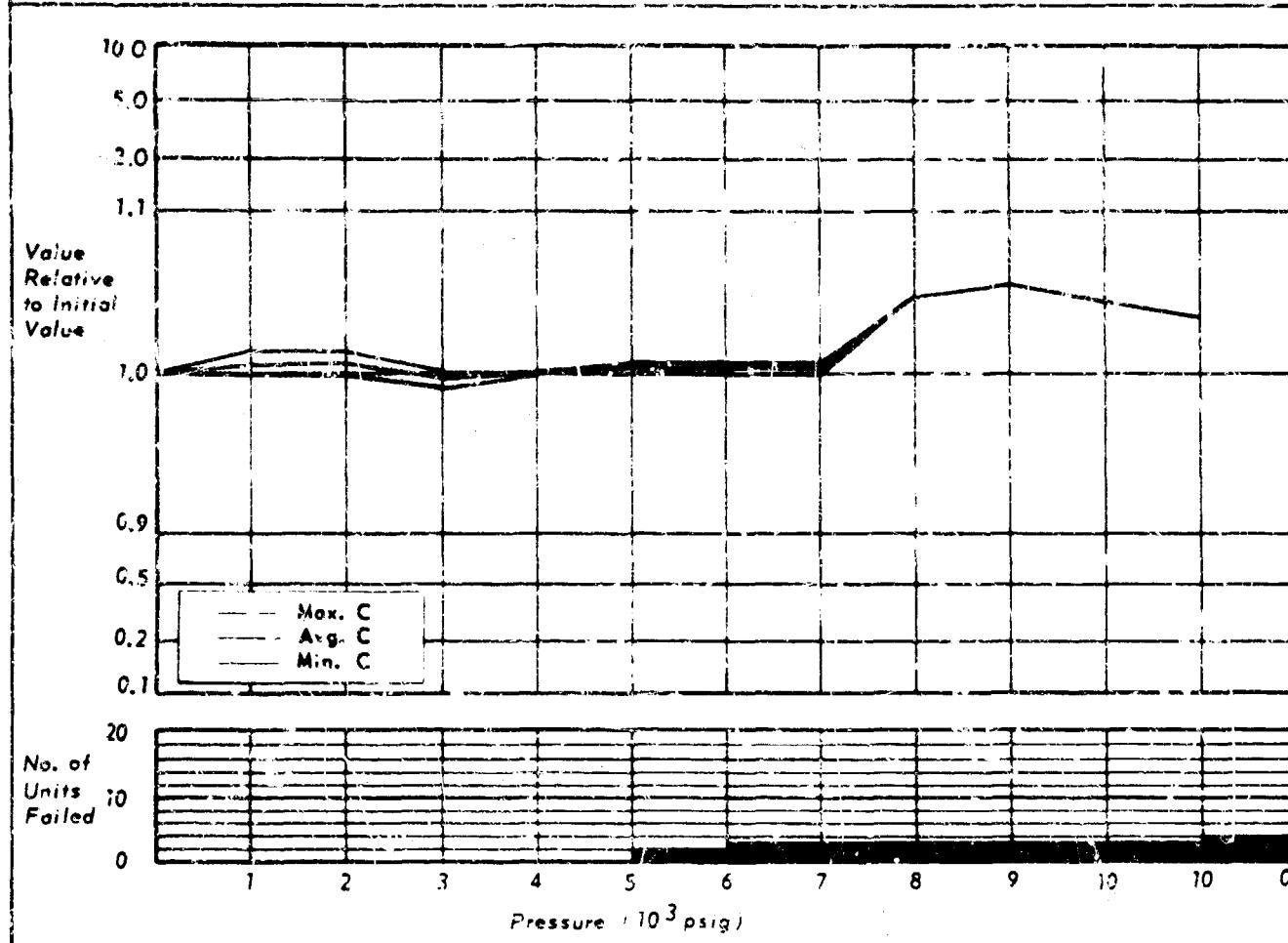
ELECTRICAL: Twelve components indicated less than 10% change.

Six components indicated a change greater than 10% and less than 50%.

FAILURES: One component indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

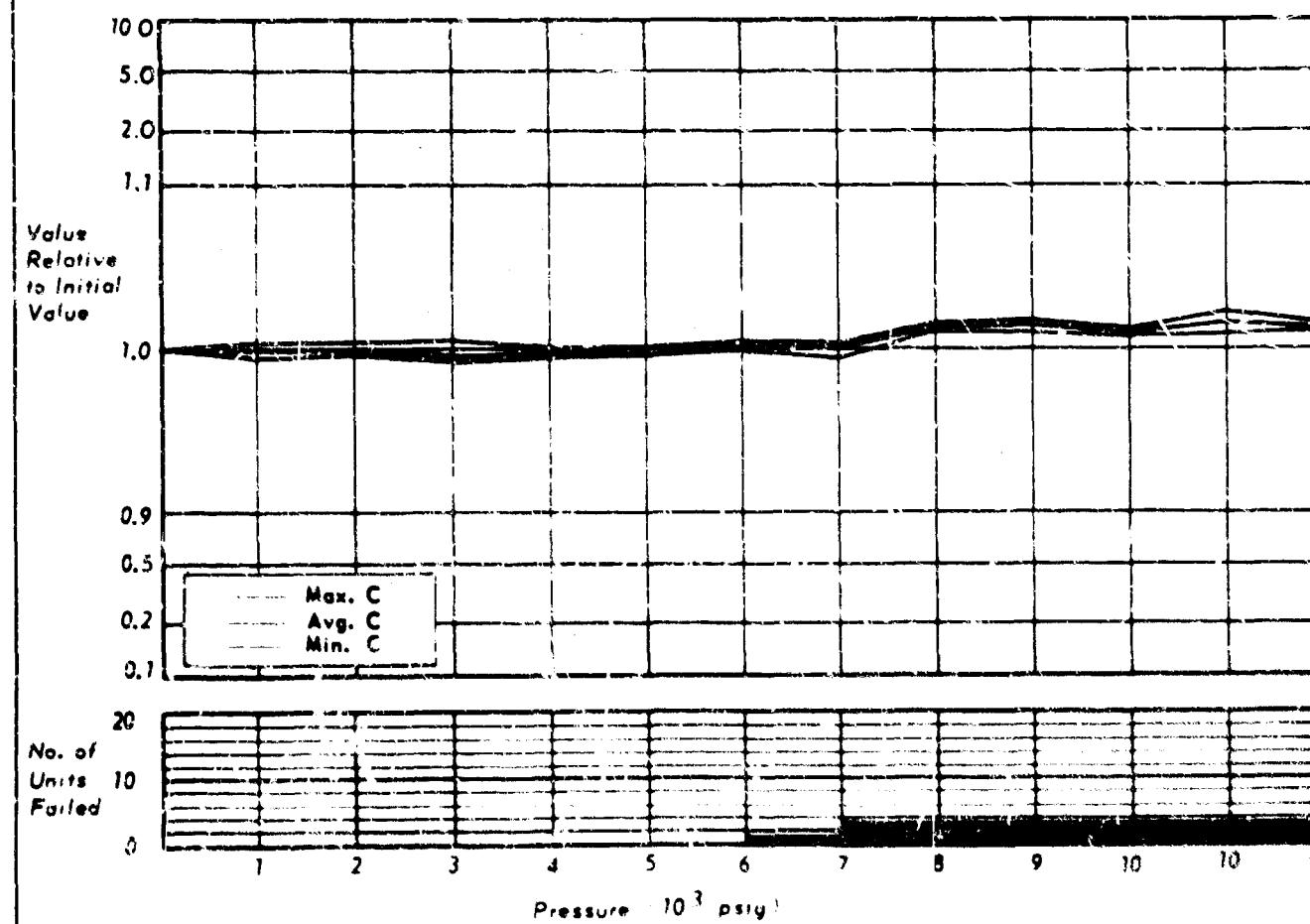
MFG. - TEXAS INSTRUMENTS
TYPE - CAPACITOR
DESCRIPTION - SCM158B7035A2

CHART NO. 53
NO. OF SAMPLES TESTED - 4



MFG. - TEXAS INSTRUMENTS
TYPE - CAPACITOR
DESCRIPTION - SCM825B7020A2

CHART NO. 54
NO. OF SAMPLES TESTED - 5



Texas Instruments

1.5 μ F

SCM 155BP035A

25 VDCW

Capacitor

Electrolytic

Tantalum, solid

Tubular, axial lead

0.438 x 0.175" diam.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: Visual inspection after completion of test showed end seals broken on three components.

ELECTRICAL: One component indicated less than 10% change.

FAILURES: Four components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.



Texas Instruments

8.2 μ F

SCM 825BP020A2

200 VDCW

Capacitor

Electrolytic

Tantalum, solid

Tubular, axial lead

0.438 x 0.175" diam.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: Visual inspection after completion of test showed deformation of the metal casing on three components and displacement of two end seals.

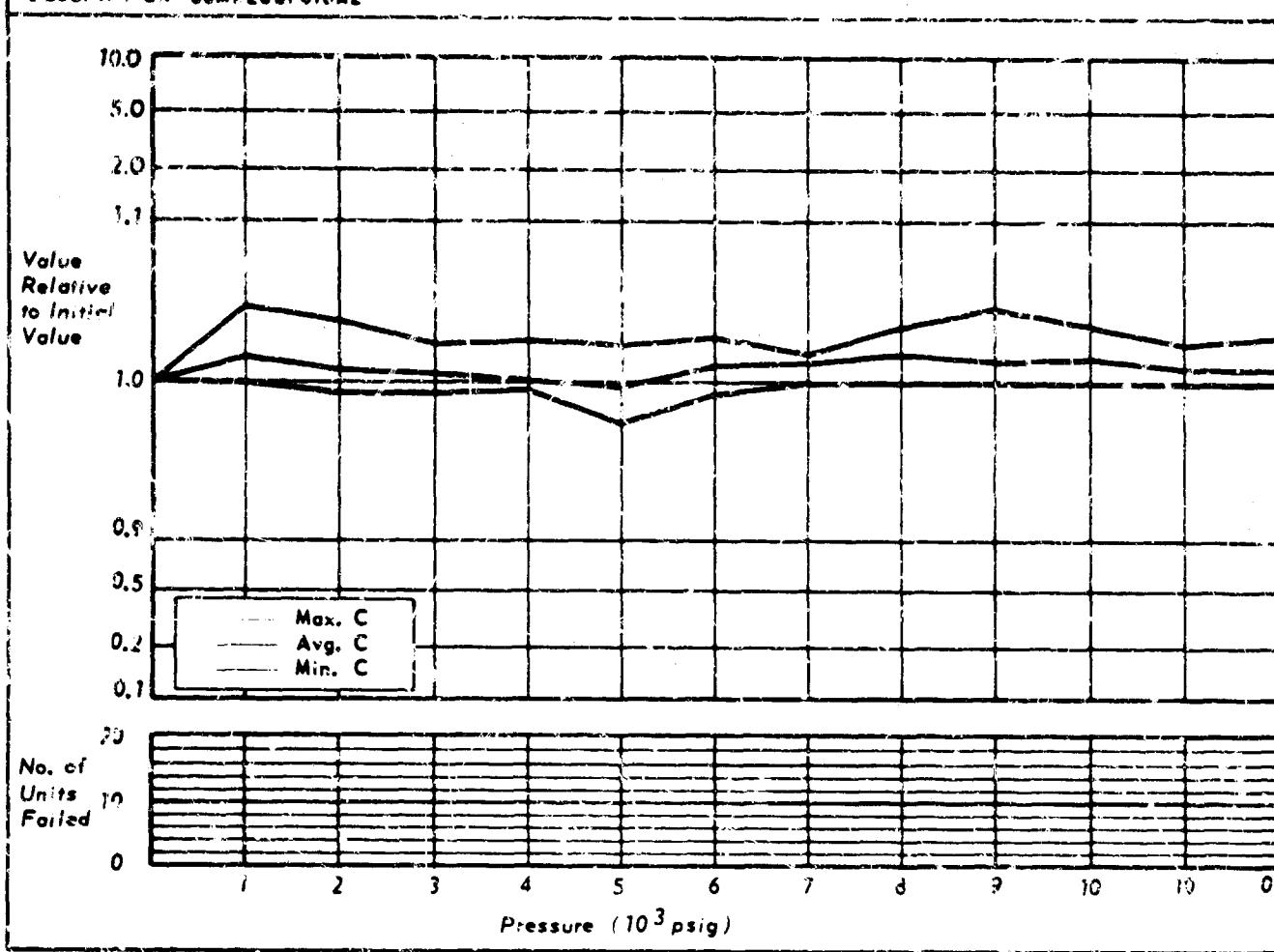
ELECTRICAL: Two components indicated less than 10% change.

FAILURES: Three components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.



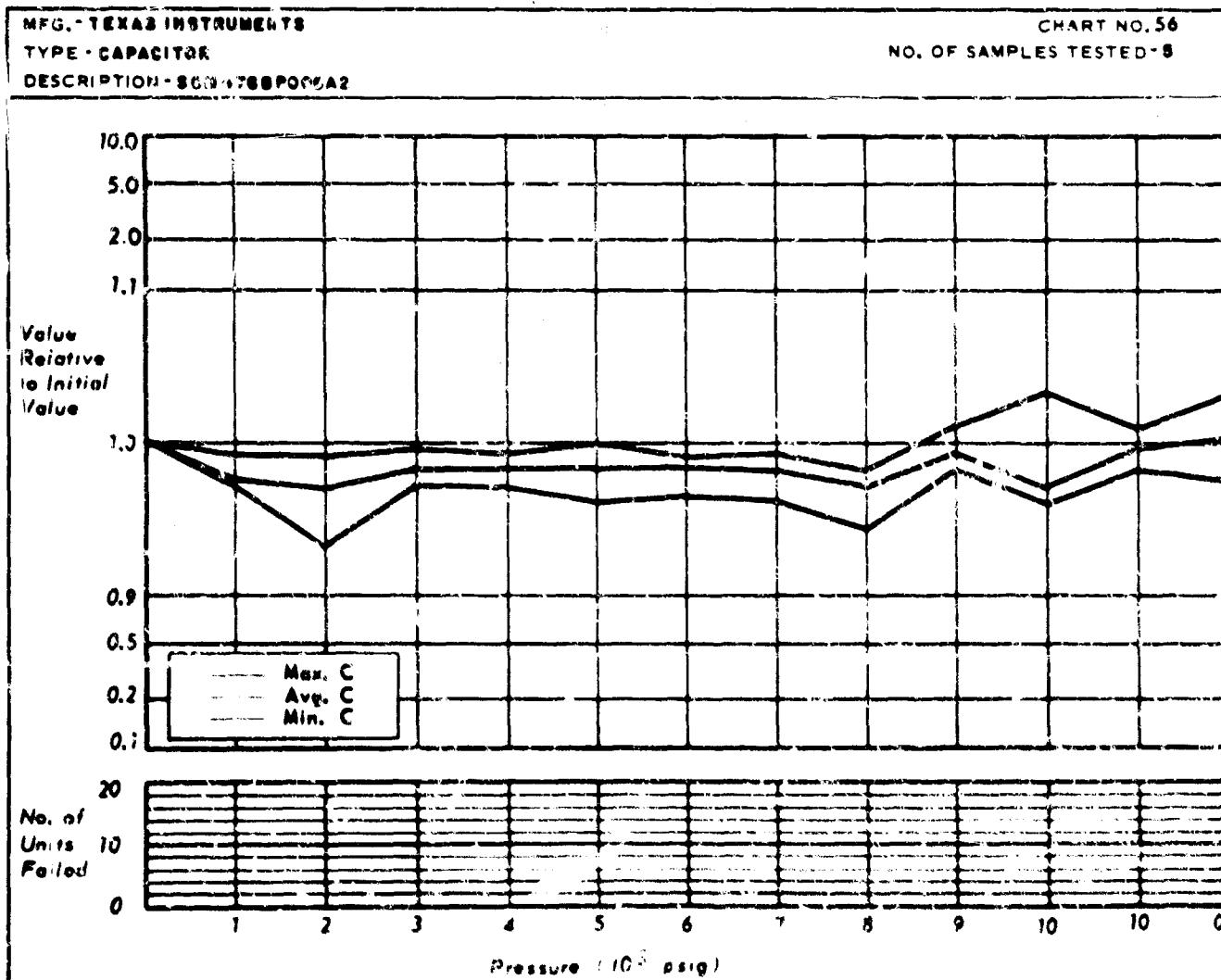
MFG. - TEXAS INSTRUMENTS
TYPE - CAPACITOR
DESCRIPTION - 8CM268P010A2

CHART NO. 55
NO. OF SAMPLES TESTED - 5



MFG. - TEXAS INSTRUMENTS
TYPE - CAPACITOR
DESCRIPTION - 8CM178P005A2

CHART NO. 56
NO. OF SAMPLES TESTED - 5



Texas Instruments
SCH226BPG10A
Capacitor

22.0 μ F
15 VDCW

Electrolytic
Tantalum, solid
Tubular, axial lead
0.438 x 0.175" diam.

SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Texas Instruments
SCH476BP006A2
Capacitor

47.0 μ F
5 VDCW

Electrolytic
Tantalum, solid
Tubular, axial lead
0.438 x 0.175" diam.

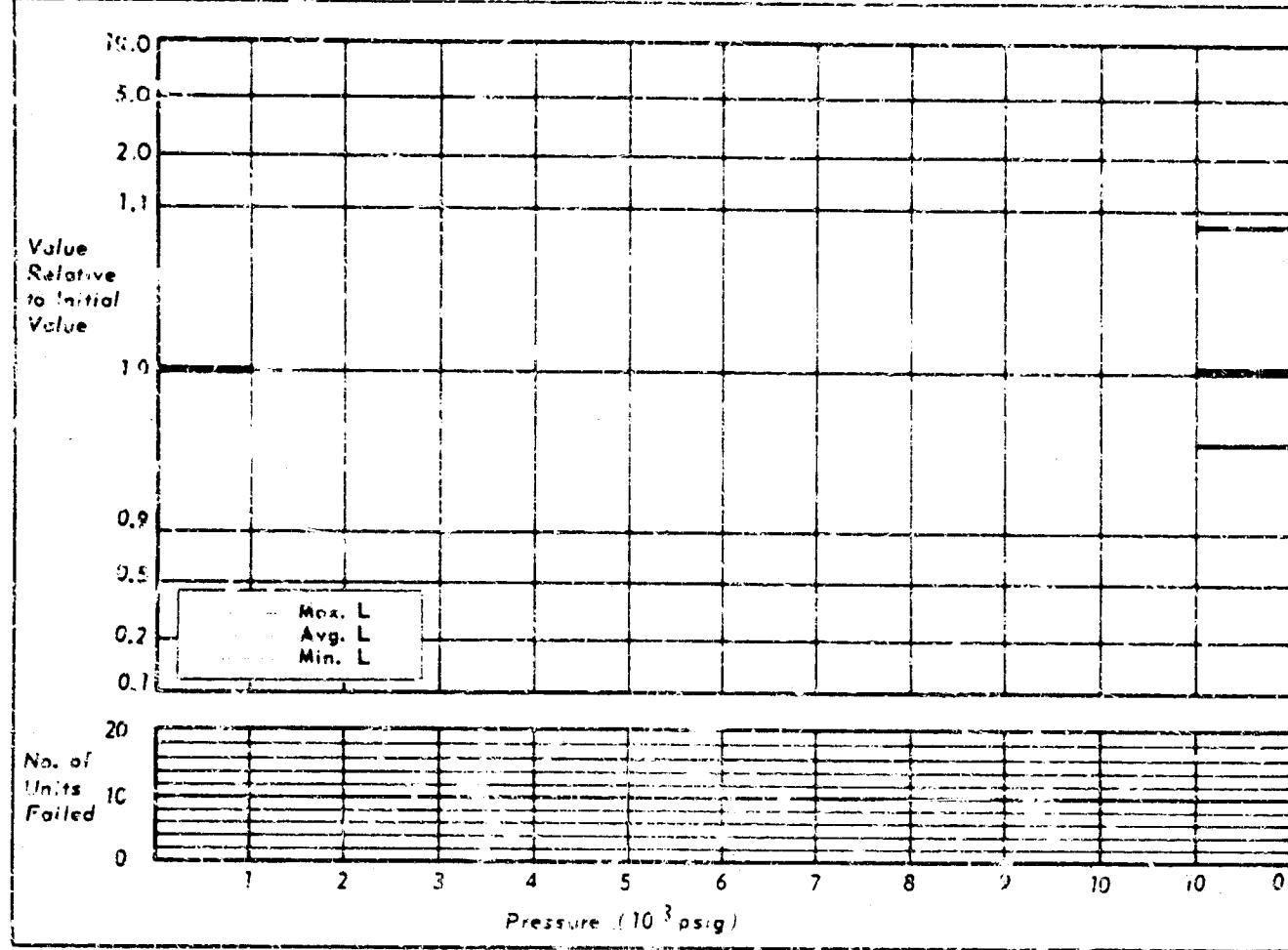
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All Components indicated less than 10% change.

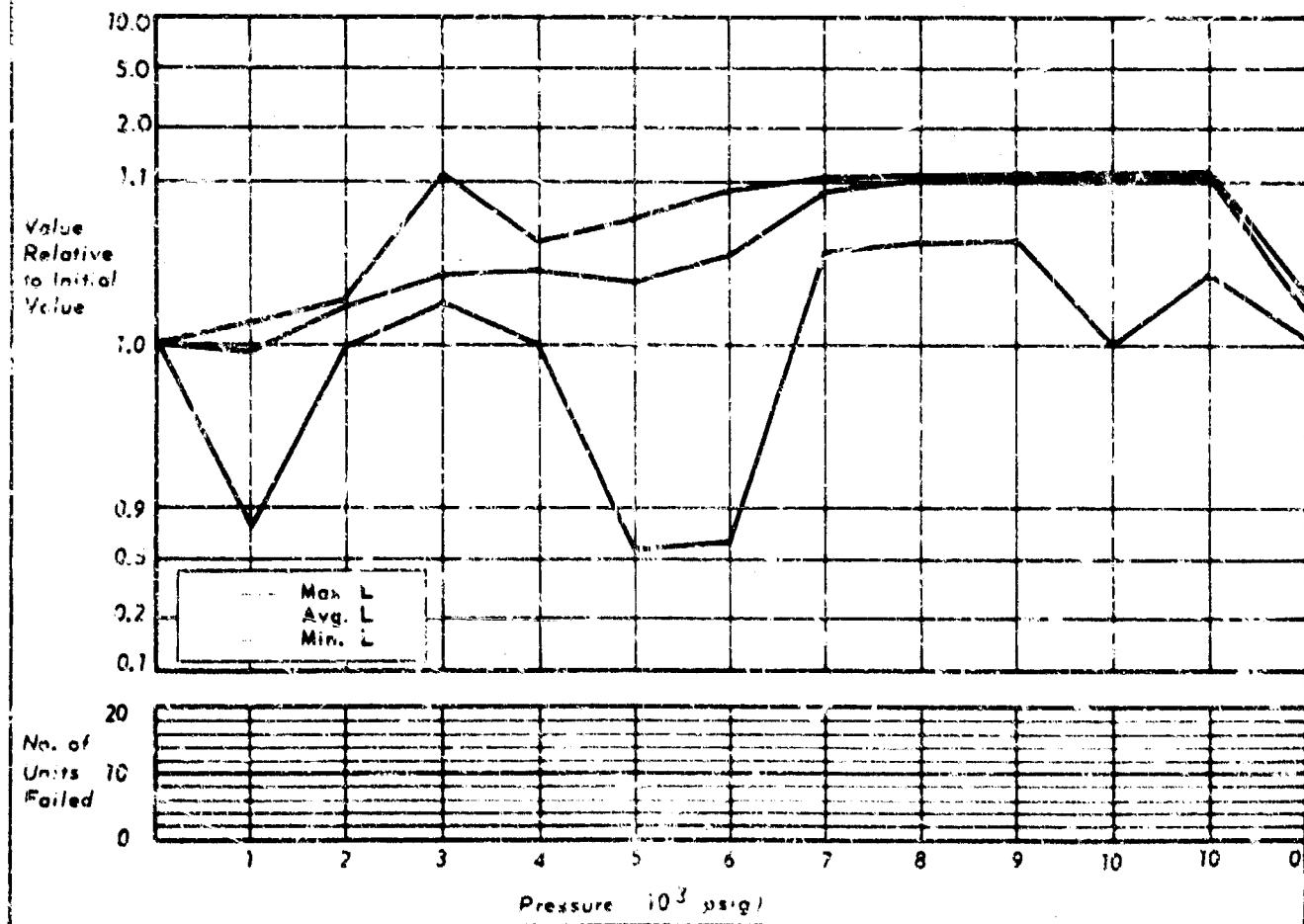
MFG.-GENERAL INSTRUMENTS
TYPE-RF COIL
DESCRIPTION - MS 7500R-8

CHART NO. 57
NO. OF SAMPLES TESTED-19



MFG.-GENERAL INSTRUMENTS
TYPE-COIL
DESCRIPTION - SM-2-249219

CHART NO. 58
NO. OF SAMPLES TESTED-19



General Instruments
FW Sickles Division
MS 7500B-B

2.2 μ H
at 7.9 Mc

Molded
Cylindrical, axial lead
0.45 x 0.15" diam.

RF coil

SOAK PERIOD: None

NOTE: Due to the low inductance value of the component relative to the inherent inductance of the test system measurements within the chamber were considered invalid.

The set was subjected to the entire pressure test program, however, only the readings taken before and after test were graphed. These readings appear in the first and last positions on the opposite graph.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change after completion of test.

General Instruments

M-6-249219

Cell

SOAK PERIOD: None

MECHANICAL: No apparent damage.

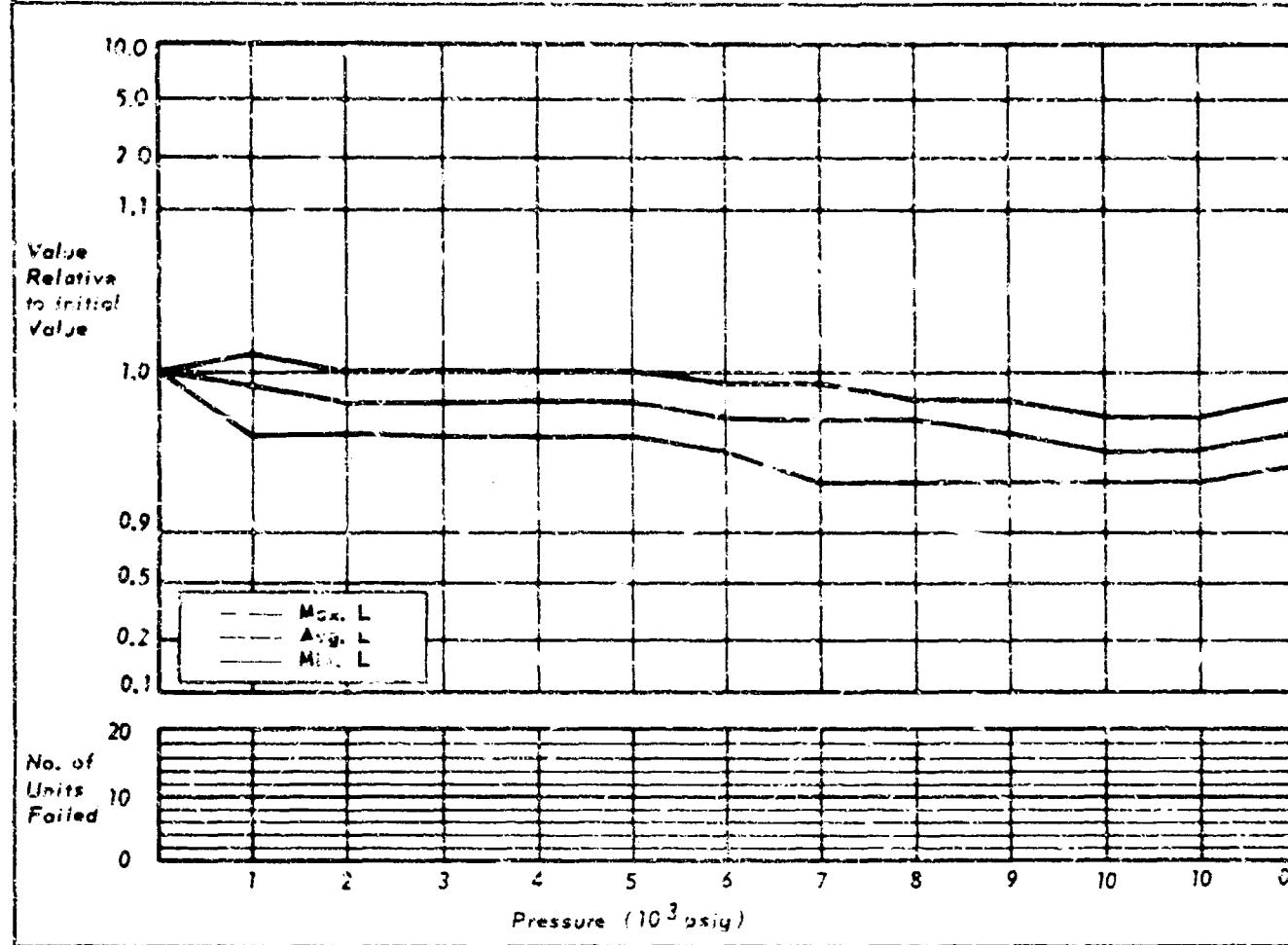
ELECTRICAL: Eighteen components indicated less than 10% change. One component indicated a change greater than 10% and less than 50%.

12 μ H
at 150 kc

Toroidal, molded
Pill box, radial lead
0.75 x 0.7 x 0.15"

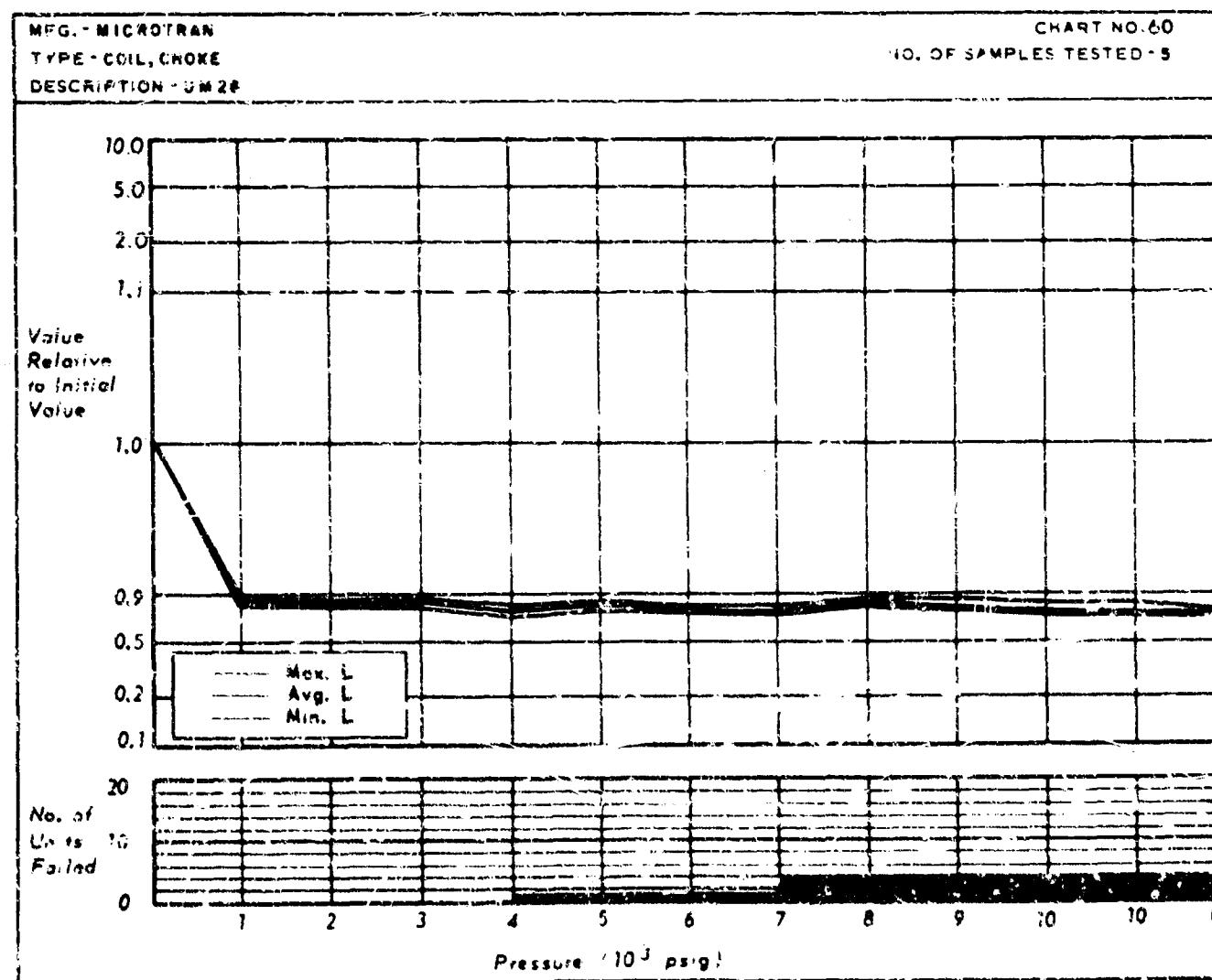
MFG - MICROTRAN
TYPE - COIL, AUDIO CHOKE
DESCRIPTION - PM 3R-M

CHART NO. 59
NO. OF SAMPLES TESTED - 6



MFG - MICROTRAN
TYPE - COIL, CHOKE
DESCRIPTION - JM 28

CHART NO. 60
NO. OF SAMPLES TESTED - 5



Microtran	6 H	Epoxy molded
PM 39-M	2.1A dc	Rectangular, parallel base lead
Audio choke coil	1800 DCR	0.465 x 0.41 x 0.3"

SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Microtran	8 H	Epoxy potted
UM 28-M	3.5 mA dc	0.5 x 9.562 x 0.437"
Choke coil		

SOAK PERIOD: None

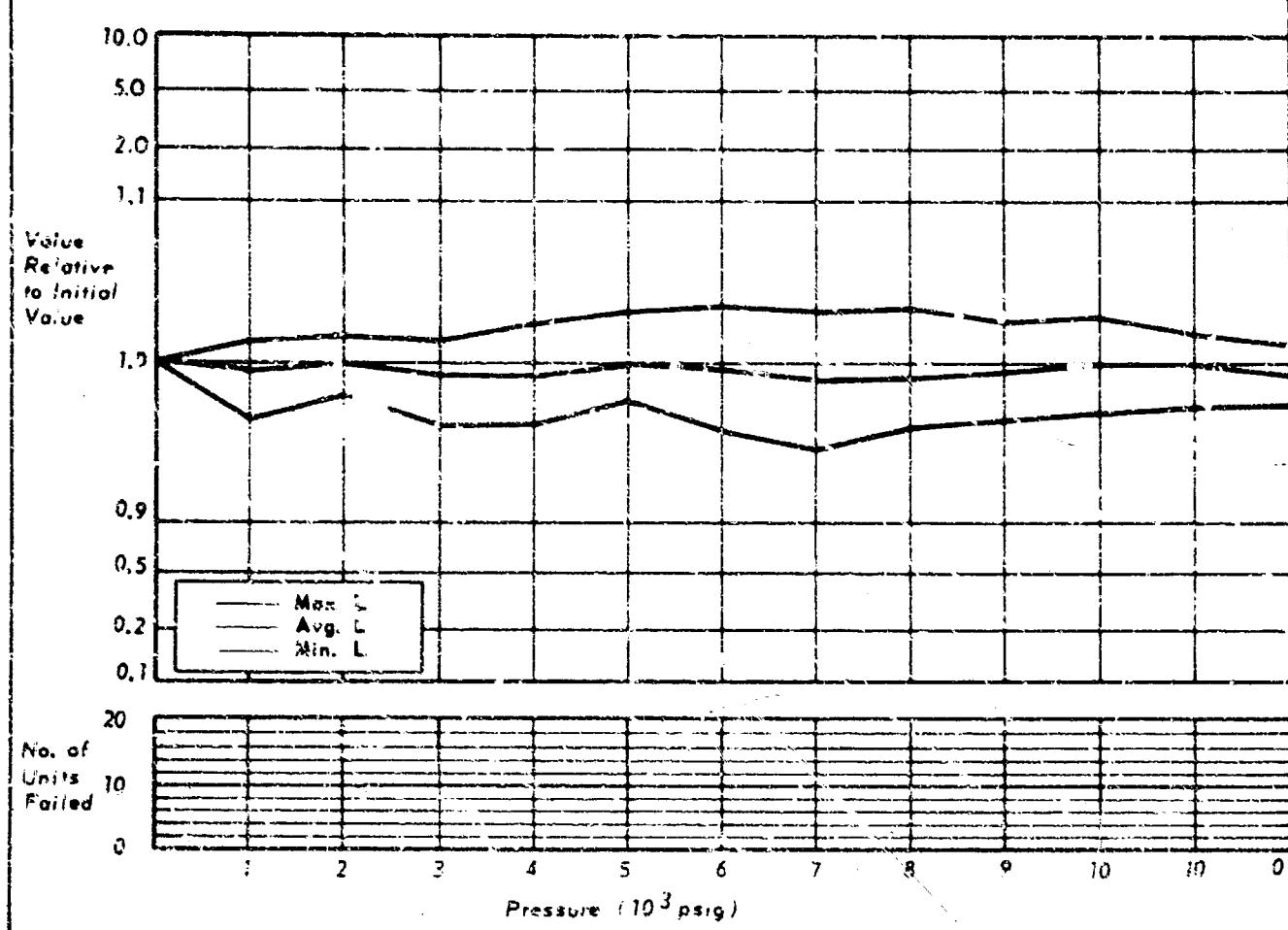
MECHANICAL: Visual inspection after completion of test showed a fractured case on one sample.

ELECTRICAL: One component indicated a change greater than 10% and less than 50% change.

FAILURES: Four components indicated a permanent change greater than 50%.

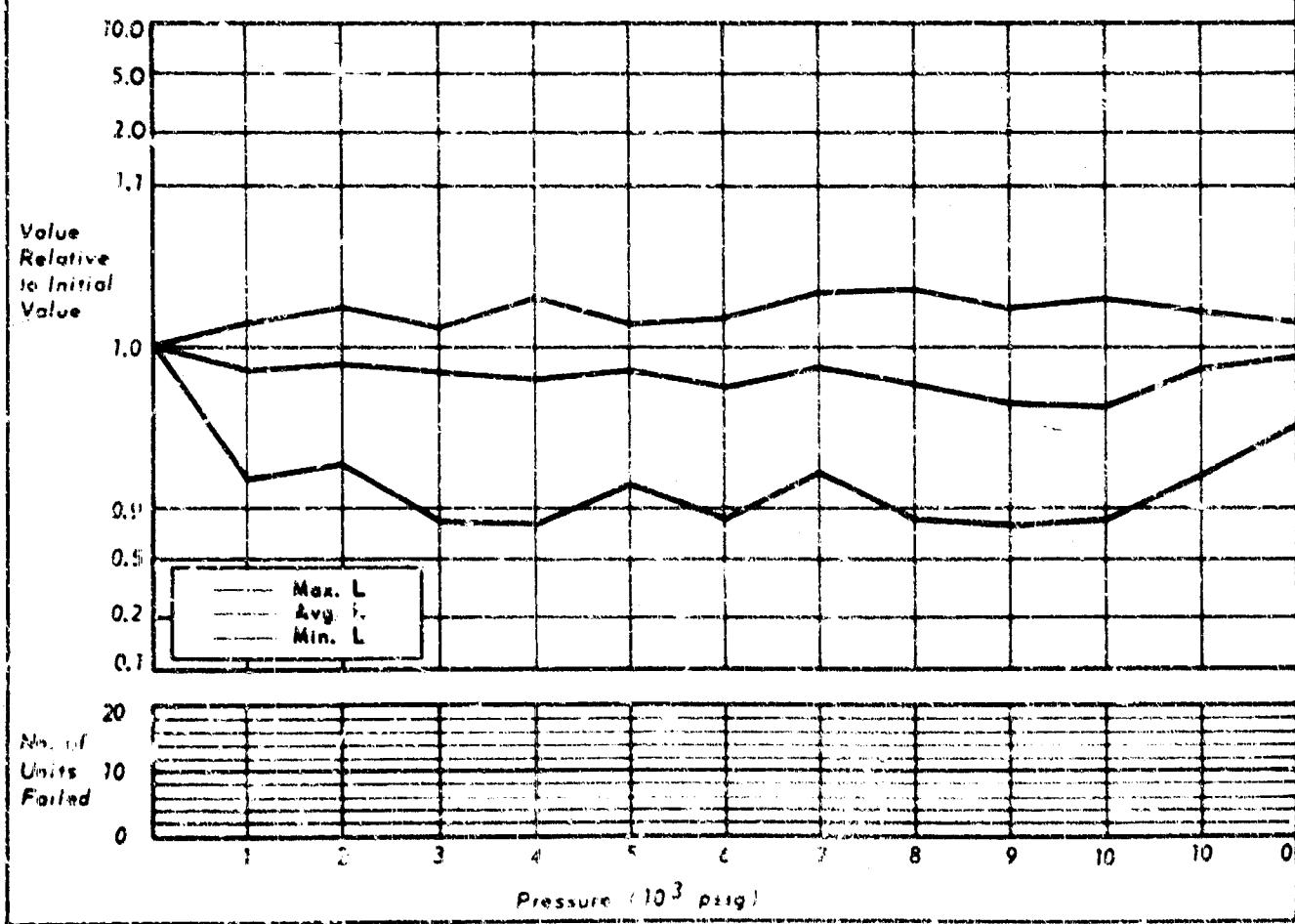
MFG. - J. W. MILLER
TYPE - R.F. CHOKES
DESCRIPTION - 8230-00

CHART NO. 61
NO. OF SAMPLES TESTED-10



MFG. - J. W. MILLER
TYPE - R.F. CHOKES
DESCRIPTION - 8240-70B

CHART NO. 62
NO. OF SAMPLES TESTED-10



J. W. Miller 0.15 μ H \pm 10% Molded case
 9230-00 at 25 Mc. Tubular, axial lead
 R. F. choke 0.25 \times 0.10" diam.

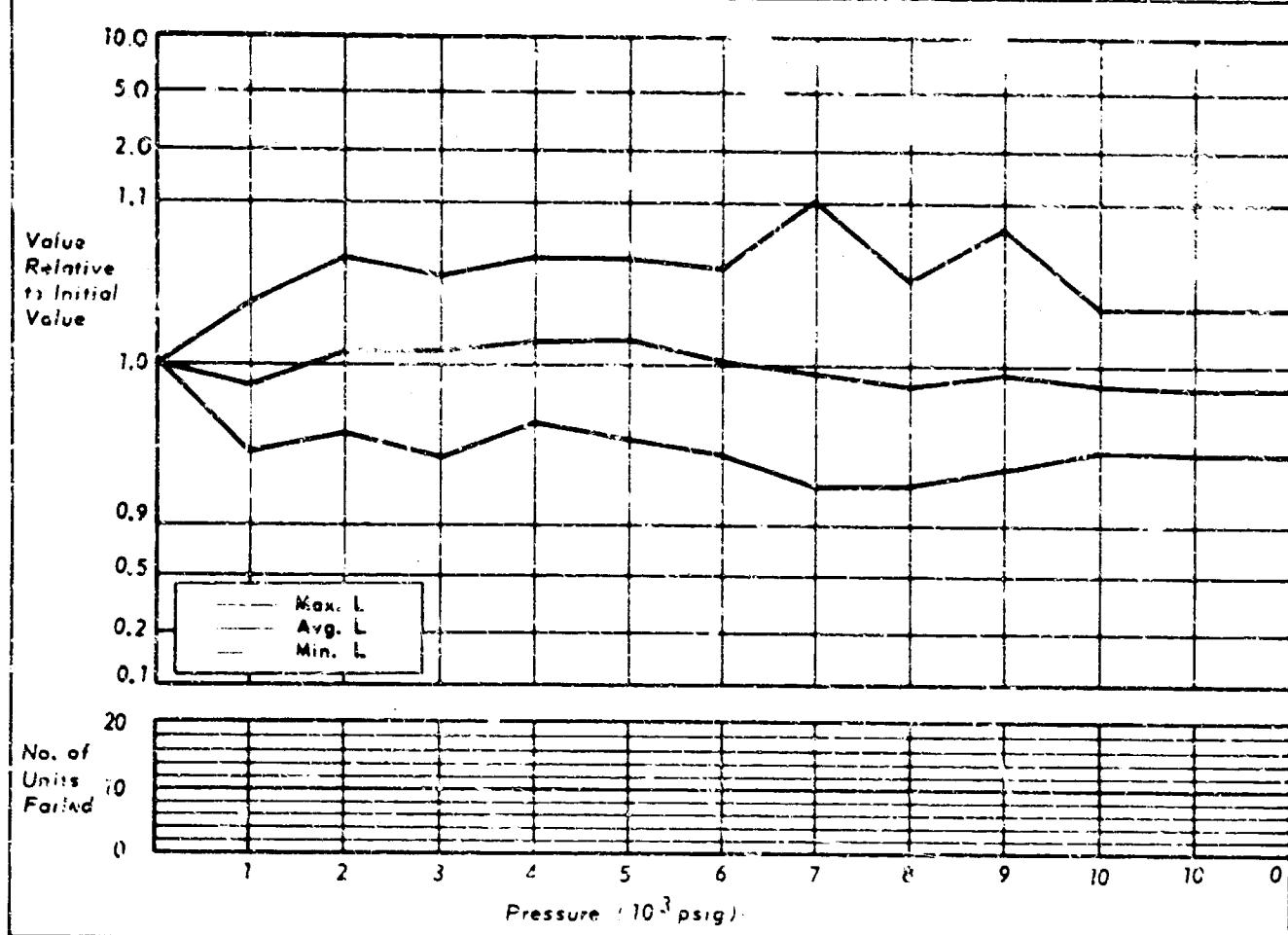
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

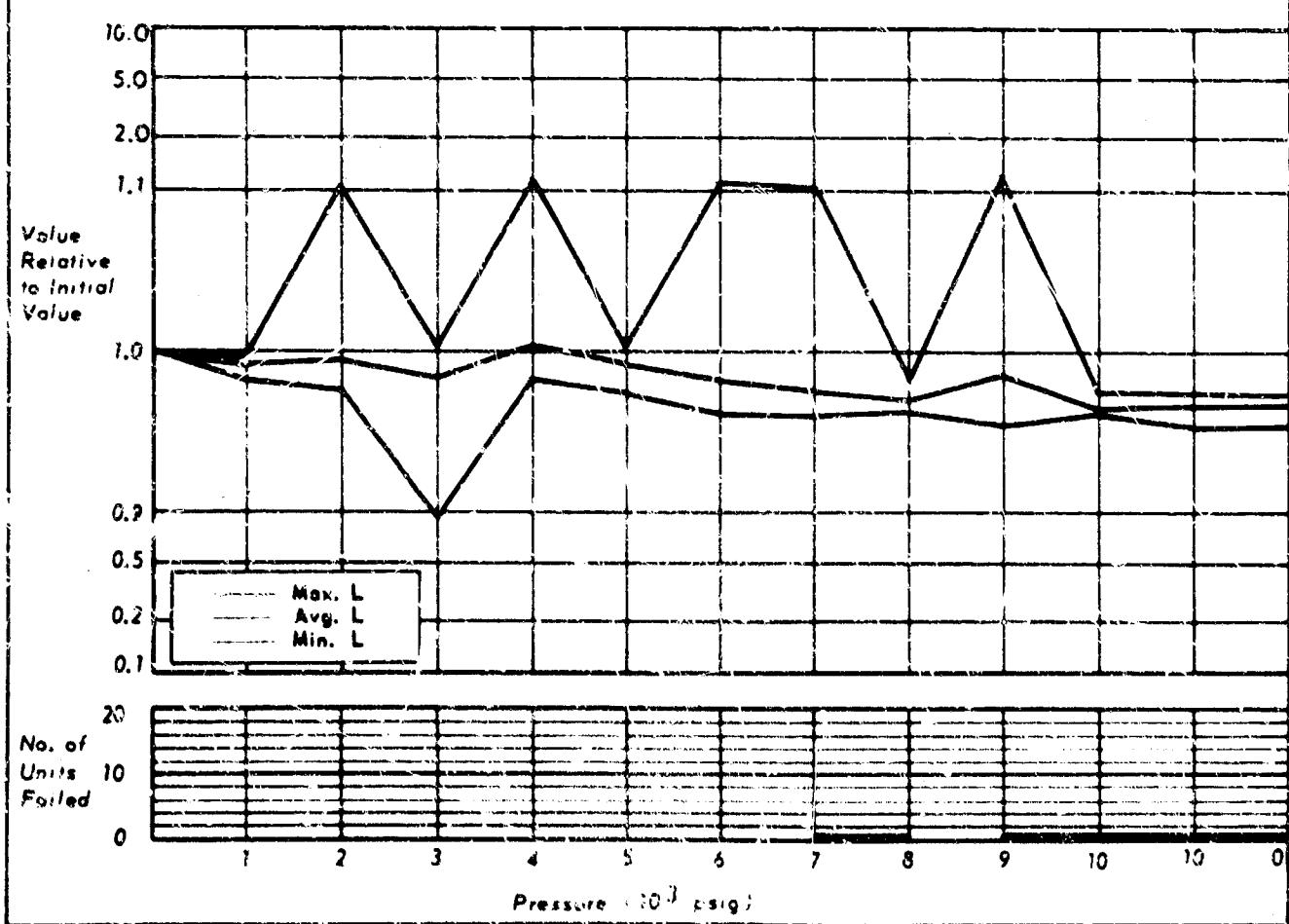
MFG. - J.W. MILLER
TYPE - RF CHOKE COIL
DESCRIPTION - 9220-00

CHART NO. 53
NO. OF SAMPLES TESTED - 10



MFG. - J.W. MILLER
TYPE - RF CHOKE COIL
DESCRIPTION - 9220-00

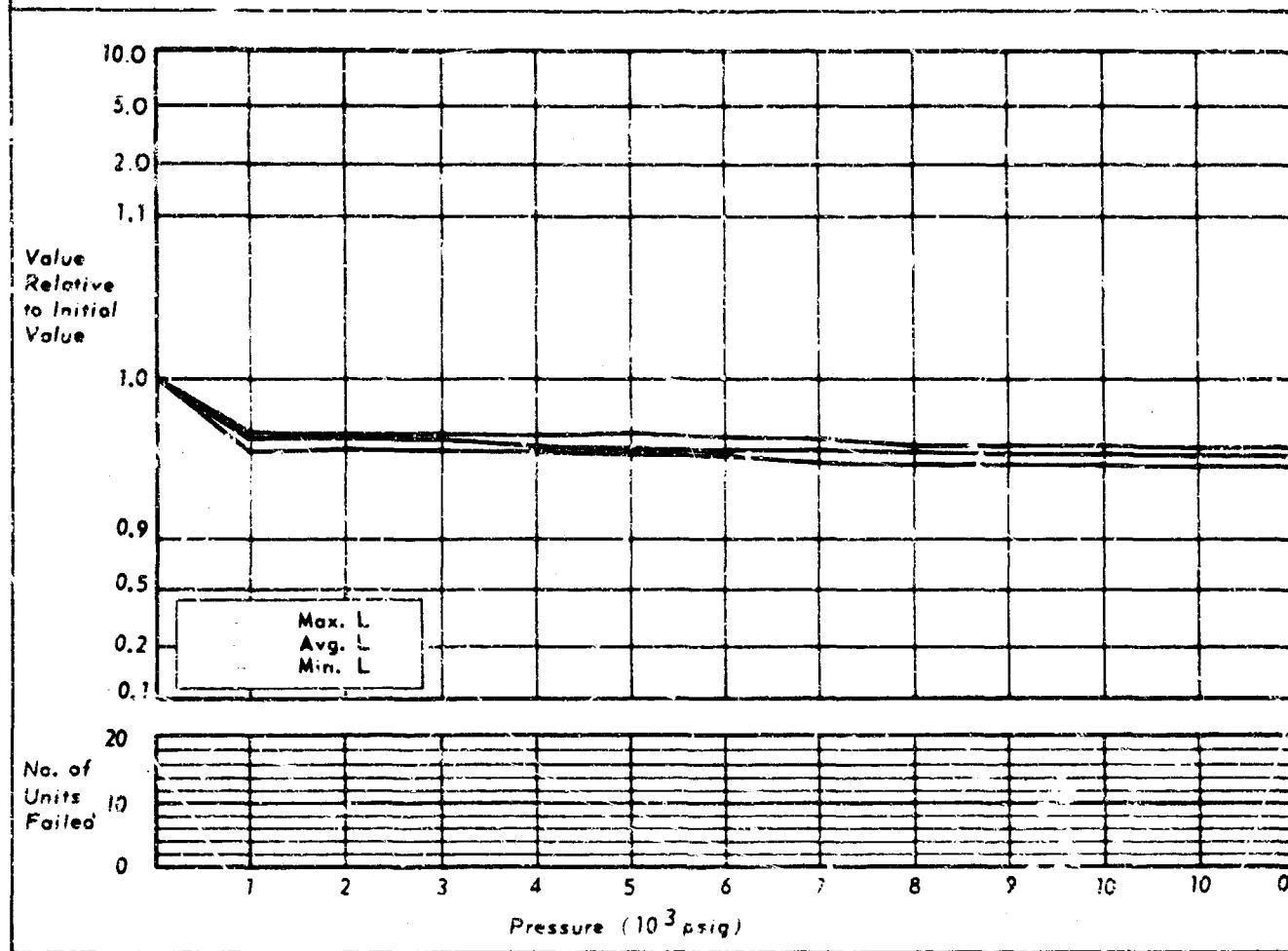
CHART NO. 64
NO. OF SAMPLES TESTED - 10



J. W. Miller	270 μ H \pm 5%	Molded
9220-00	at 0.78 Mc	Tubular, axial lead
R. F. choke		0.44 x 0.19" diam.
SOAK PERIOD:	16 hours at 8,000 psig.	
MECHANICAL:	No apparent damage.	
FAILURE:	The inductance varied more than 50% on one component at the pressures shown on graph on opposite page.	

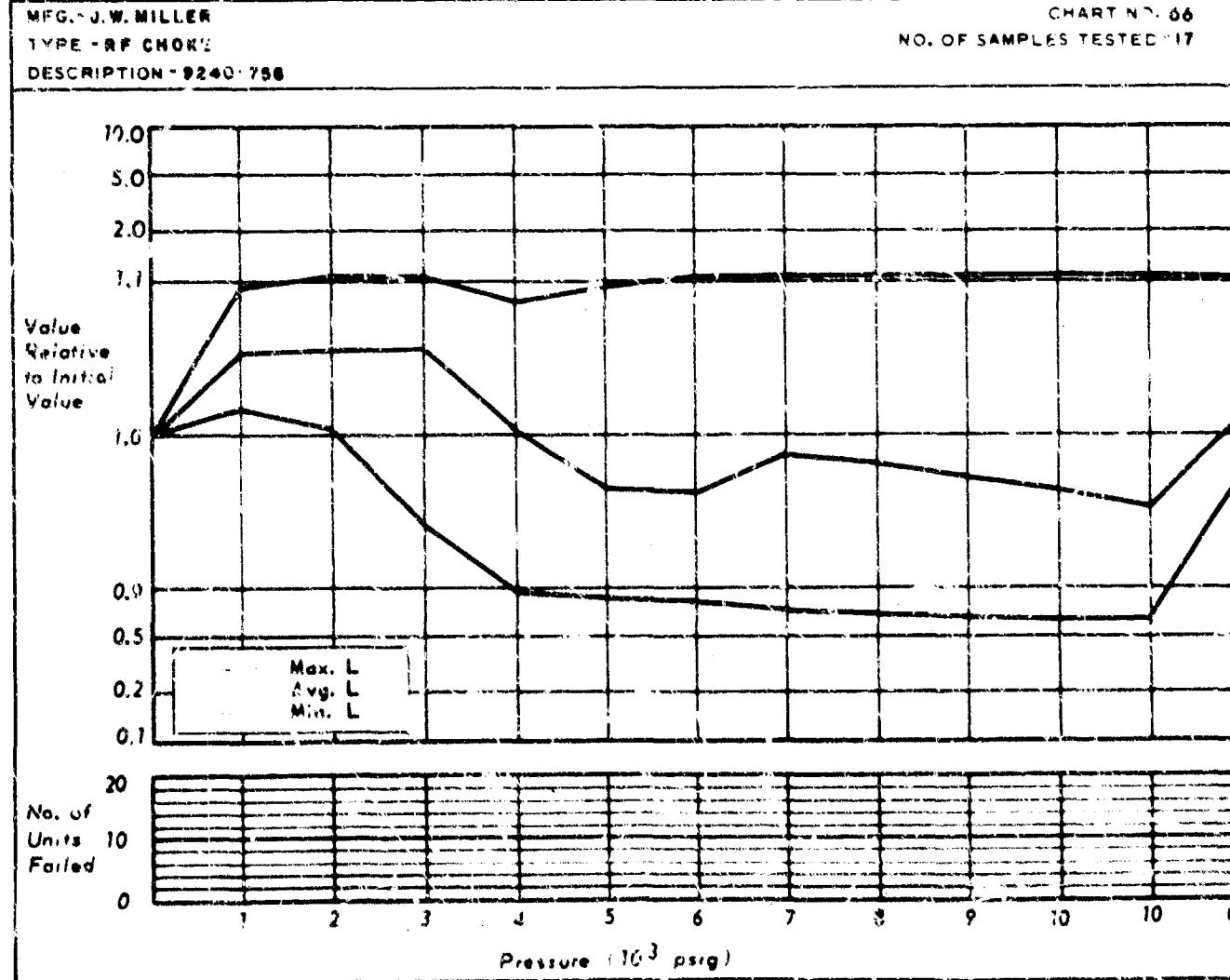
MFG. - J.W. MILLER
TYPE - RF CHOKES
DESCRIPTION - 9220-78

CHART NO. 65
NO. OF SAMPLES TESTED - 18



MFG. - J.W. MILLER
TYPE - RF CHOKES
DESCRIPTION - 9240-788

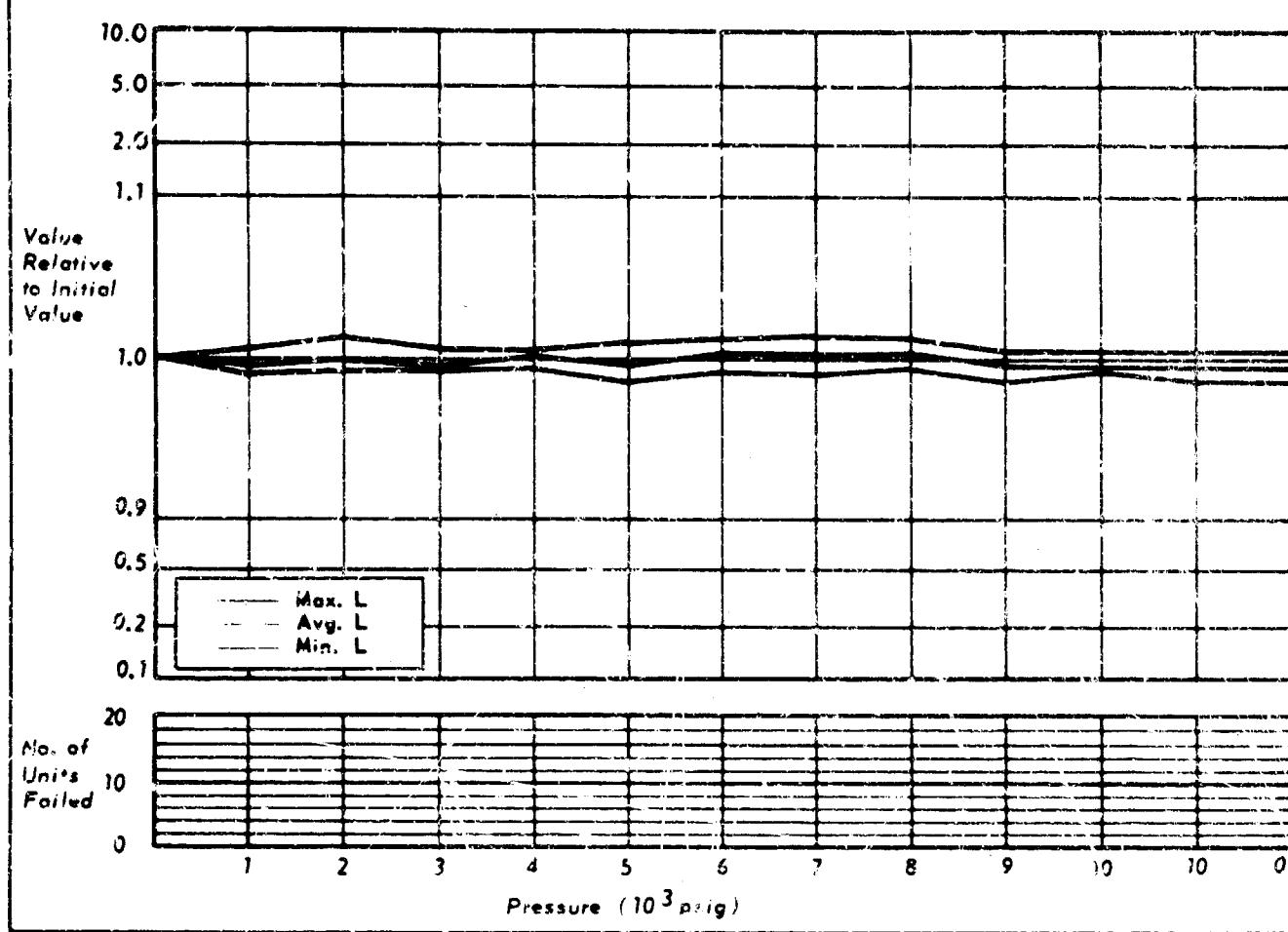
CHART NO. 66
NO. OF SAMPLES TESTED - 17



J. W. Miller	10 μ H \pm 10%	Molded, shielded
7240-756	at 250 kc	Tubular, axial lead
R. L. choke		0.36 x 0.15" diam.
SOAK PERIOD:	None	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	Nine components indicated less than 10% change.	
	Eight components indicated a change greater than 10% and less than 50%.	

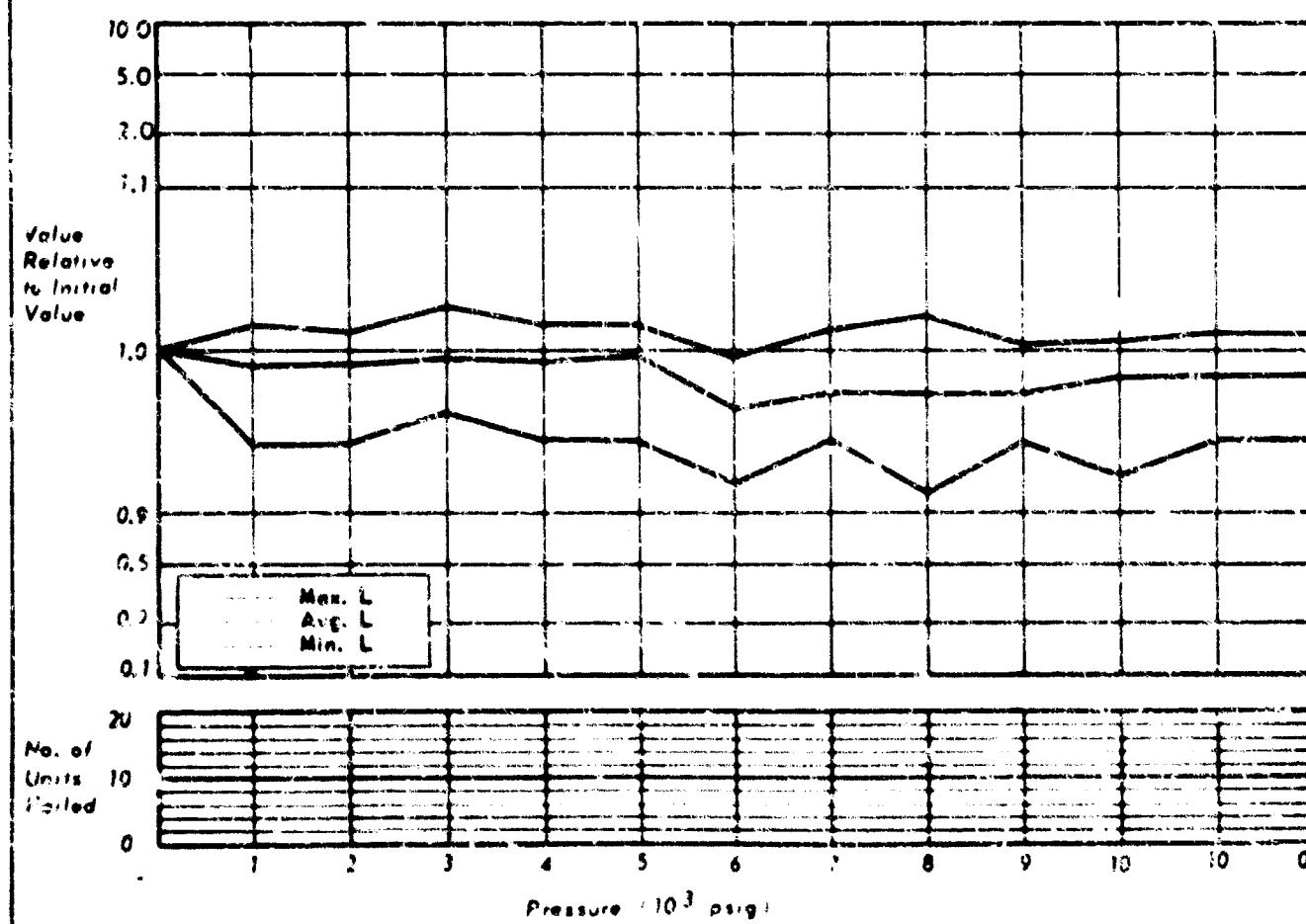
MFG.-J.W.MILLER
TYPE-RF COIL
DESCRIPTION-50A 108 ZPI

CHART NO. 67
NO. OF SAMPLES TESTED-19



MFG.-J.W.MILLER
TYPE-RF COIL
DESCRIPTION-4632-E

CHART NO. 68
NO. OF SAMPLES TESTED-20

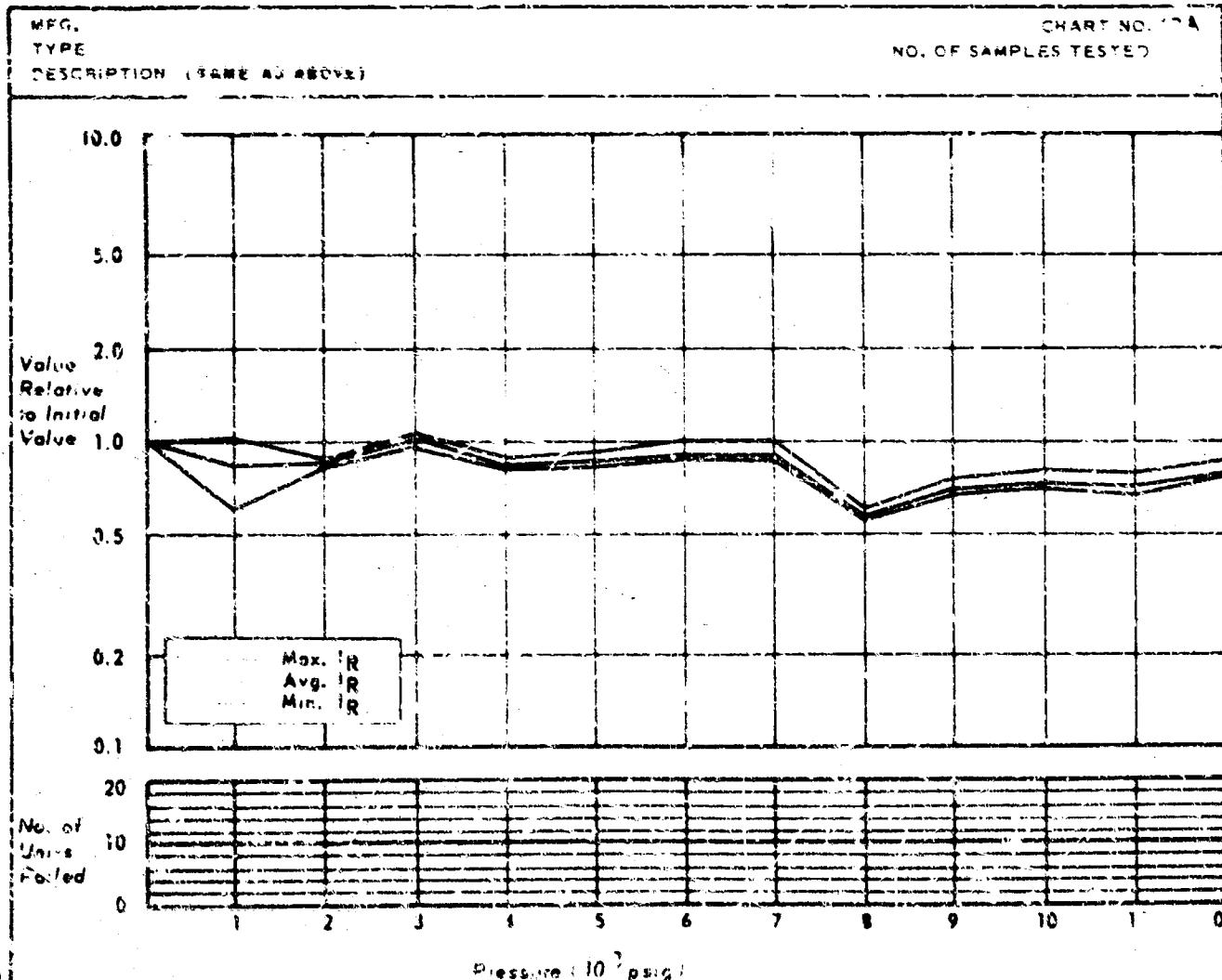
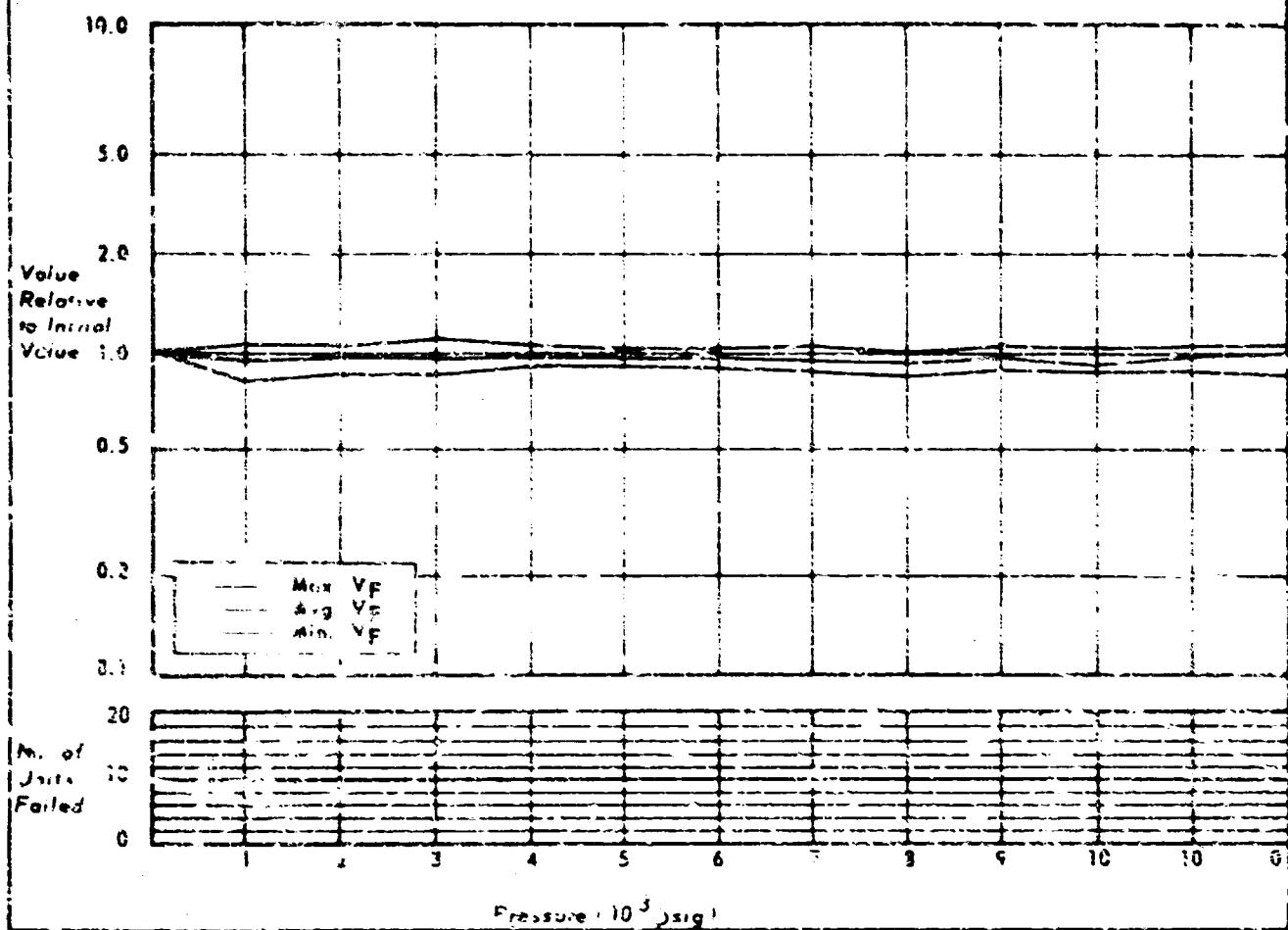


J. W. Miller 0.77 to 1.25 μ H Encap, adjustable
50A 103 EBI at 25 kc Cylindrical, radial studs
R. F. coil 1.6 x 0.625" diam.

SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

MFG. - GENERAL INSTRUMENT
TYPE - DIODE
DESCRIPTION - IN649

CHART NO. 69
NO. OF SAMPLES TESTED - 19



General Instruments

IN 649

Diodes, rectifier

P₁ = 600 V

I_{dc avg.} = 400

Silicone, glass

Tubular, axial lead

0.30 x 0.195" diam.

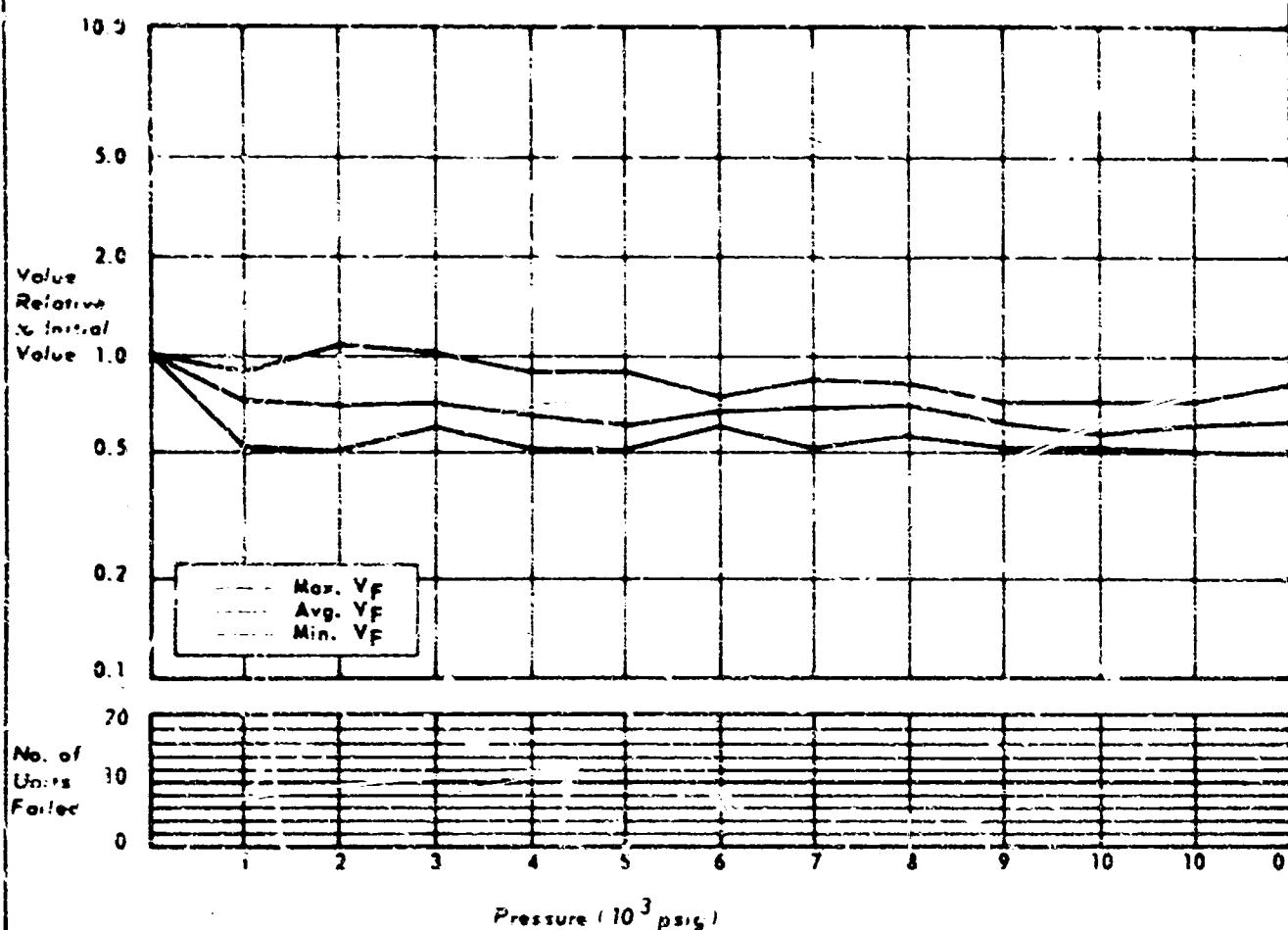
SOAK PERIOD: 16 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

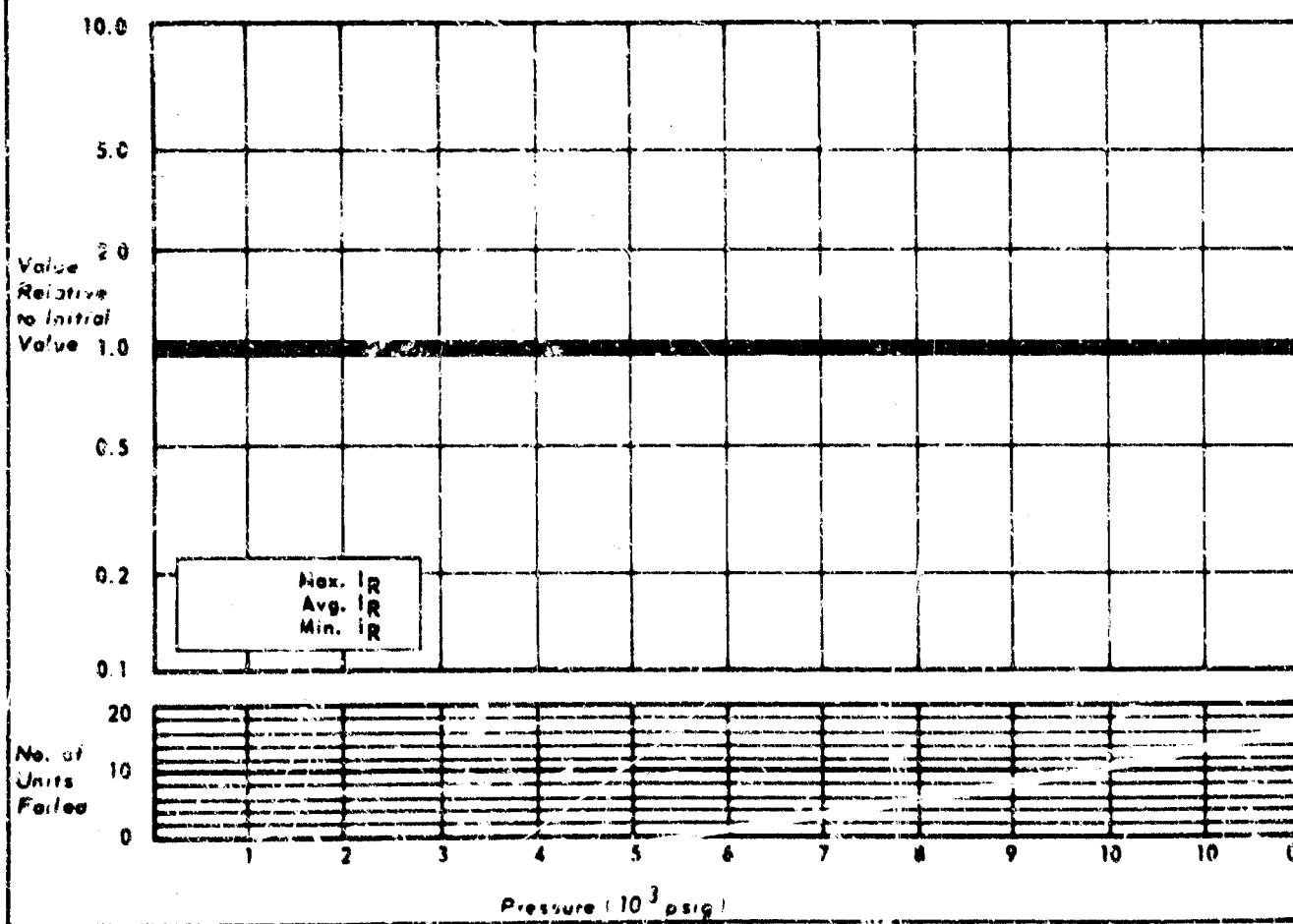
MFG. - GENERAL INSTRUMENT
TYPE - DIODE
DESCRIPTION - 1K5246

CHART NO. 70
NO. OF SAMPLES TESTED - 19



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 70A
NO. OF SAMPLES TESTED



Gates & Crellin Instruments

IN 36x6M2

Diode

PIV = 89 V dc

$I_{dc\ avg.} = 10\text{ mA}$

Silicone

Glass case

0.36 x 0.15" dia.

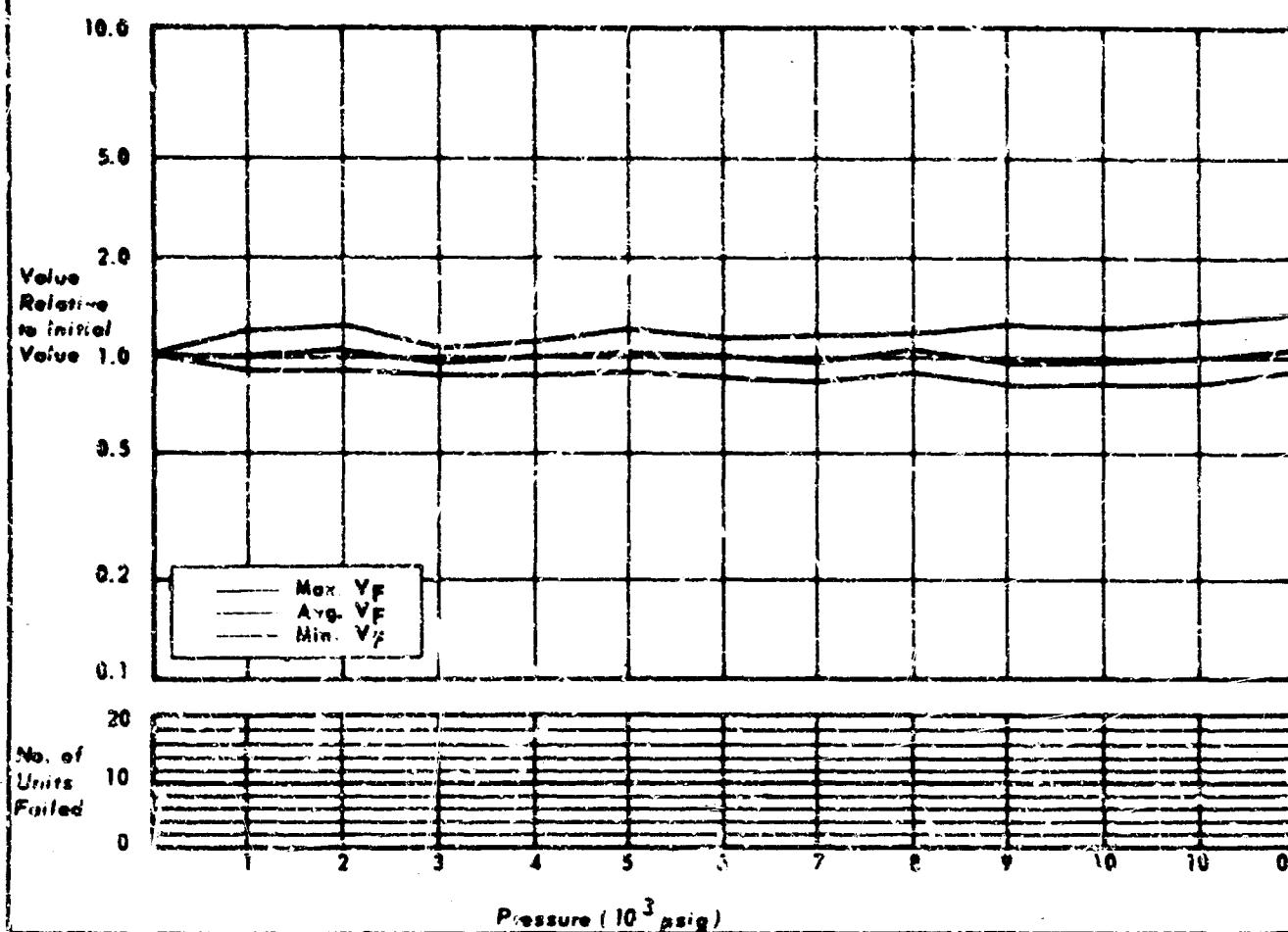
SOAK PERIOD: 1' hours at 6000 sig.

MECHANICAL: No apparent damage.

ELECTRICAL: Two components indicated less than 10% change and seventeen indicated greater than 10% and less than 50% change.

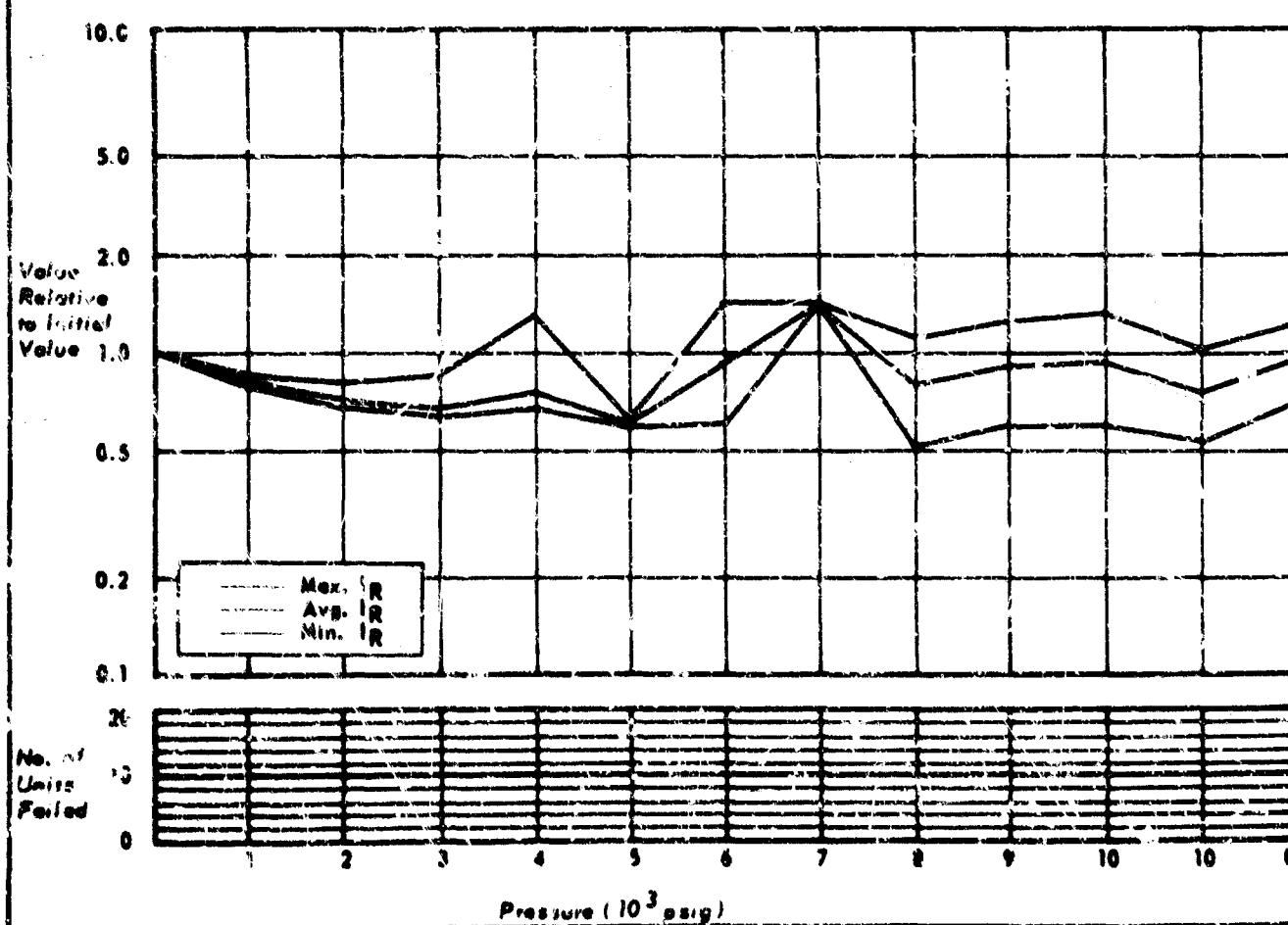
MFG. - GENERAL INSTRUMENT
TYPE - DIODE
DESCRIPTION - 10947

CHART NO. 71
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 71A
NO. OF SAMPLES TESTED



General Item: 1N 547

Diode, rectifier

PIV = 600 V

I_{dc} (avg.) = 250 mA

Silicone

DO case

0.90 x 0.40" diam

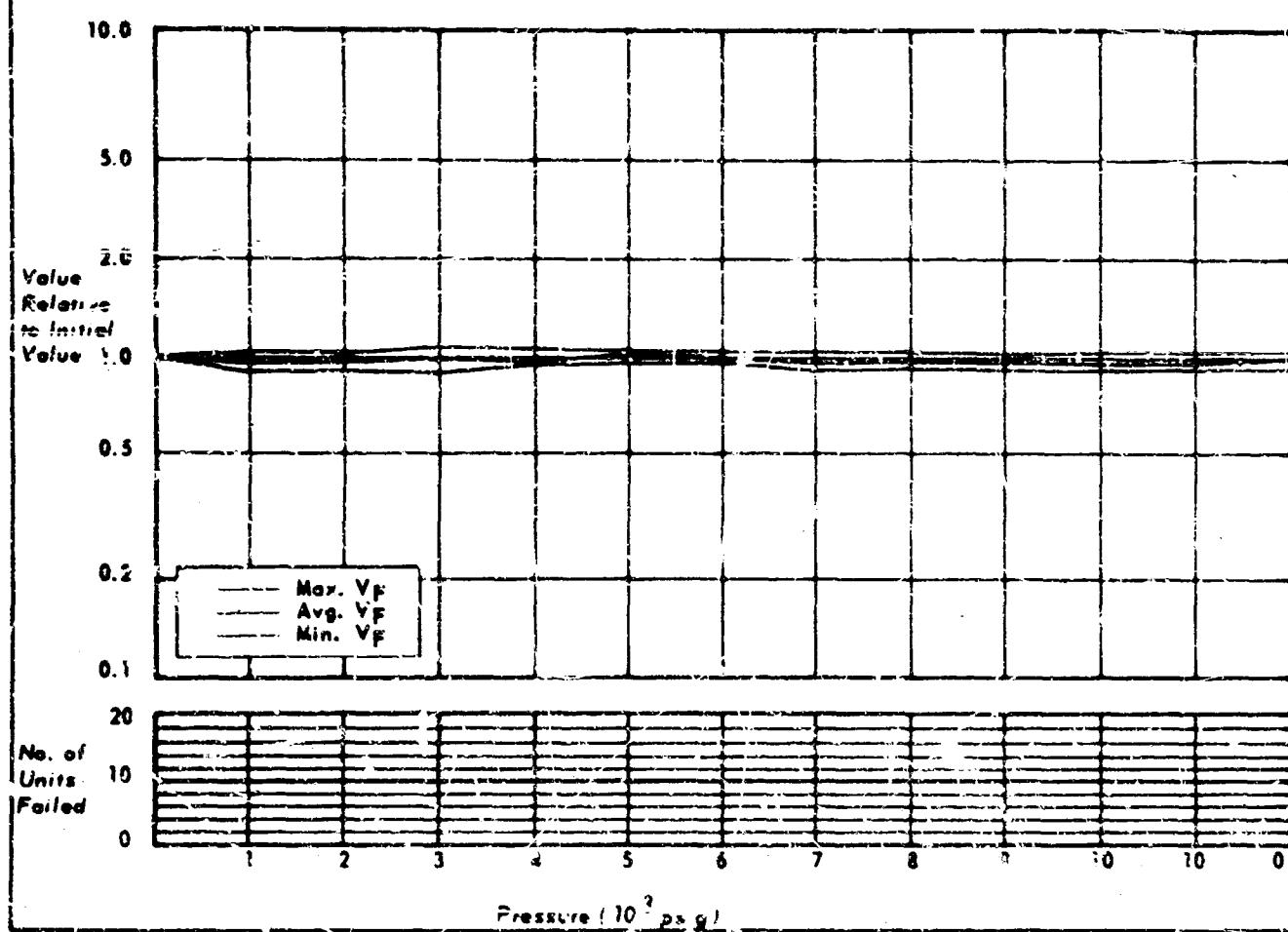
SOAK PERIOD: 16 hours at 10,900 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

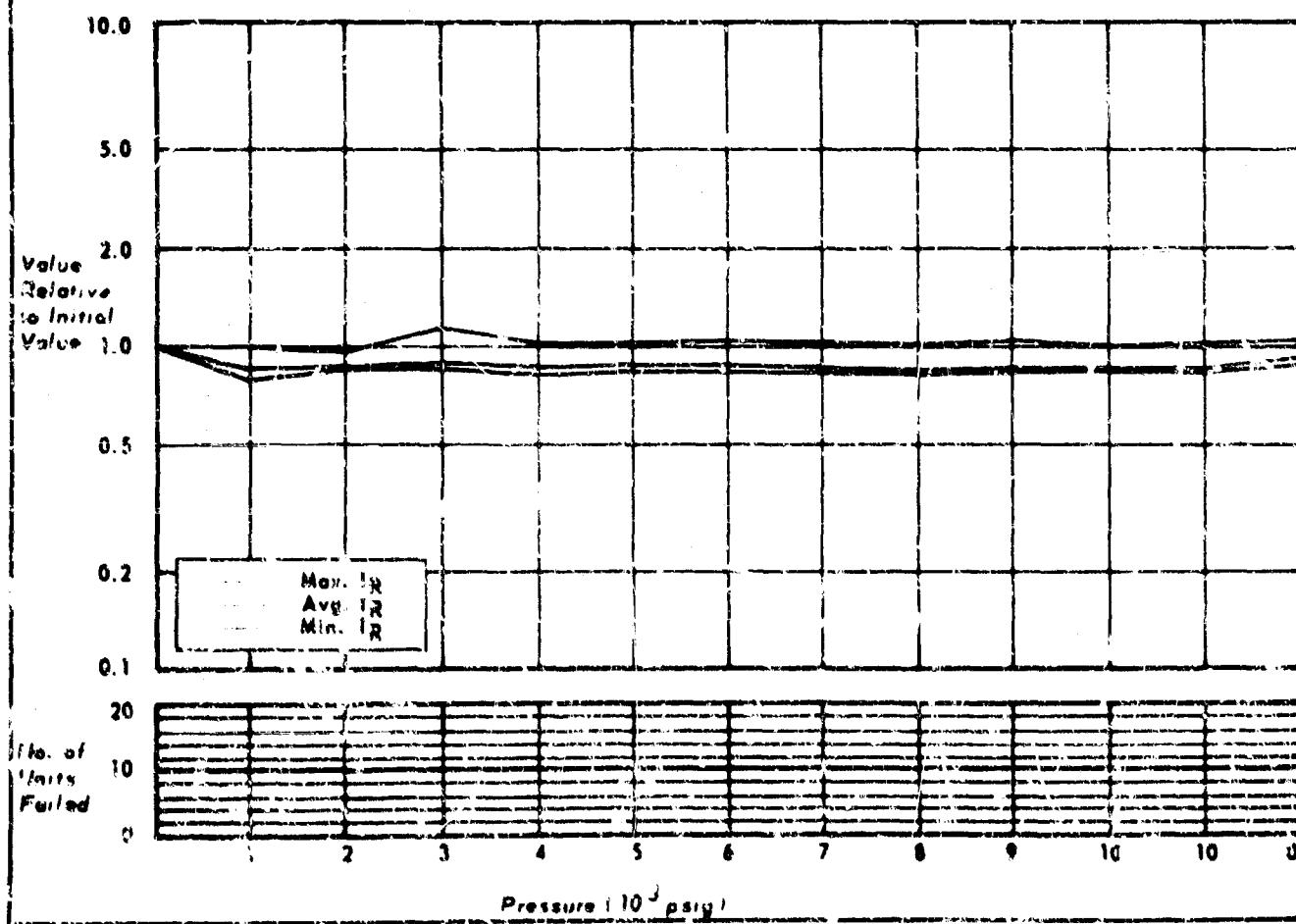
MFG.-GENERAL INSTRUMENT
TYPE - DIODE
DESCRIPTION - 181298A

CHART NO. 72
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 72A
NO. OF SAMPLES TESTED



General Instruments

IN 1206A

Diode, rectifier

PIV = 50-600 V

$I_{dc\ avg.} = 6$ Amp

Silicone

DO case

Stud mount

0.40 x 0.40" diam

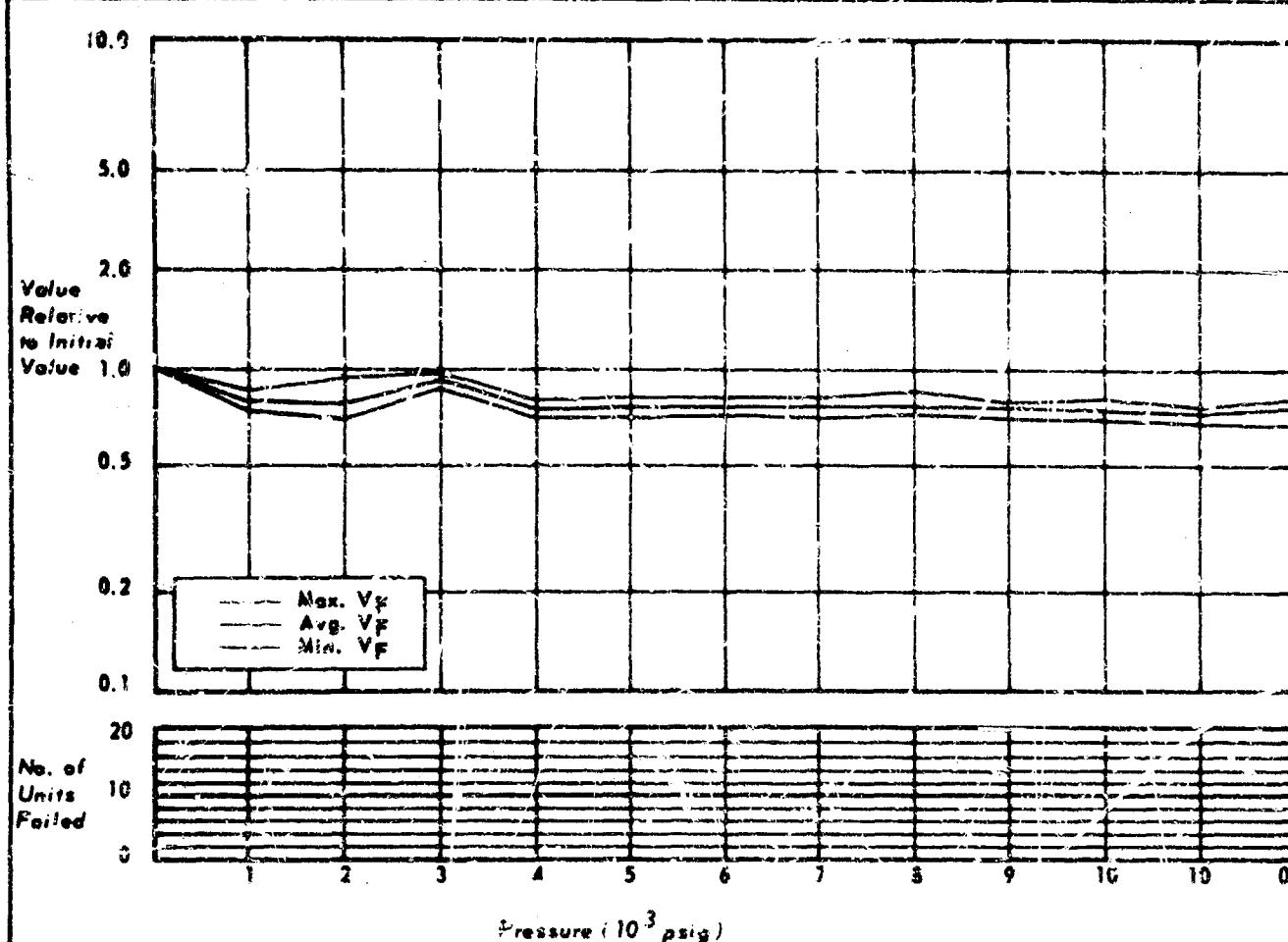
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

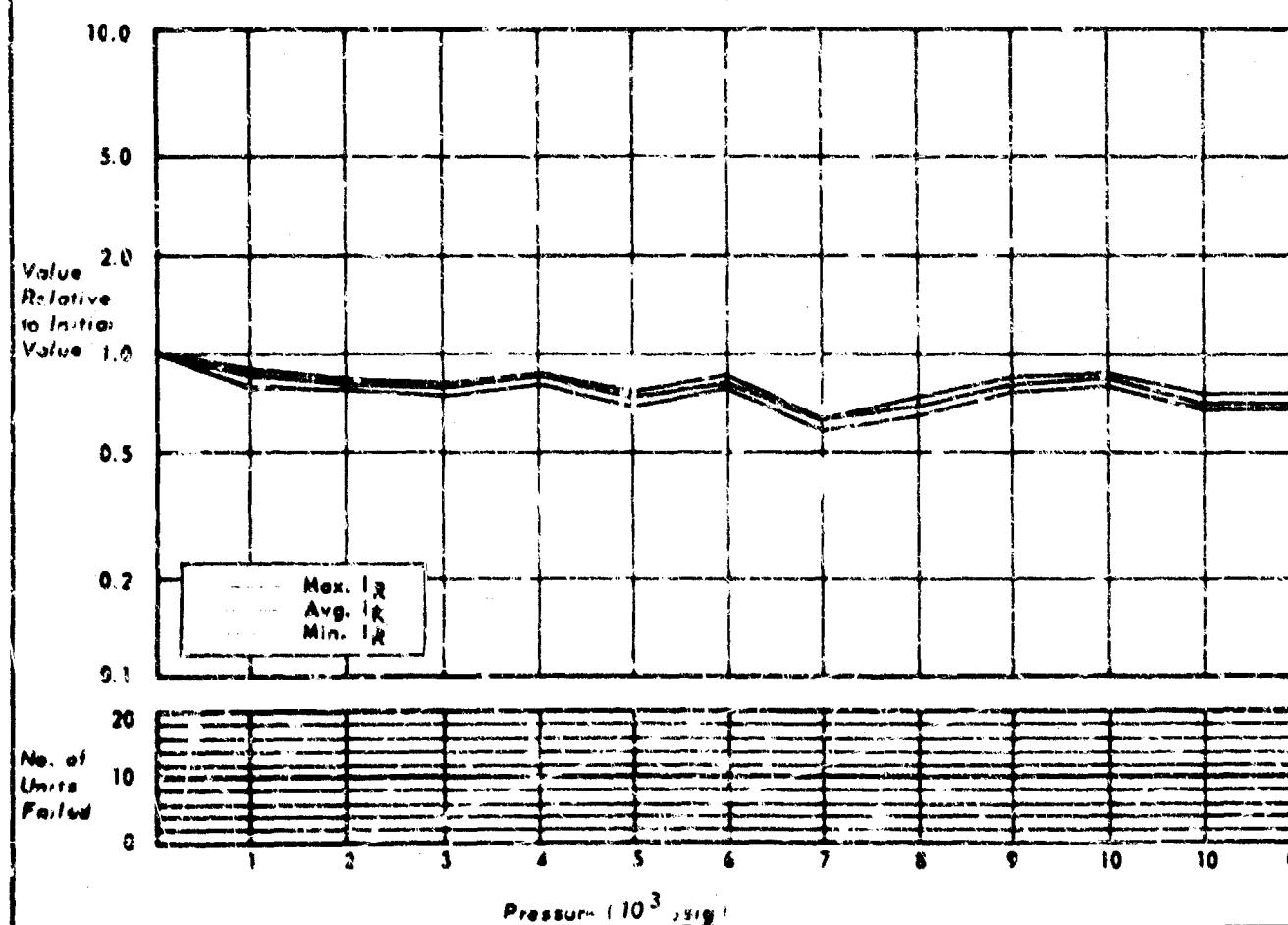
MFG. GENERAL INSTRUMENT
TYPE - DIODE, RECTIFIER
DESCRIPTION - 6100J

CHART NO. 73
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 73A
NO. OF SAMPLES TESTED



General Instruments

G 100 J

Diode, rectifier

PIV = 600 V

$I_{dc\ avg.}$ = 1.0 Amp

Silicone

Lead mount

Glass encap

0.36 x 0.15" diam

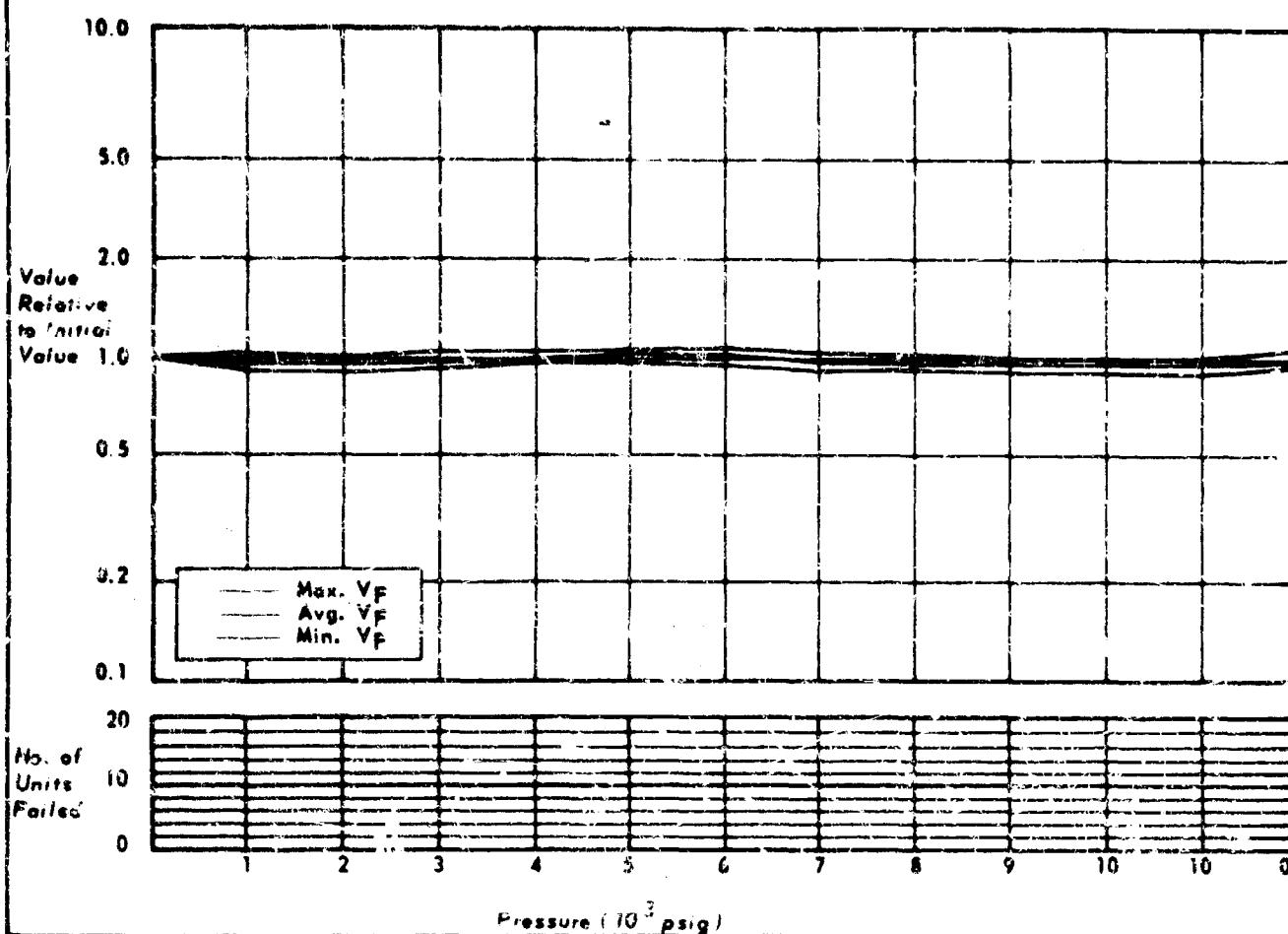
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% and less than 50%.

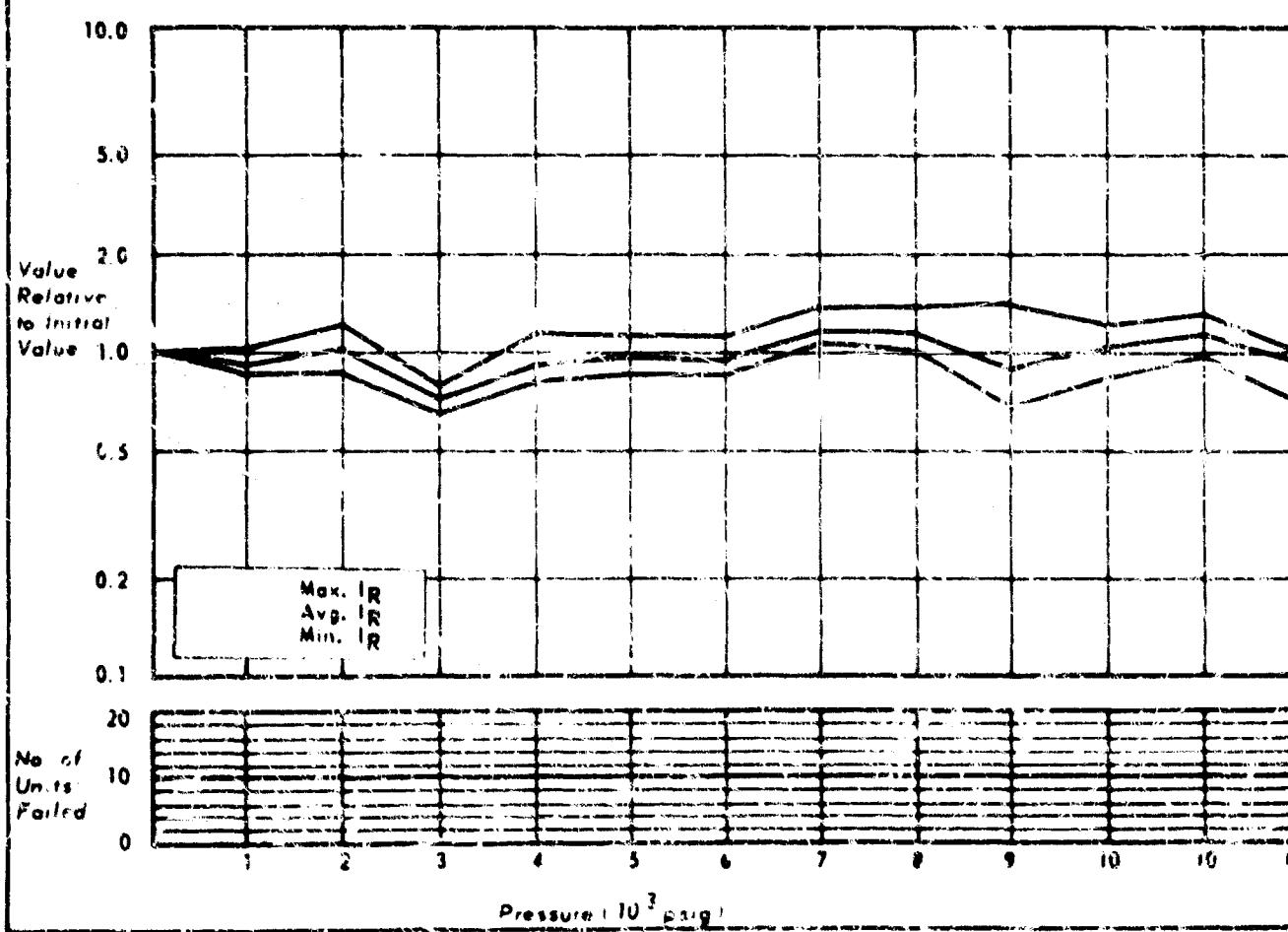
MFG. - MOTOROLA
TYPE - DIODE, RECTIFIER
DESCRIPTION - IN3101

CHART NO. 74
NO. OF SAMPLES TESTED - 19



MFG.
TYPE
DESCRIPTION - (SAME AS ABOVE)

CHART NO. 74A
NO. OF SAMPLES TESTED



Motorola
1N 3191
Diode, rectifier

Hermetically sealed steel case
Tubular, axial lead
0.32 x 0.22" diam

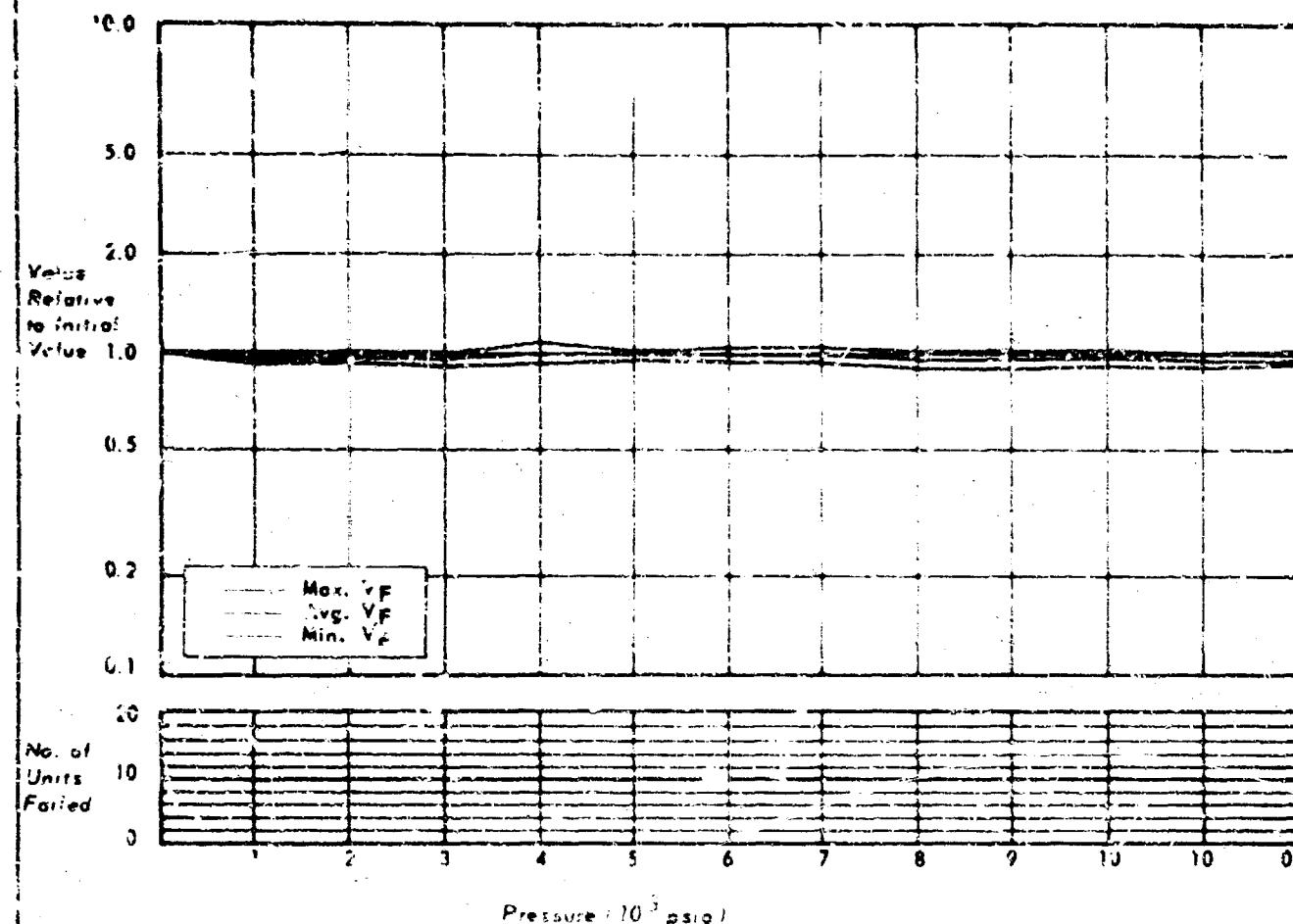
SOAK PERIOD: 16 hours at 3,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

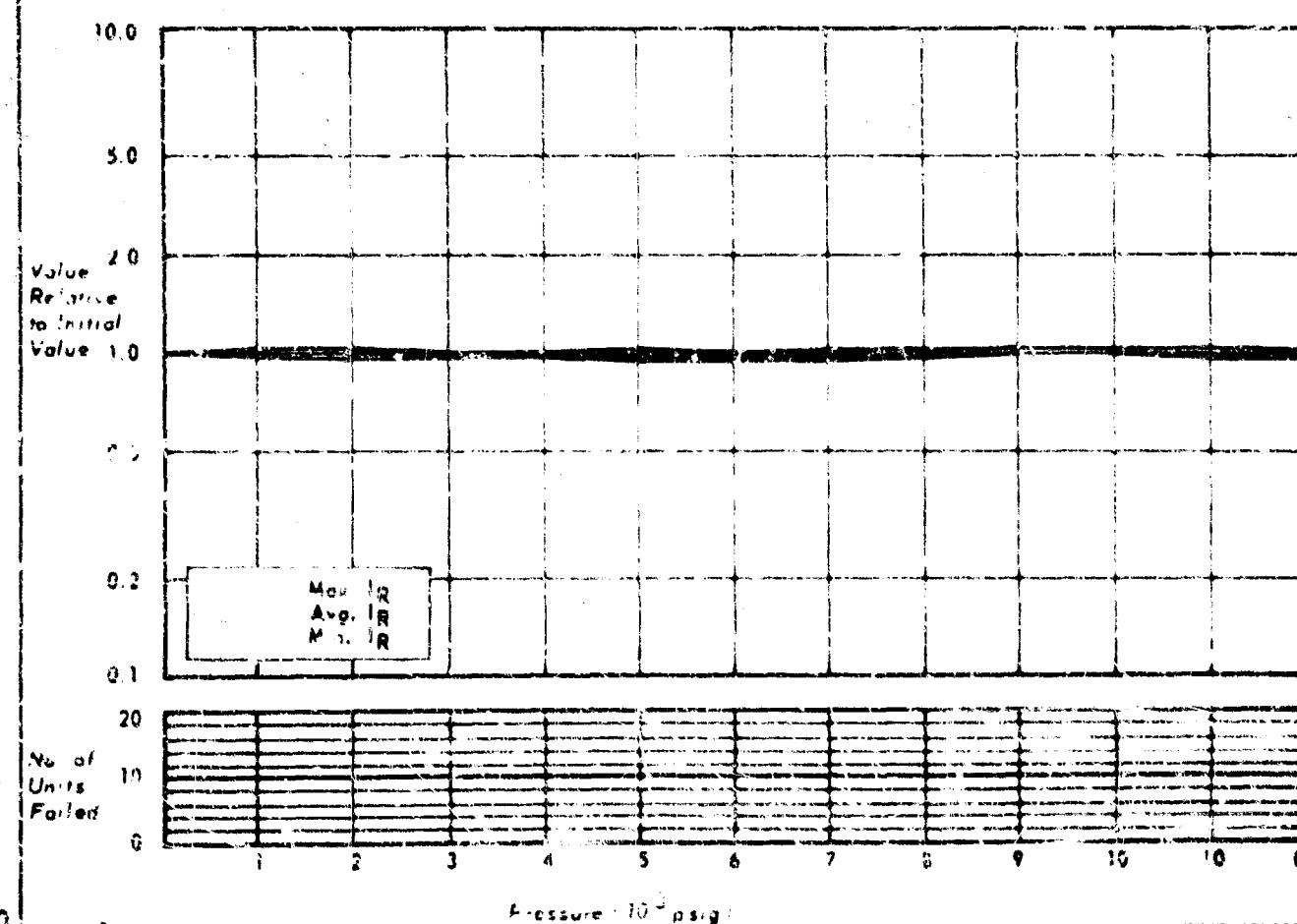
MFG. NO. 4040A
TYPE - CHODE, RECTIFIER
DESCRIPTION - 100000

CH. 77 NO. 75
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 75A
NO. OF SAMPLES TESTED



Materials

IN 4605

Diode, rectifier

PIV = 500 V

$I_{dc\ avg.} = 1$ Amp

Plastic enclp

Passivated

Tubular, axial lead

0.18 x 0.1" diam

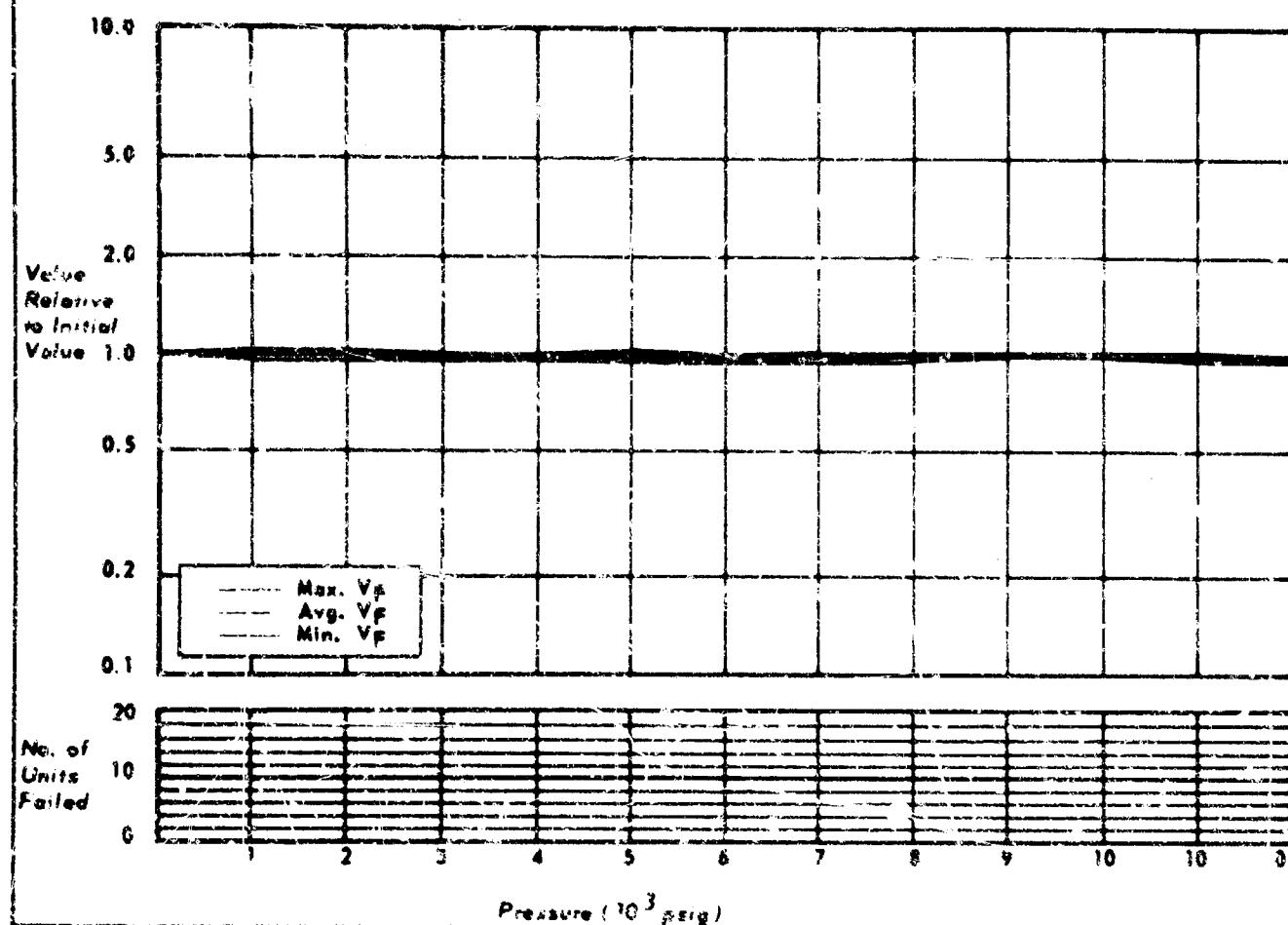
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

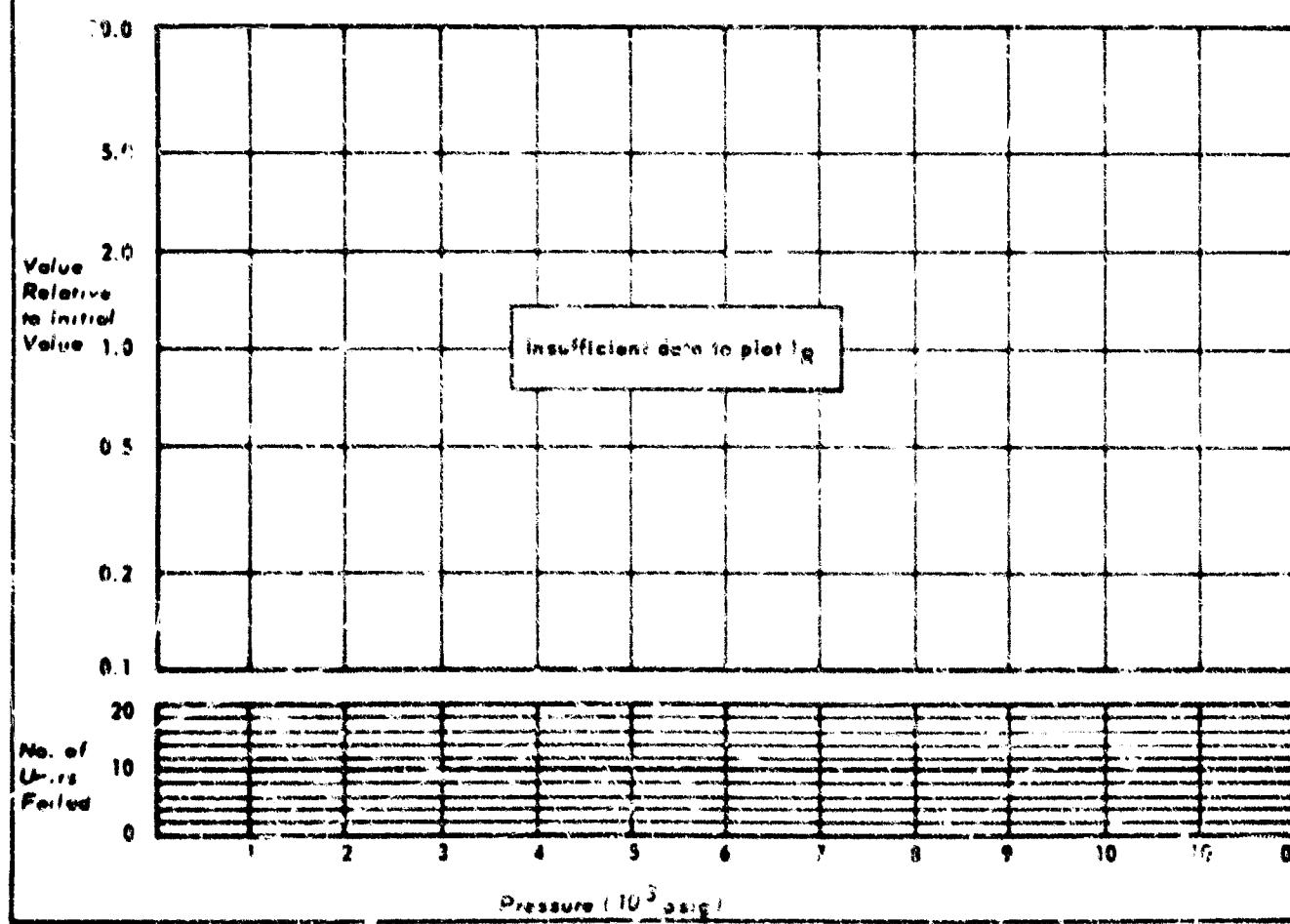
MFG. - MOTOROLA
TYPE - DIODE
DESCRIPTION - IN 3045

CHART NO. 76
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION

CHART NO. 76 A
NO. OF SAMPLES TESTED



Motorola
1N 3043B
Diode, zener

$V_Z = 9.1$ V
 $I_{ZT} = 2.8$ mA

drawn sealed metal case
Tubular, axial lead
0.375 x 0.22" diam

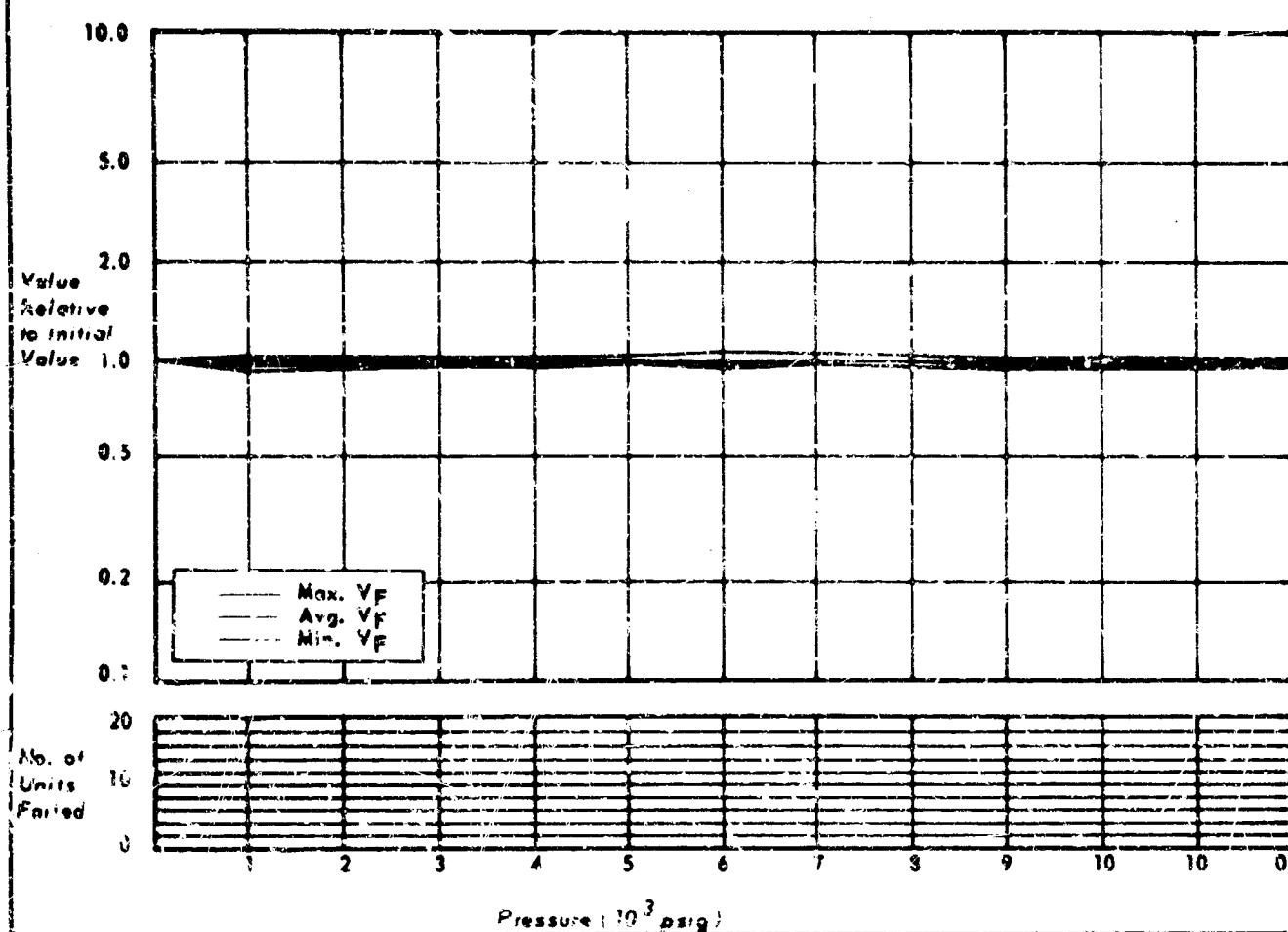
SOAK PERIOD: None

MECHANICAL: N = apparent damage.

ELECTRICAL: All components indicated less than 10% change.

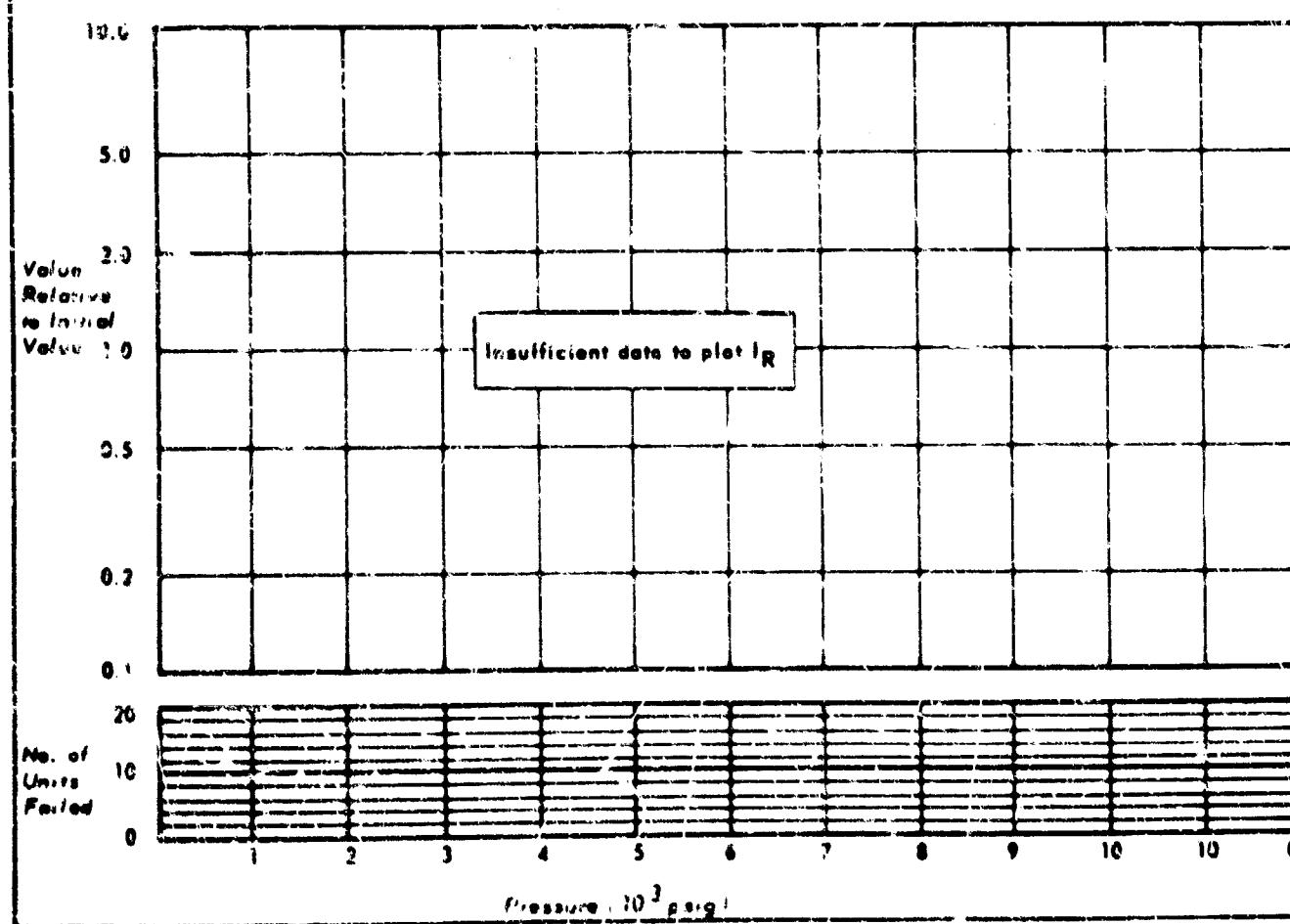
MFG. - MOTOROLA
TYPE - DIODE, ZENER
DESCRIPTION - 400MW

CHART NO. 77
NO. OF SAMPLES TESTED - 18



MFG.
TYPE
DESCRIPTION

CHART NO. 77A
NO. OF SAMPLES TESTED



Motorola

See Note #1

Type 400, See note

Diodes, zeners

Glass, molded

Tubular, axial lead

0.24 ± 0.00" diam

SOAK PERIOD: 16 hours at 10,000 psig.

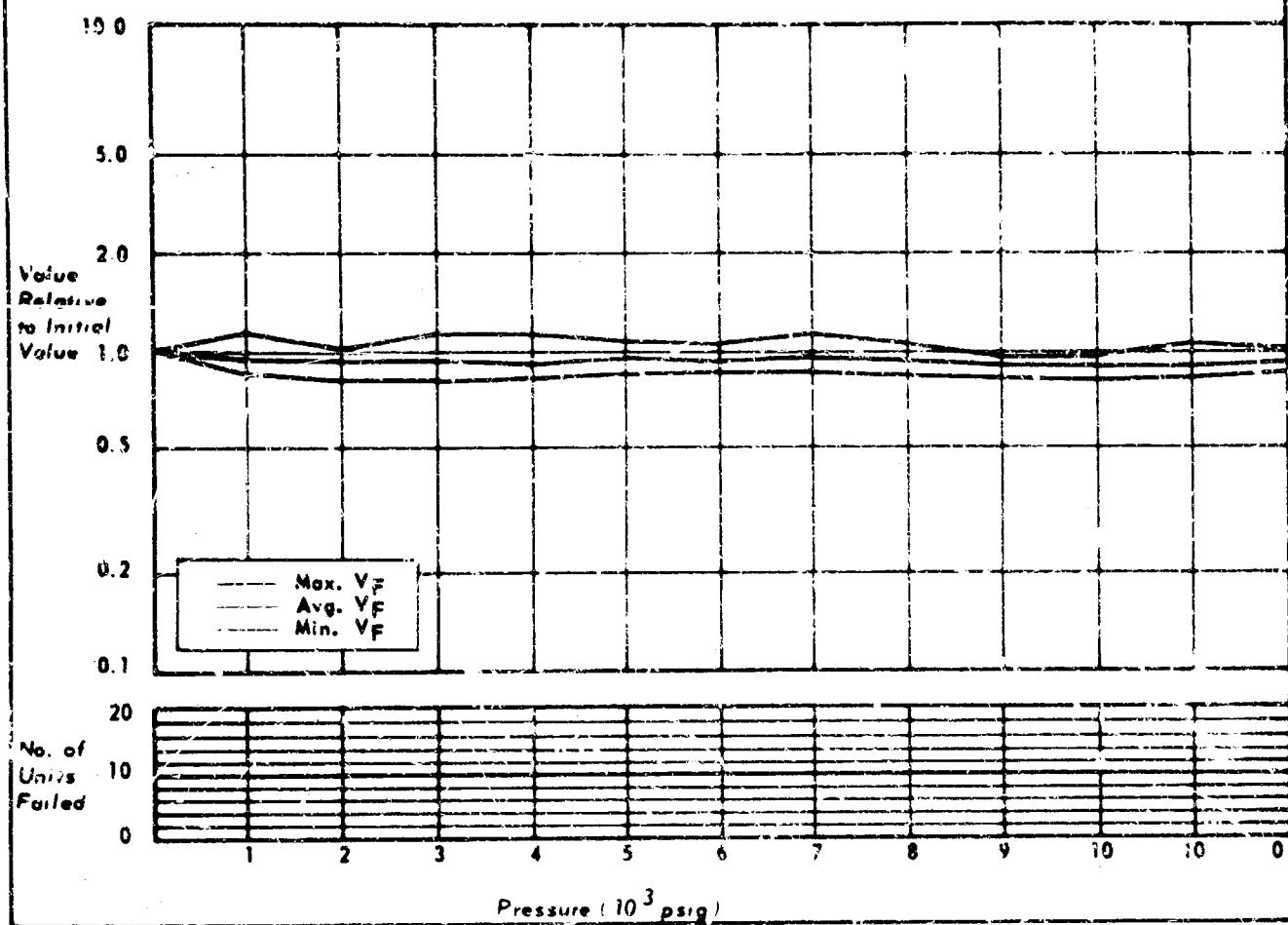
MECHANICAL: No apparent damage.

NOTE #1: Twenty components, two each of ten various values were submitted. Since all components were of the same type the set of twenty was tested and the results of the set graphed. The part numbers, description and components failed are listed below.

Part No.	P.V	I _{dc} avg.	No. failed	Part No.	P.V	I _{dc} avg.	No. failed
IN 746A	3.3 V	20 mA	0	IN 952A	14.0 V	11.5 mA	0
IN 749A	4.3 V	20 mA	0	IN 966B	16.0 V	7.8 mA	0
IN 741A	5.1 V	20 mA	0	IN 969B	22.0 V	5.6 mA	0
IN 755A	7.5 V	20 mA	0	IN 975B	35.0 V	3.2 mA	0
IN 759A	12.0 V	20 mA	0	IN 989B	91.0 V	1.4 mA	2

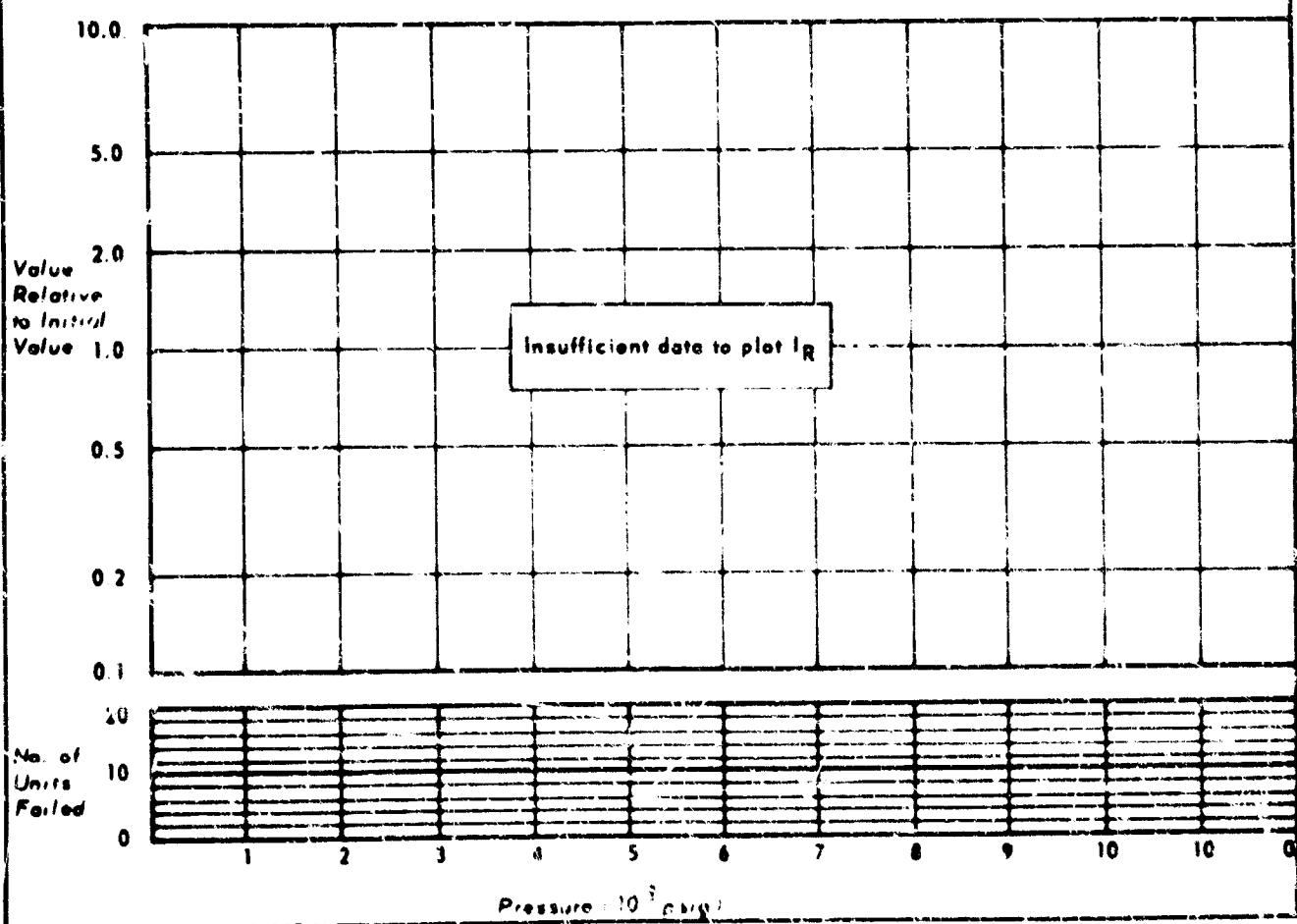
MFG. - CHMITE
TYPE - SILICON DIODE
DESCRIPTION - (NONE AVAILABLE)

CHART NO. 78
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION

CHART NO. 78A
NO. OF SAMPLES TESTED



Ohmite

Diode

SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

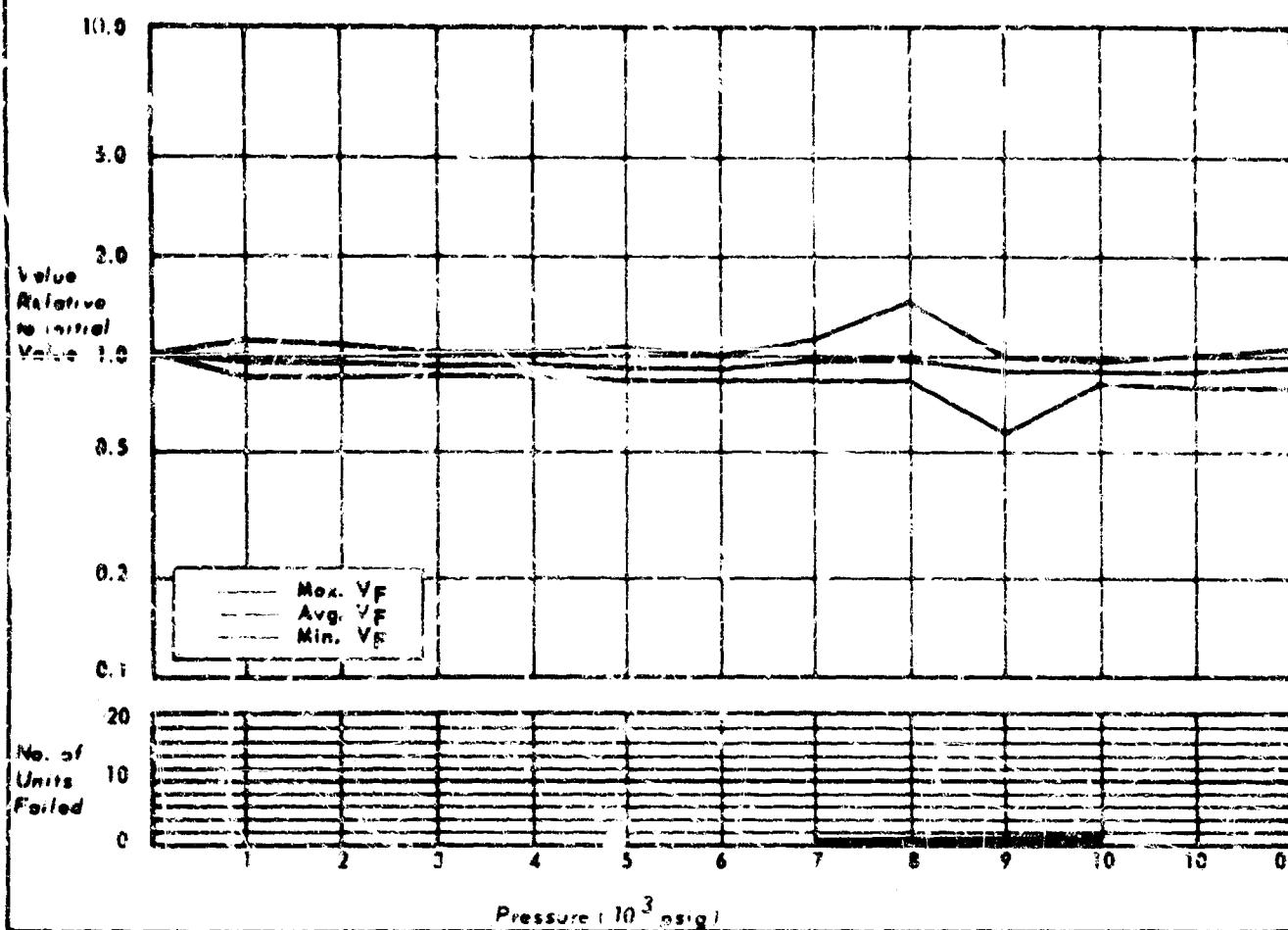
Silicon

Tubular, extruded

0.26 x 0.08" diam

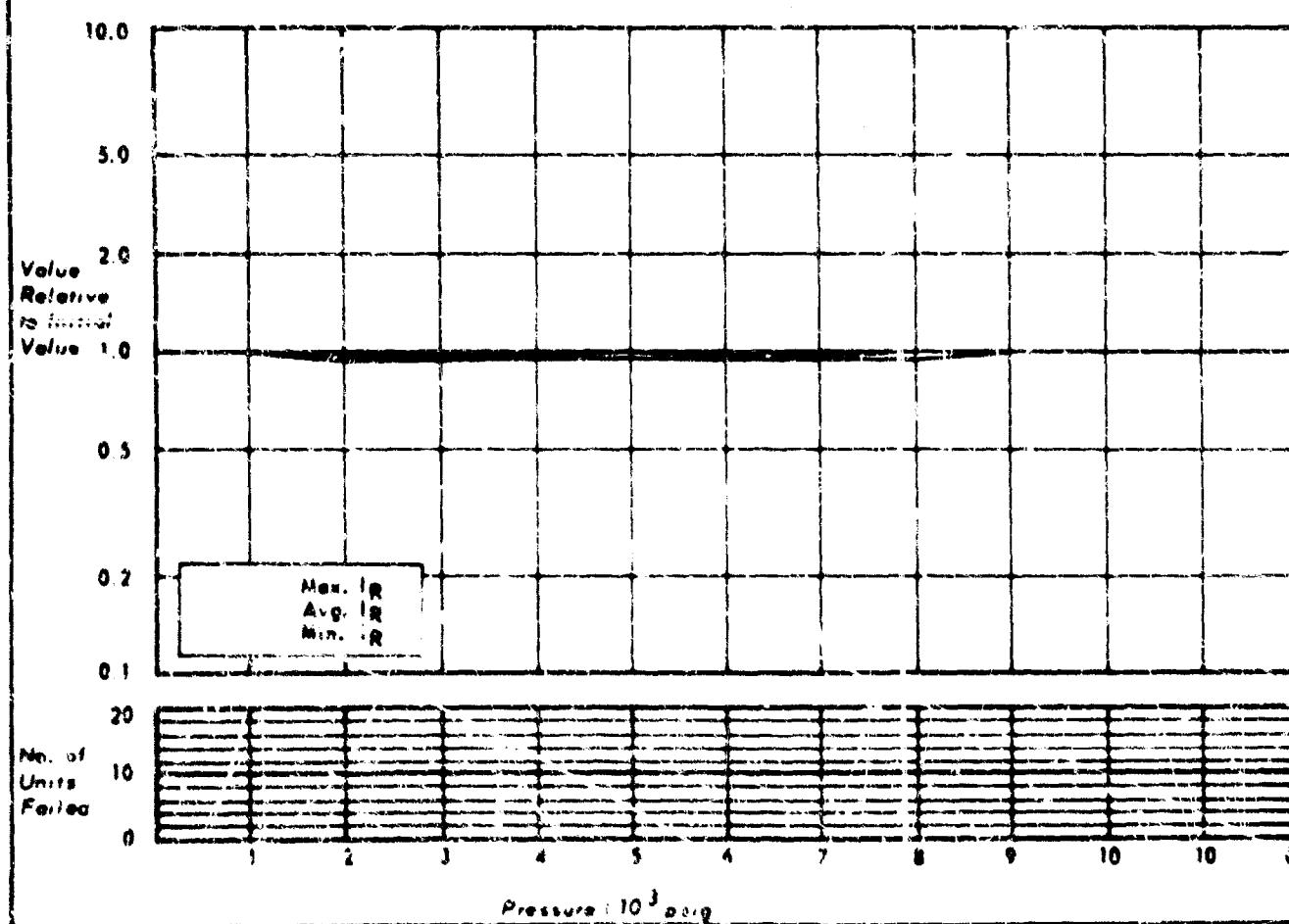
TYPE - SILICON DIODE (UNNER PRESSURE)
DESCRIPTION - (NONE AVAILABLE)

CHART NO. 79
NO. OF SAMPLES TESTED



MEG.
TYPE
DESCRIPTION - (SAME AS ABOVE)

CHART NO. 79A
NO. OF SAMPLES TESTED



Ohmite
Red dot
Diode

Silicone, pressurized units
Tubular, axial lead
0.26 x 0.18" diam

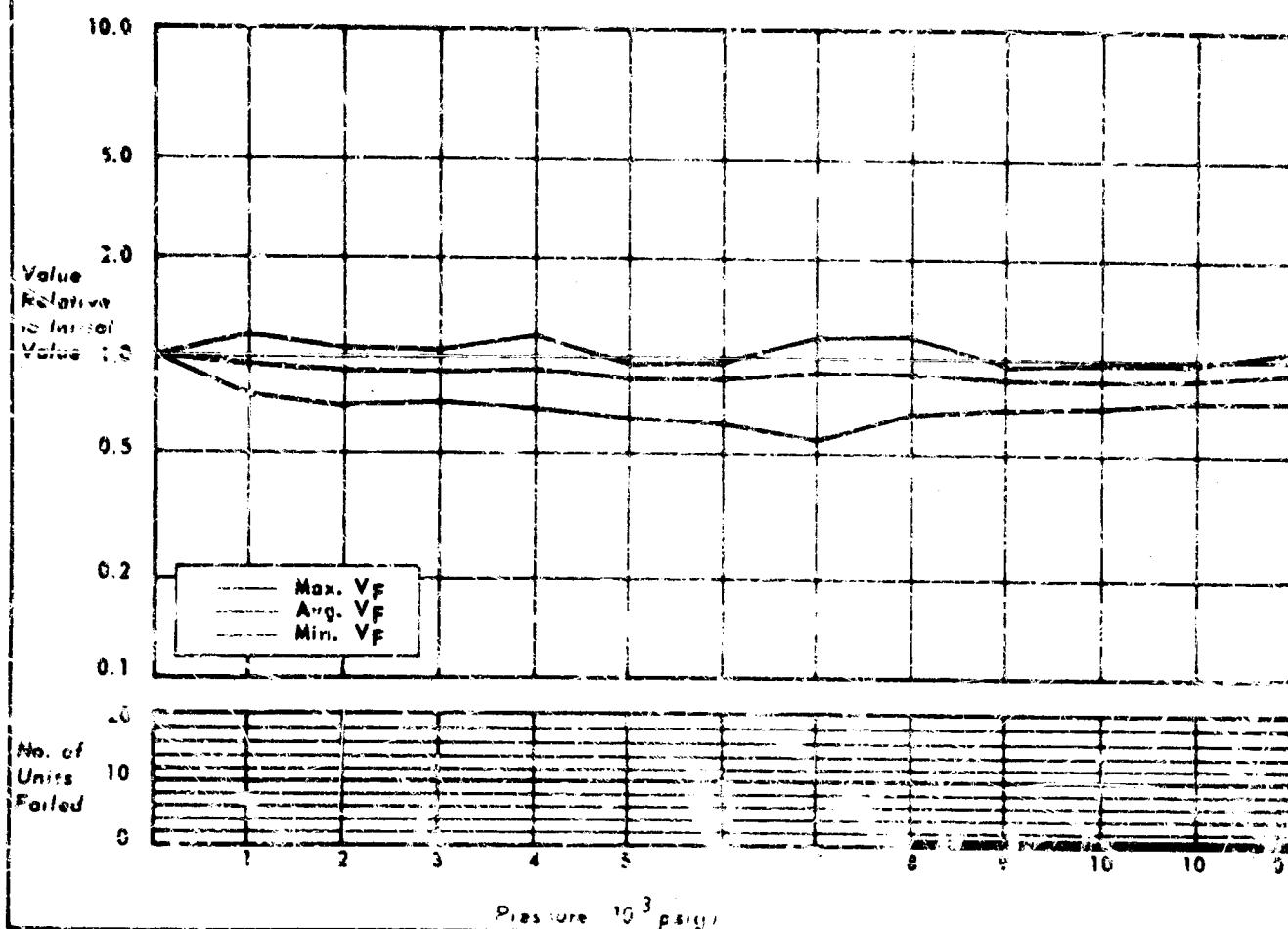
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: Eleven components indicated less than 10% change.
Seven components indicated a change greater than 10% and less than 50%.
One component indicated a change greater than 50% with subsequent recovery at pressures
shown on return graph on opposite page.

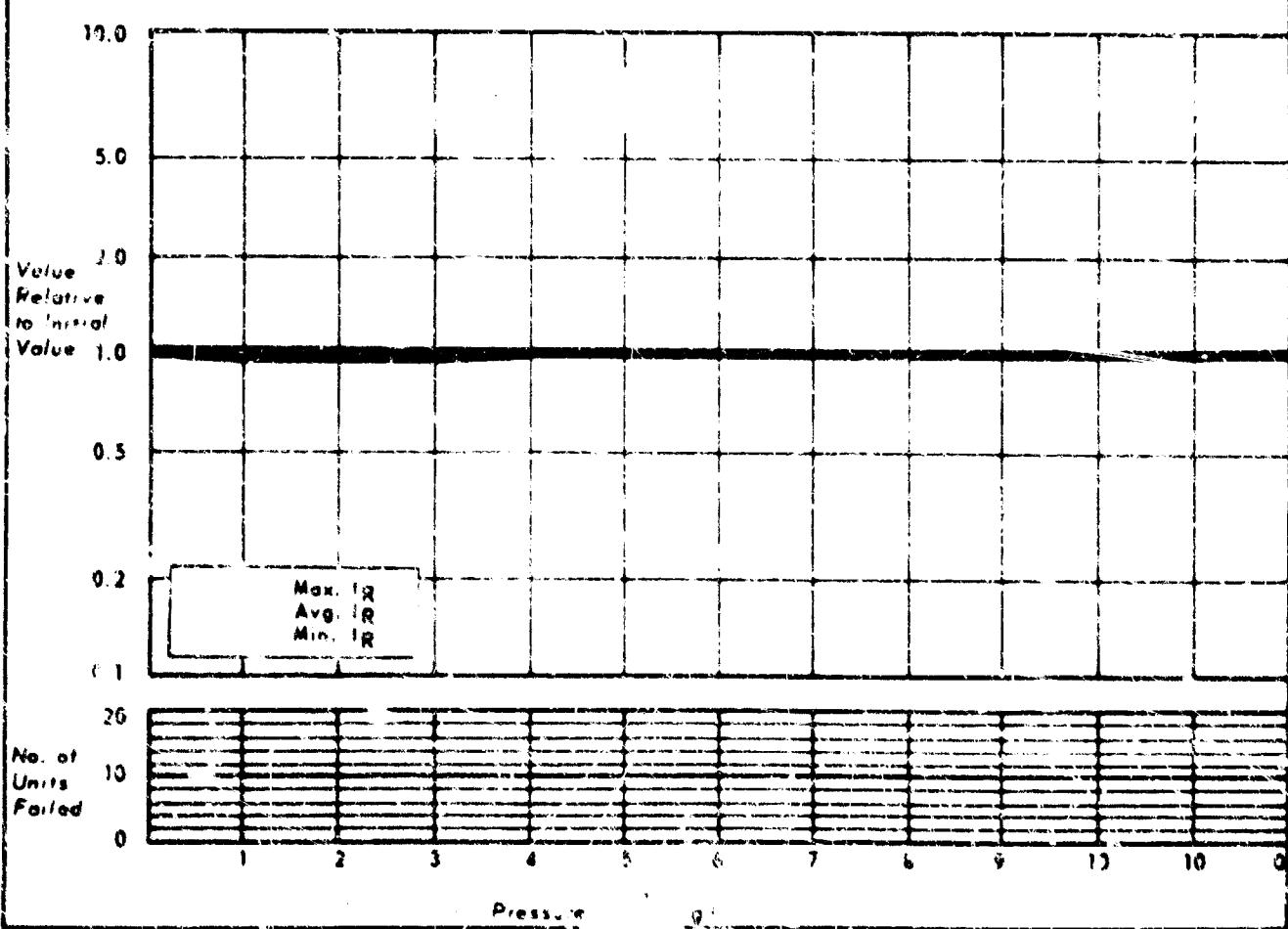
MFG. OHMITE
TYPE - GERMANIUM DIODE
DESCRIPTION - (NONE AVAILABLE)

CHART NO. 80
NO. OF SAMPLES TESTED - 50



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 80A
NO. OF SAMPLES TESTED



Ohmite

Germanium, glass encap

Diode

Tubular, extel lead

0.26 x 0.06" diam

SOAK PERIOD: None

MECHANICAL: No apparent damage.

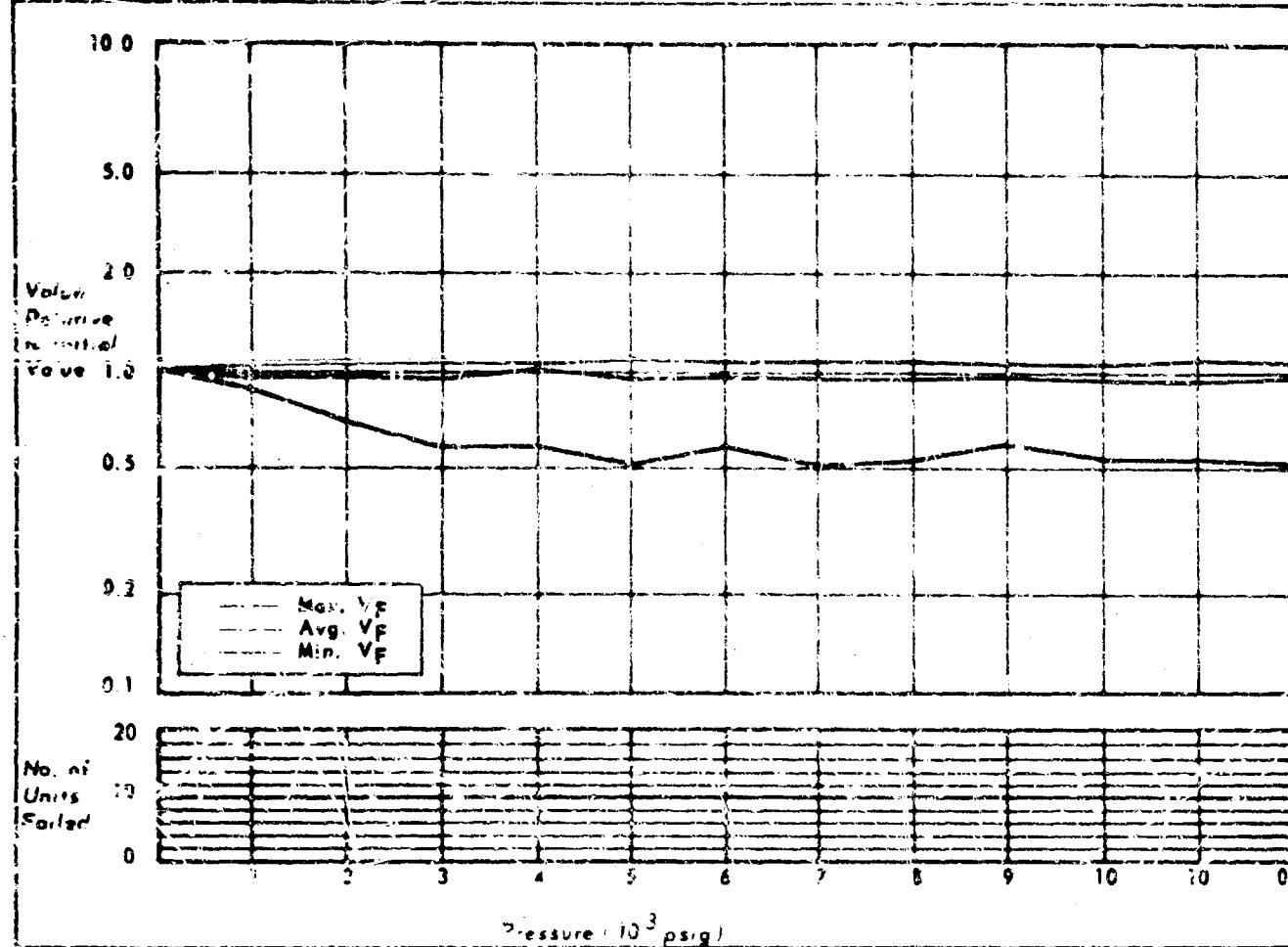
ELECTRICAL: Fourteen components indicated less than 10% change.

Four components indicated a change greater than 10% and less than 50%.

FAILURES: Two components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.

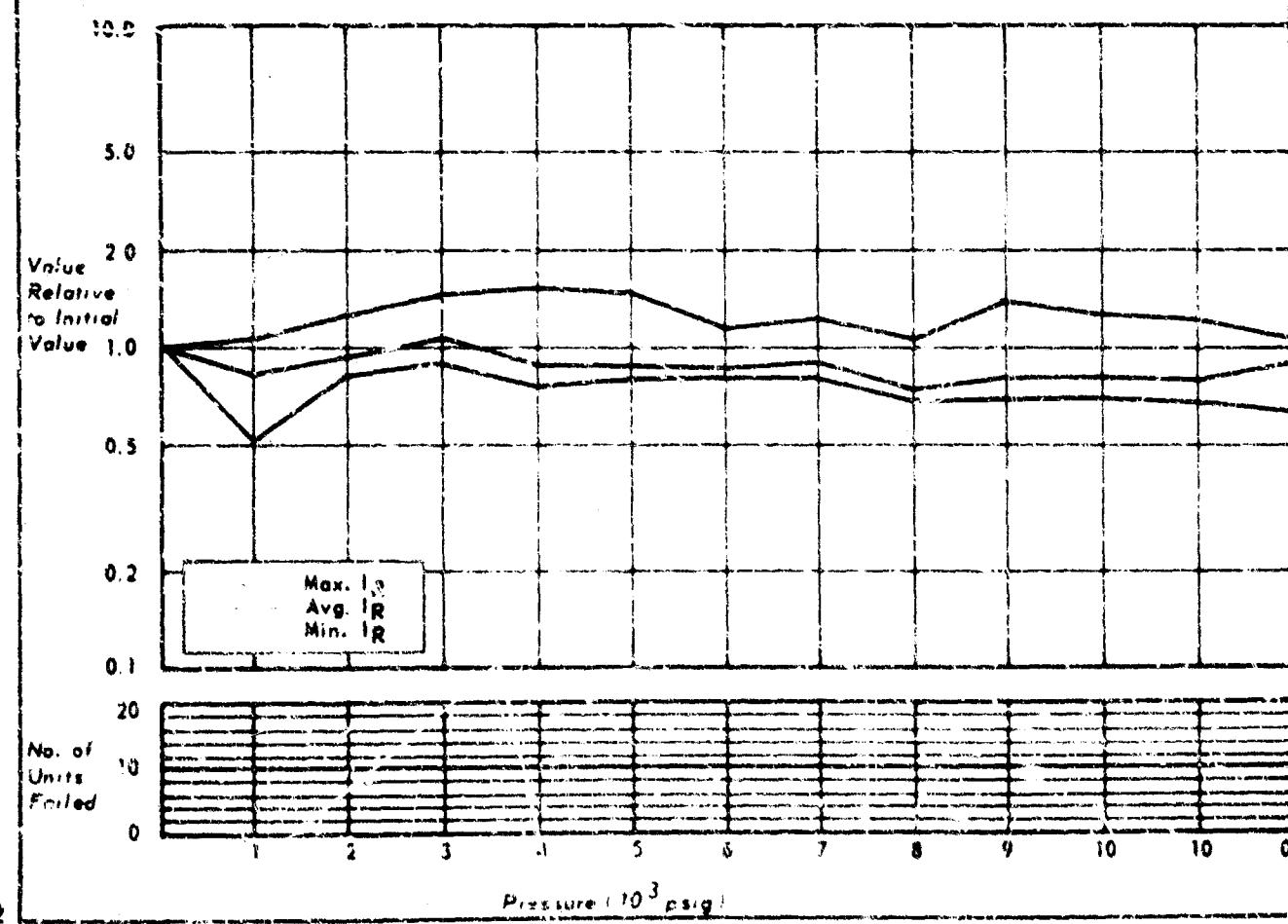
MFG. SYLVANIA
TYPE: DIODE, RECTIFIER
DESCRIPTION: 142089

CHART NO. 81
NO. OF SAMPLES TESTED: 19



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 81A
NO. OF SAMPLES TESTED



Sylvania
IN 2069
Diode, rectifier

PIV = 200 V
I_{dc avg.} = 750 mA

Silicon
Epoxy, encap
Bullet type

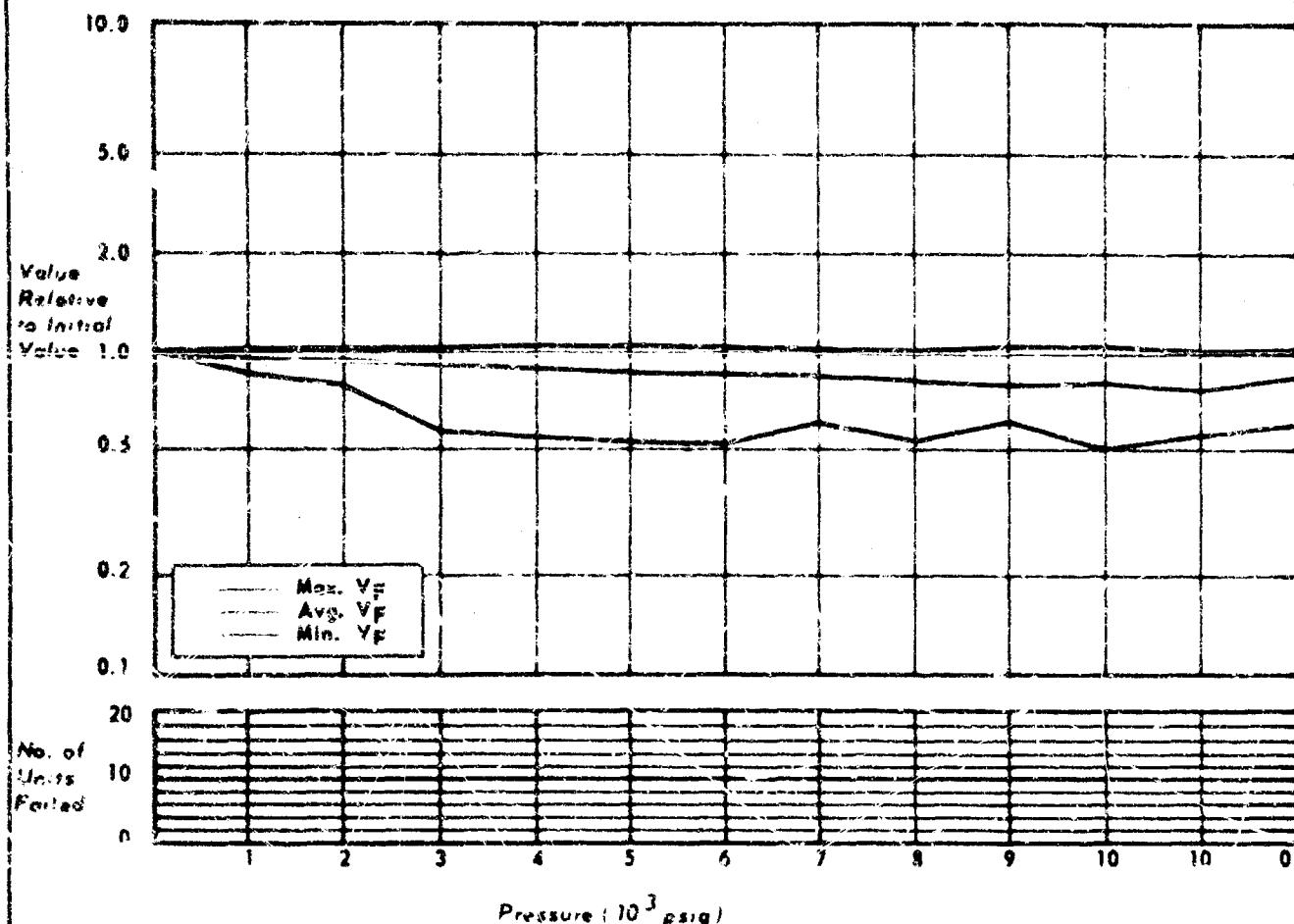
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 50% and greater than 10% change.

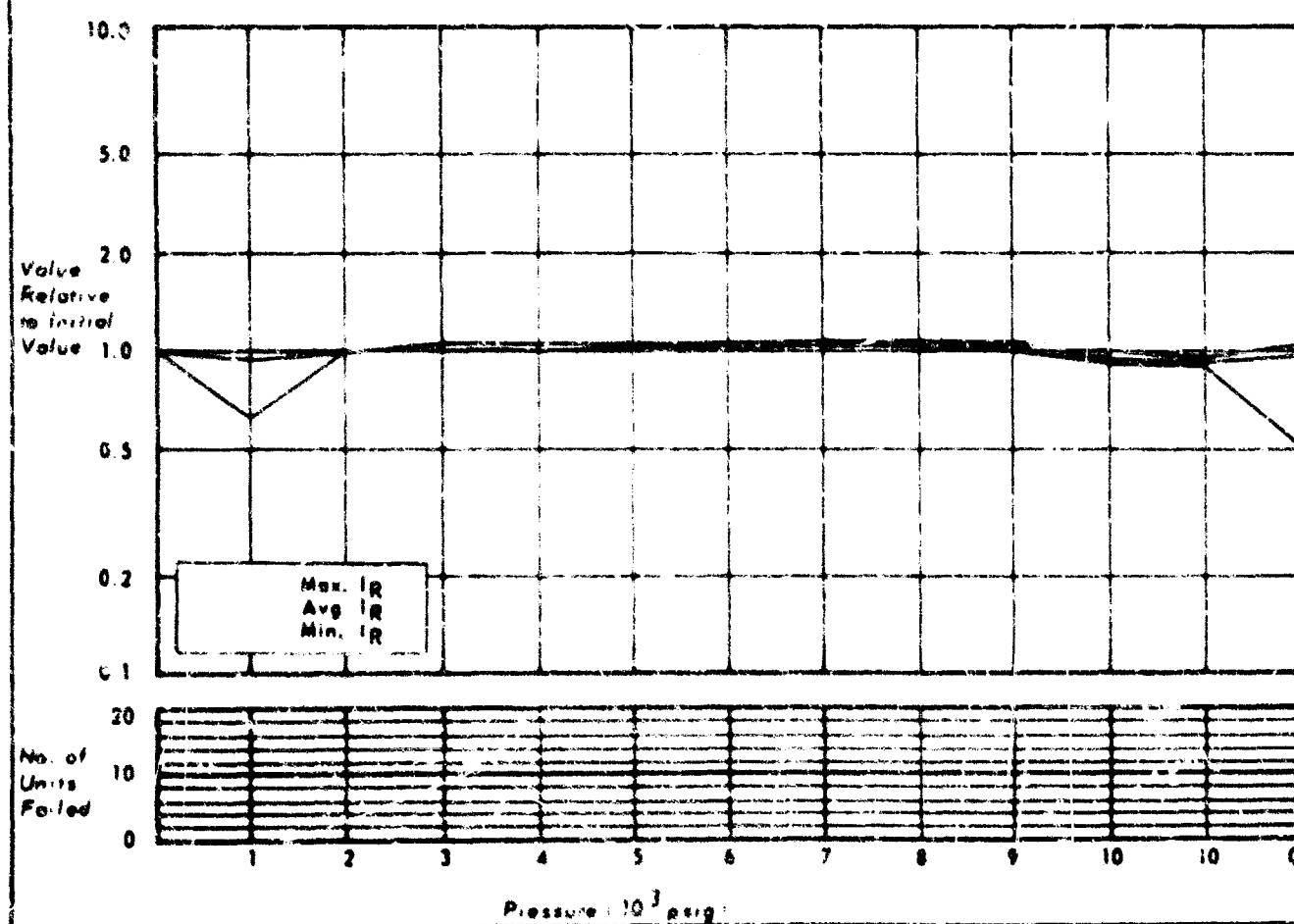
MFG. - SYLVANIA
TYPE - DIODE
DESCRIPTION - 5X38

CHART NO. 82
NO. OF SAMPLES TESTED - 17



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 82A
NO. OF SAMPLES TESTED



Sylvania

DF 28

Diode, "whiskerless"

$V_F = 1.0 \text{ V} @ 10 \text{ mA}$

$I_R = 0.1 \mu\text{A} @ -20 \text{ V}_R$

Planar diffused

Passivated

Gloss, metal seal

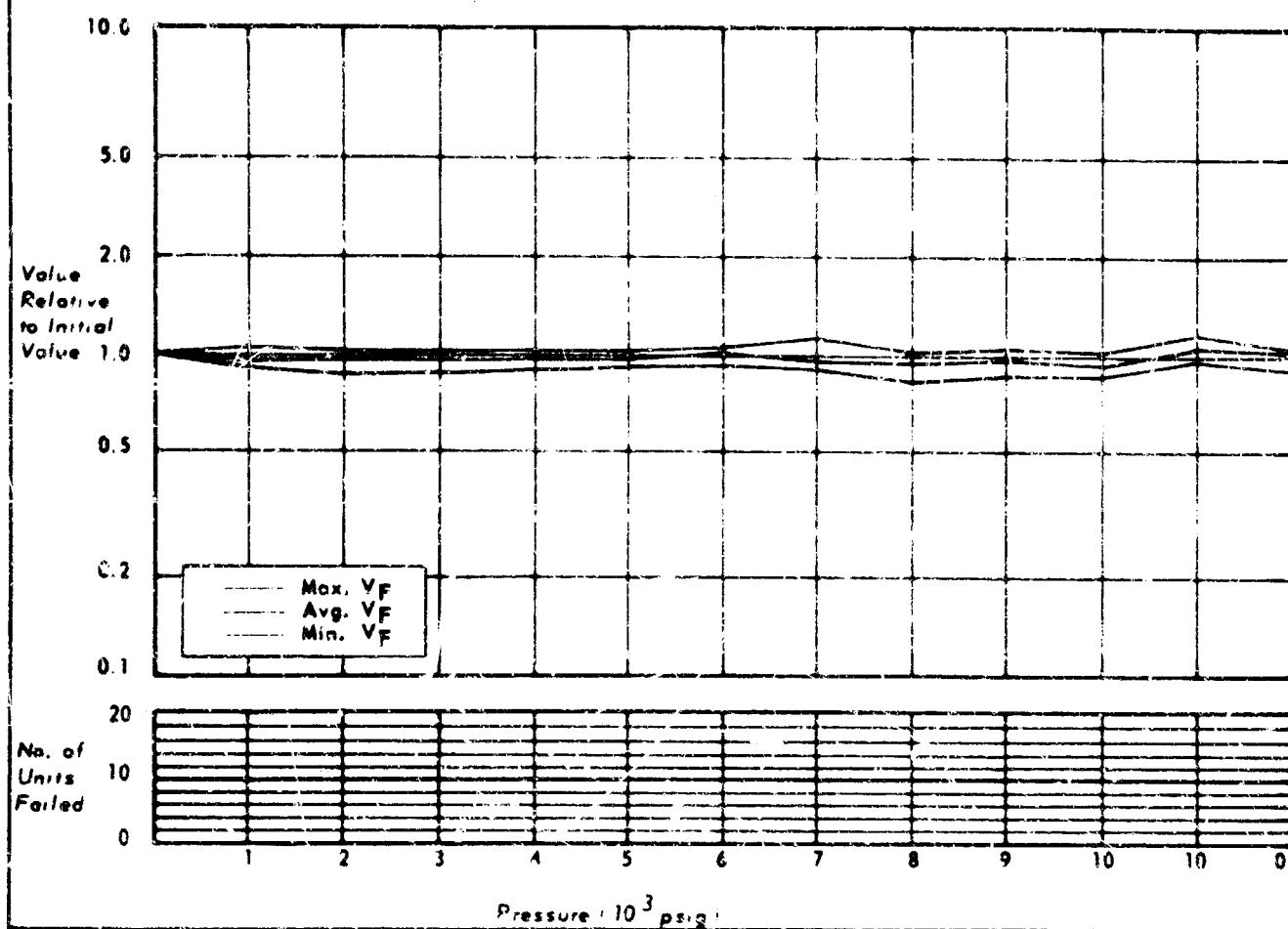
SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: Two components indicated less than 10% change. Fifteen components indicated greater than 10% and less than 50% change.

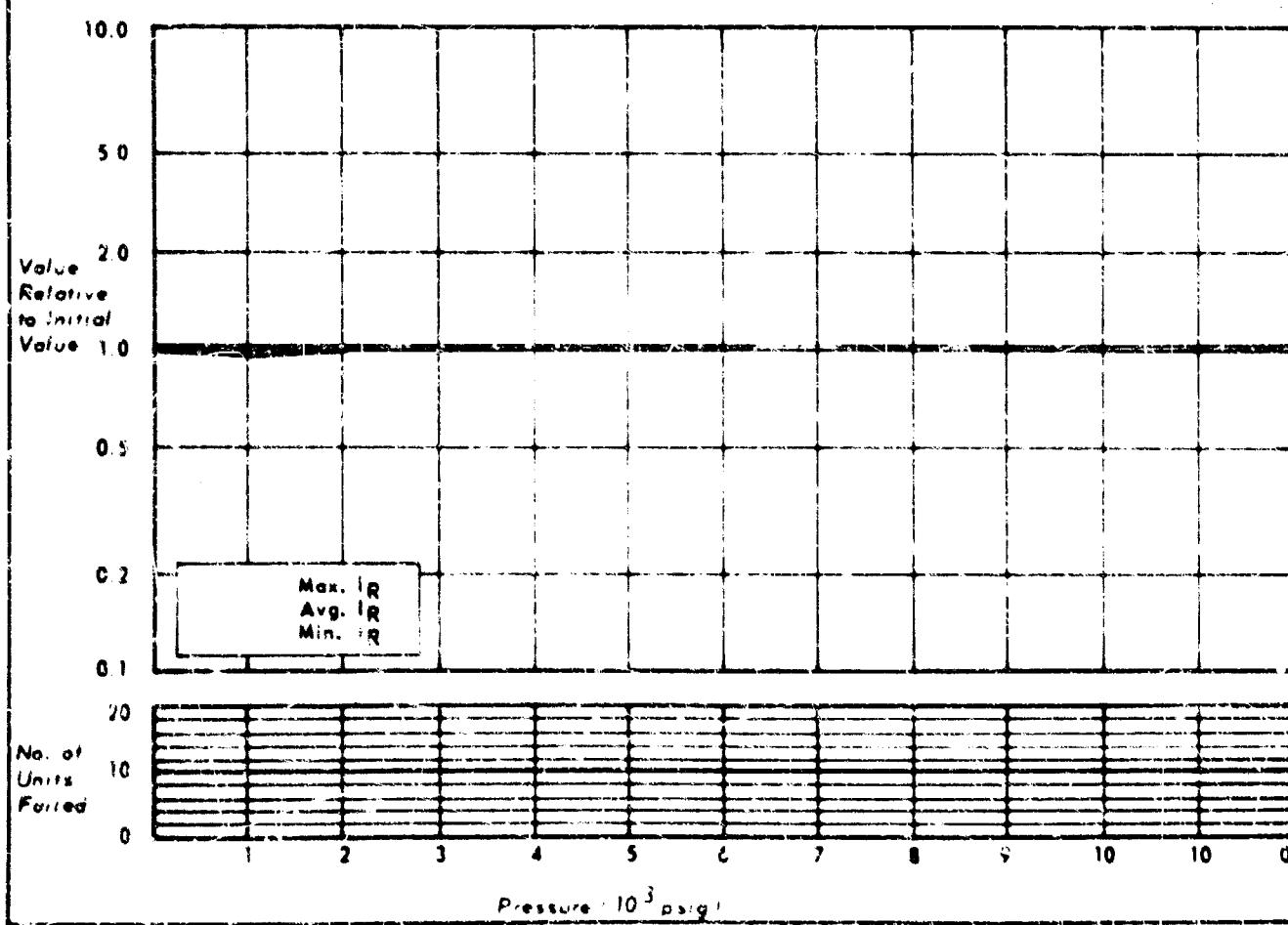
MFG. - TEXAS INSTRUMENT
TYPE - DIODE
DESCRIPTION - IX251

CHART NO. 83
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 83A
NO. OF SAMPLES TESTED



Texas Instrument

IN 251

Diode, computer

PIV = 30 V

I_{dc} avg. = 75 mA

Silicone, glass

Diffused, mesa

Tubular, axial lead

0.22 x 0.035" diam

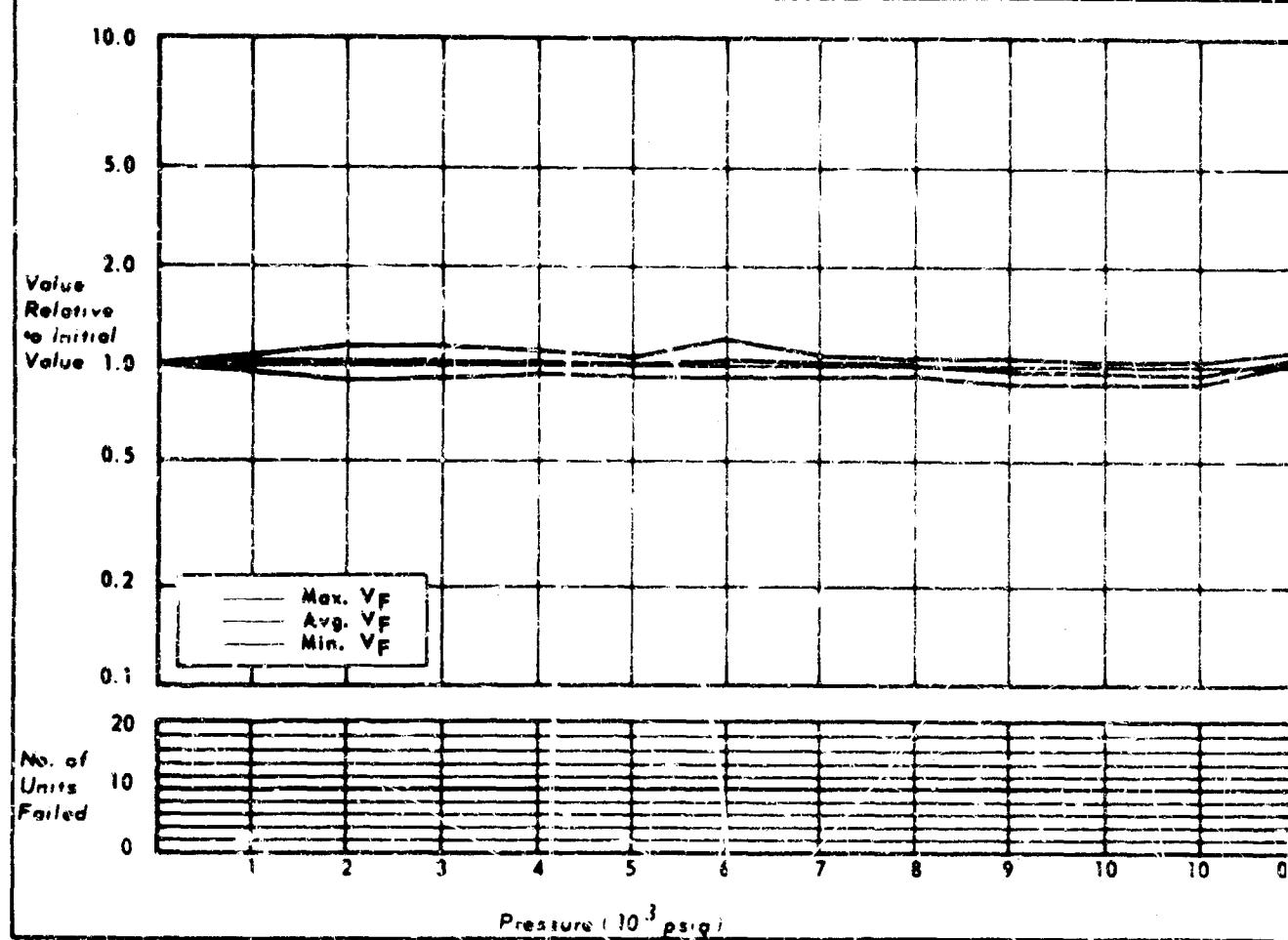
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

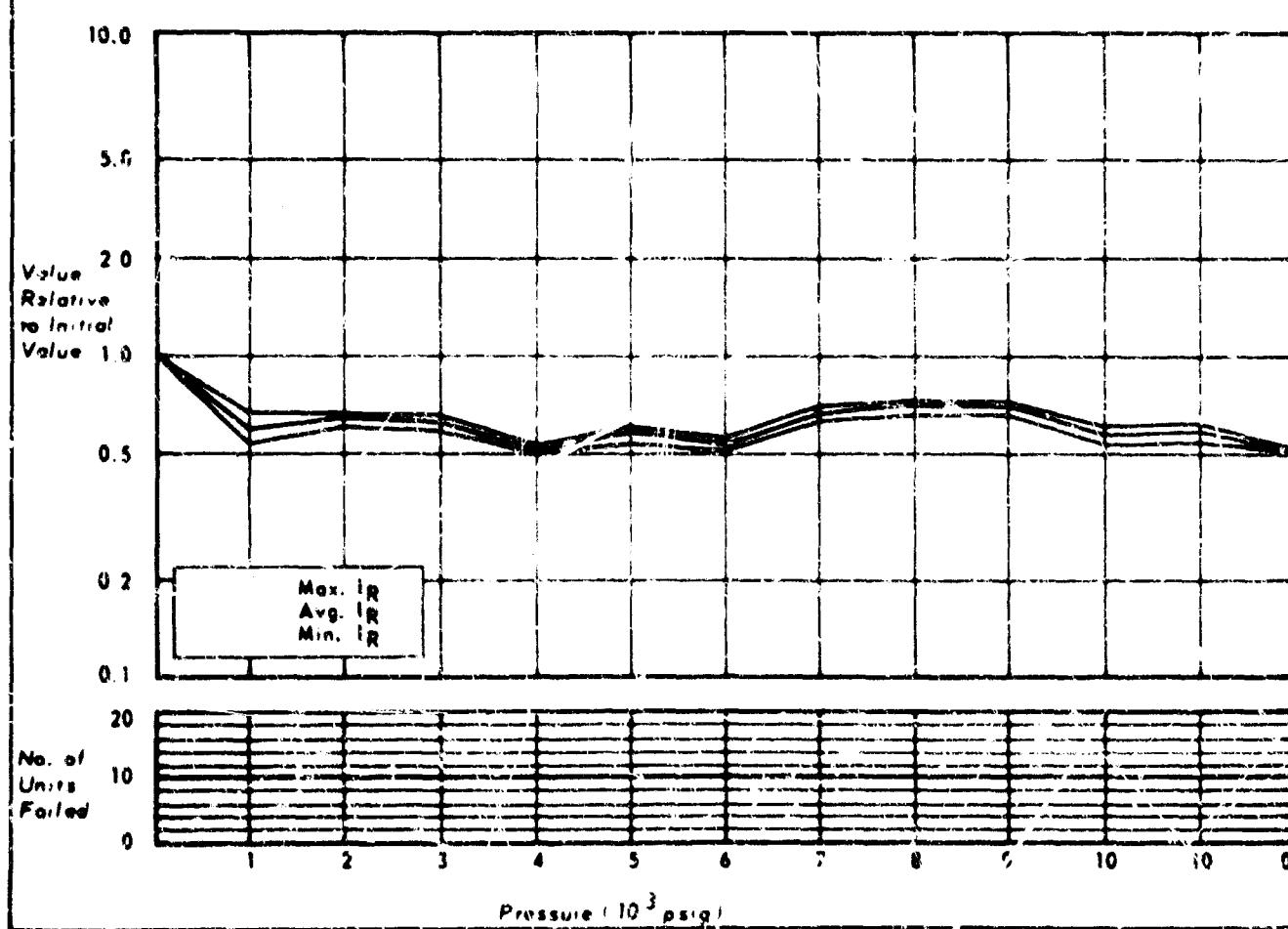
MFG. - TEXAS INSTRUMENT
TYPE - DIODE
DESCRIPTION - 1N645

CHART NO. 84
NO. OF SAMPLES TESTED - 19



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 84A
NO. OF SAMPLES TESTED



Texas Instrument
IN 645
Diode, general

PIV = 225 V
 $I_{dc \ average} = 400 \text{ mA}$

Silicone, glass
Tubular, axial lead
0.3 x 0.02" diam

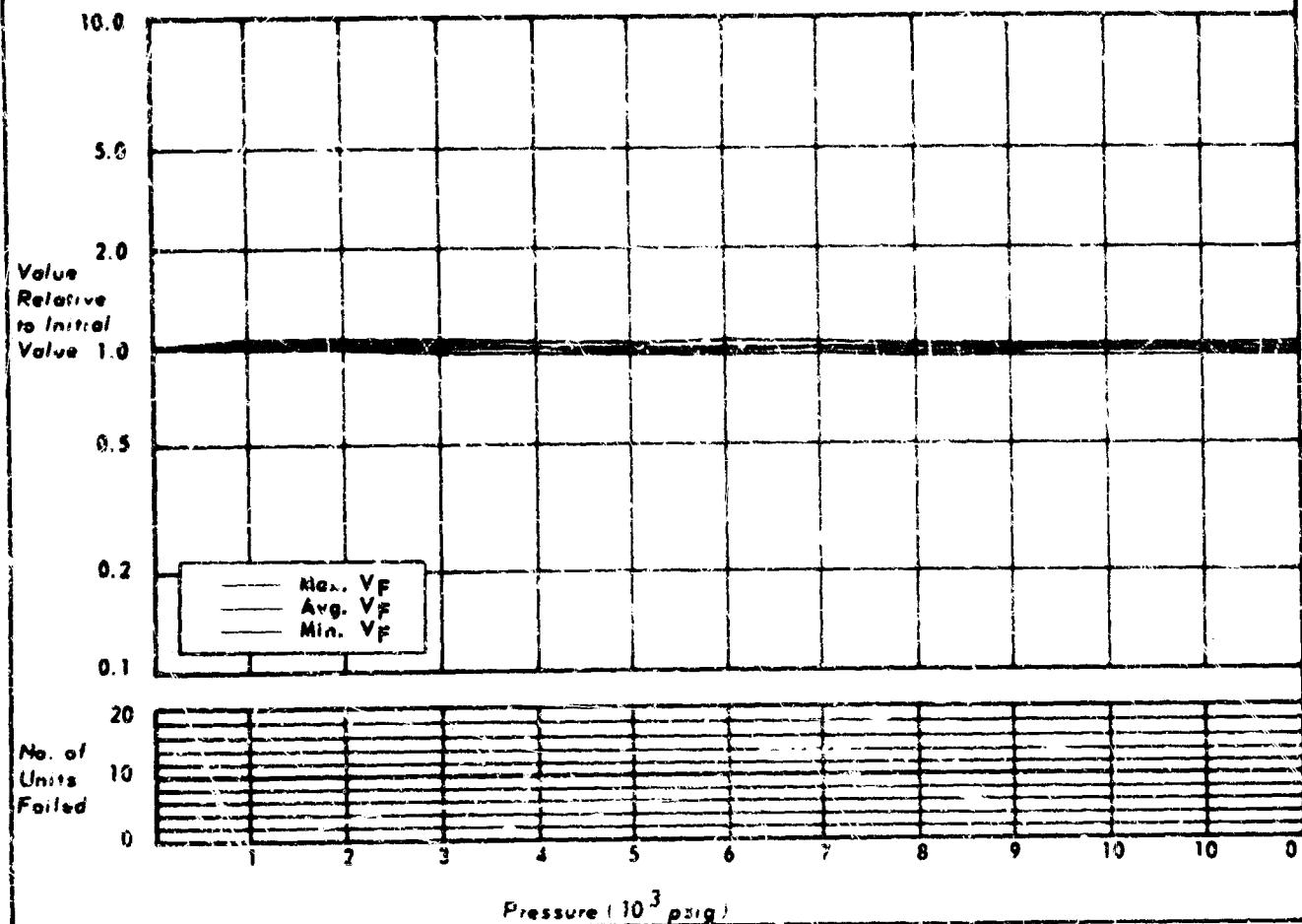
SOAK PERIOD: 16 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

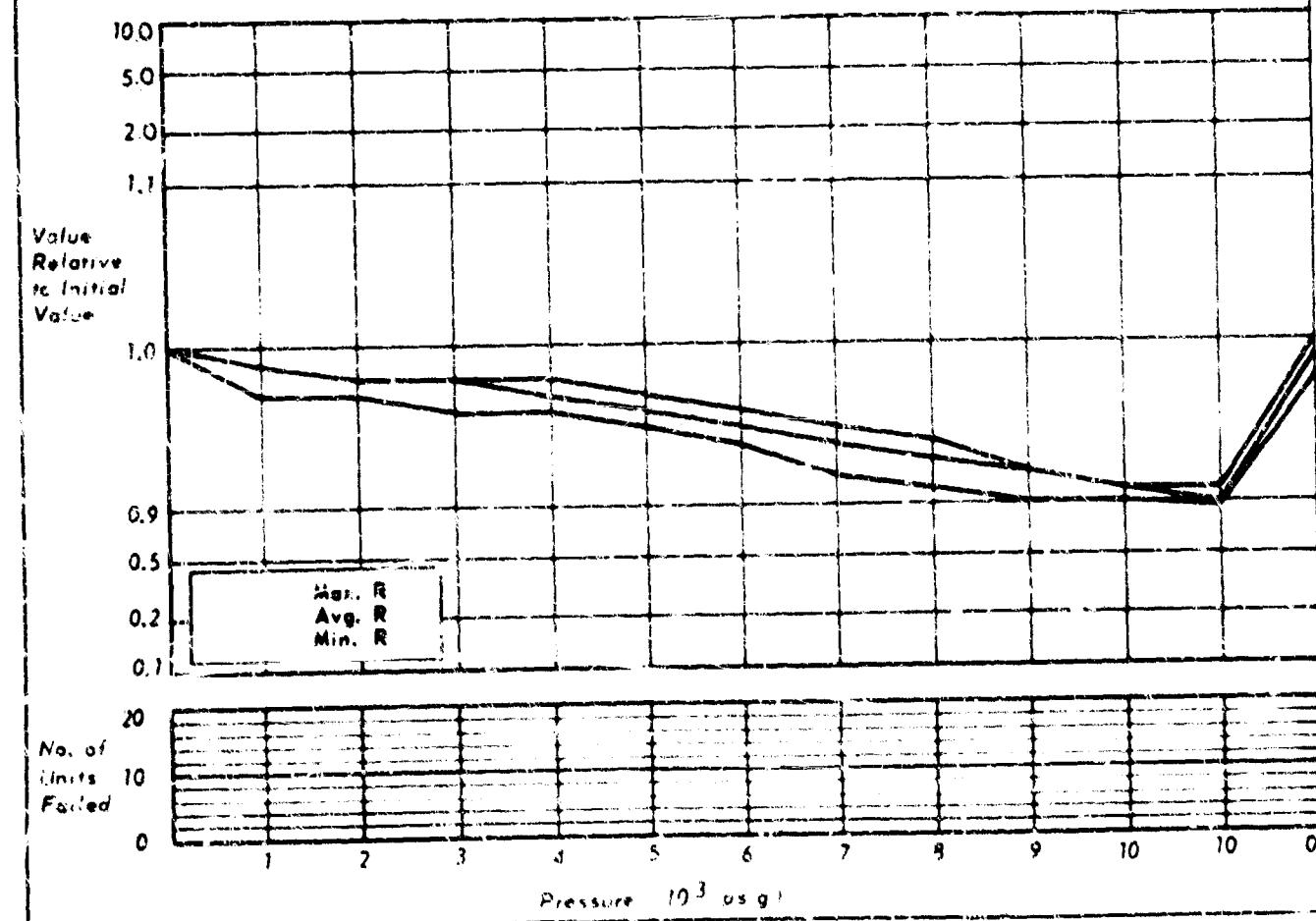
MFG. - TEXAS INSTRUMENT
TYPE - D100Z
DESCRIPTION - INT81

CHART NO. 85
NO. OF SAMPLES TESTED - 20



MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - BB 1015

CHART NO. 86
NO. OF SAMPLES TESTED - 20



Texas Instruments

IN 751

Diode

$V_Z = 2.1 \text{ V}$

$P = 400 \text{ mW} @ 25^\circ\text{C}$

Silicon, glass enclap

Tubular, axial lead

$0.3 \times 0.02^\circ \text{ diam}$

SOAK PERIOD: None

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Allen-Bradley

BB 1015

Resistor

$100 \Omega \pm 5\%$

3.54 V max

0.125 W

Composition

Tubular, axial lead

$0.145 \times 0.062^\circ \text{ diam}$

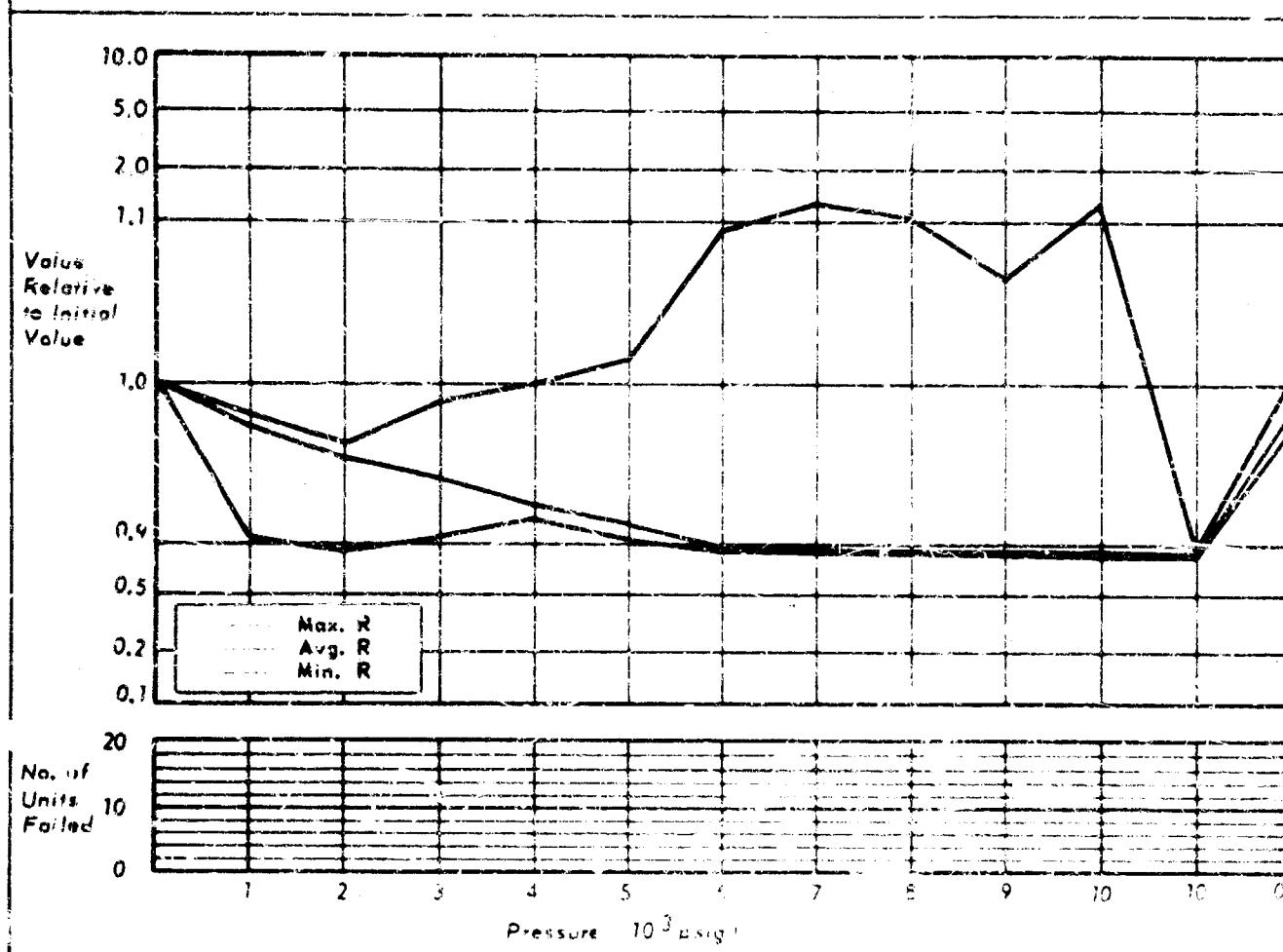
SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

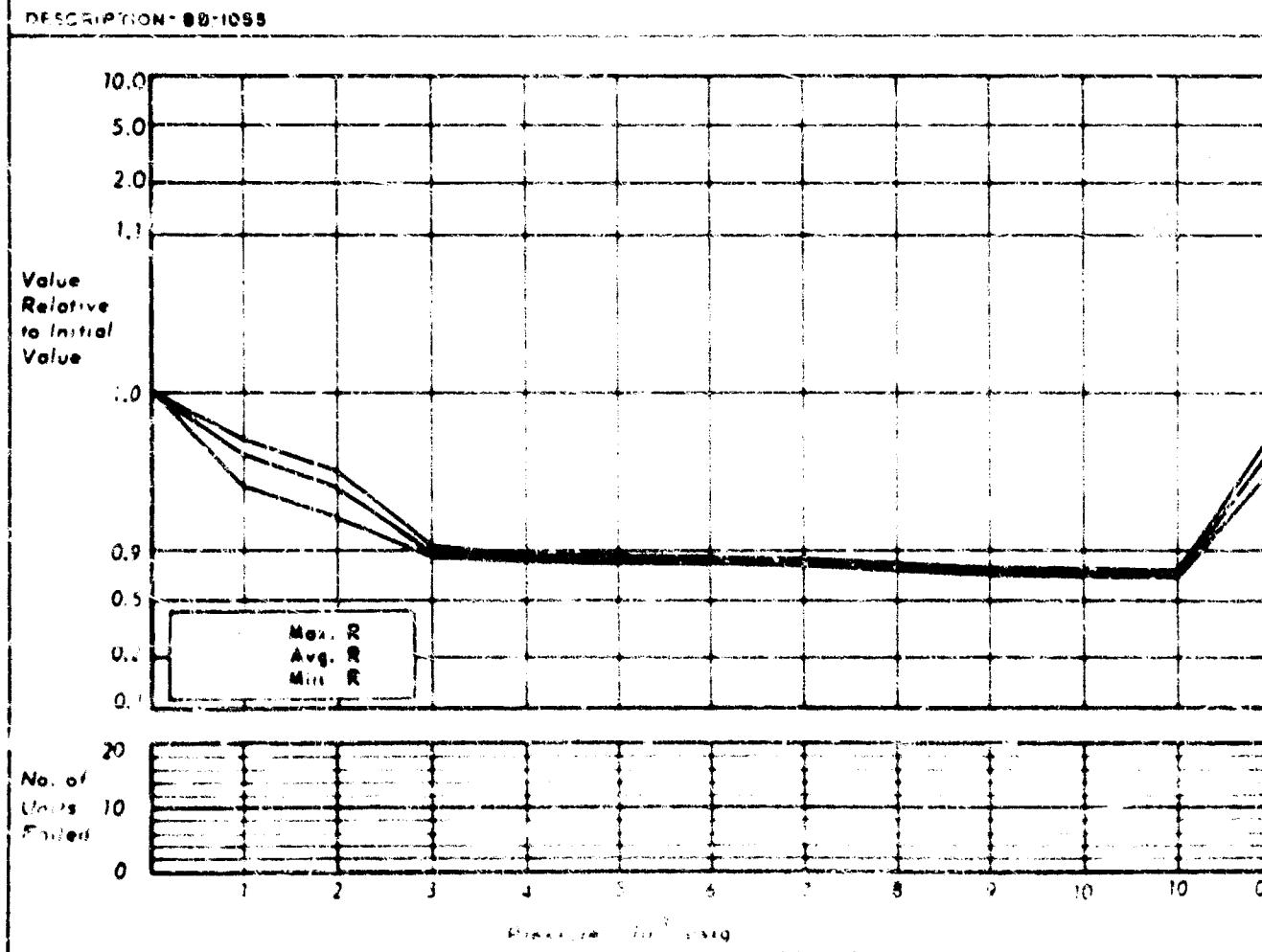
MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - 88-1085

CHART NO. 87
NO. OF SAMPLES TESTED - 20



MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - 88-1085

CHART NO. 88
NO. OF SAMPLES TESTED - 18



Allen-Bradley	10 K Ω \pm 5%	Composition
BB 1035	35.36 V max	Tubular, axial lead
Resistor	0.125 W	0.175 x 0.062" diam.

SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% and less than 50%.

Allen-Bradley	1.0 M Ω \pm 5%	Composition
BR 1055	150.00 V max	Tubular, axial lead
Resistor		0.145 x 0.062" diam.

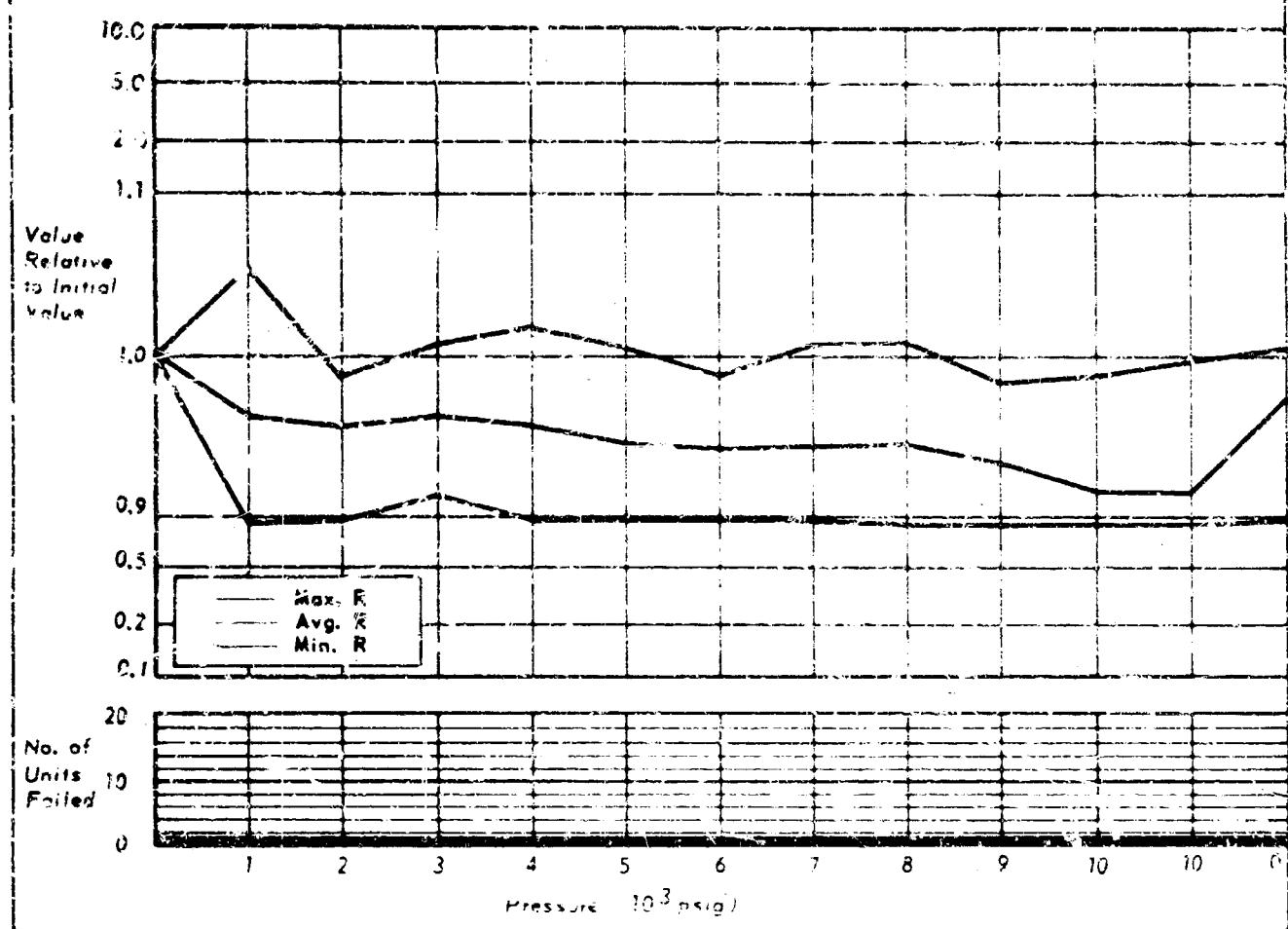
SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.

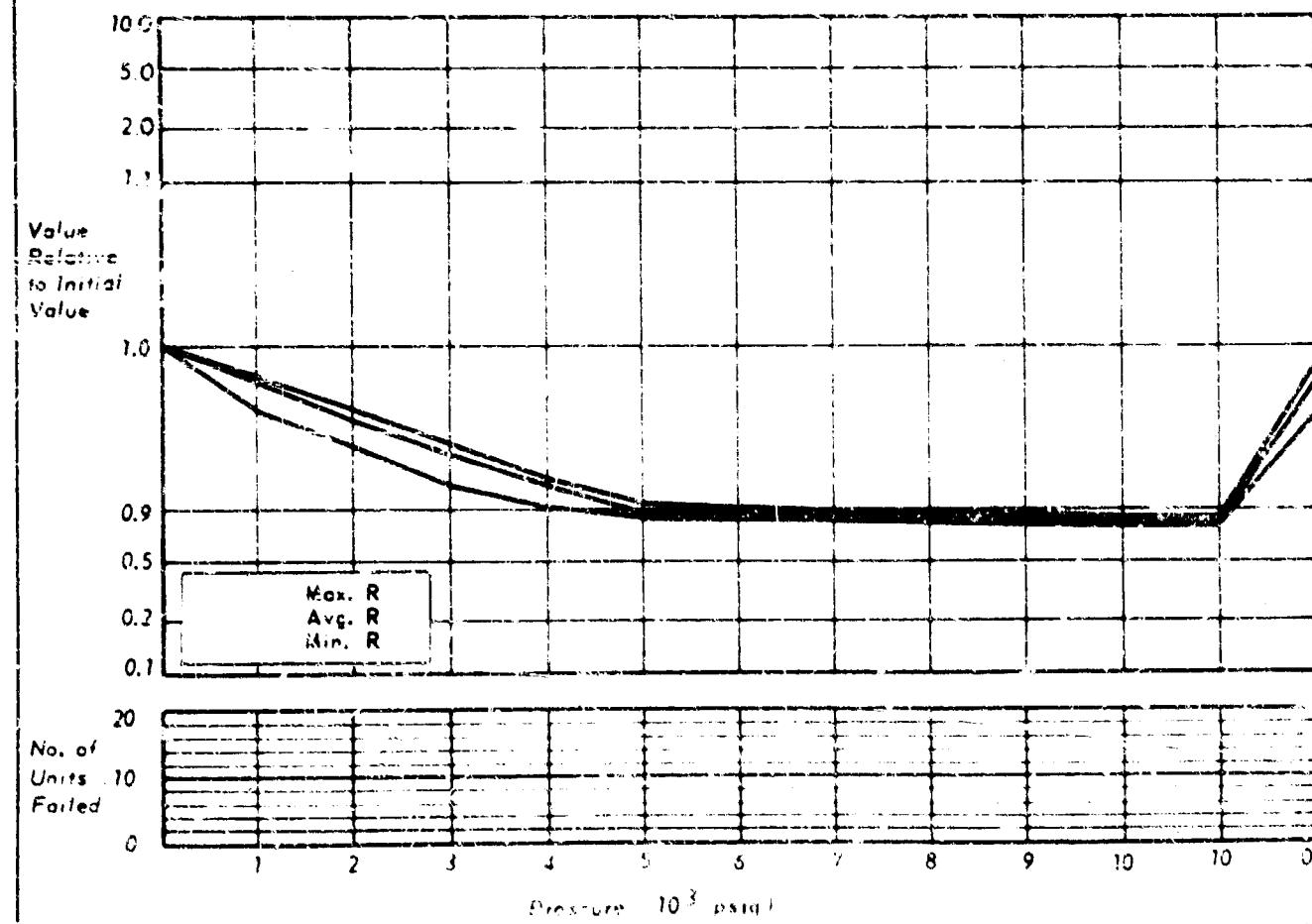
MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - CB-1005

CHART NO. 89
NO. OF SAMPLES TESTED - 18



MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - FB-1035

CHART NO. 90
NO. OF SAMPLES TESTED - 20

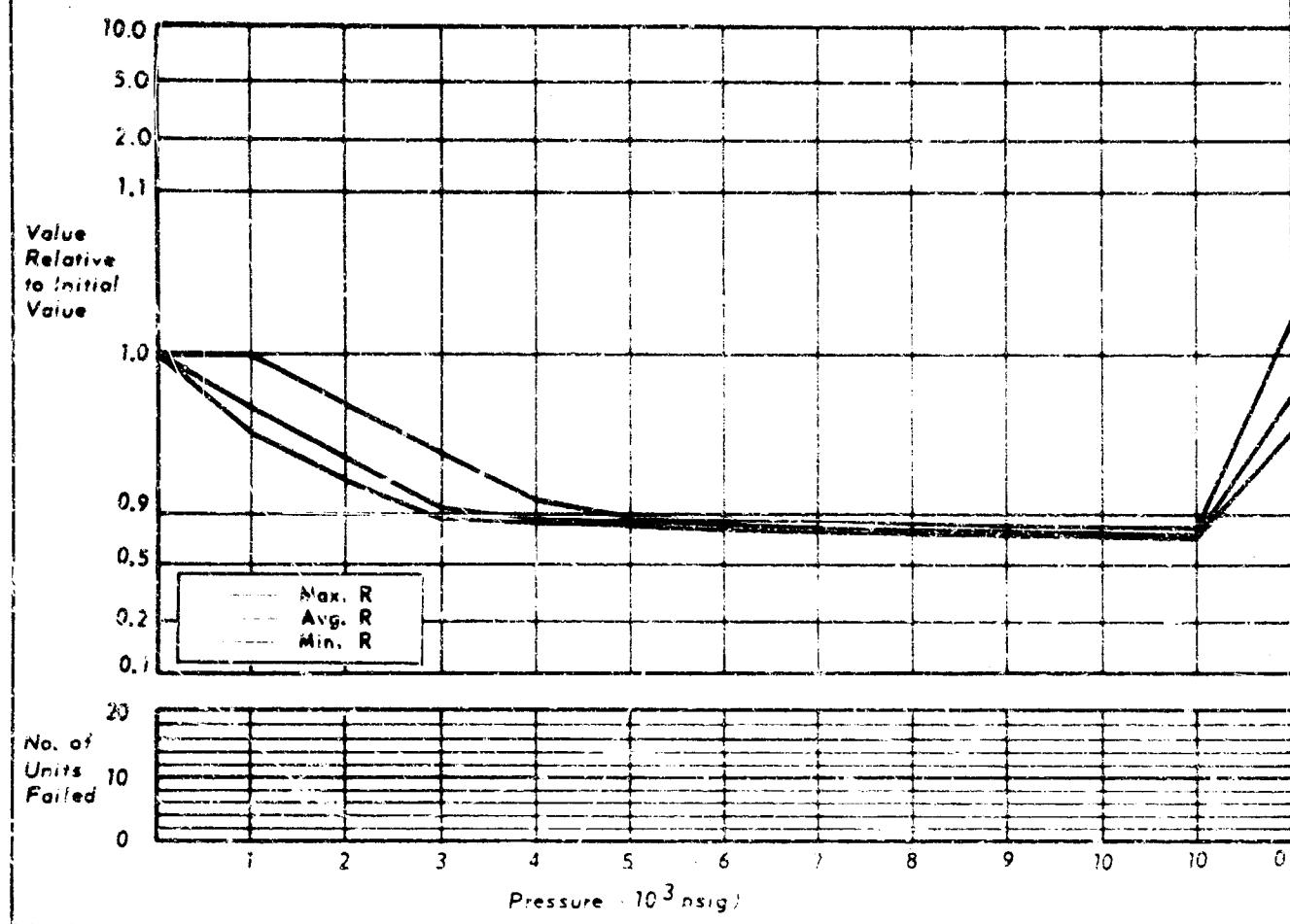


Allen-Bradley	$10 \Omega \pm 5\%$	Composition
CB 1005	1.58 V max	Tubular, axial lead
Resistor	0.25 W	$0.25 \times 0.09^{\prime\prime}$ diam.
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: One component indicated a change greater than 10% and less than 50%.		
Eighteen components indicated less than 10% change.		
FAILURES: One component indicated a change greater than 50% with subsequent recovery at pressures shown on failure graph on opposite page.		

Allen-Bradley	$10 K \Omega \pm 5\%$	Composition
CB 1035	50.0 V max	Tubular, axial lead
Resistor	0.25 V max	$0.25 \times 0.09^{\prime\prime}$ diam.
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.		

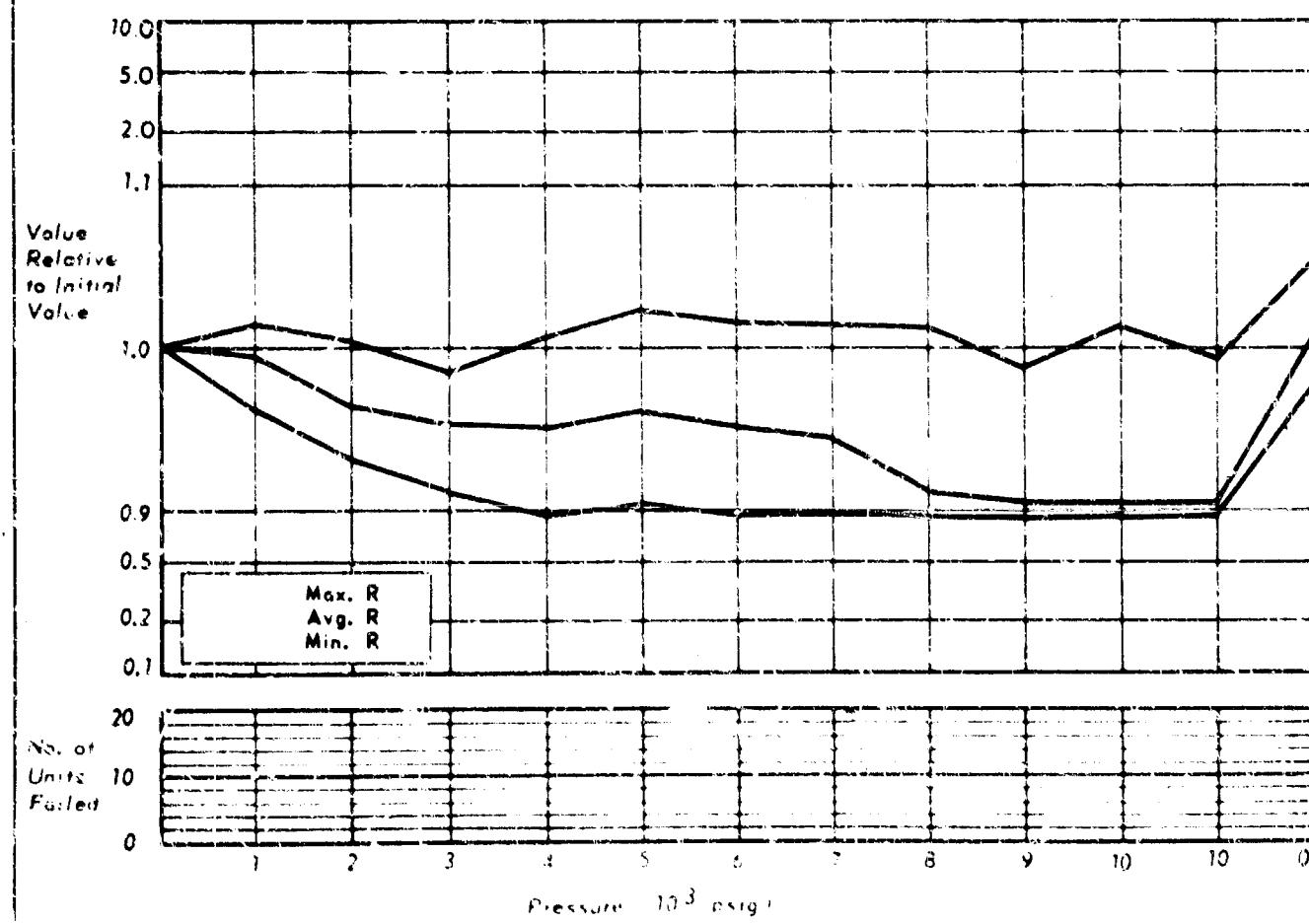
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-CU-1055

CHART NO. 91
NO. OF SAMPLES TESTED-20



MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-EB-1005

CHART NO. 92
NO. OF SAMPLES TESTED-19

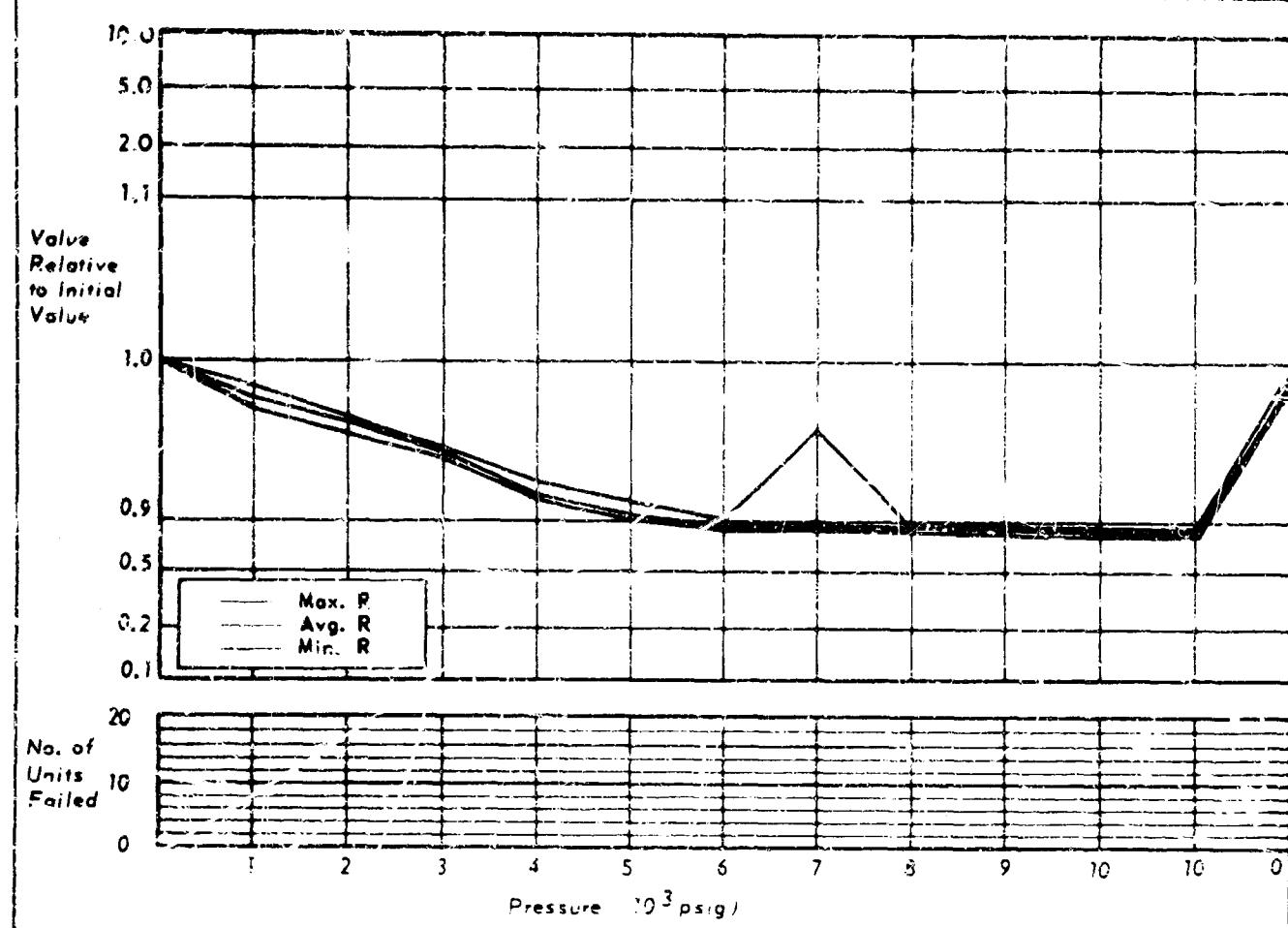


Allen-Bradley	$1.0 \text{ M}\Omega \pm 5\%$	Composition
CB 1055	250.0 V max	Tubular, axial lead
Resistor		$0.375 \times 0.14^{\text{in}}$ diem.
SOAK PERIOD:	None	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	

Allen-Bradley	$10 \text{ }\Omega \pm 5\%$	Composition
EB 1005	2.23 V max	Tubular, axial lead
Resistor	0.5 W	$0.375 \times 0.14^{\text{in}}$ diem.
SOAK PERIOD:	16 hours at 7,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	Six components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	
	Thirteen components indicated less than 10% change.	

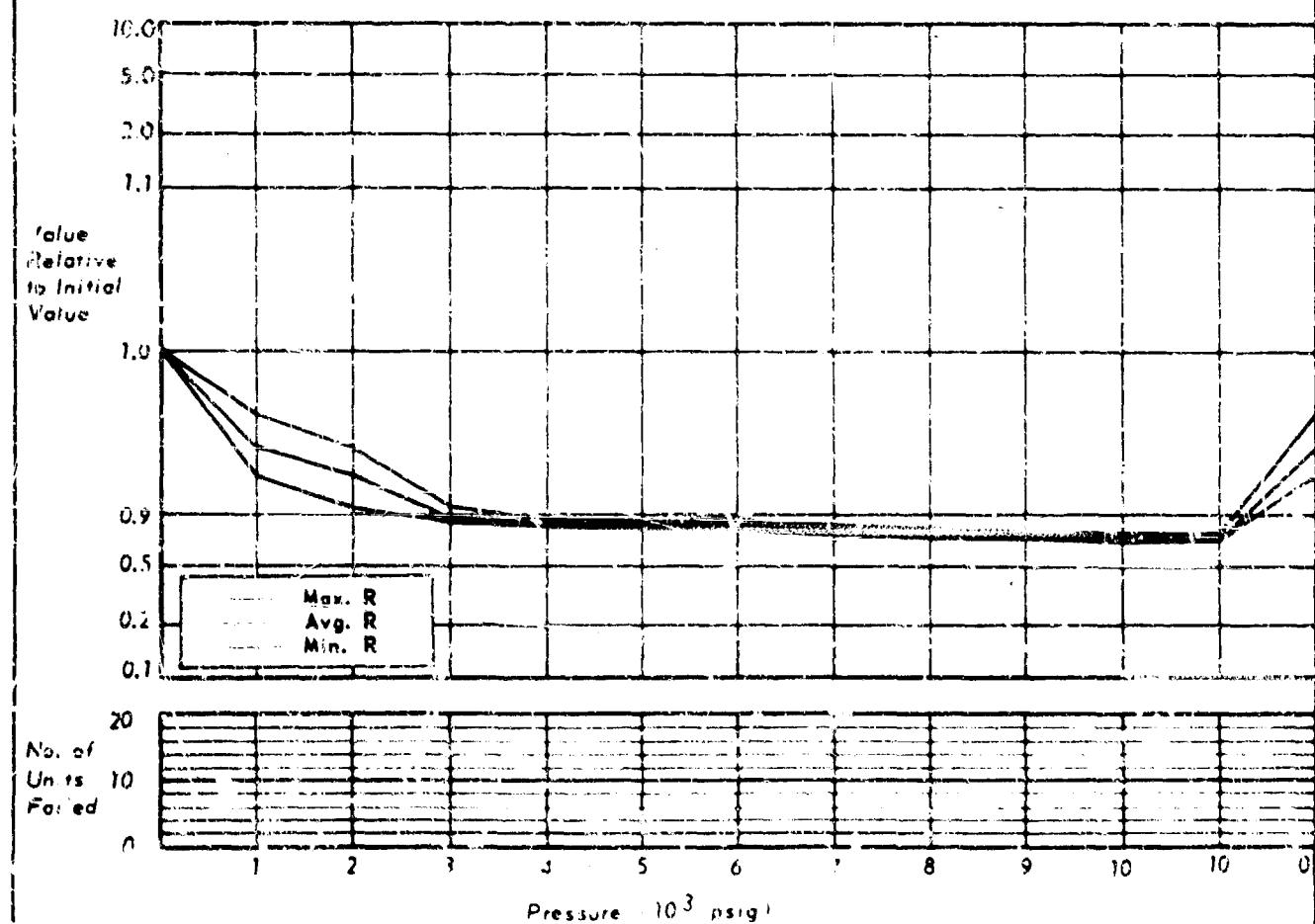
MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - EB-1035

CHART NO. 93
NO. OF SAMPLES TESTED - 10



MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - EB-1085

CHART NO. 94
NO. OF SAMPLES TESTED - 19



Allen-Bradley	10 K Ω \pm 5%	Composition
EB 1035	70.71 V max	Tubular, axial lead
Resistor	0.5 W	0.375 x 0.14" diam.

SOAK PERIOD: 16 hours at 7,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.

Allen-Bradley	1.0 M Ω \pm 5%	Composition
EB 1055	350.0 V max	Tubular, axial lead
Resistor		0.375 x 0.14" diam.

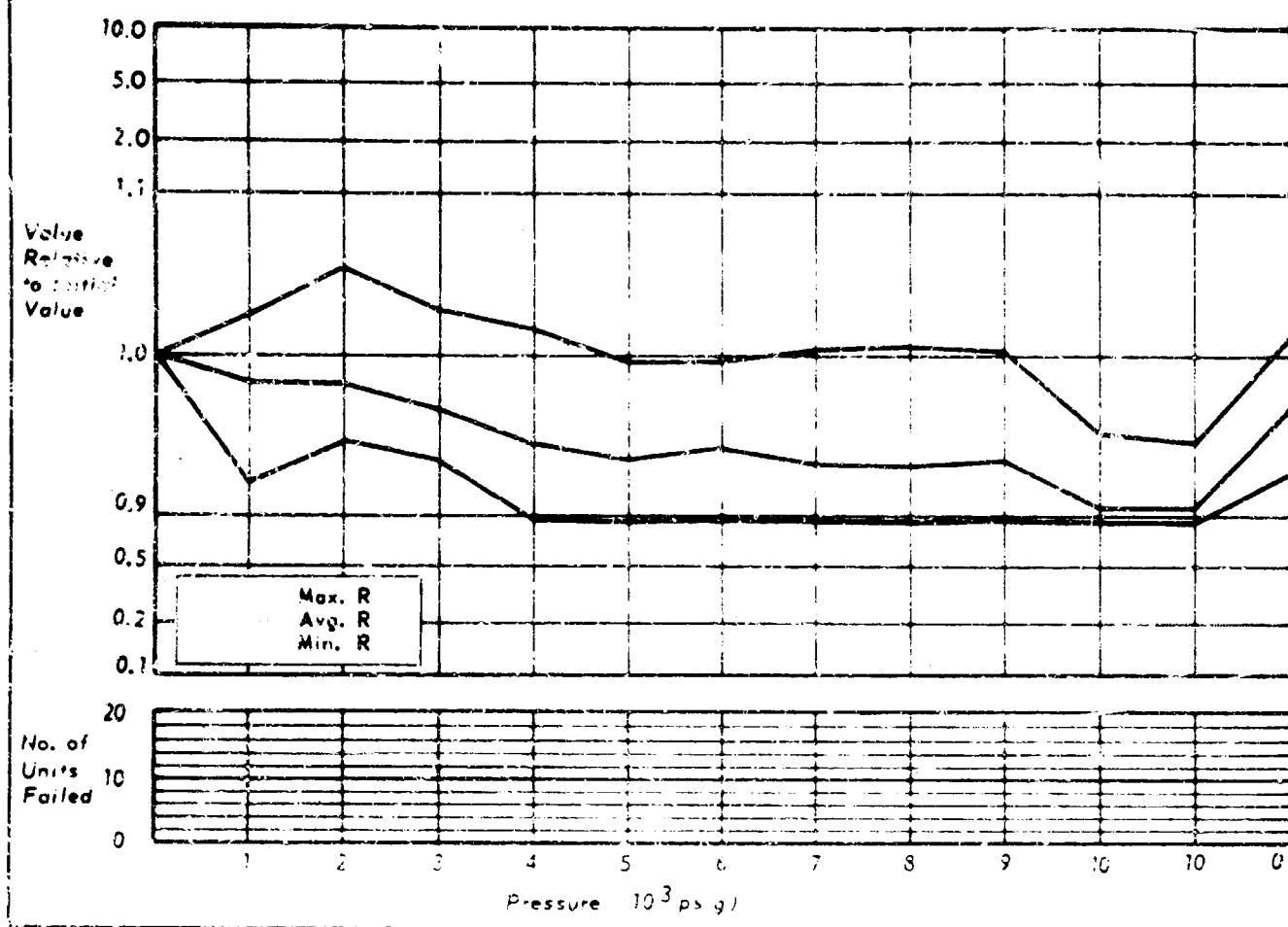
SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.

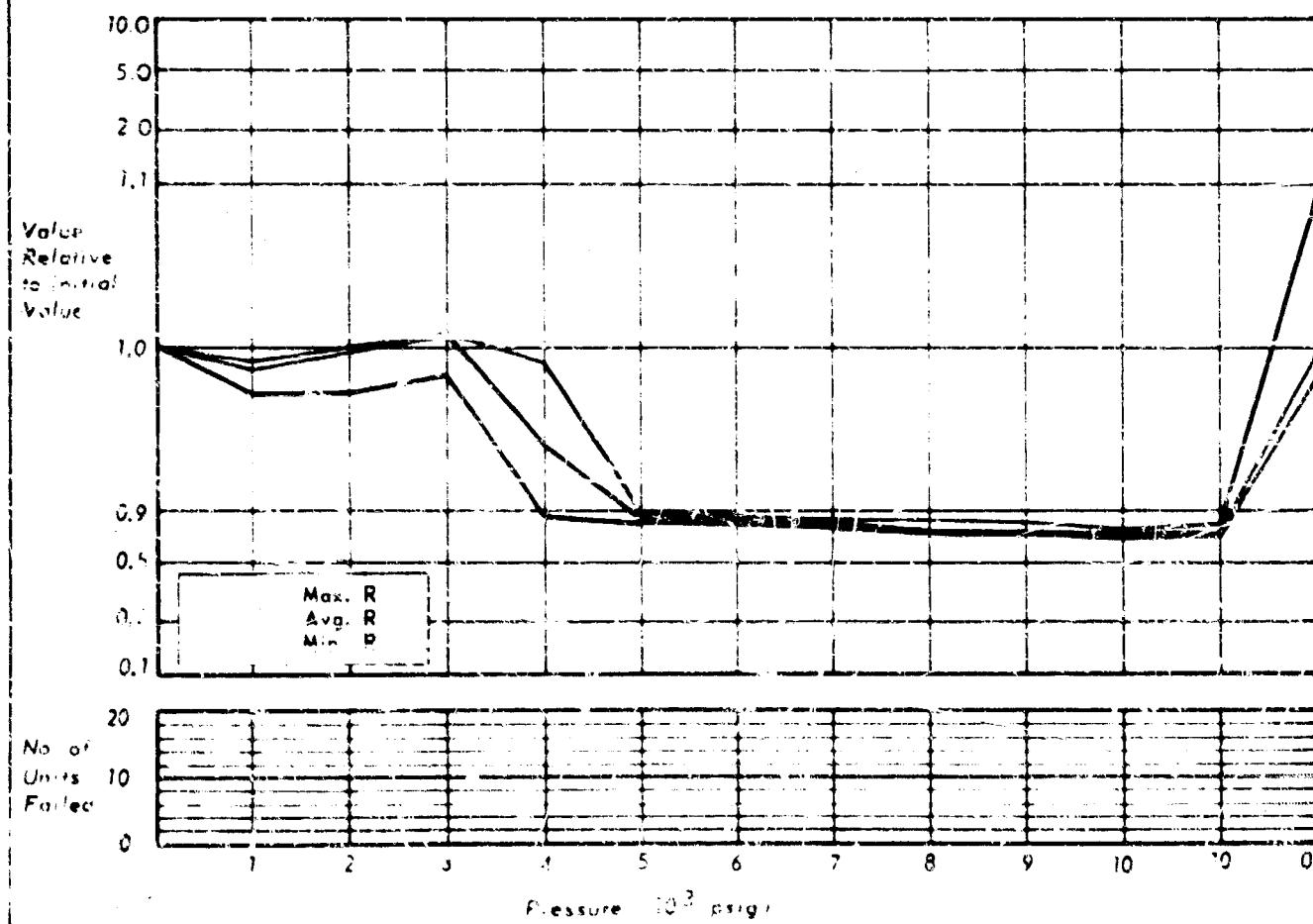
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-CS-1004

CHART NO. 95
NO. OF SAMPLES TESTED-20



MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-CS-1034

CHART NO. 95
NO. OF SAMPLES TESTED-20



Allen-Bradley	$10\Omega \pm 2\%$	Composition, herm sealed
CS 1004	1.58 V max	Tubular, axial lead
Resistor	0.25 W	0.375 x 0.14" diam

SOAK PERIOD: 15 hours at 8,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: Three components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.

Allen-Bradley	$10\text{ K}\Omega \pm 2\%$	Composition, herm sealed
CS 1034	50.0 V max	Tubular, axial lead
Resistor	0.25 W	0.375 x 0.14" diam

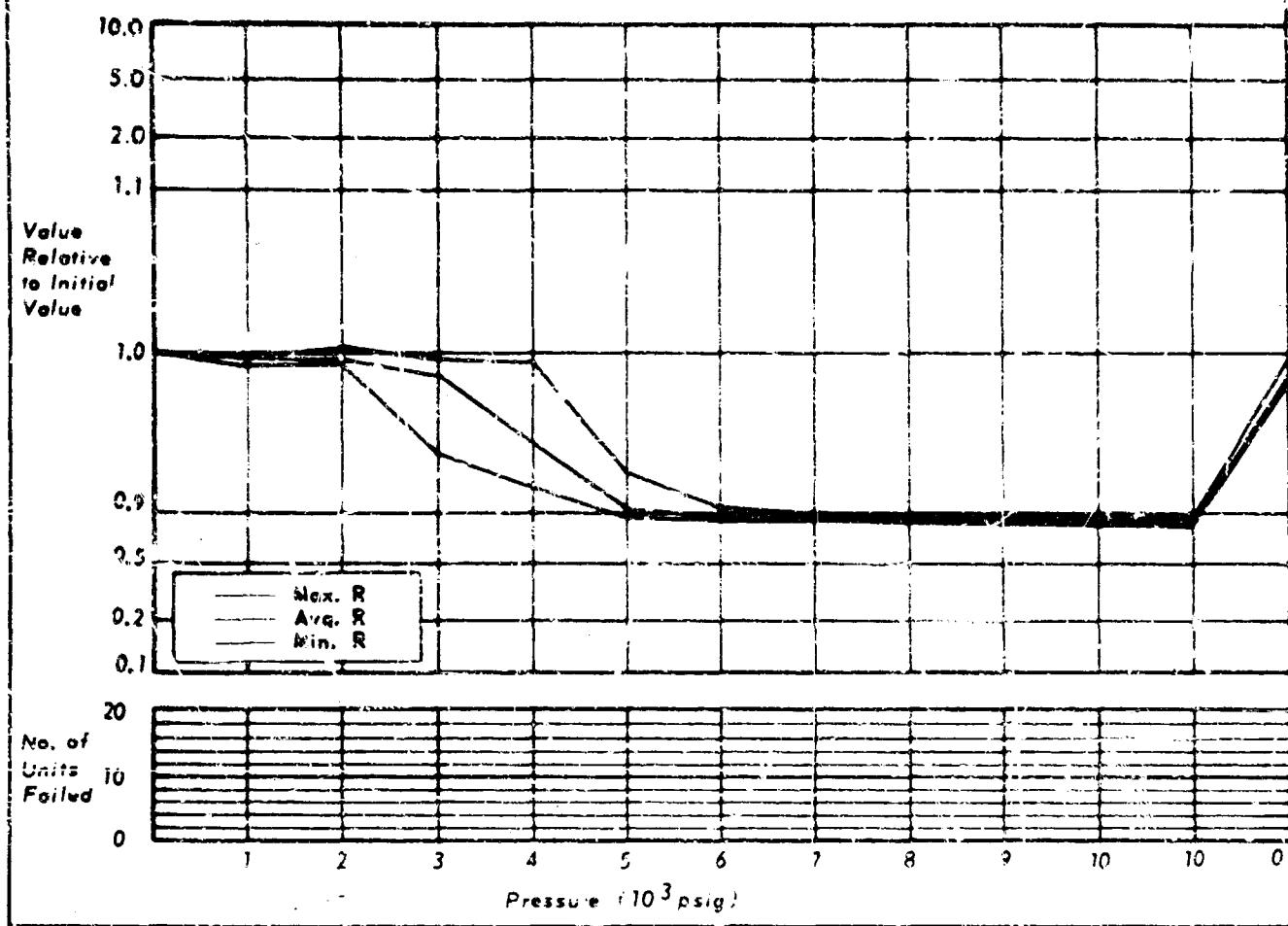
SOAK PERIOD: 16 hours at 7,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.

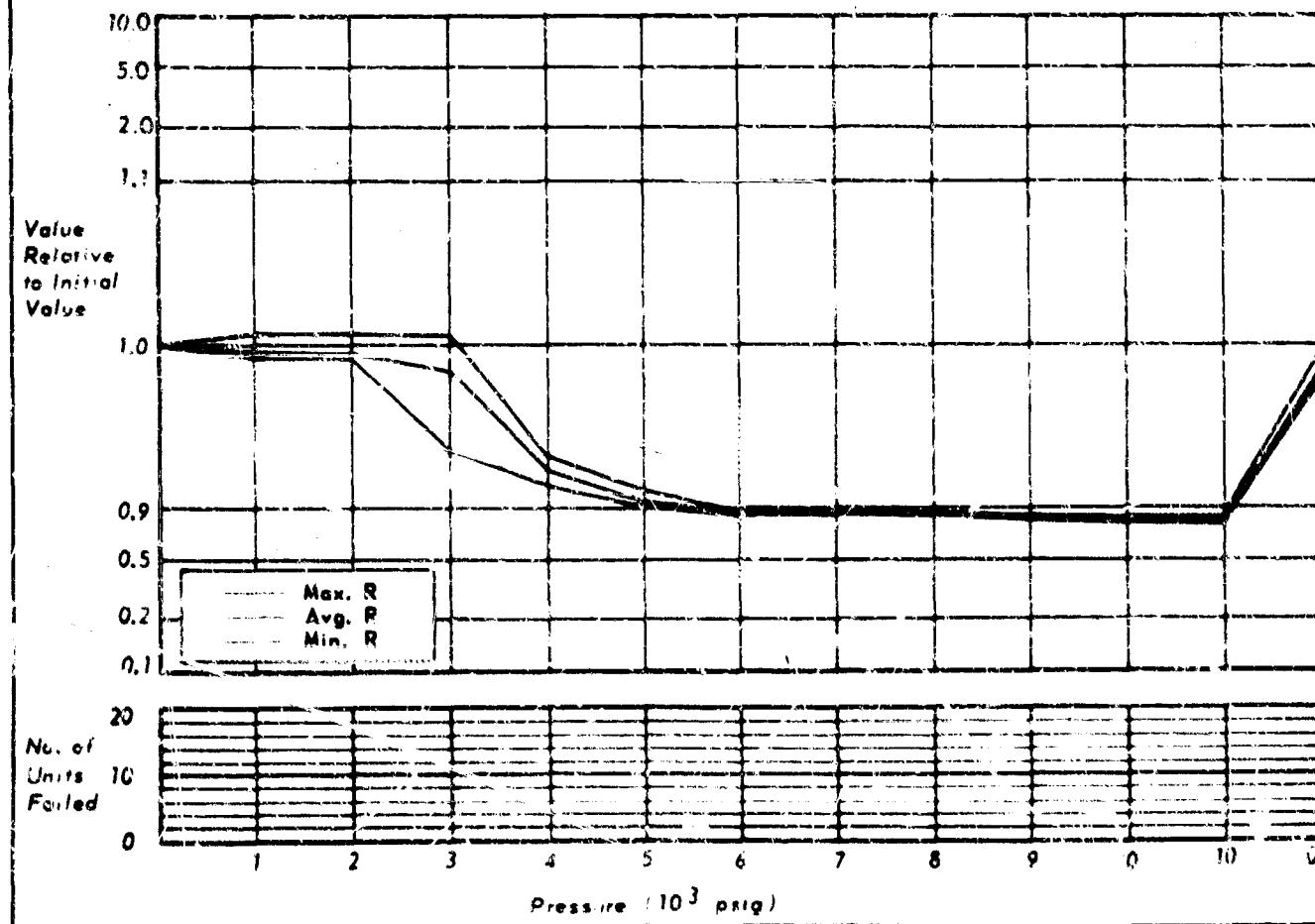
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-E3-1086

CHART NO. 97
NO. OF SAMPLES TESTED-20



MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-E3-1004

CHART NO. 55
NO. OF SAMPLES TESTED-19

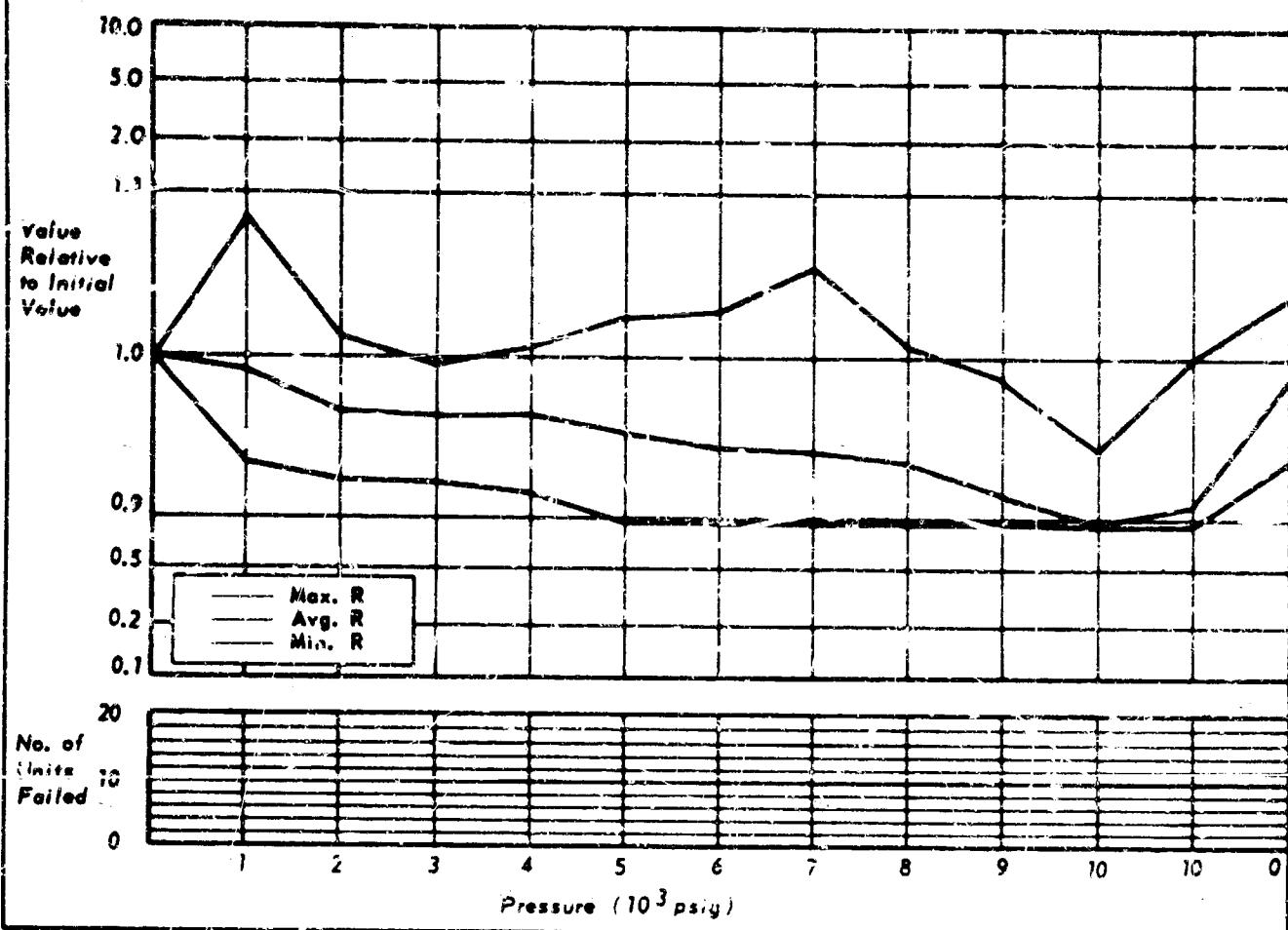


Aller-Bradley	1.0 M Ω \pm 2%	Composition, horn sealed
C3 1034	250.0 V max	Tubular, axial lead
Resistor		0.375 x 0.14" diam.
SOAK PERIOD:	16 hours at 7,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	

Aller-Bradley	10 Ω \pm 2%	Composition, horn sealed
HS 1004	2.23 V max	Tubular, axial lead
Resistor	0.5 W	0.56 x 0.255" diam.
SOAK PERIOD:	16 hours at 8,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	

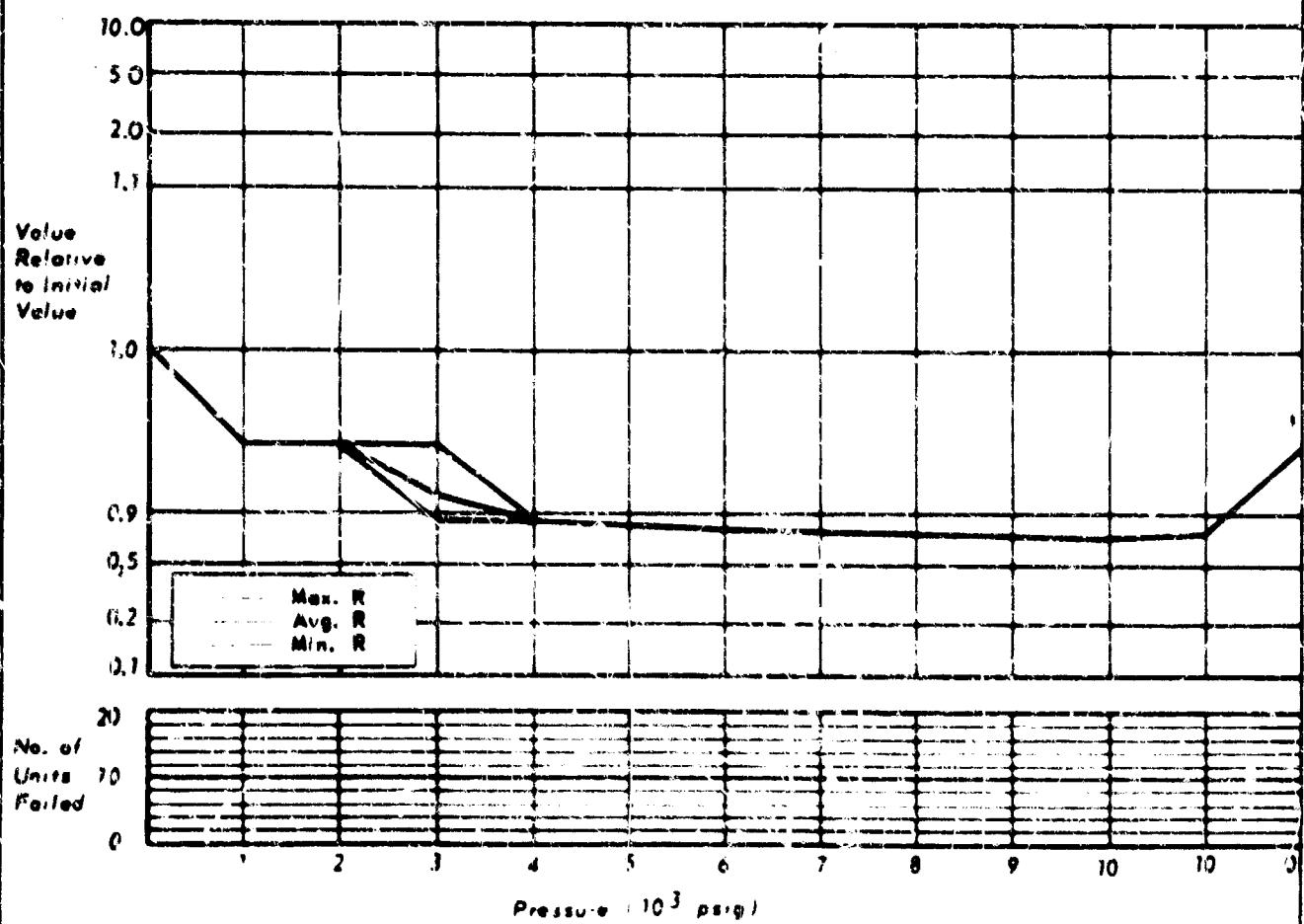
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-E3-1084

CHART NO. 99
NO. OF SAMPLES TESTED-20



MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-E3-1084

CHART NO. 100
NO. OF SAMPLES TESTED-20

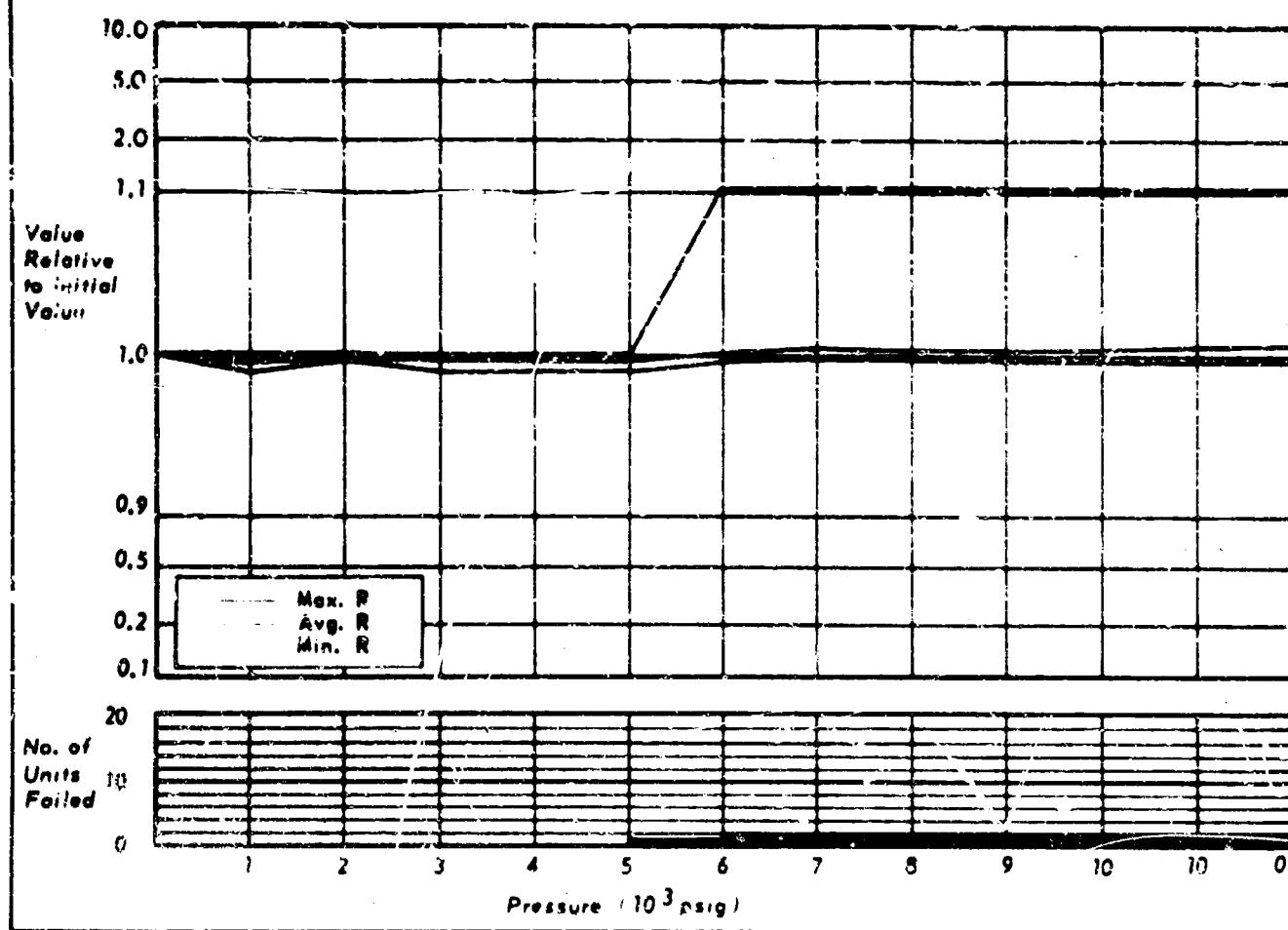


Allen-Bradley	$10\text{ k}\Omega \pm 2\%$	Composition, herm sealed
ES 103A	70.71 V max	Tubular, axial lead
Resistor	0.5 W	$0.56 \times 0.245''$ diam.
SOAK PERIOD:	16 hours at 8,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	

Allen-Bradley	$1.0\text{ M} \pm 2\%$	Composition, herm sealed
ES 1034	350.0 V max	Tubular, axial lead
Resistor		$0.36 \times 0.225''$ diam.
SOAK PERIOD:	16 hours at 8,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated a change greater than 10% with subsequent recovery to less than 10% change on return to 0 psig.	

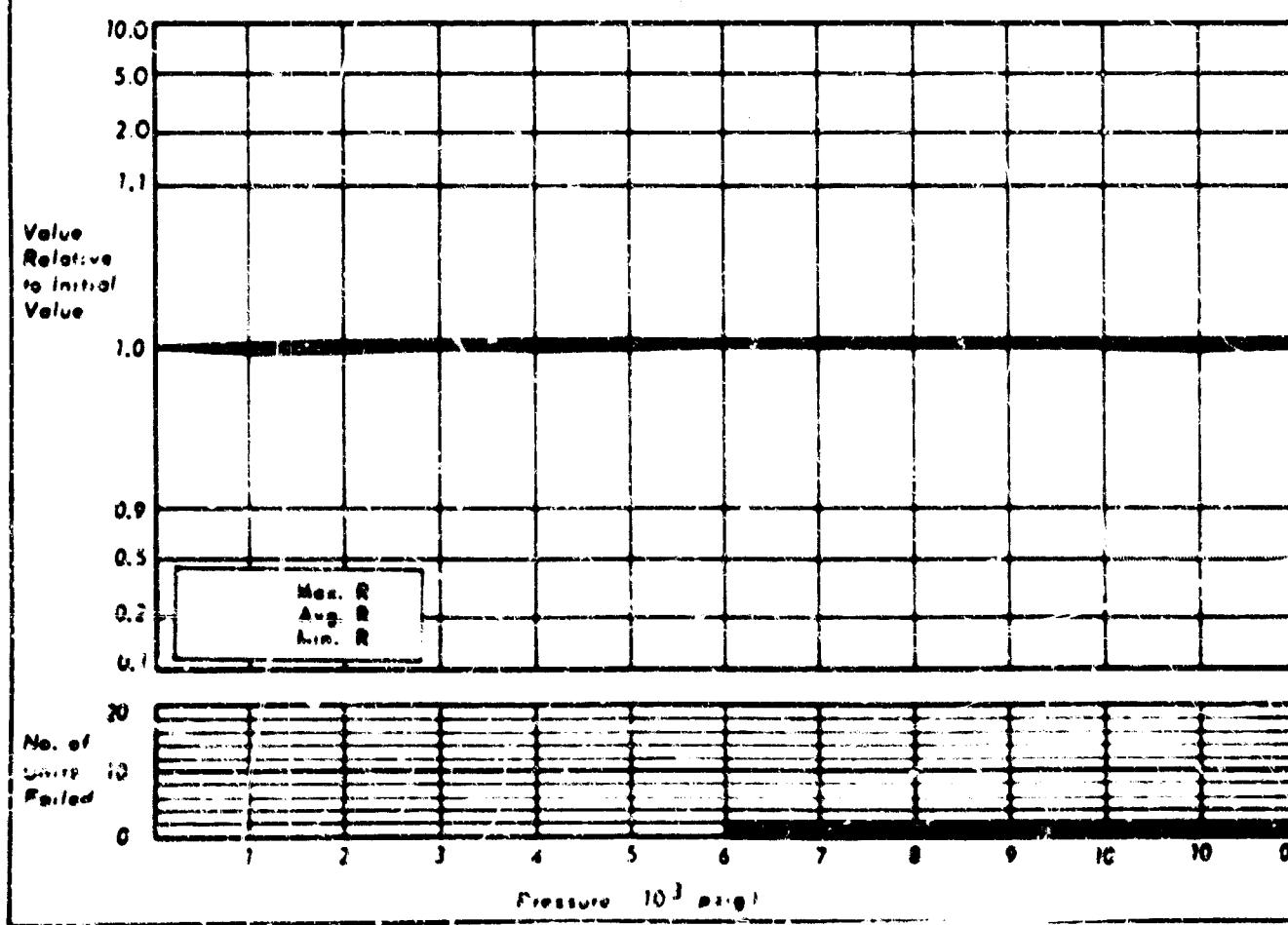
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-CAB410000FY

CHART NO. 101
NO. OF SAMPLES TESTED-20



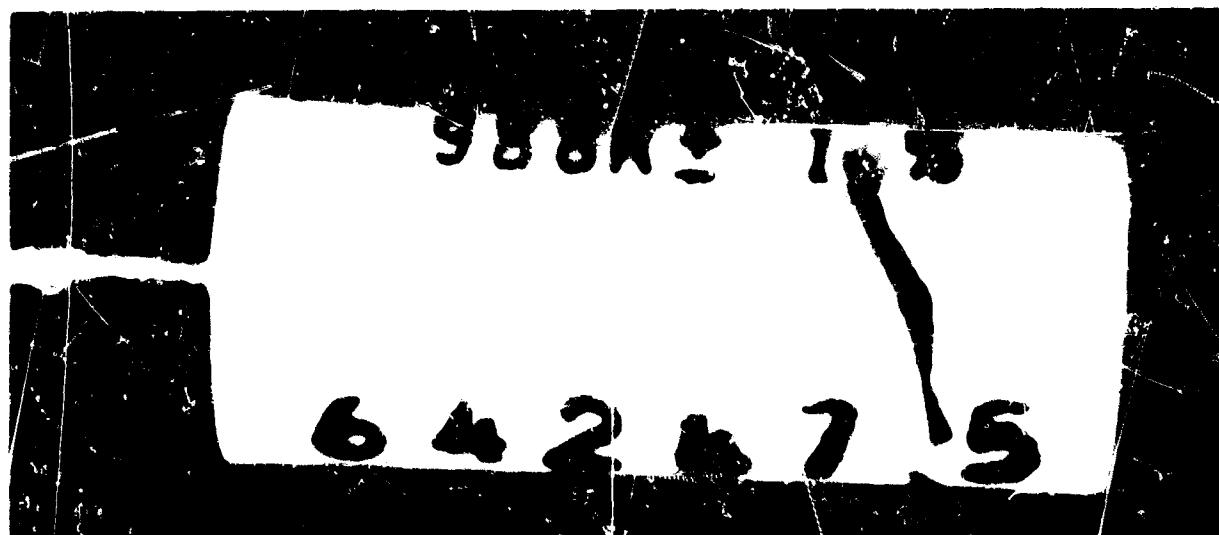
MFG.-ALLEN BRADLEY
TYPE-RESISTOR
DESCRIPTION-CAB 98602FY

CHART NO. 102
NO. OF SAMPLES TESTED-20



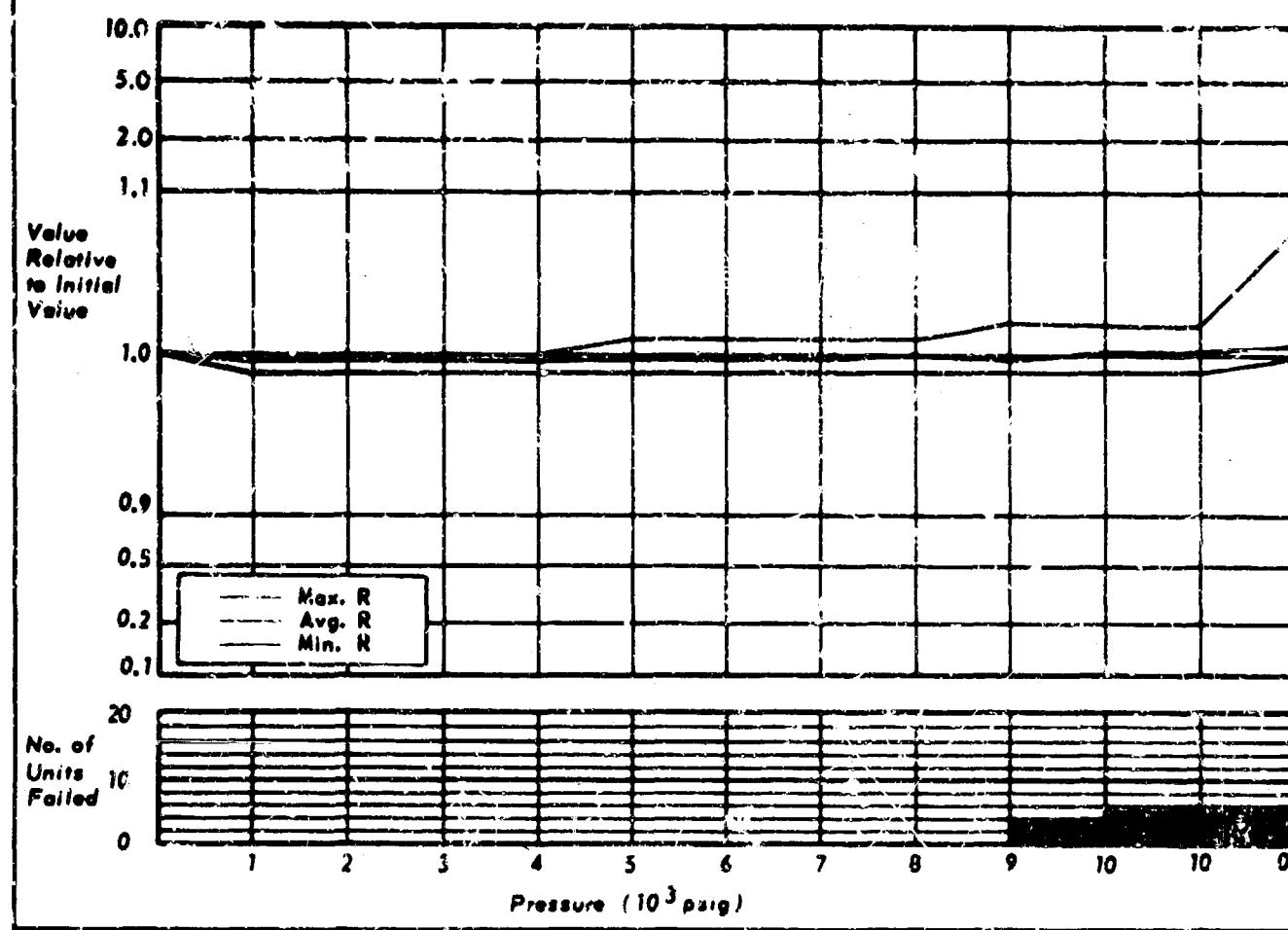
Allen-Bradley	1 K Ω \pm 1%	Metal film, herm sealed
CAH 10000 FY	15.01 V max	Tubular, axial lead
Resistor	0.25 W	0.56 x 0.225" diam.
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Eighteen components indicated less than 10% change.		
FAILURES: Two components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.		

Allen-Bradley	968 K Ω \pm 1%	Metal film, herm sealed
CAH 98002 FY	300.0 V max	Tubular, axial lead
Resistor	1 W	0.56 x 0.225" diam
SOAK PERIOD: None		
MECHANICAL: Visual inspection after completion of test showed a crack in the ceramic case of one component. This component functioned normally throughout the test.		
ELECTRICAL: Eighteen components indicated less than 10% change.		
FAILURES: Two components indicated a permanent change greater than 50% at the pressures shown on the failure graph on opposite page.		



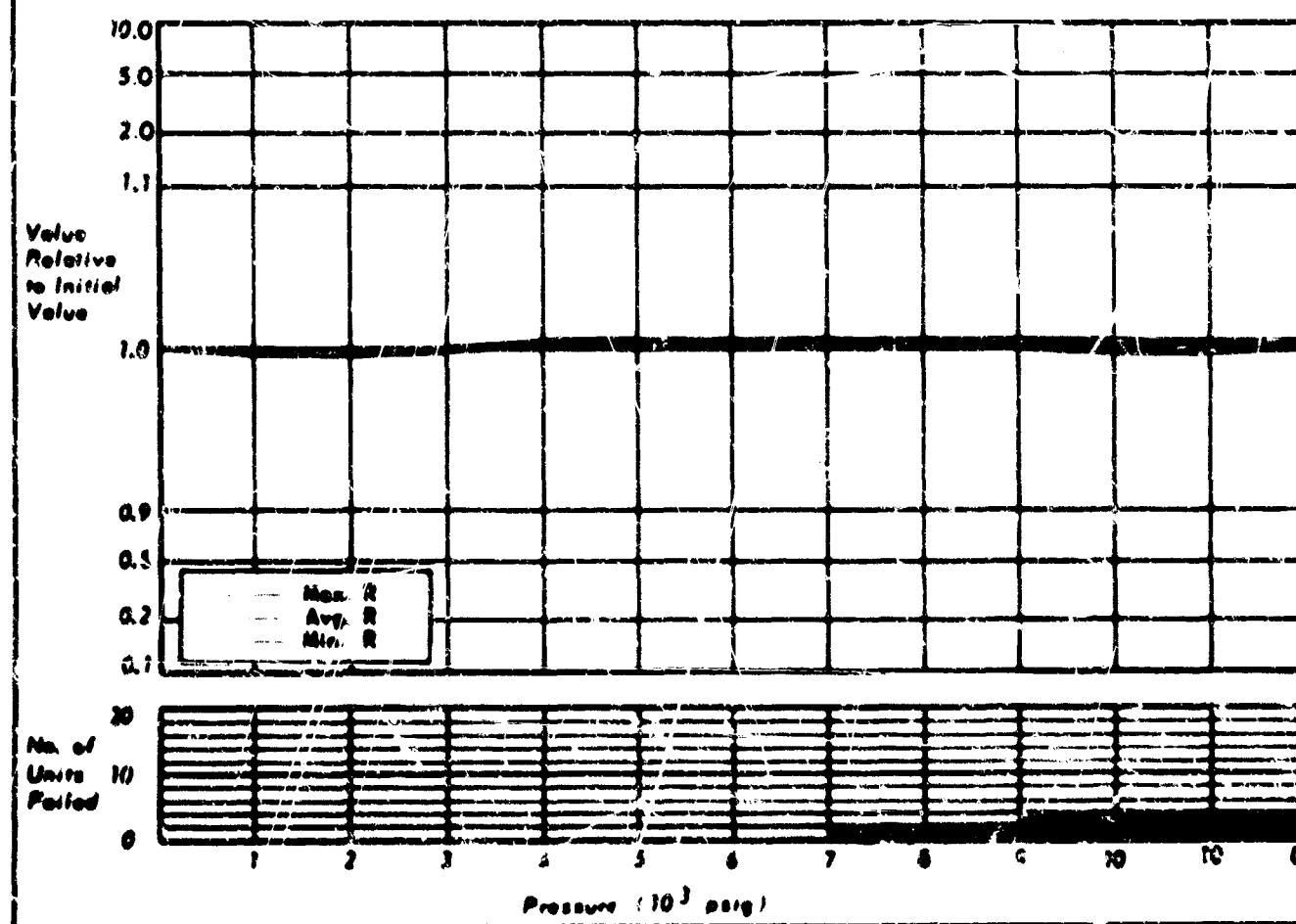
MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - ZAN12001.F3

CHART NO. 103
NO. OF SAMPLES TESTED - 10

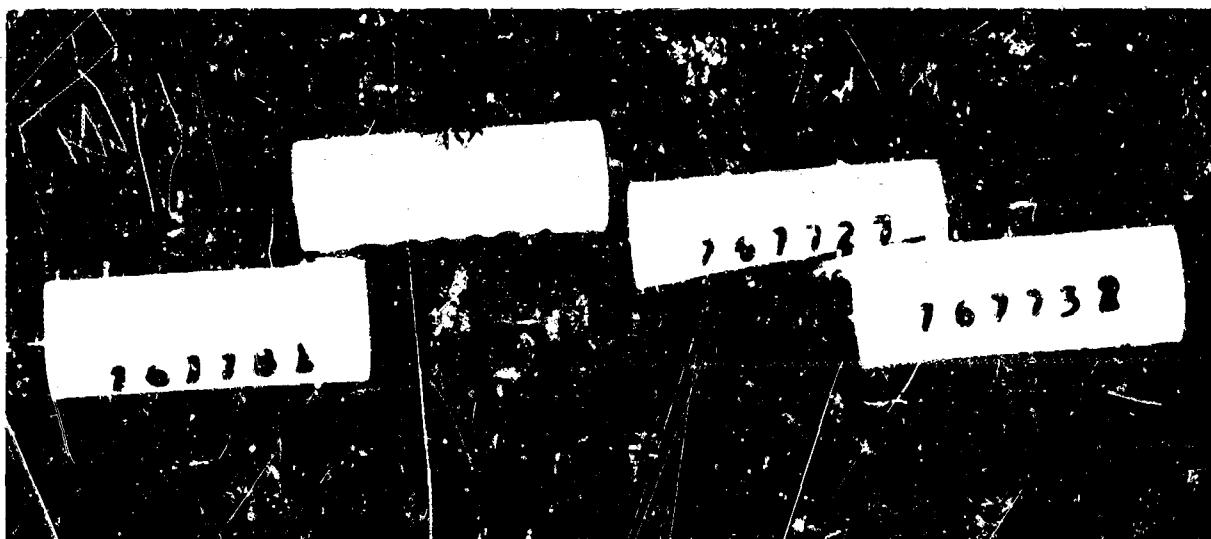


MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - ZAN10001.FY

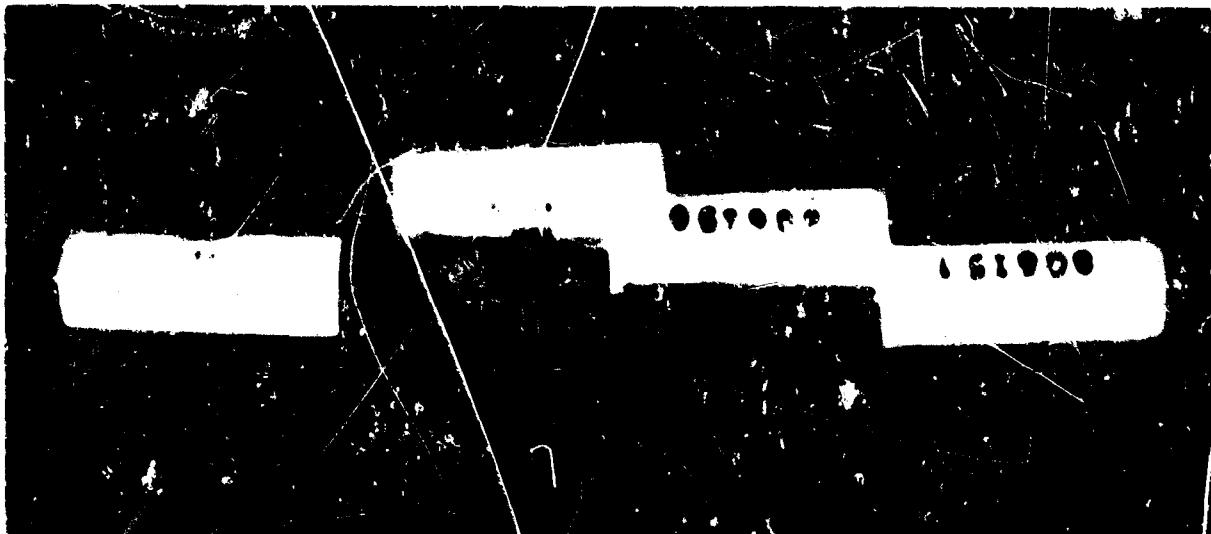
CHART NO. 104
NO. OF SAMPLES TESTED - 20



Allen-Bradley 1 K Ω \pm 1% Metal film, herm sealed
 EAH 10000 FY 22.36 V max Tubular, axial lead
 Resistor 0.5 W 0.83 x 0.312" diam.
SOAK PERIOD: None
MECHANICAL: Visual inspection following completion of tests showed cracked ceramic cases of ten components. Five of the damaged components remained functional throughout the entire test.
ELECTRICAL: Fourteen components indicated less than 10% change.
FAILURES: Five components indicated a permanent change greater than 50% of the pressures shown on the failure graph on opposite page.

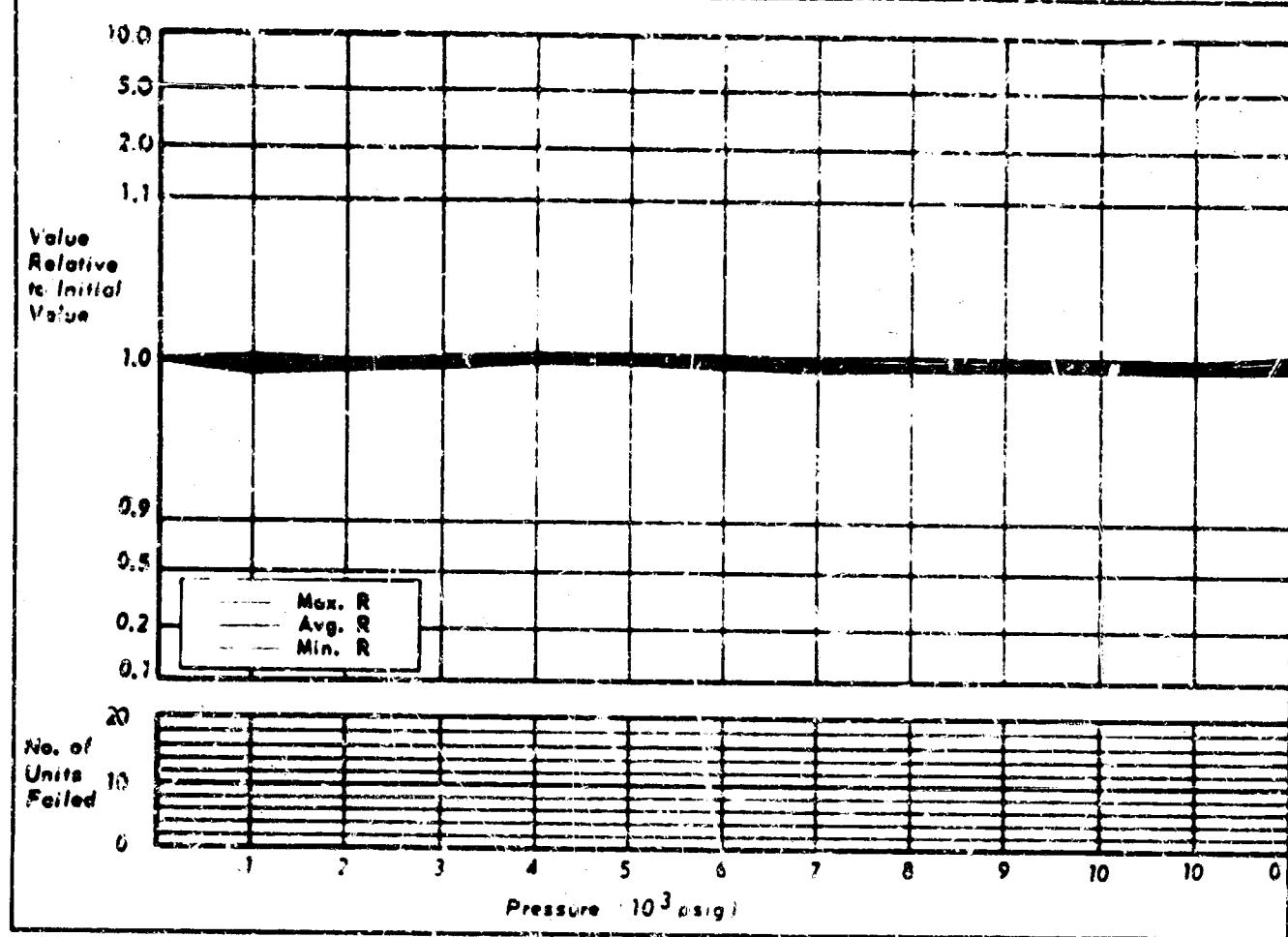


Allen-Bradley 10 K Ω \pm 1% Metal film, herm sealed
 EAH 100001 FY 78.21 V max Tubular, axial lead
 Resistor 0.5 W 0.83 x 0.312" diam.
SOAK PERIOD: None
MECHANICAL: Visual inspection following completion of tests showed cracked ceramic cases of ten components. Three of the damaged components remained functional throughout the entire test.
ELECTRICAL: Seventeen components indicated less than 10% change.
FAILURES: Three components indicated a permanent change greater than 50% of the pressures shown on the failure graph on opposite page.



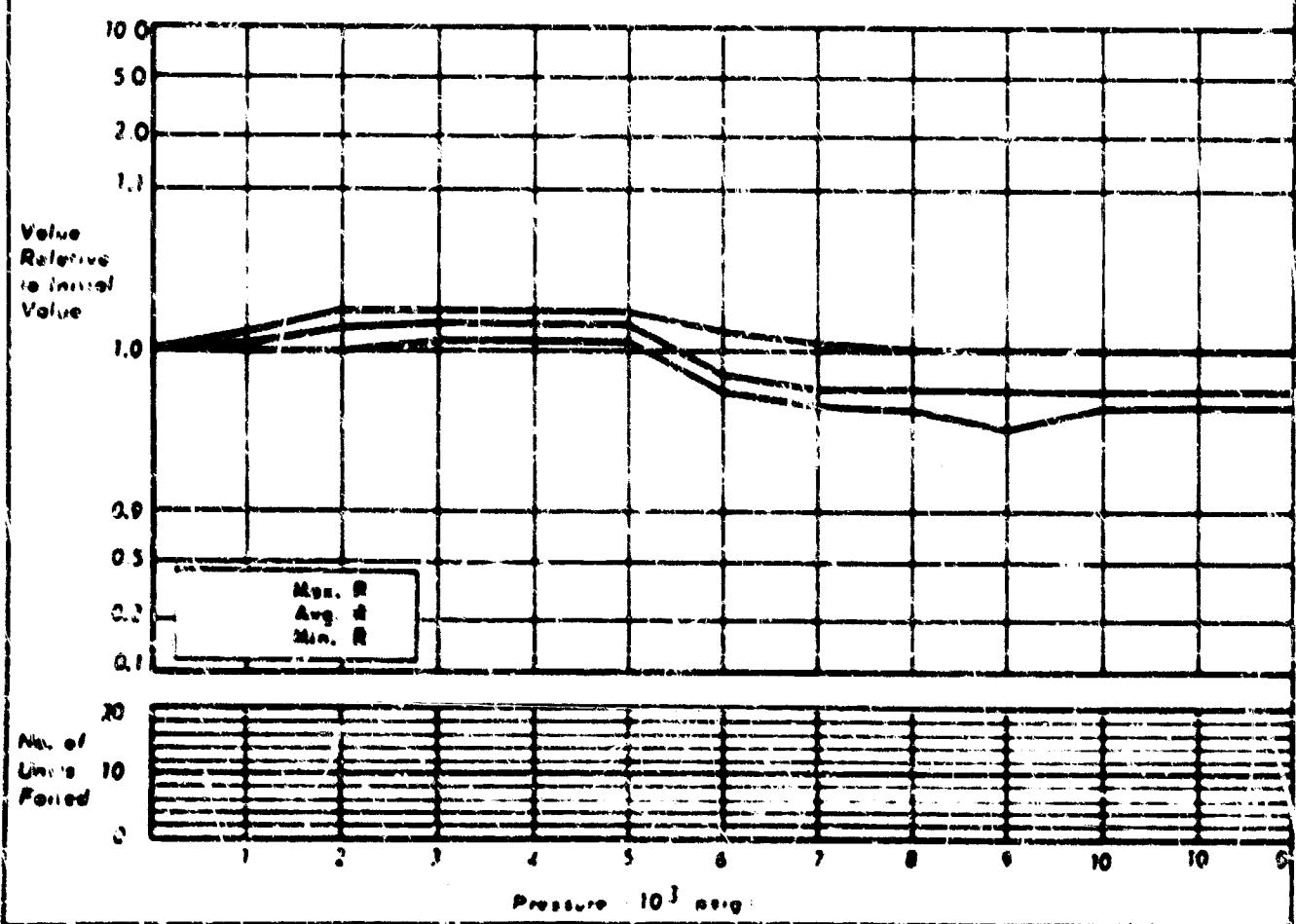
MFG. - ALLEN BRADLEY
TYPE - RESISTOR
DESCRIPTION - CAR 1000CIPV

CHART NO. 105
NO. OF SAMPLES TESTED - 20



MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - C-100

CHART NO. 106
NO. OF SAMPLES TESTED - 20



Allison-Bradley
CAH100001PY
Resistor
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

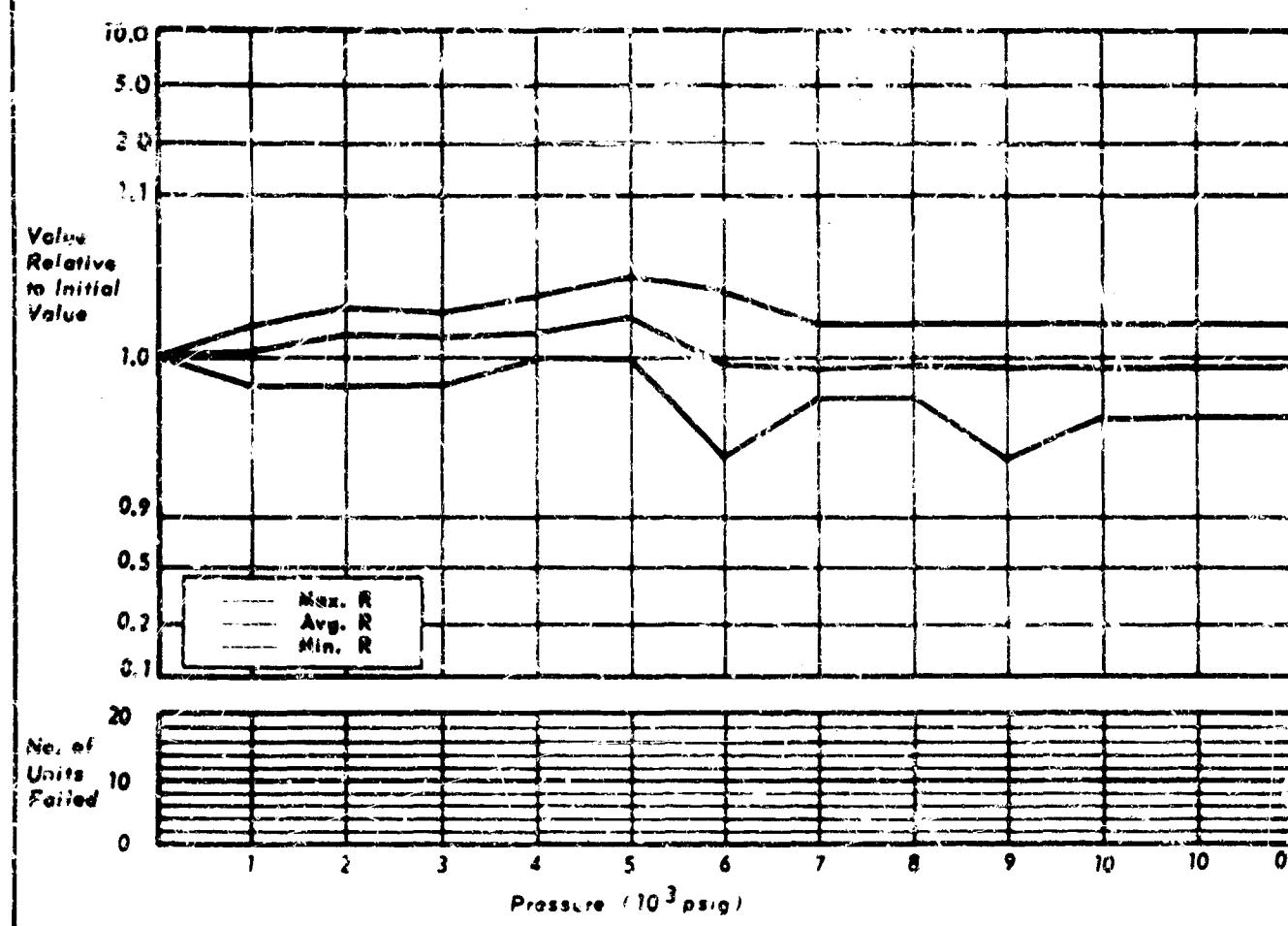
10 K Ω \pm 1%
300 V max
1W
Metal film, herm sealed
Tubular, axial lead
0.33 x 0.312" dia.

Corning
CT-20
Resistor
SOAK PERIOD: None
MECHANICAL: All components indicated less than 10% change.

209 Ω & 470 K Ω
Experimental

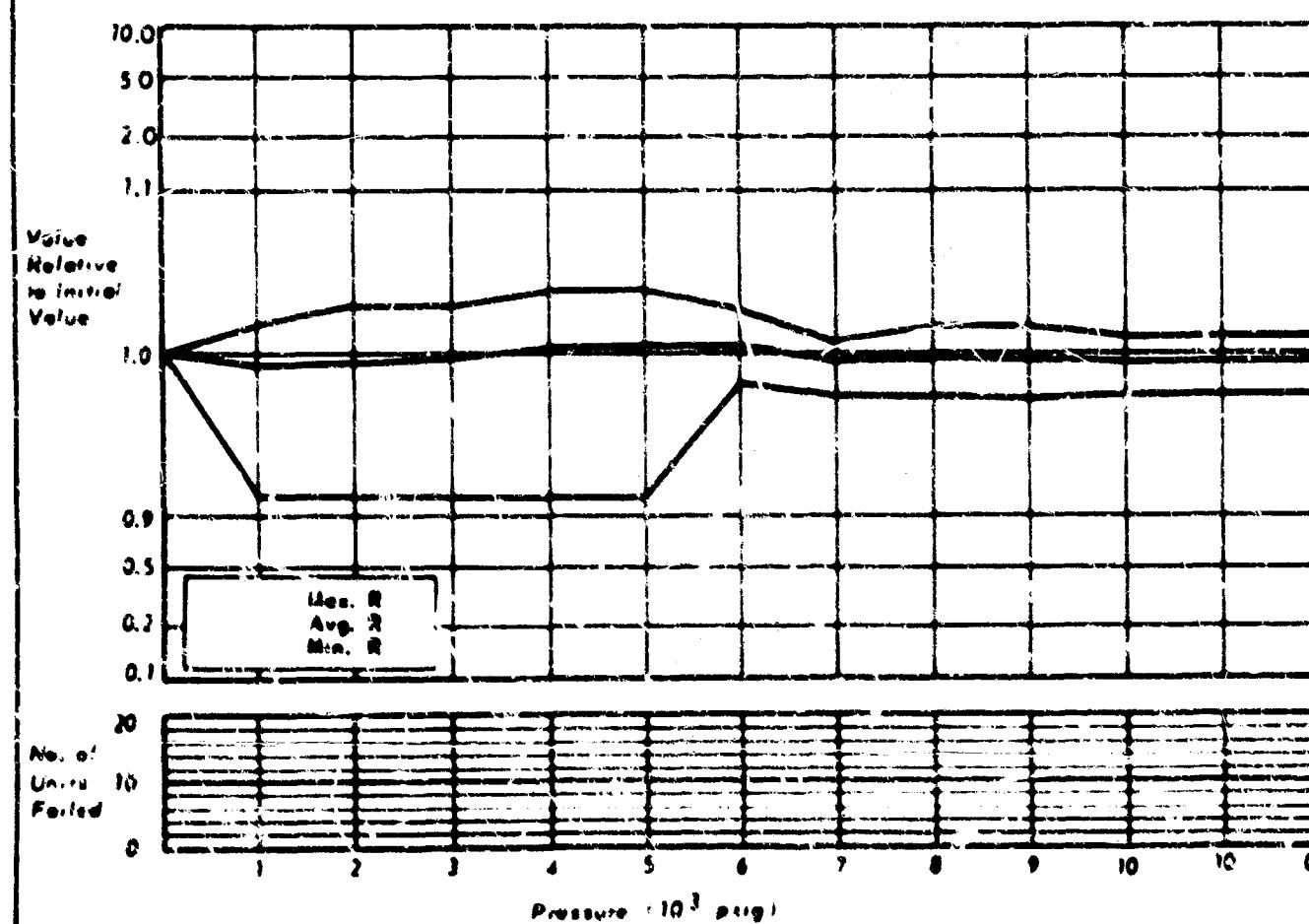
MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - NA-68

CHART NO. 107
NO. OF SAMPLES TESTED - 20



MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - NA-68

CHART NO. 108
NO. OF SAMPLES TESTED - 20



Corning

See Note

Silicon-epoxy coat

NA-65

Tubular, metal lead

Resistor

NOTE: Nine different values of the NA-65 type resistor were submitted for test. Since all components were of the same type the twenty components were tested as a set. The values and numbers submitted are listed below.

Value	Quantity	Value	Quantity
10.0 Ω	2	255 Ω	2
14.7 Ω	2	494 Ω	2
20.6 Ω	2	51.1 Ω	3
100.0 Ω	2	100.0 K Ω	3
10 K Ω	2		

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Corning

See Note

Silicon-epoxy coat

NA-60

Tubular, metal lead

Resistor

NOTE: Nine different values of the NA-65 type resistor were submitted for test. Since all components were of the same type the twenty components were tested as a set. The values and numbers submitted are listed below.

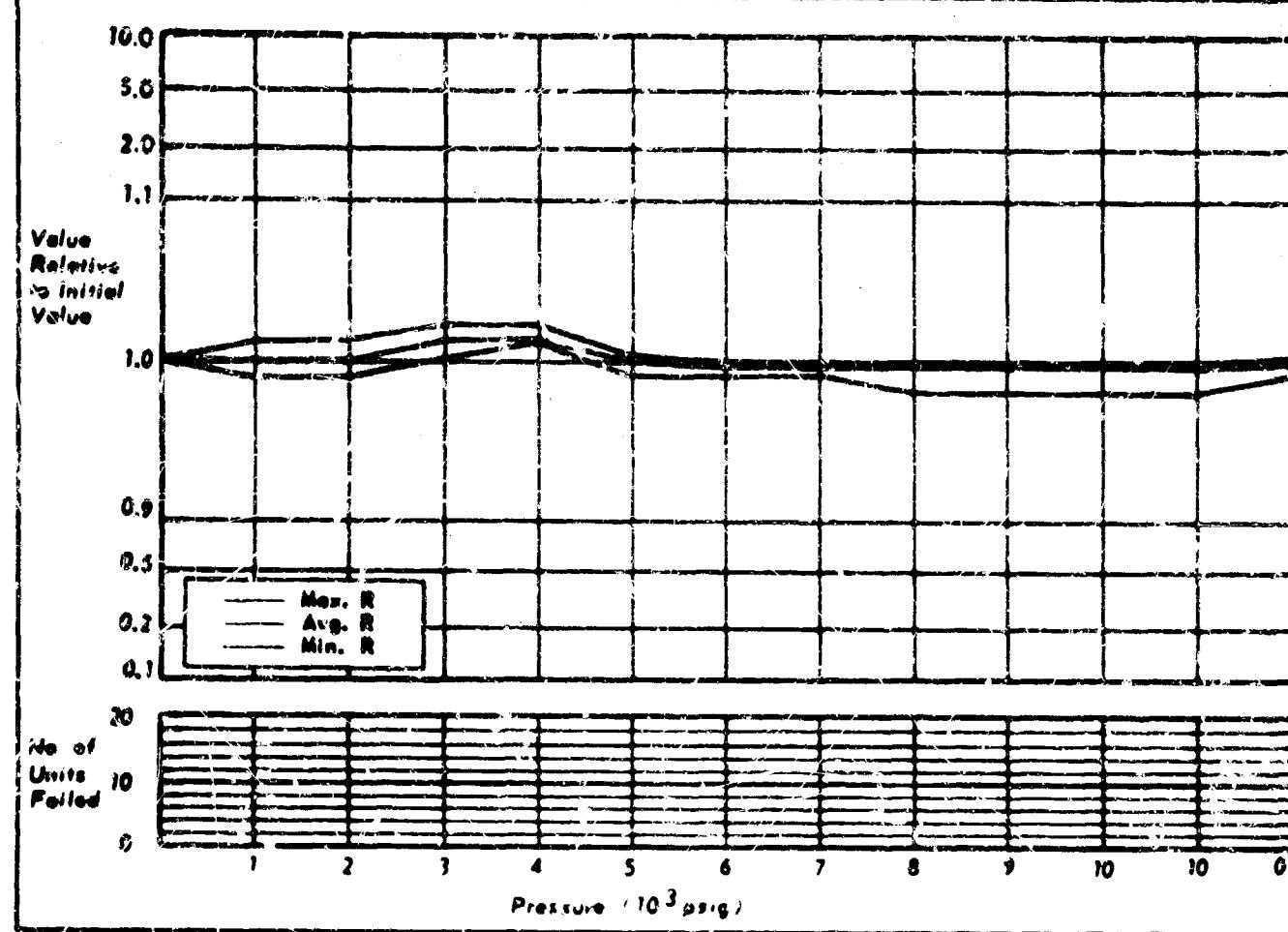
Value	Quantity	Value	Quantity
10.0 Ω	3	100 K Ω	3
23.7 Ω	3	150 K Ω	3
51.1 Ω	3	82.5 Ω	2
100.0 Ω	3		

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

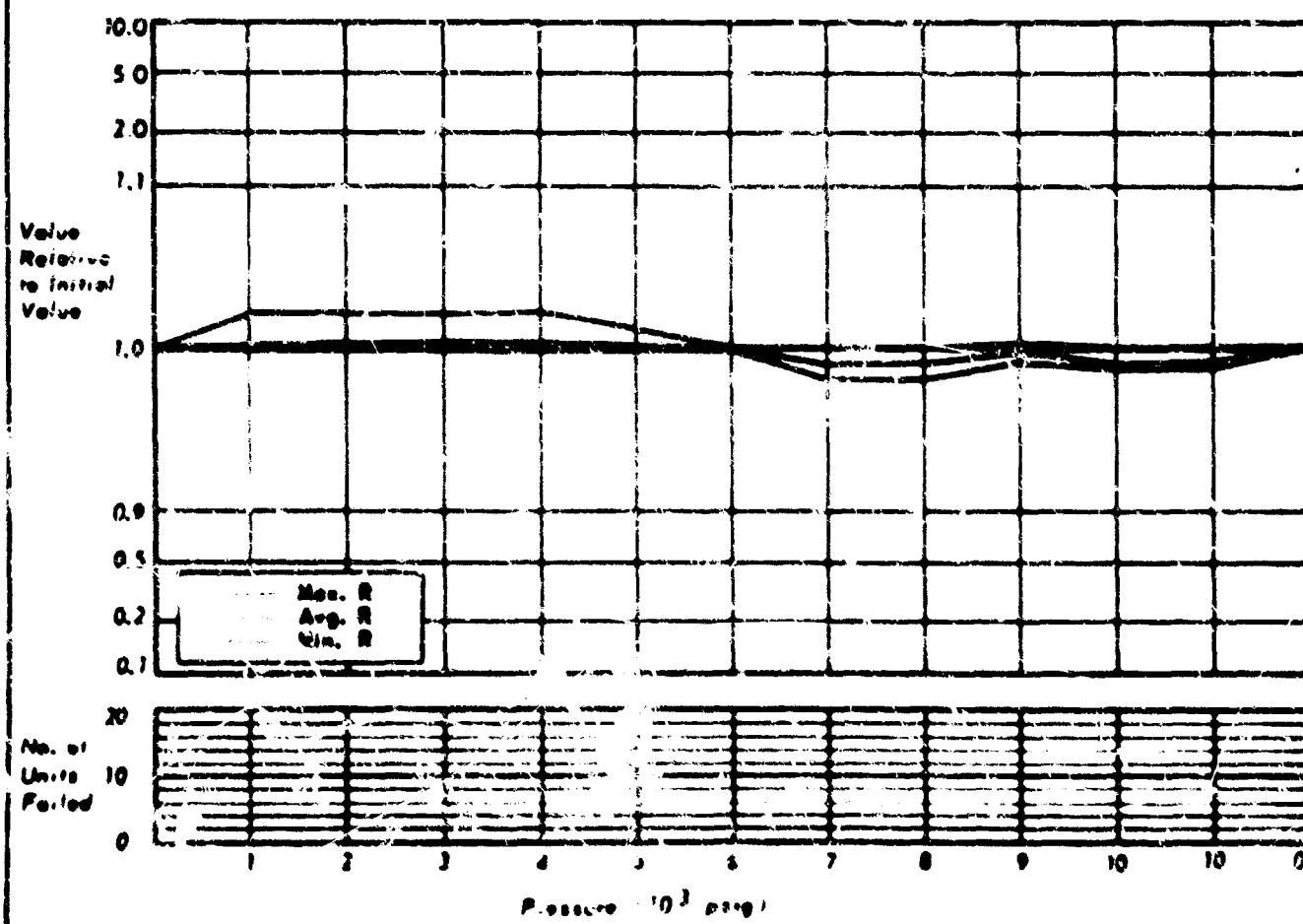
MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - 8A TO

CHART NO. 109
NO. OF SAMPLES TESTED - 21



MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - 8TX-8

CHART NO. 110
NO. OF SAMPLES TESTED - 20



Corning	See Note	Metal film, epoxy coat
MA-70	0.5 W	Tubular, axial lead
Resistor		3.70 x 0.25" diam.

NOTE: Three components of each of the seven values listed below were submitted. All components were of the same type and were therefore tested as a set of twenty-one.

84.5 Ω 1 K Ω 100 K Ω 1 M Ω
 100.0 Ω 10 K Ω 499 K Ω

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Corning	See Note	Tin oxide film, glass coat
GTX-3	0.25 W	Tubular, axial lead
Resistor		0.34 x 0.15" diam.

NOTE: Ten components of each of the two values listed below were submitted for test. All components were of the same type and were therefore tested as a set of twenty.

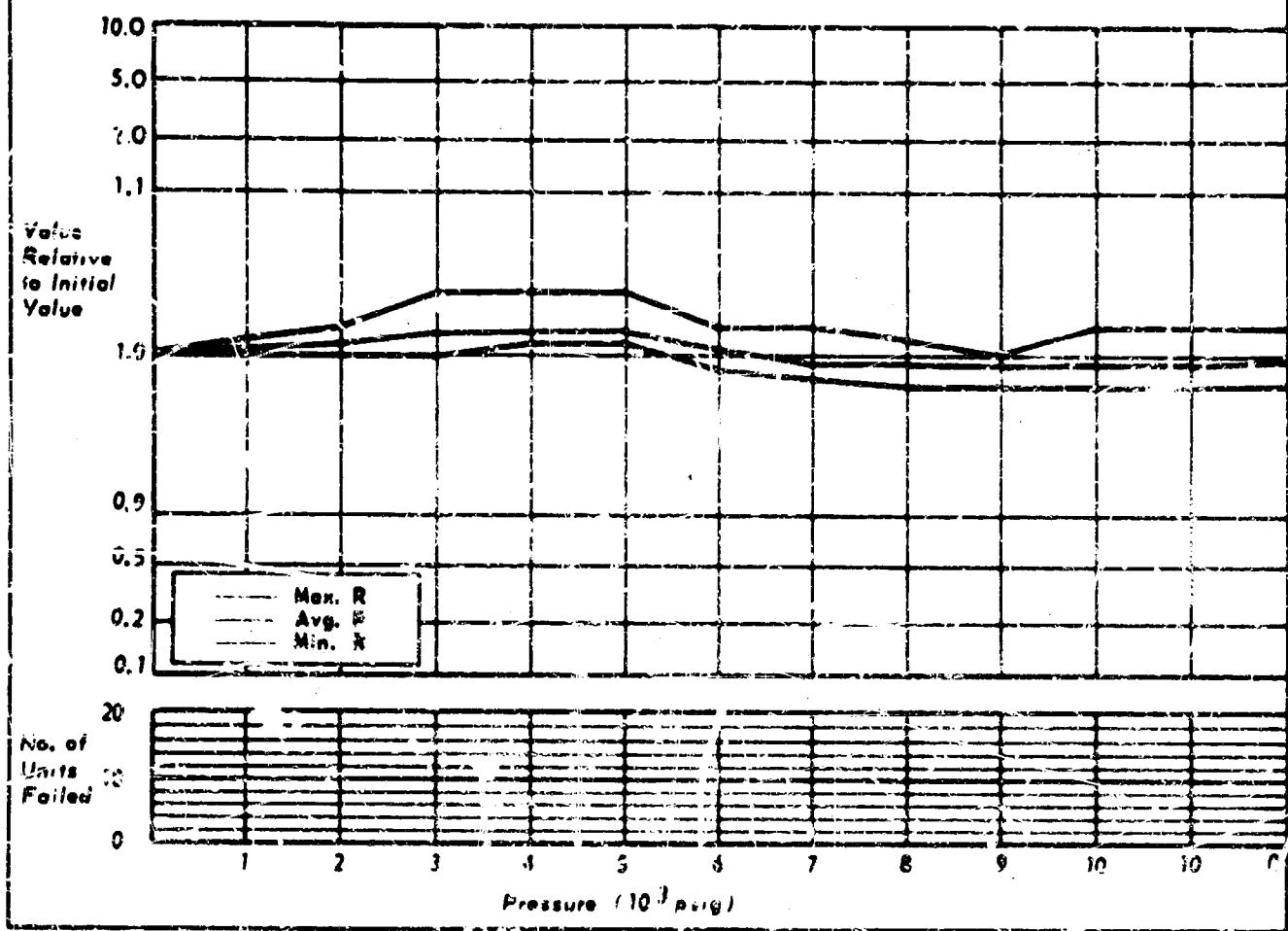
49.9 Ω
 50 K Ω

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

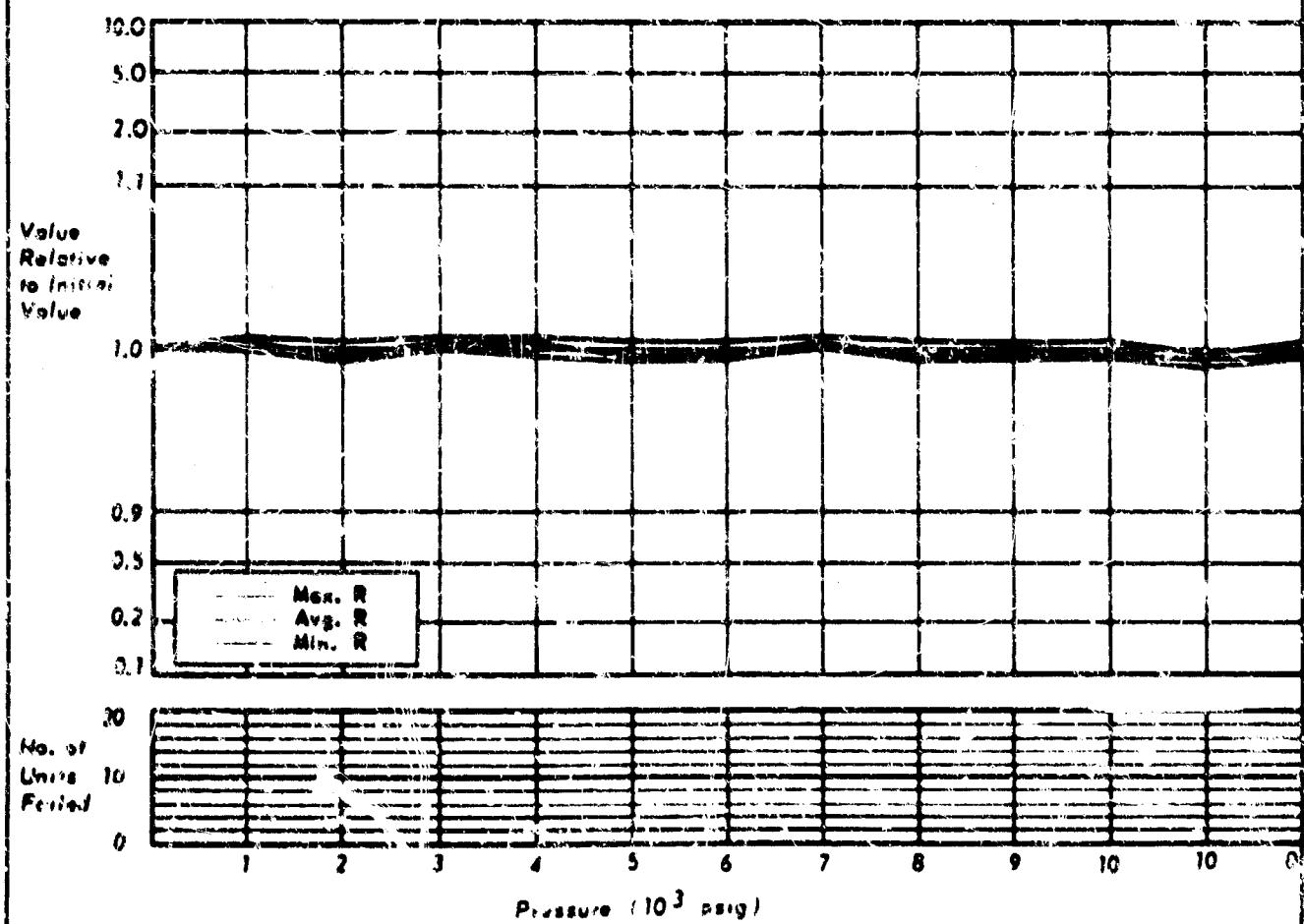
MFG. - CORNING
TYPE - RESISTOR
DESCRIPTION - RA-88

CHART NO. 111
NO. OF SAMPLES TESTED - 21



MFG. - DALE ELECTRONICS
TYPE - RESISTOR
DESCRIPTION - T-8MPC

CHART NO. 112
NO. OF SAMPLES TESTED - 29



Corning	See Note	Metal film, epoxy coat
NA-55	0.125 W	Tubular, axial lead
Resistor		0.62 x 0.167" diam.

NOTE: Three components of each the seven resistance values listed below were submitted. All were NA-55 type and were therefore tested as a set of twenty one.

51 B 100 Ω 10 K Ω 130 K Ω

75 Ω 150 Ω 100 K Ω

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Dale	See Note	Metal film, epoxy coat
T-2 MPS-H	0.5 W	Tubular, axial lead
Resistor		0.70 x 0.25" diam

NOTE: Twenty components of three different resistance values were submitted. All were T-2 MPS-H type and were therefore tested as a set. The values and quantity of each value are listed below.

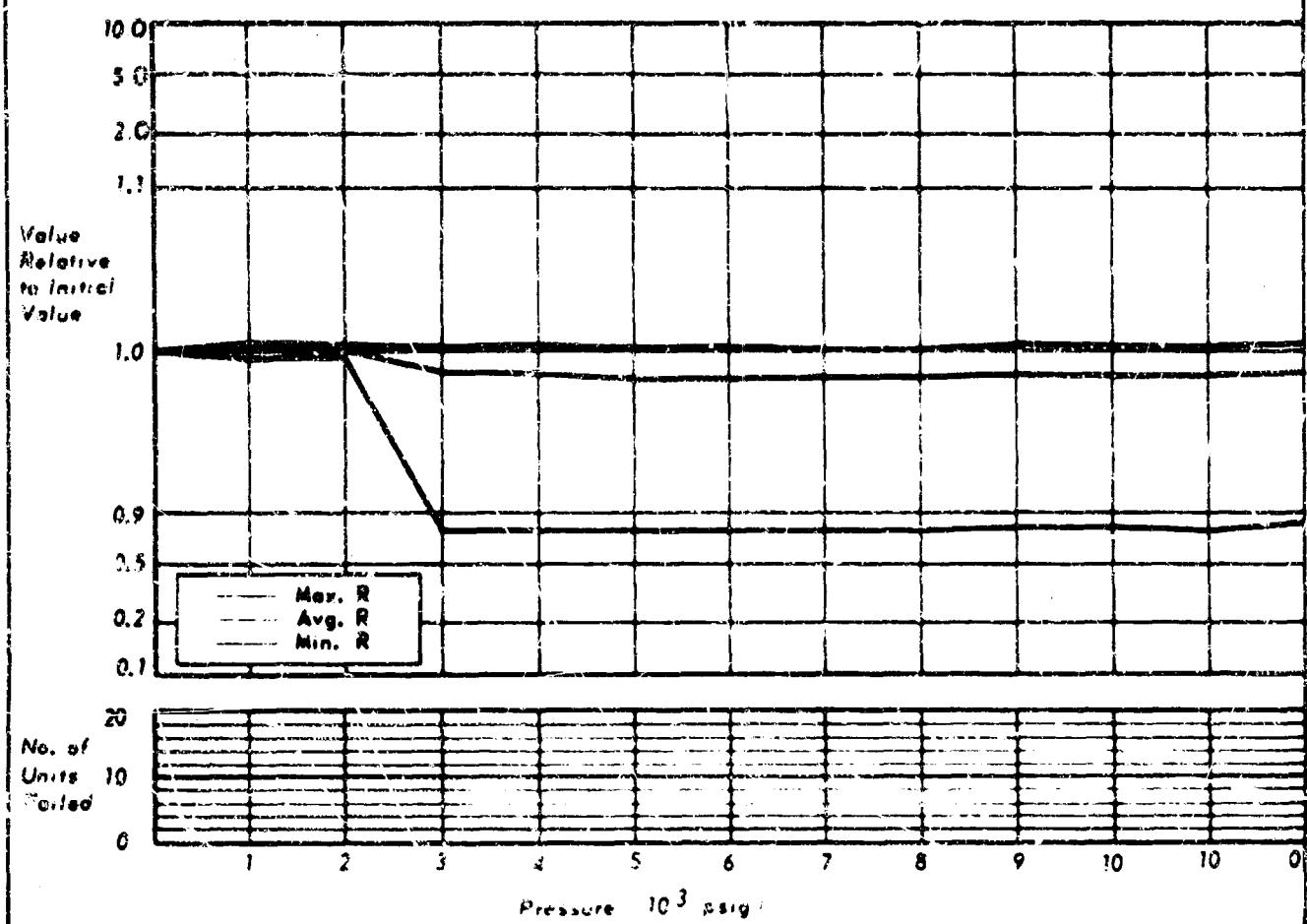
Value	Quantity
100 Ω	5
250 K Ω	10
1 M Ω	5

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

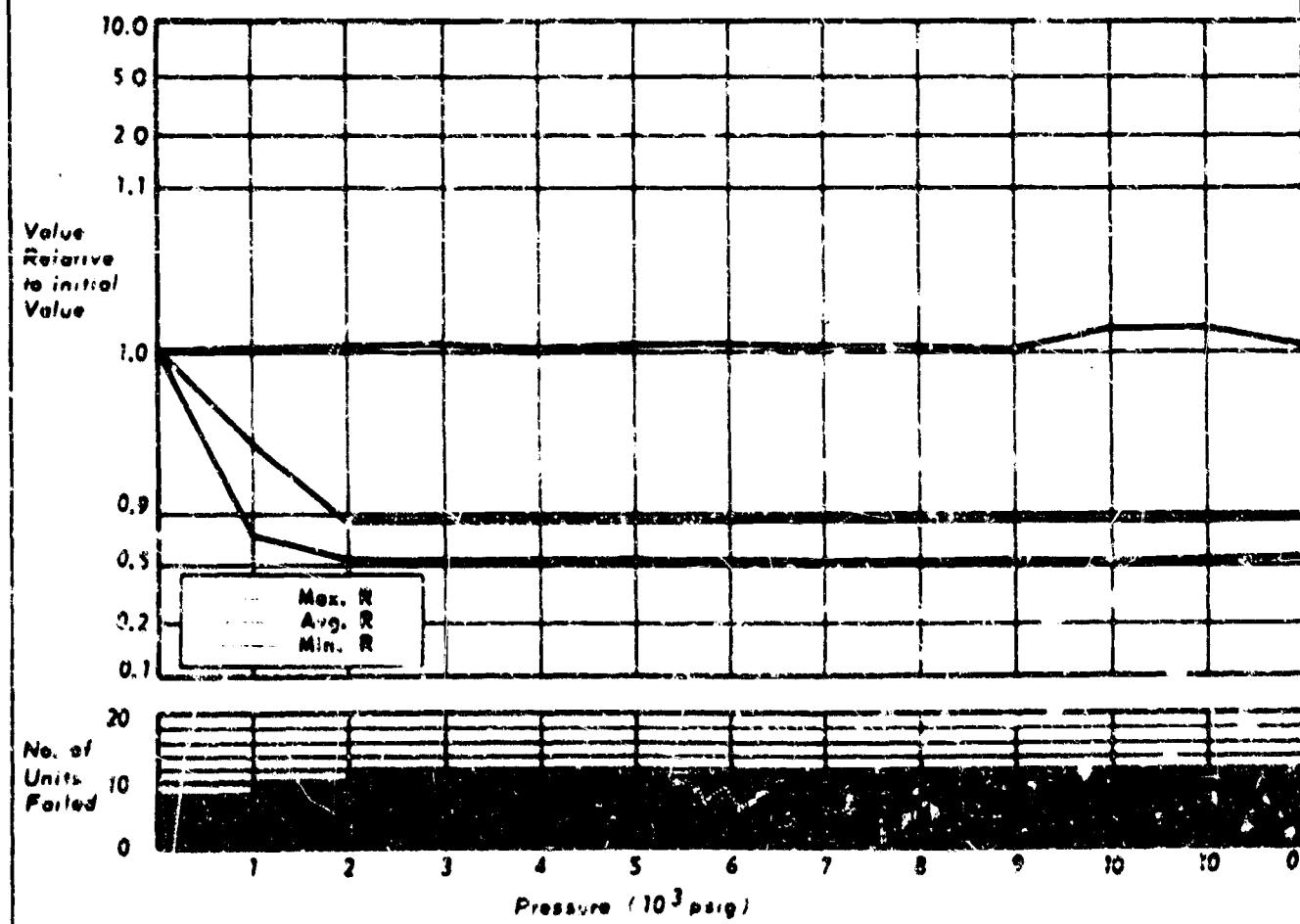
MFG.-GENERAL INSTRUMENT
TYPE-RESISTOR
DESCRIPTION-SIR-1C

CHART NO. 113
NO. OF SAMPLES TESTED-20



MFG.-GENERAL INSTRUMENT
TYPE-RESISTOR
DESCRIPTION-SIR-3

CHART NO. 114
NO. OF SAMPLES TESTED-20



General Instruments

$20\text{ K} \pm 0.02\%$

Wire wound

R10

0.5 W

Sealed, metal cap

Resistor

Tubular, axial lead

$0.45 \times 0.28\text{''}$ diam.

SOAK PERIOD: 16 hours at 9,000 psig.

MECHANICAL: Visual inspection after completion of test showed the metal caps of two components were deformed and the end seal of one component cracked and separated from the case. All damaged units functioned normally through the entire test program.

ELECTRICAL: Nineteen components indicated less than 10% change. One component indicated less than 50% and greater than 10% change.



General Instruments

$5\text{ K}\Omega \pm 0.05\%$

Wire wound

RS

0.5 W

Sealed, metal cap

Resistor

Pill box, parallel lead

$0.30 \times 0.34\text{''}$ diam.

SOAK PERIOD: 16 hours at 9,000 psig.

MECHANICAL: Visual inspection after completion of test showed the top of all metal caps were deformed.

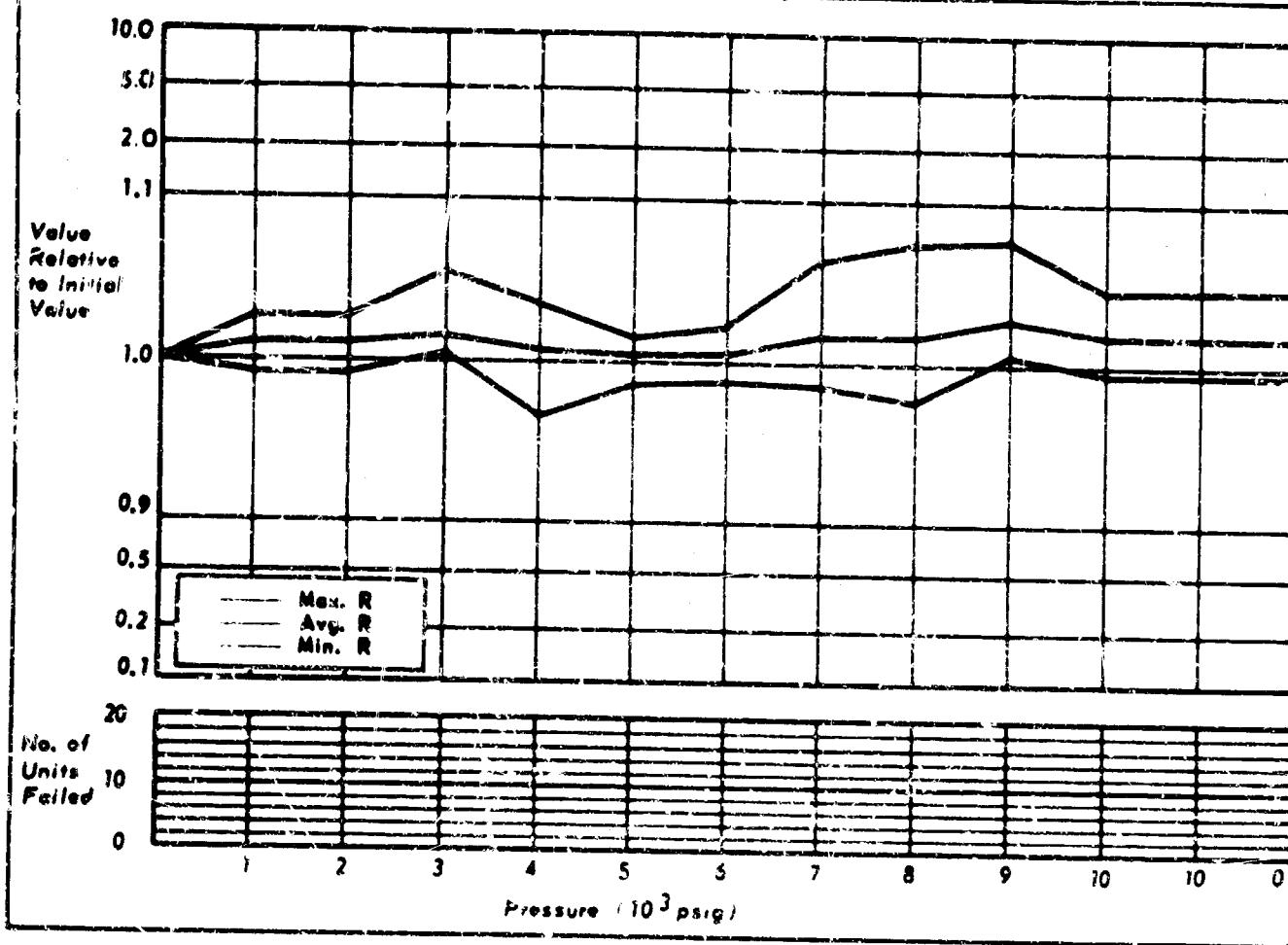
ELECTRICAL: Four components varied less than 5% and two varied more than 30% and less than 50%.

FAILURES: Thirteen components indicated a change greater than 50%.



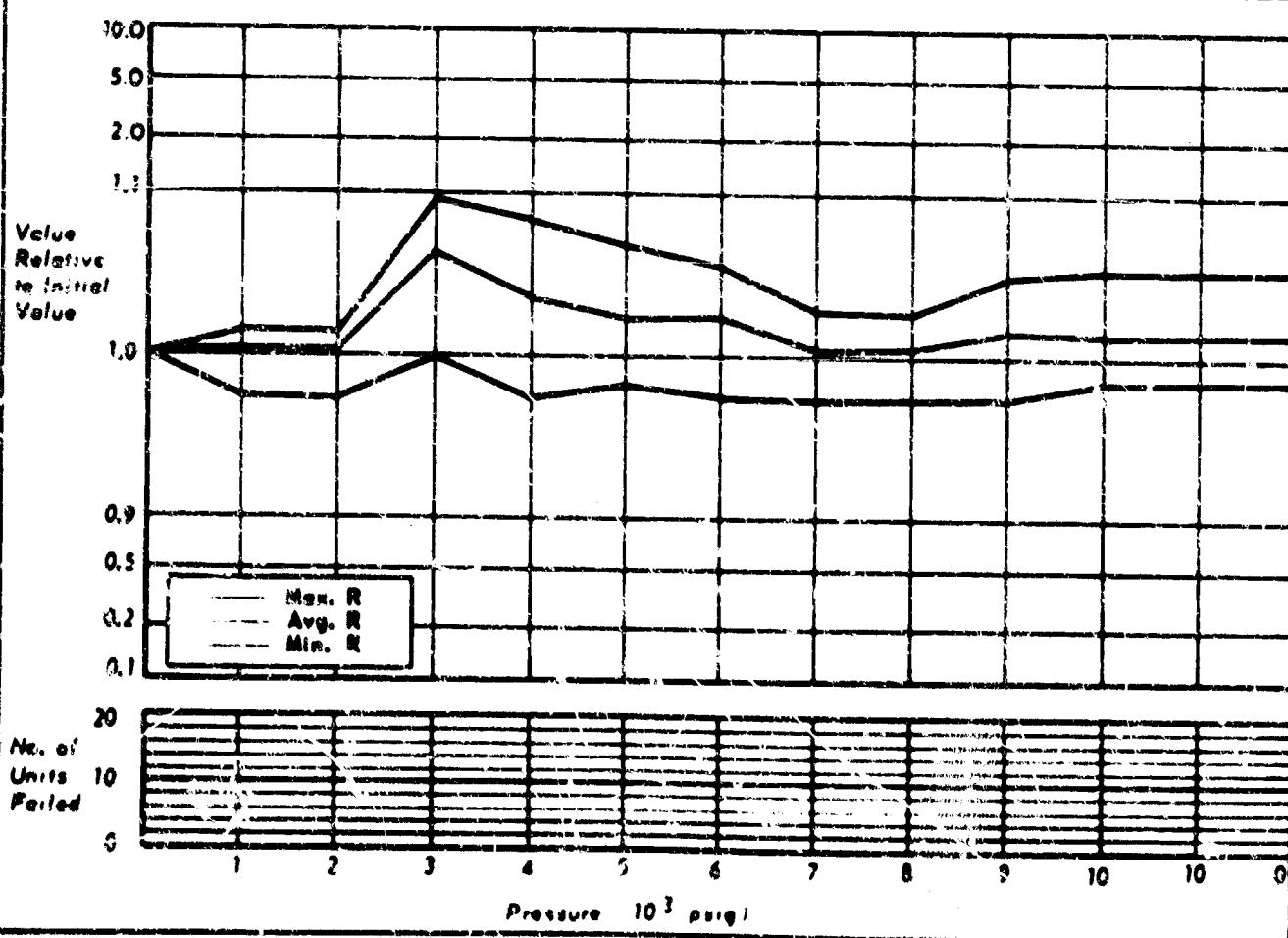
MFG.-ONNITE
TYPE - RESISTOR
DESCRIPTION - 884-1A

CHART NO. 115
NO. OF SAMPLES TESTED - 19



MFG.-ONNITE
TYPE - RESISTOR
DESCRIPTION - 884-B

CHART NO. 116
NO. OF SAMPLES TESTED - 20



Chmite
884-1A
Resistor
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

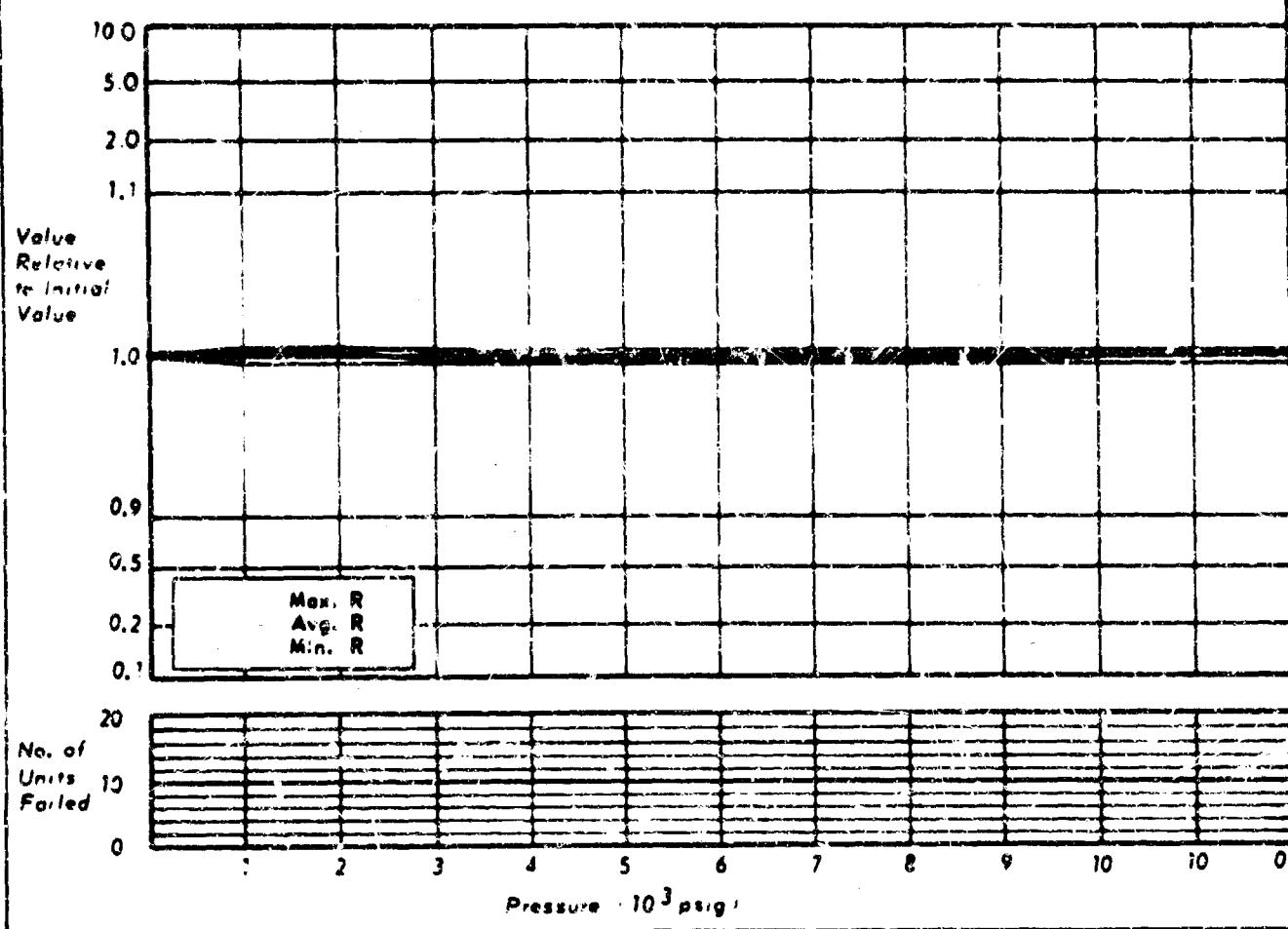
$4 \Omega \pm 5\%$
1.5 W
Wire wound, silicon mold
Tubular, axial lead
 $0.406 \times 0.125''$ diam.

Chmite
88-5
Resistor
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

$5 \Omega \pm 5\%$
5 W
Wire wound, silicon mold
Tubular, axial lead
 $0.875 \times 0.34''$ diam.

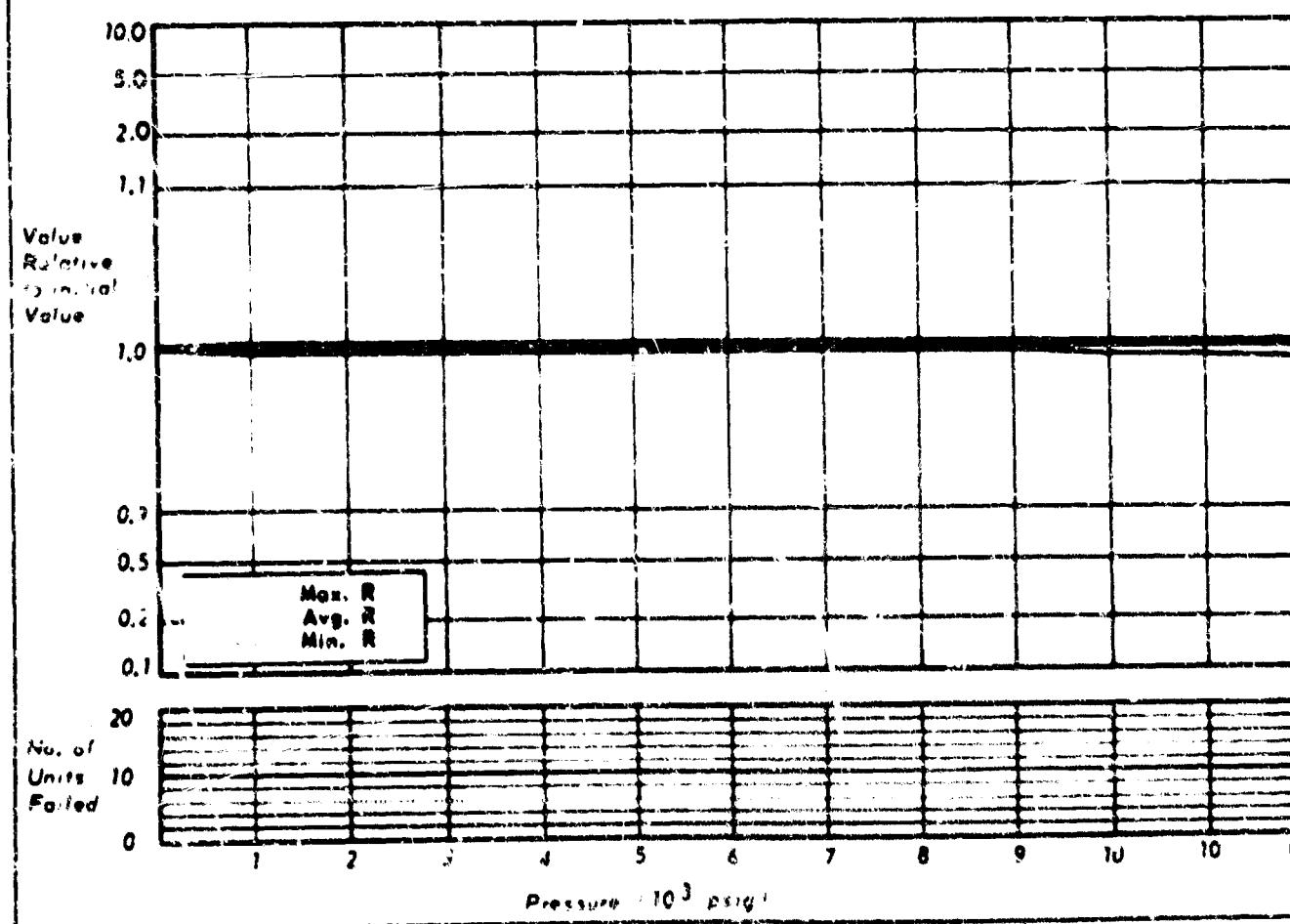
MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 881-II

CHART NO. 117
NO. OF SAMPLES TESTED - 19



MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 882-IIA

CHART NO. 118
NO. OF SAMPLES TESTED - 19



Ohmite
881-11
Resistor
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

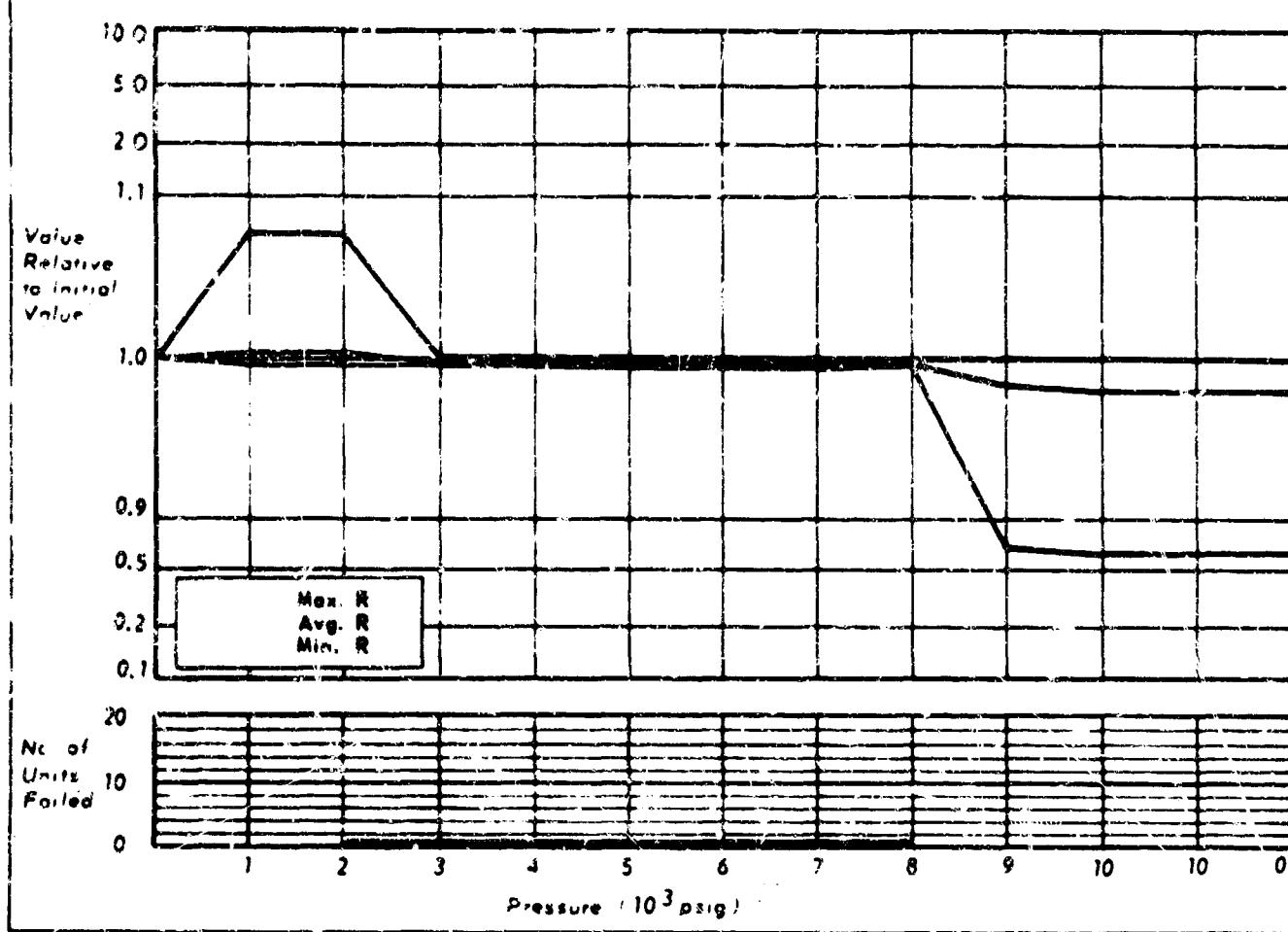
14 Ω \pm 3%
11W
Wire wound, silicon mold
Tubular, axial lead
1.312 x 0.625" diam.

Ohmite
882-1A
Resistor
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

2.5 K Ω \pm 3%
1 W
Wire wound, silicon mold
Tubular, axial lead
0.496 x 0.125" diam.

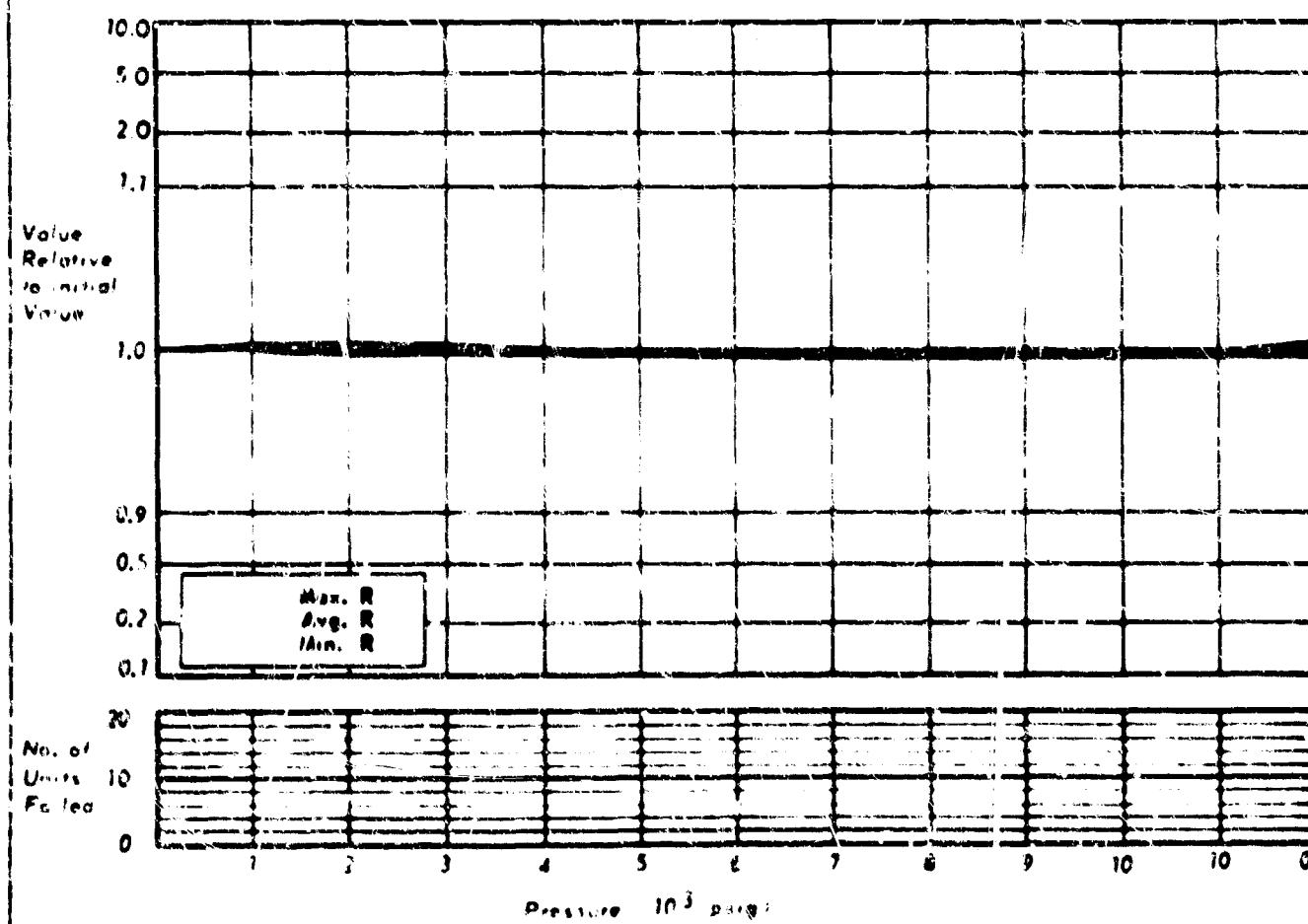
MFG. - CHMITE
TYPE - RESISTOR
DESCRIPTION - 884-8

CHART NO. 119
NO. OF SAMPLES TESTED - 20



MFG. - CHMITE
TYPE - RESISTOR
DESCRIPTION - 884-10

CHART NO. 120
NO. OF SAMPLES TESTED - 20



Ohmite 51.1 K Ω \pm 1% Wire wound, silicon mold
884-5 5 W Tubular, axial lead
Resistor 0.875 x 0.34" diam.

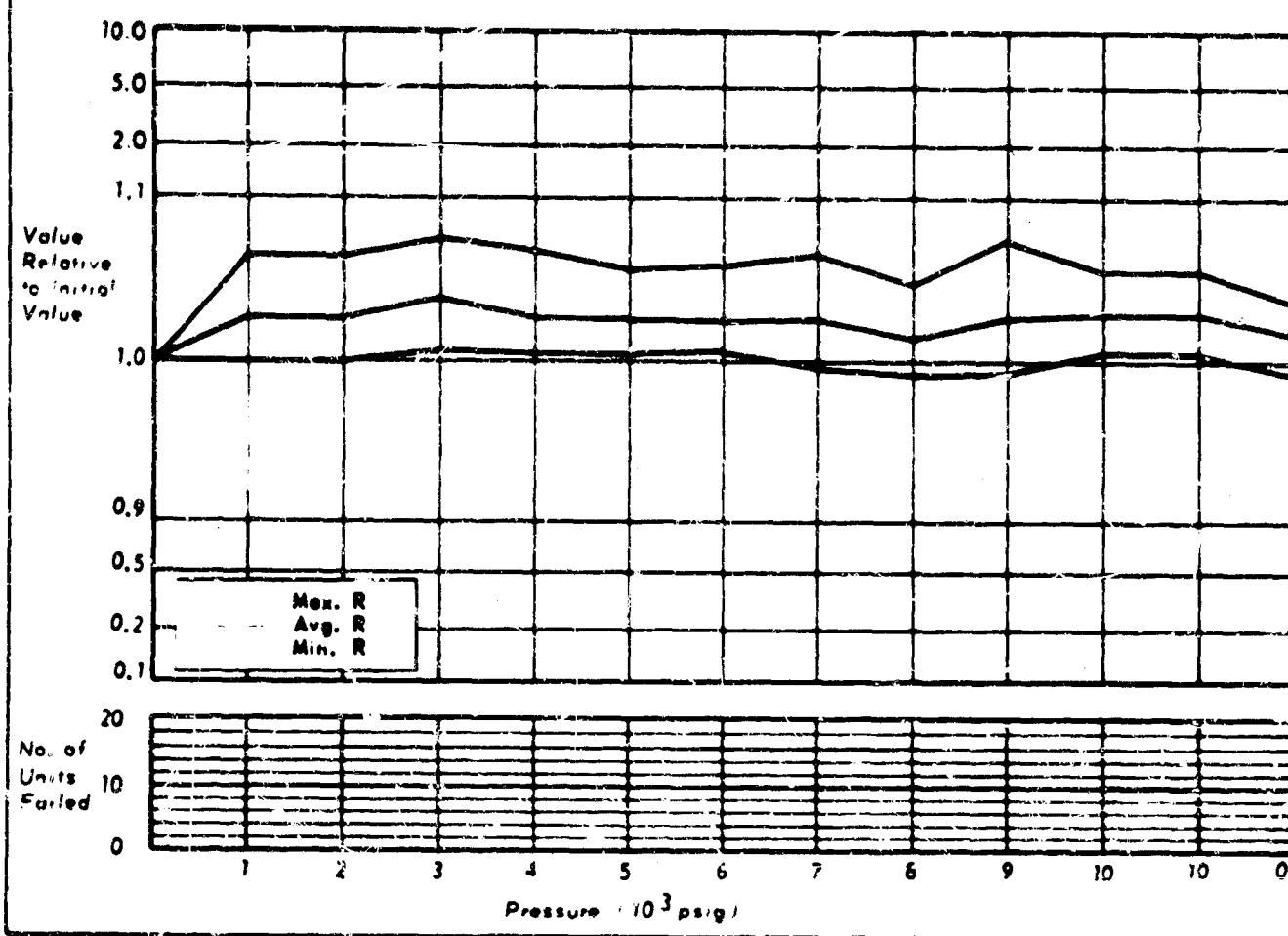
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: Minetsan components indicated less than 10% change.
FAILURES: One component indicated a change greater than 50% with subsequent recovery to less than 50% at the pressures shown on the failure graph on facing page.

Ohmite 84.5 K Ω \pm 1% Wire wound, silicon mold
884-10 5 W Tubular, axial lead
Resistor 1.312 x 0.625" diam.

SOAK PERIOD: 15.5 hours at 10,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: Twenty components indicated less than 10% change.

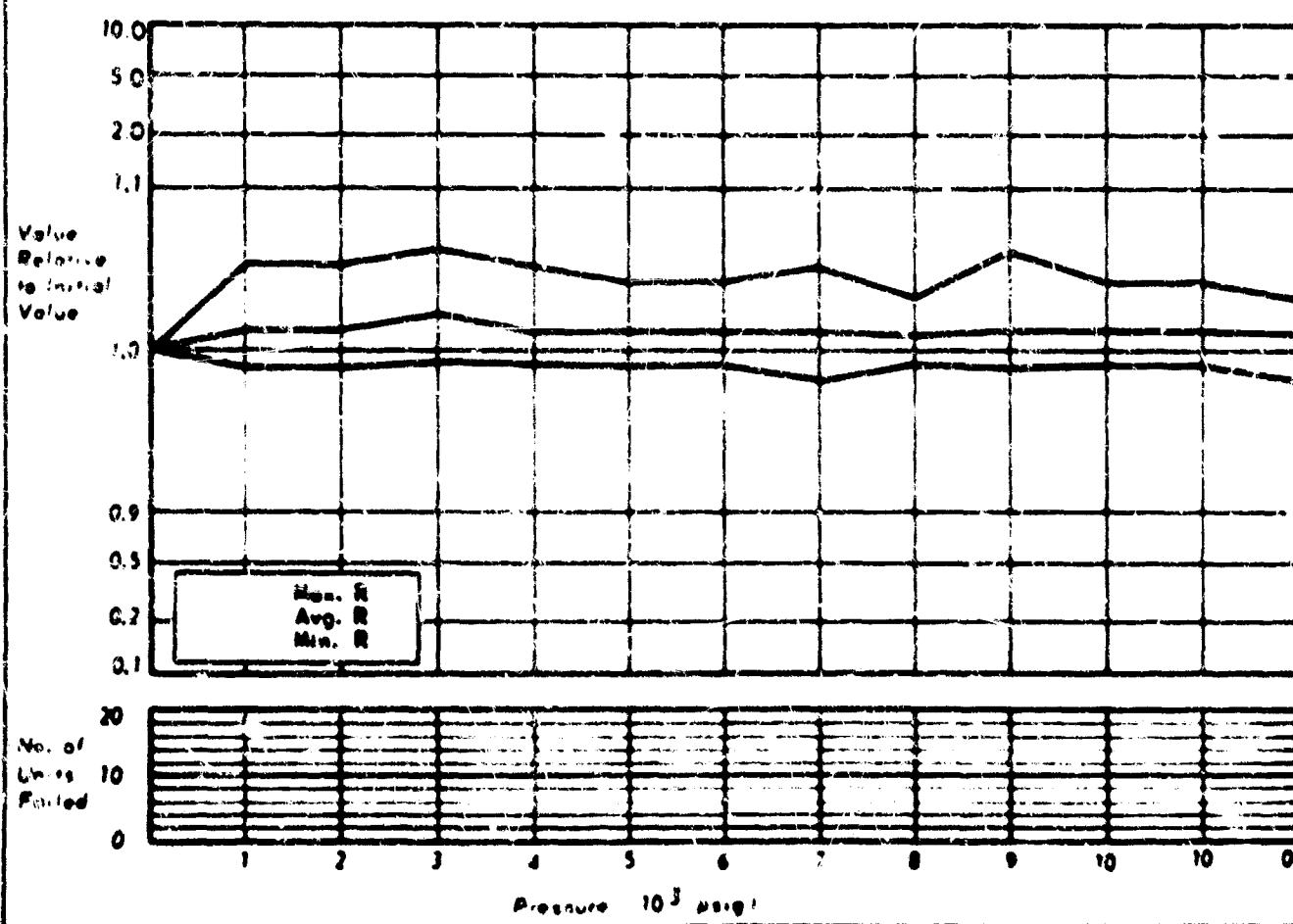
MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 888-10A

CHART NO. 121
NO. OF SAMPLES TESTED - 20



MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 888-10A

CHART NO. 122
NO. OF SAMPLES TESTED - 19

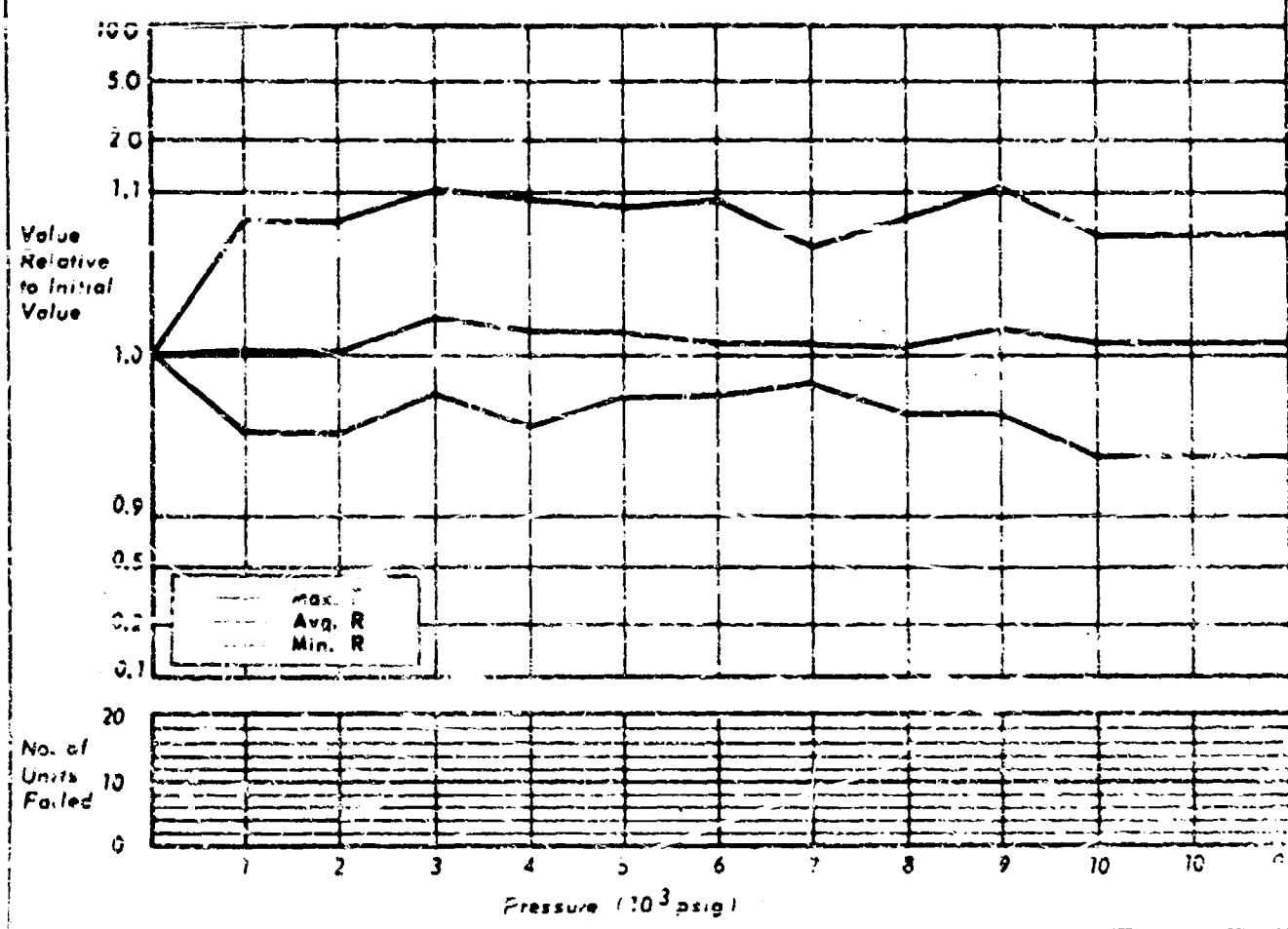


Chmite 5 $\Omega \pm 5\%$ Wire wound, vitreous mold
995-50 5W Tubular, axial lead
Resistor 0.875 x 0.218" diam.
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

Chmite 5 $\Omega \pm 5\%$ Wire wound, vitreous mold
995-10A 10W Tubular, axial lead
Resistor 1.25 x 0.312" diam.
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

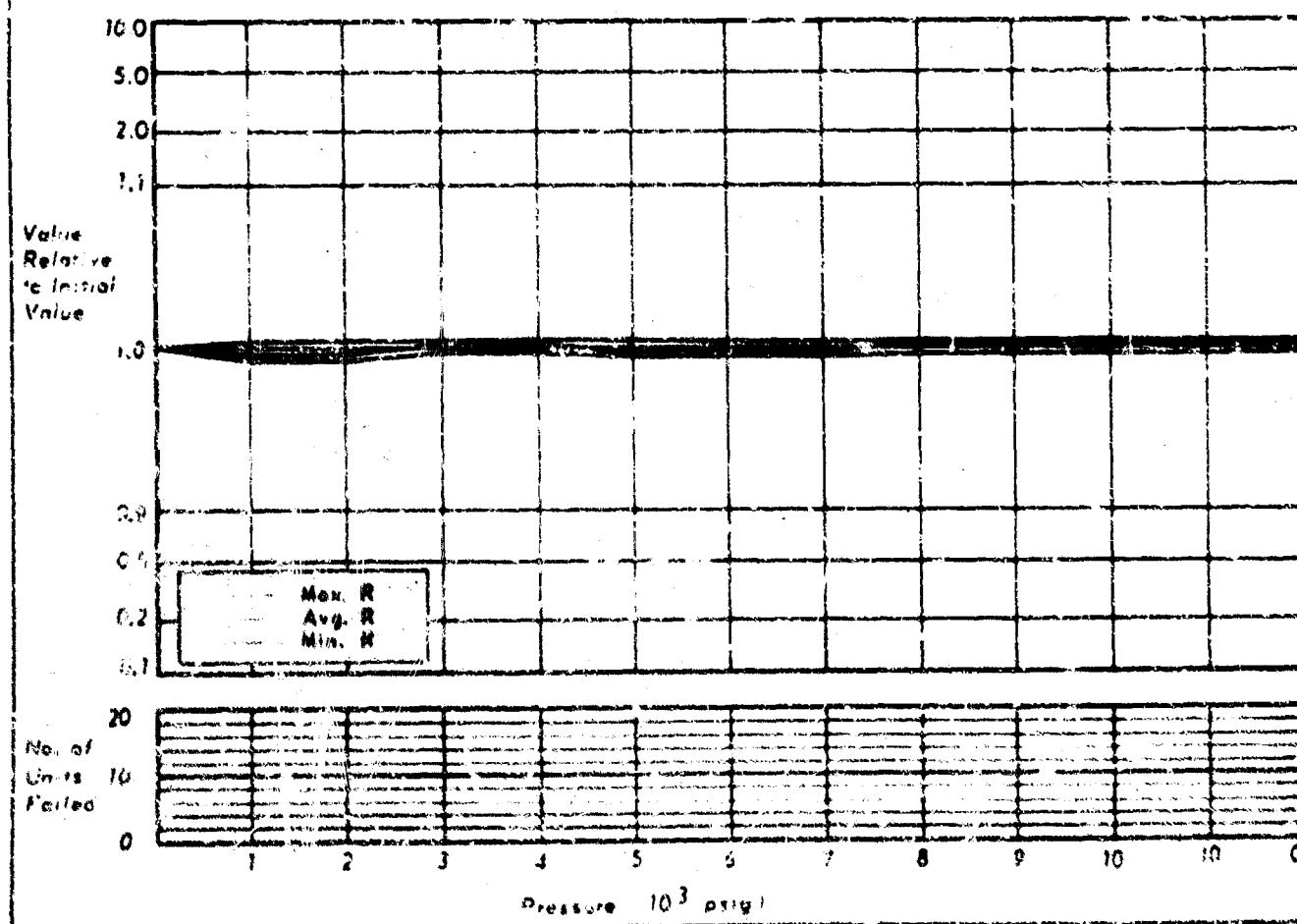
MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 635-1A 50Ω

CHART NO. 123
NO. OF SAMPLES TESTED - 20



MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 635-1A 5000Ω

CHART NO. 124
NO. OF SAMPLES TESTED - 20

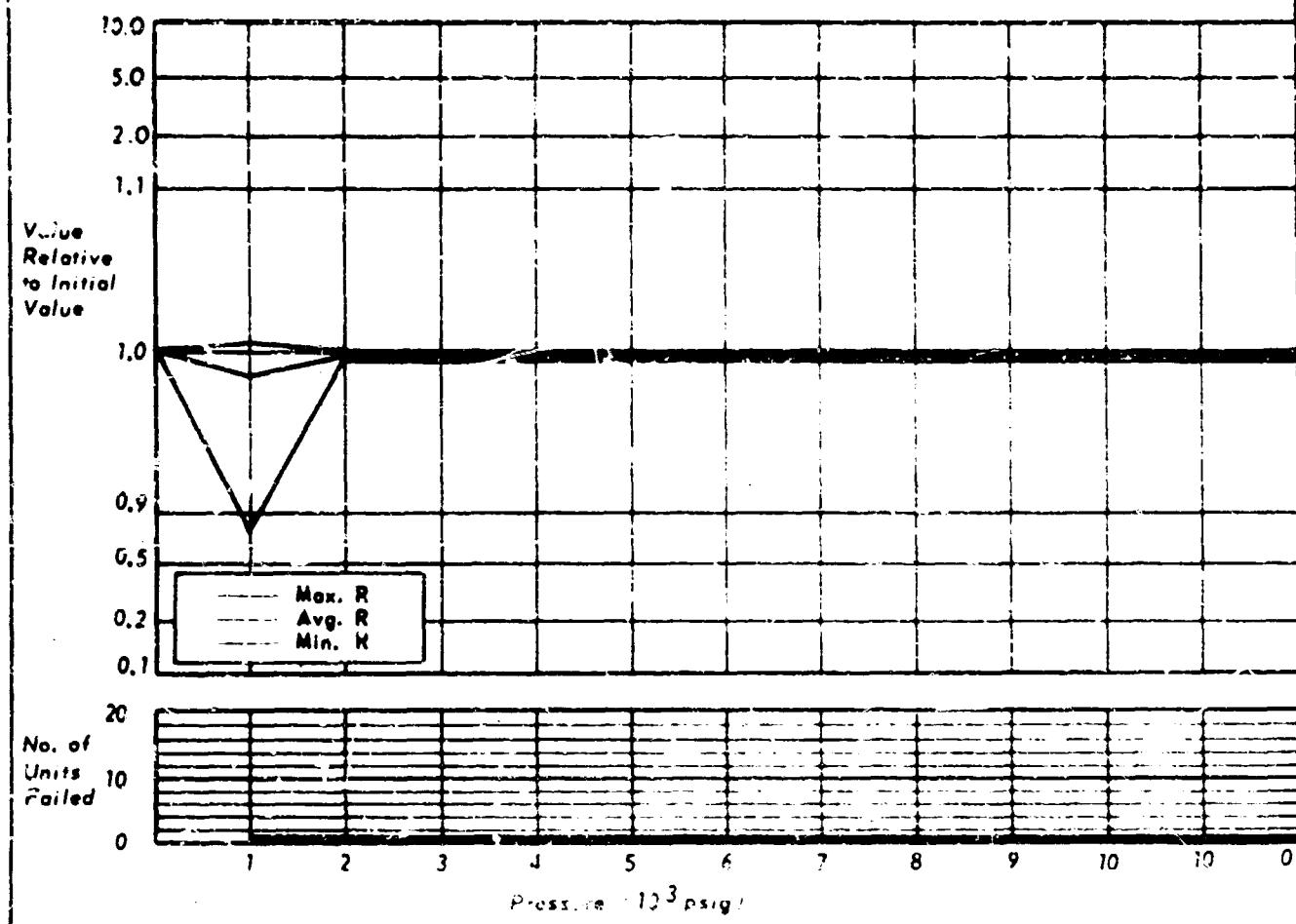


Ohmite 5Ω ± 5% Wire wound, vitreous mold
995-1A 1.5 W Tubular, exalt lead
Resistor 0.406 x 0.125" diam.
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

Ohmite 3.0 XΩ ± 5% Wire wound, vitreous mold
995-1A 1.5 W Tubular, exalt lead
Resistor 0.406 x 0.125" diam.
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

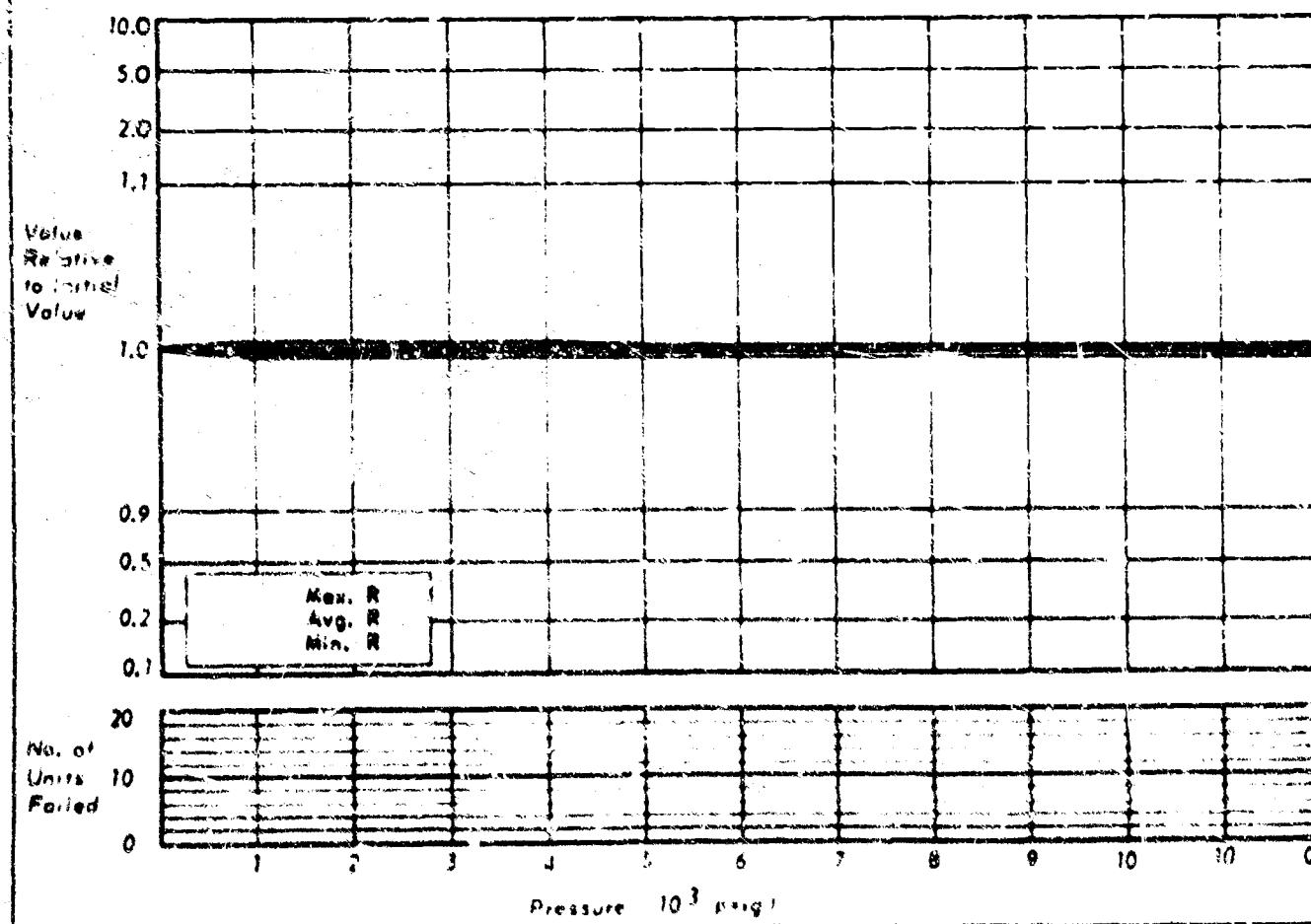
MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 988-98

CHART NO. 125
NO. OF SAMPLES TESTED - 20



MFG. - OHMITE
TYPE - RESISTOR
DESCRIPTION - 988-10A

CHART NO. 126
NO. OF SAMPLES TESTED - 20

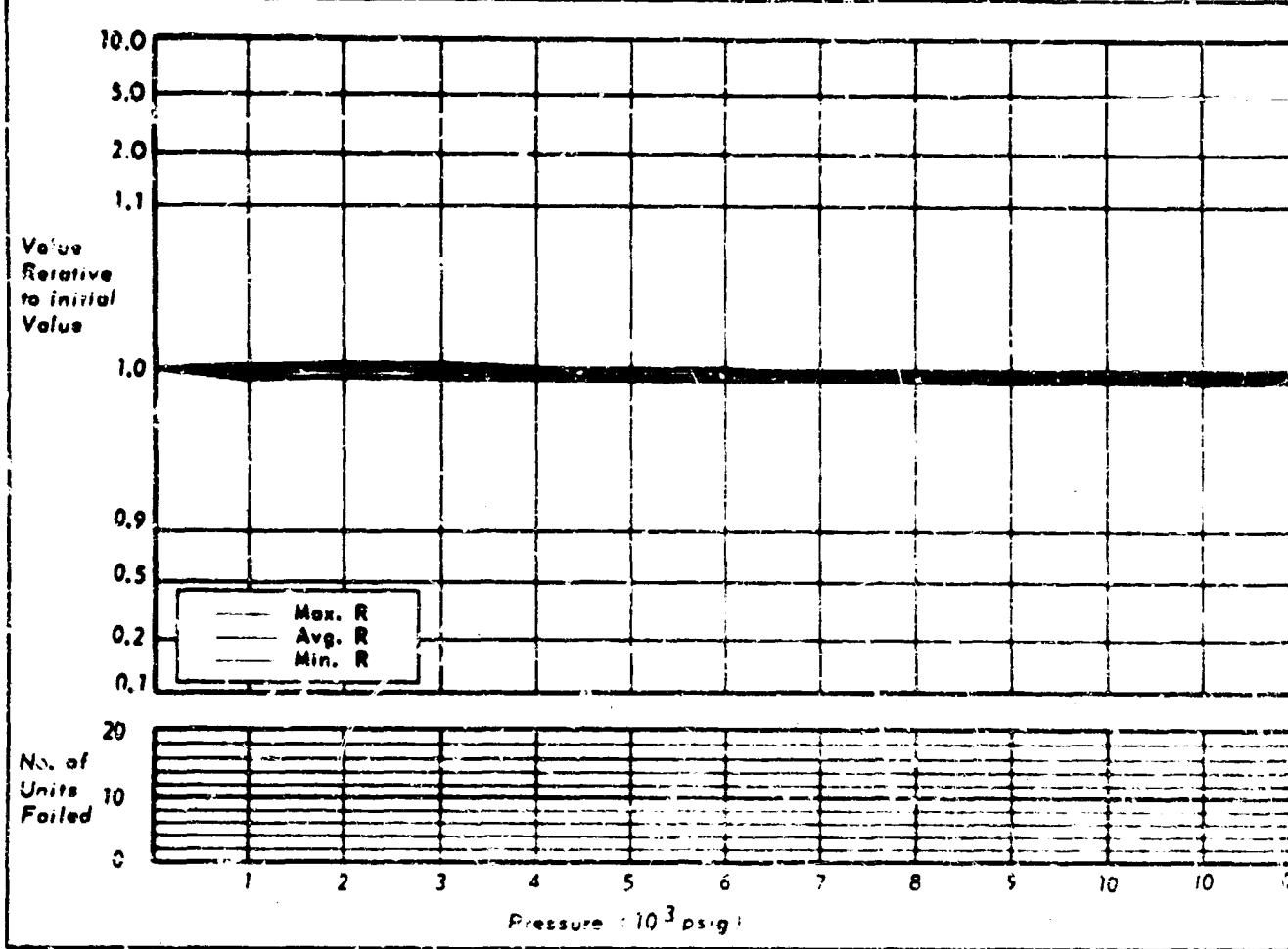


Ohmite 20.0 K Ω \pm 5% Wire wound, vitreous
995-5B 5W Tubular, axial lead
Resistor 0.375 x 0.218" diam.
SOAK PERIOD: 16 hours at 10,000 psig.
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

Ohmite 20.0 K Ω \pm 5% Wire wound, vitreous
995-10A 10W Tubular, axial lead
Resistor 1.23 x 0.312" diam.
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated less than 10% change.

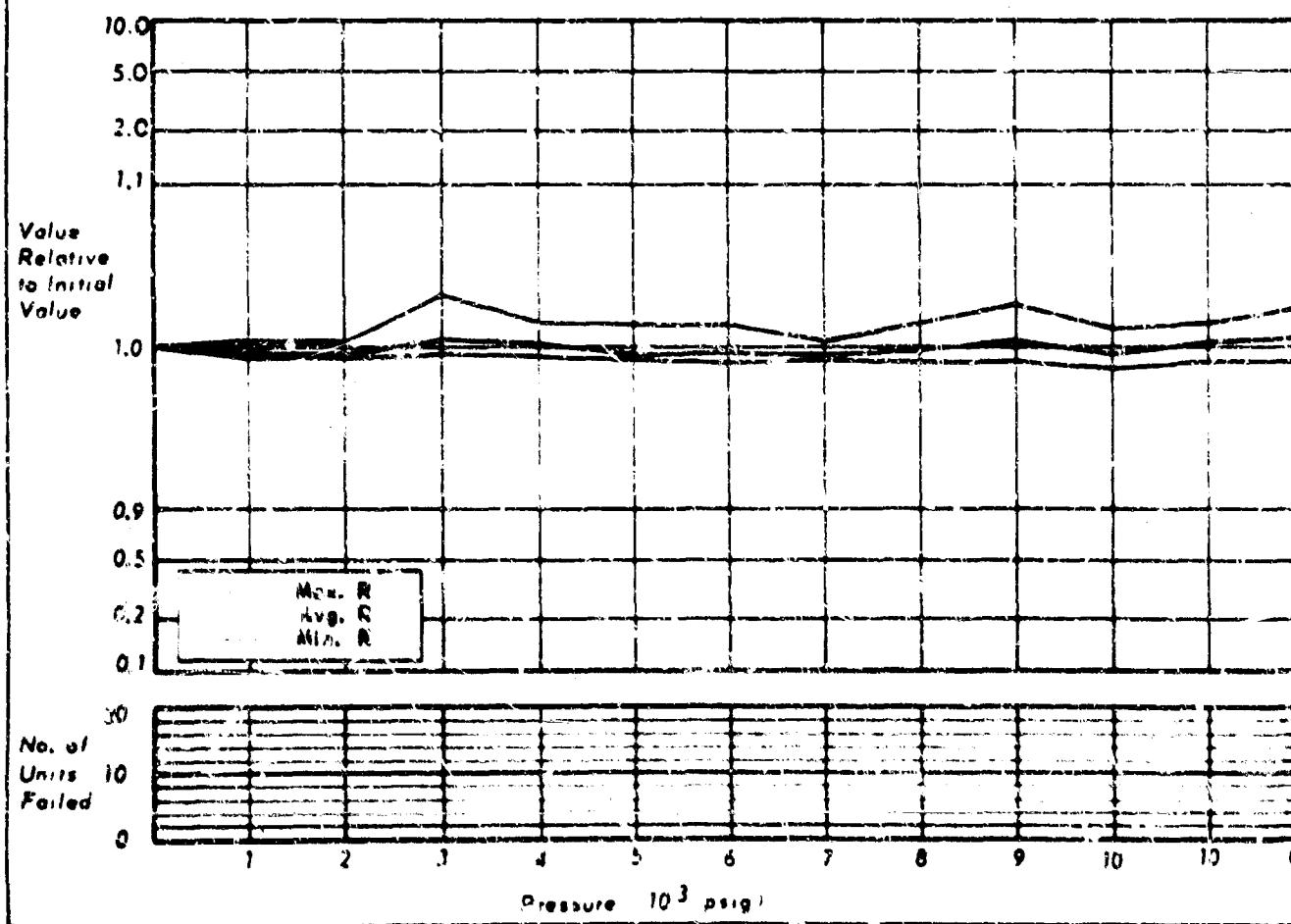
MFG. - TEXAS INSTRUMENT
TYPE - RESISTOR
DESCRIPTION - MM80

CHART NO. 127
NO. OF SAMPLES TESTED - 20



MFG. - TEXAS INSTRUMENT
TYPE - RESISTOR
DESCRIPTION - CR 1/4 102

CHART NO. 128
NO. OF SAMPLES TESTED - 10



Texas Instruments	100 & 100 K Ω \pm 1%	Metal film, molded
MM40	0.125 W	Tubular, axial lead
Resistor		0.4 x 0.135" diam

NOTE: Ten components of each of the two resistance values shown were submitted and tested as a set of twenty.

SOAK PERIOD: 15.5 hours at 10,000 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

Texas Instruments	100 Ω	Carbon film, epoxy encap
CR 1/4	0.15 W	Tubular, axial lead
Resistor		0.375 x 0.103" diam.

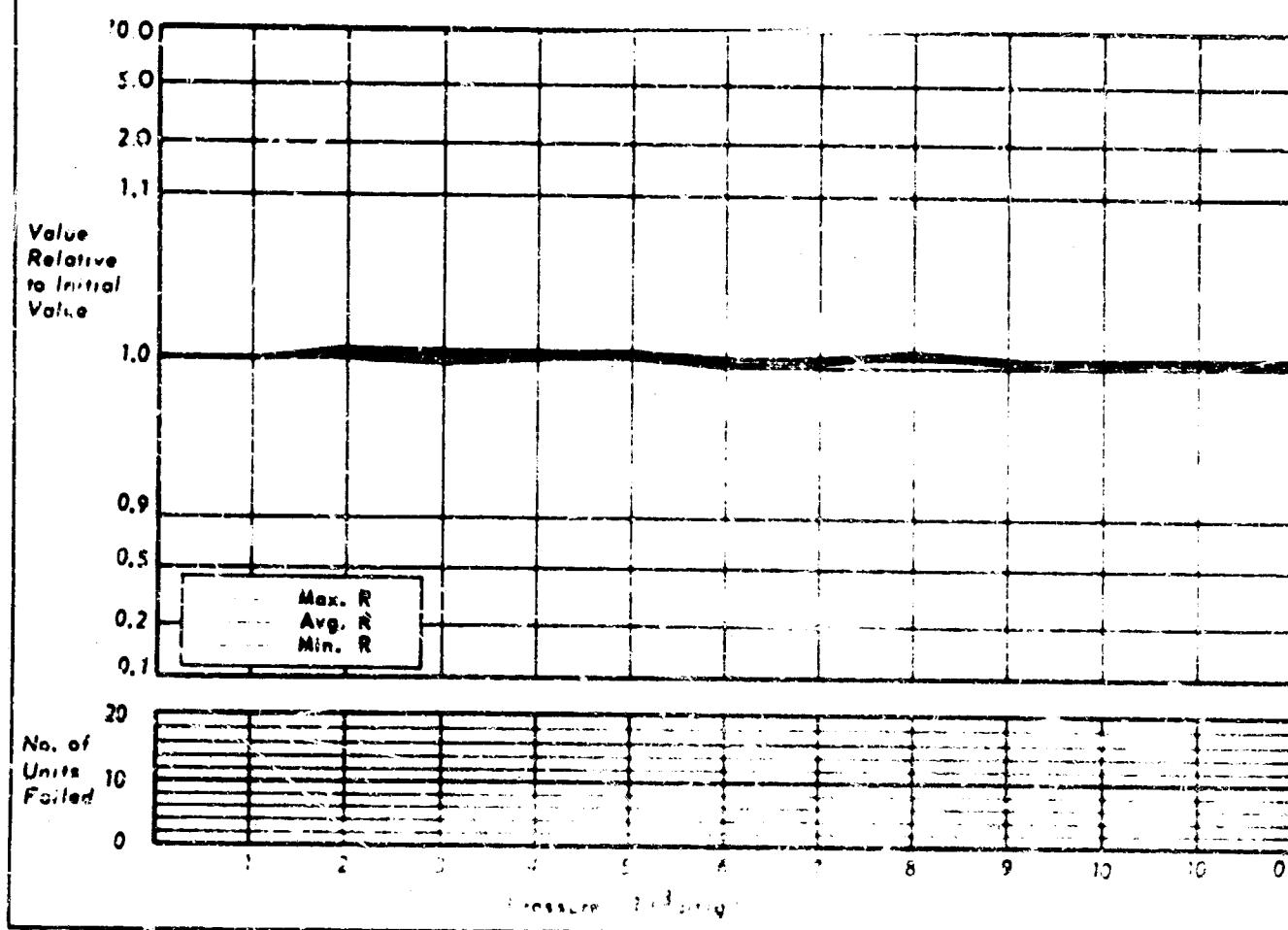
SOAK PERIOD: 15.5 hours at 10,00 psig.

MECHANICAL: No apparent damage.

ELECTRICAL: All components indicated less than 10% change.

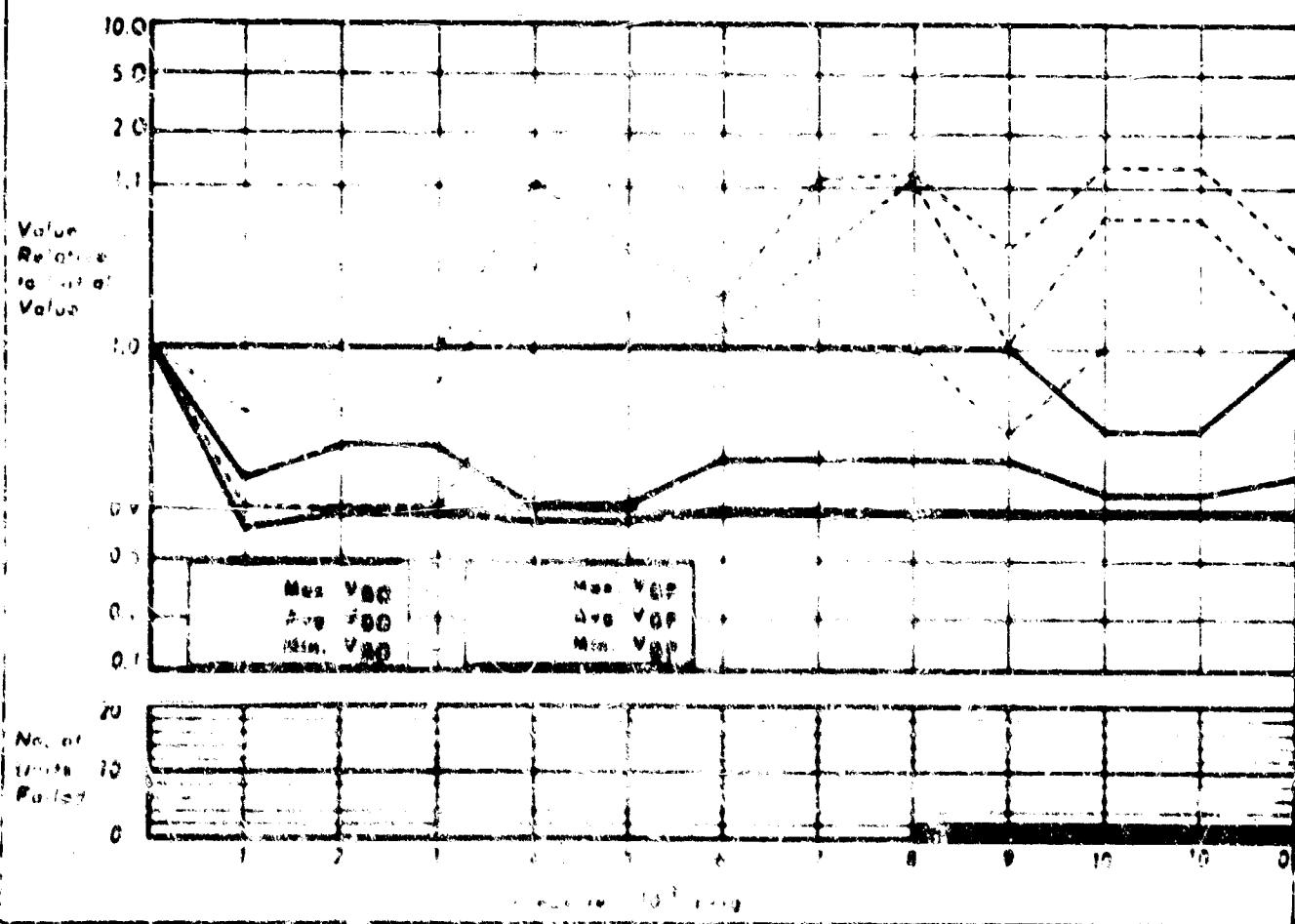
MFG. - TEPAS INSTRUMENT
TYPE - RESISTOR
DESCRIPTION - CR 1/4

CHART NO. 120
NO. OF SAMPLES TESTED - 10



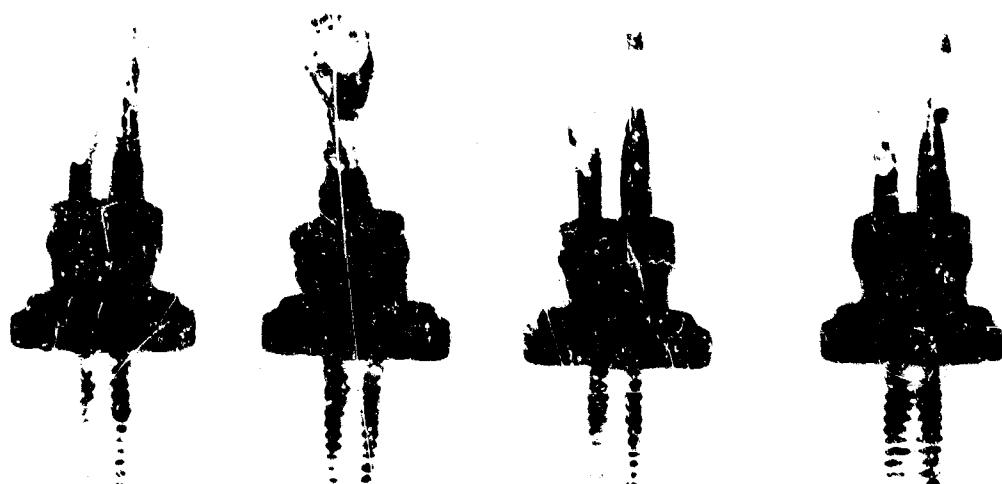
MFG. - MOTOROLA
TYPE - SILICON CONTROLLED RECTIFIER
DESCRIPTION - 2N602

CHART NO. 120
NO. OF SAMPLES TESTED - 15



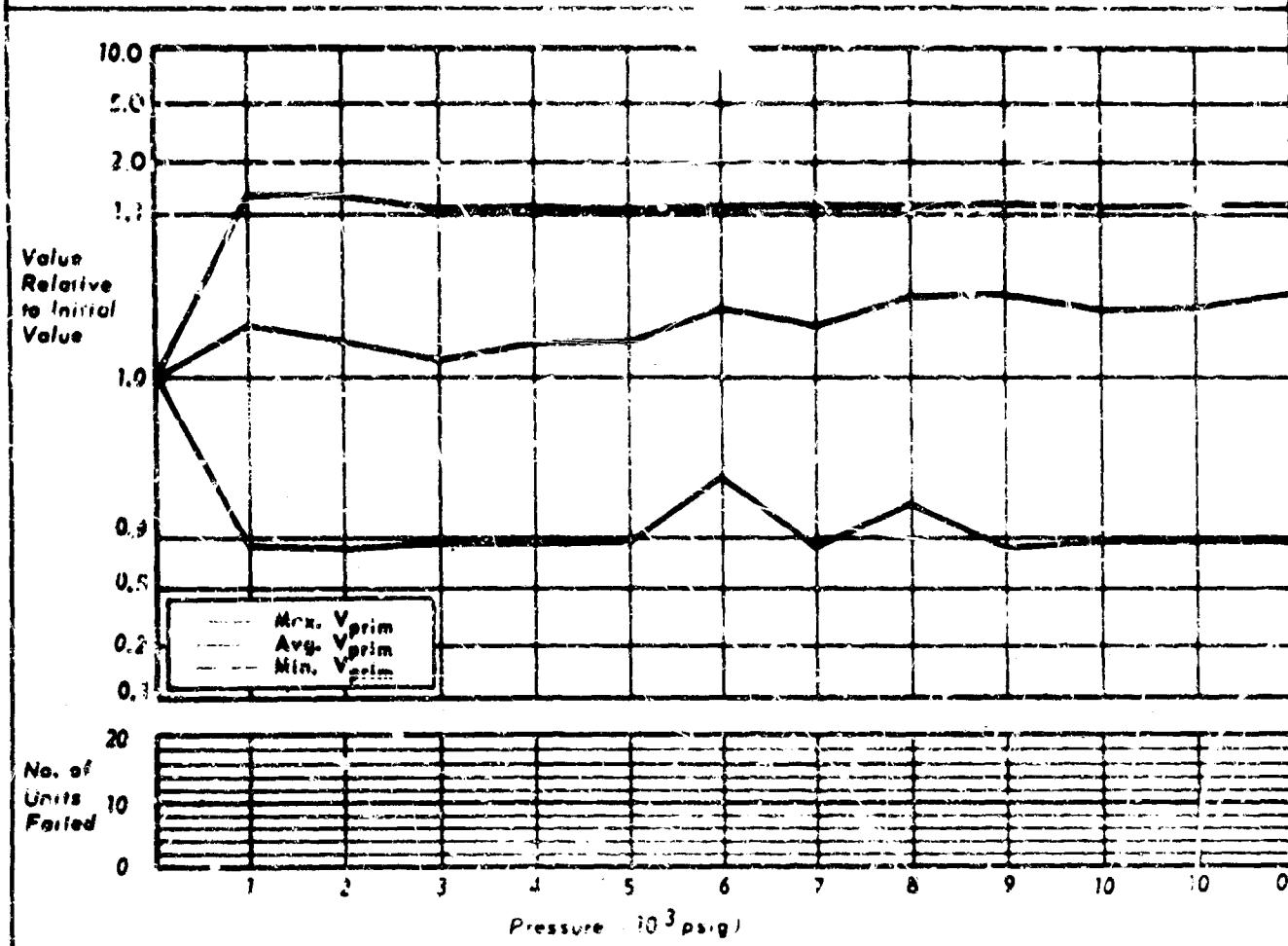
Texas Instruments	100 k Ω	Carbon film, epoxy encaps.
CR 1/4	0.25 W	Tubular, axial lead
Resistor		0.375 x 0.105" diam.
SOAK PERIOD: 15.5 hours at 10,000 psig.		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated less than 10% change.		

Motorola	Si PRV	Silicon, diffused junction
2N682	25 A rms	Welded esp., stud mount
Silicon controlled rectifier		0.75 x 0.56" diam.
SOAK PERIOD: None		
MECHANICAL: Visual inspection after completion of testing showed deformed cases on three components.		
ELECTRICAL: Two components indicated less than 10% change. One component indicated greater than 10% and less than 25% change.		
FAILURES:	Two components failed above 0,001 psig.	



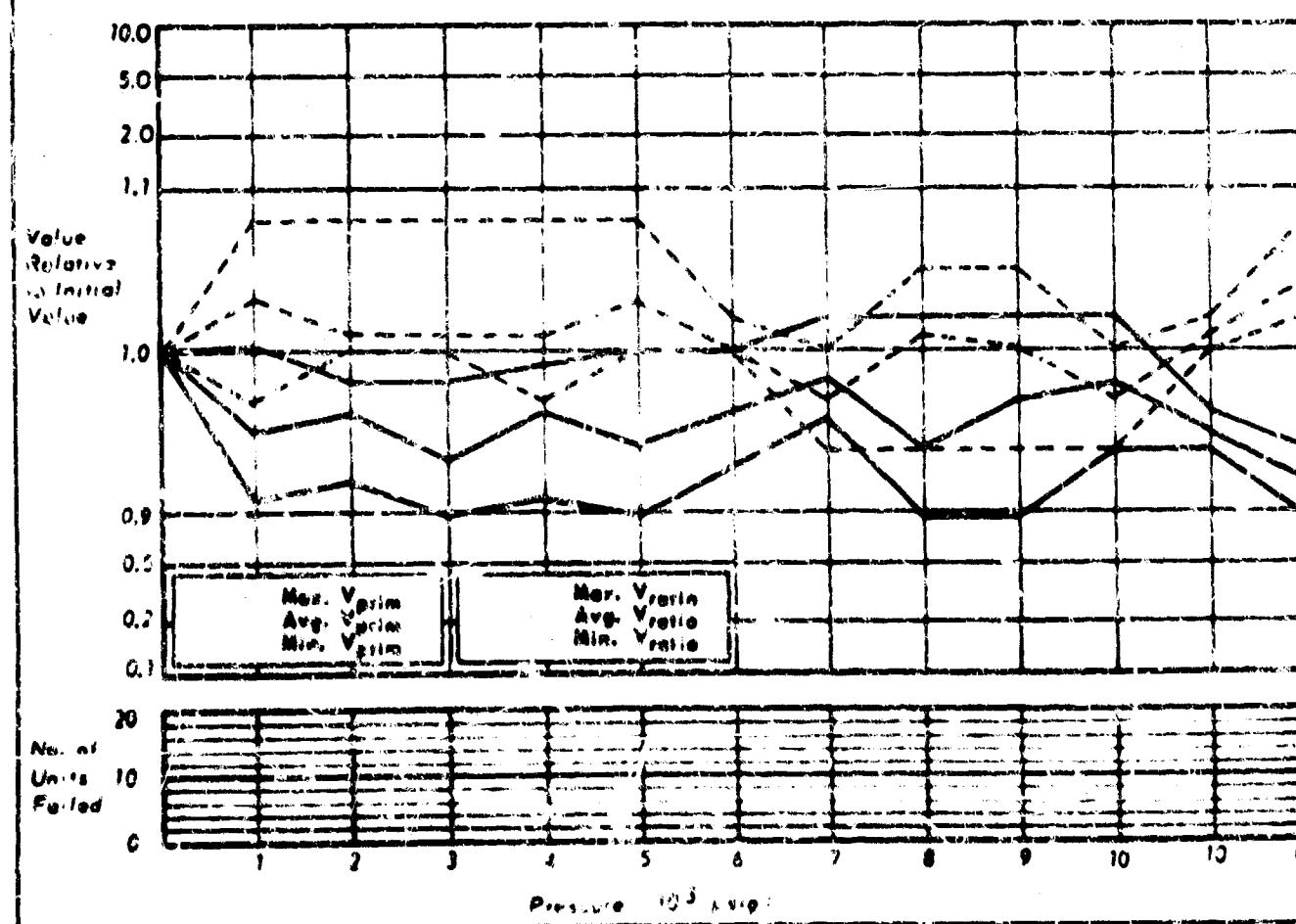
MFG. - GENERAL INSTRUMENTS
TYPE - TRANSFORMER
DESCRIPTION - C-8248758

CHART NO. 131
NO. OF SAMPLES TESTED - 20



MFG. - MICROTRAN
TYPE - TRANSFORMER
DESCRIPTION - M-9318

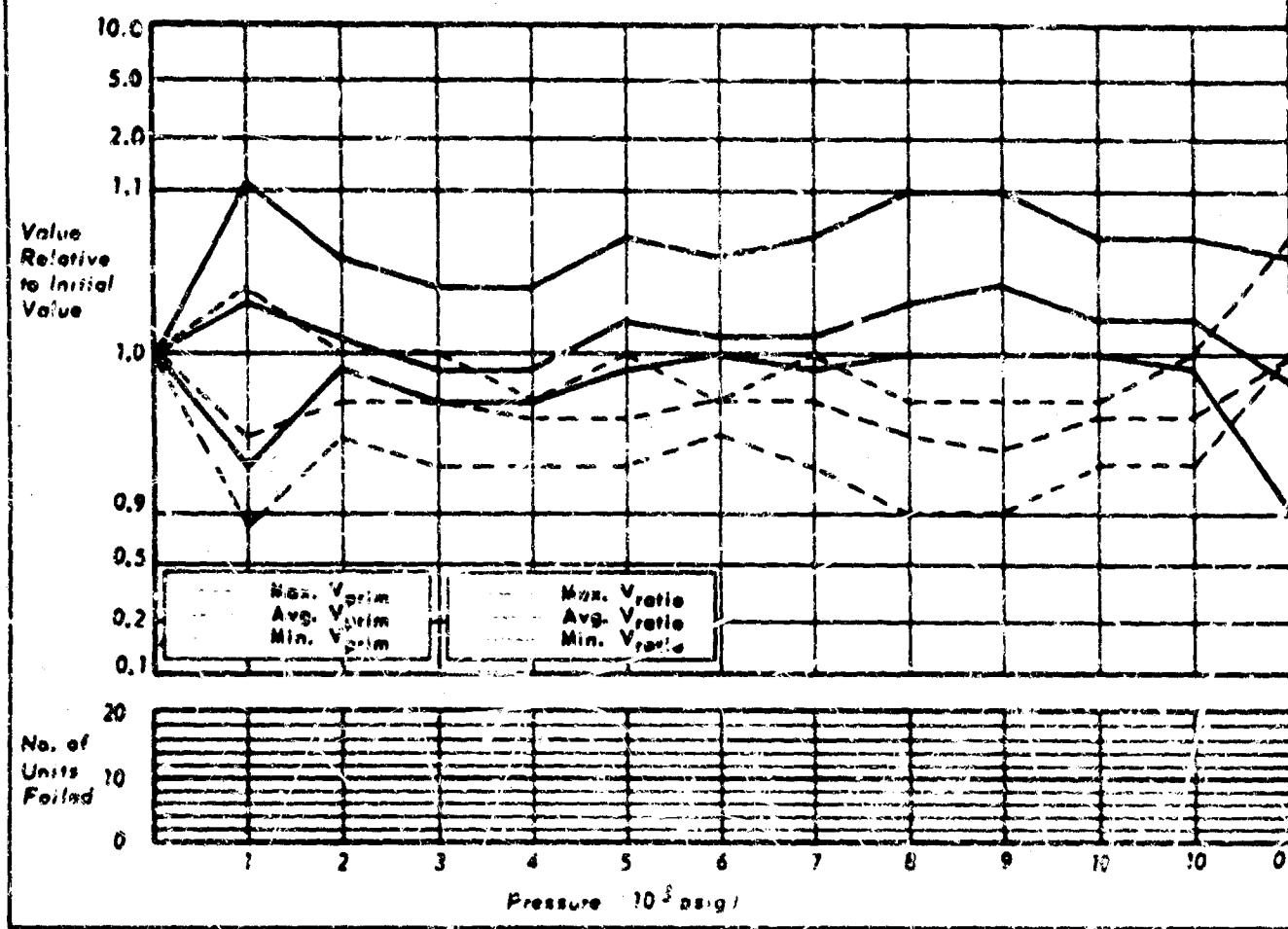
CHART NO. 132
NO. OF SAMPLES TESTED - 3



General Instruments	Prt. Induct. 500 μ H	Adj. tuning core
P. W. Sickles Div.	Sec. Induct. 500 μ H	Ceramic form
CS249726	at 20 Mc	
R. F. Transformer.		
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Ten components indicated less than 10% change.		
	Ten components indicated a change greater than 10% and less than 50%.	
Microtran	Prt. Imp. 10,000	Cast epoxy
MM3-M	Sec. Imp. 200	Plug in type
Transformer	Freq. resp. 150-10,000	0.875 x 0.781 x 0.531"
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Four components indicated a change greater than 10% and less than 50%.		
	One component indicated a change greater than 50% with subsequent recovery to less than 50% at the pressures shown on failure graph on opposite page.	

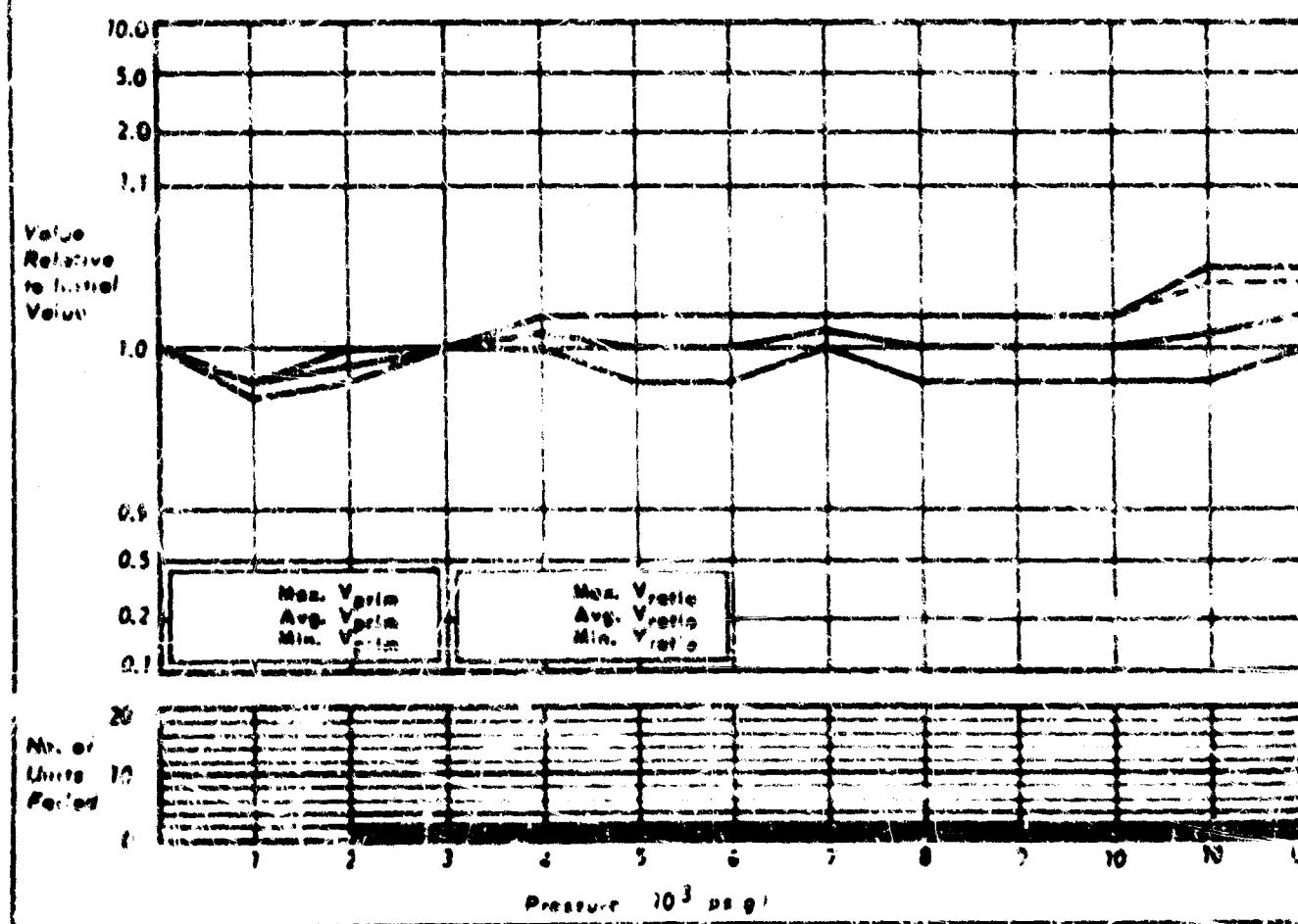
MFG. - MICROTRAN
TYPE - TRANSFORMER
DESCRIPTION - MM7-P8

CHART NO. 133
NO. OF SAMPLES TESTED - 6



MFG. - MICROTRAN
TYPE - TRANSFORMER
DESCRIPTION - VM16H

CHART NO. 134
NO. OF SAMPLES TESTED - 8

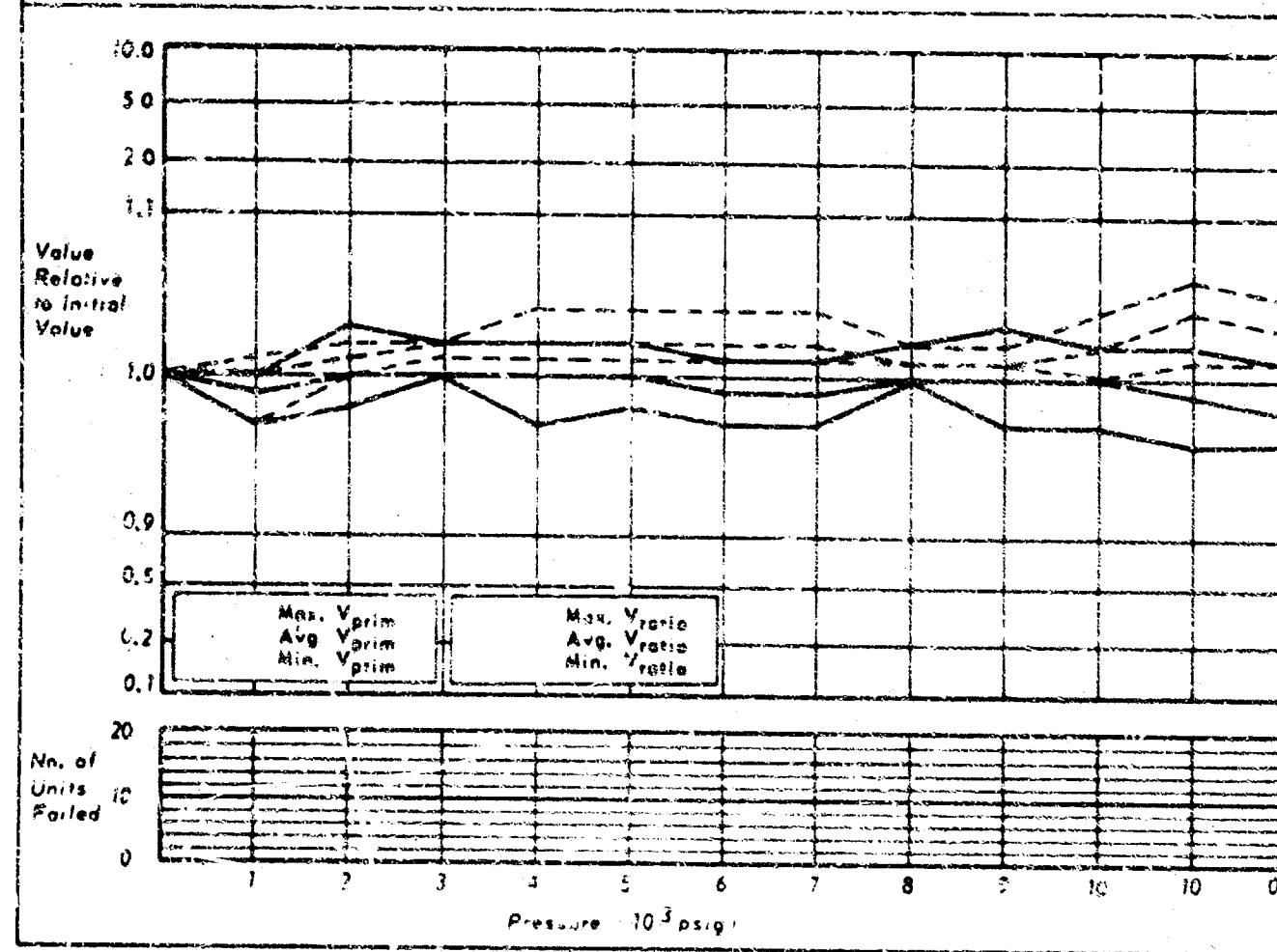


Microtron	Prv. Imp. 30,000	Open frame
MM7-FB	Sec. Imp. 1,200	Bracket mount
Transformer, output	Freq resp 200-10,000	0.5 x 0.342 x 0.437"
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated less than 10% change.		

Microtron	Prv. Imp. 500	Epoxy potted
VM 16-M	Sec. Imp. 250	Plug-in type
Transformer, driver	16W level 15	0.5 x 0.342 x 0.437"
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: One component indicated a greater than 20% change with subsequent recovery of previous values on graph on opposite page.		
FAILURES: Four components indicated a permanent change greater than 50%.		

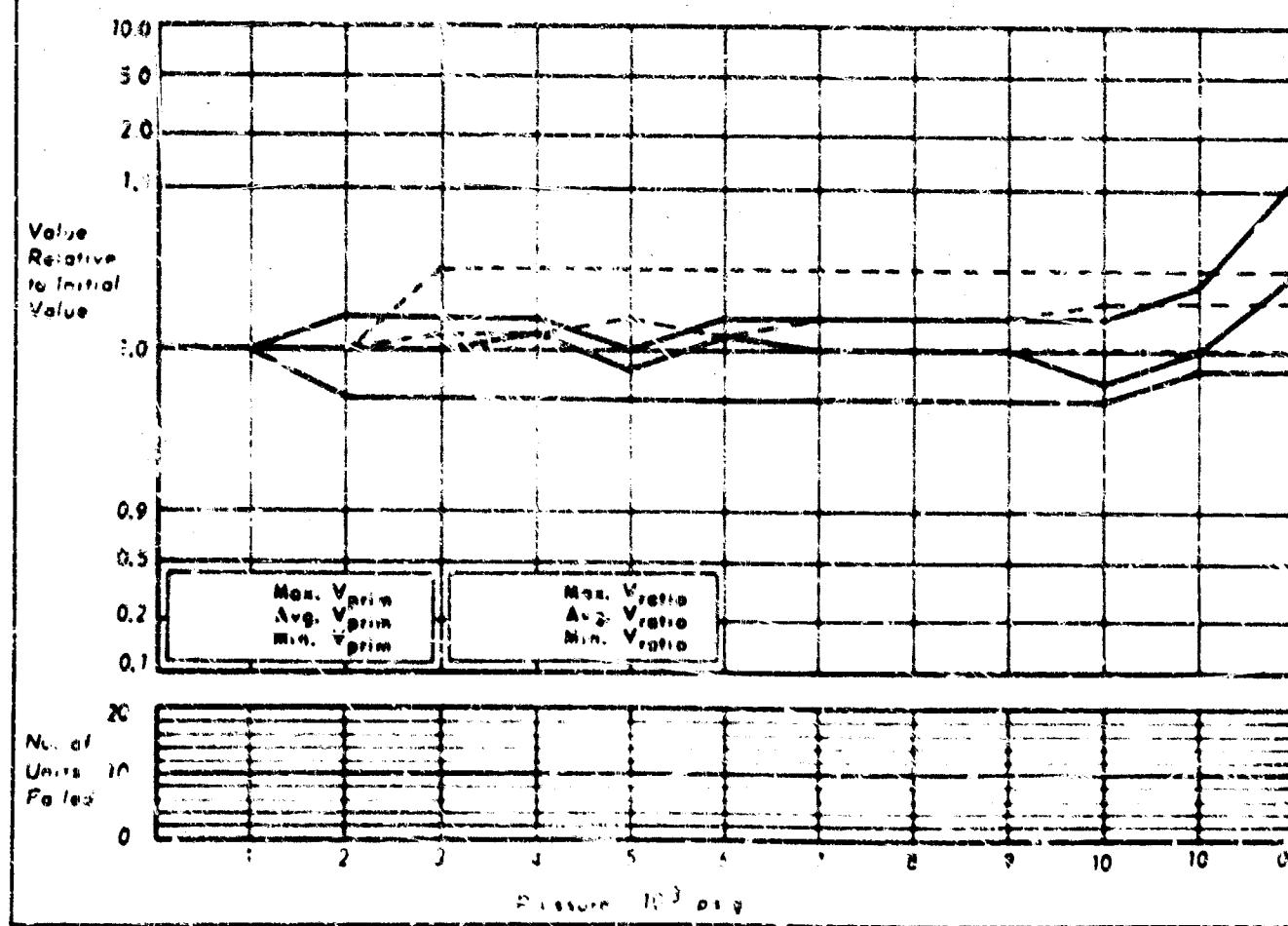
MFG. - MICROTRAN
TYPE - TRANSFORMER
DESCRIPTION - VM 31-4

CHART NO. 135
NO. OF SAMPLES TESTED - 8



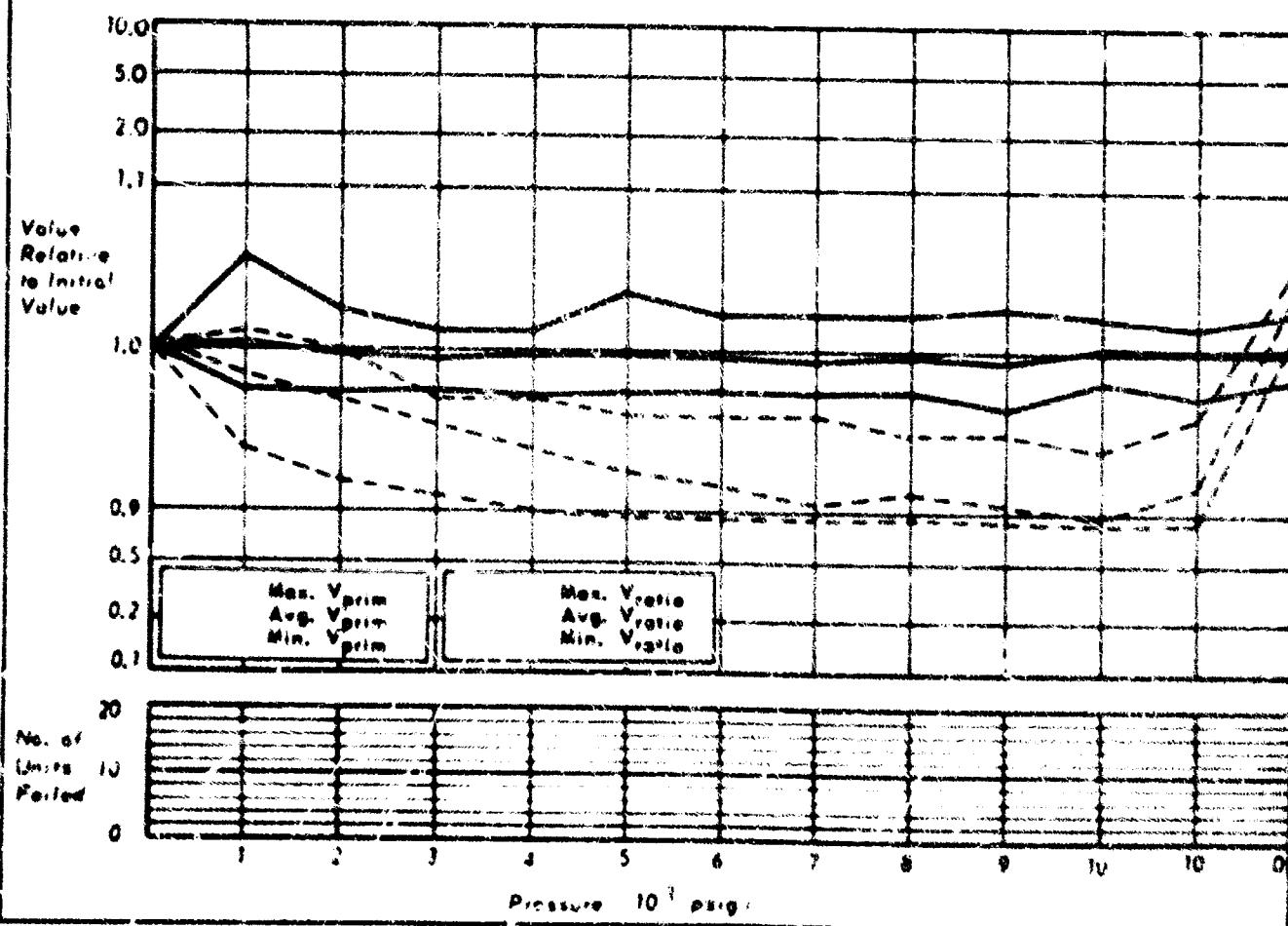
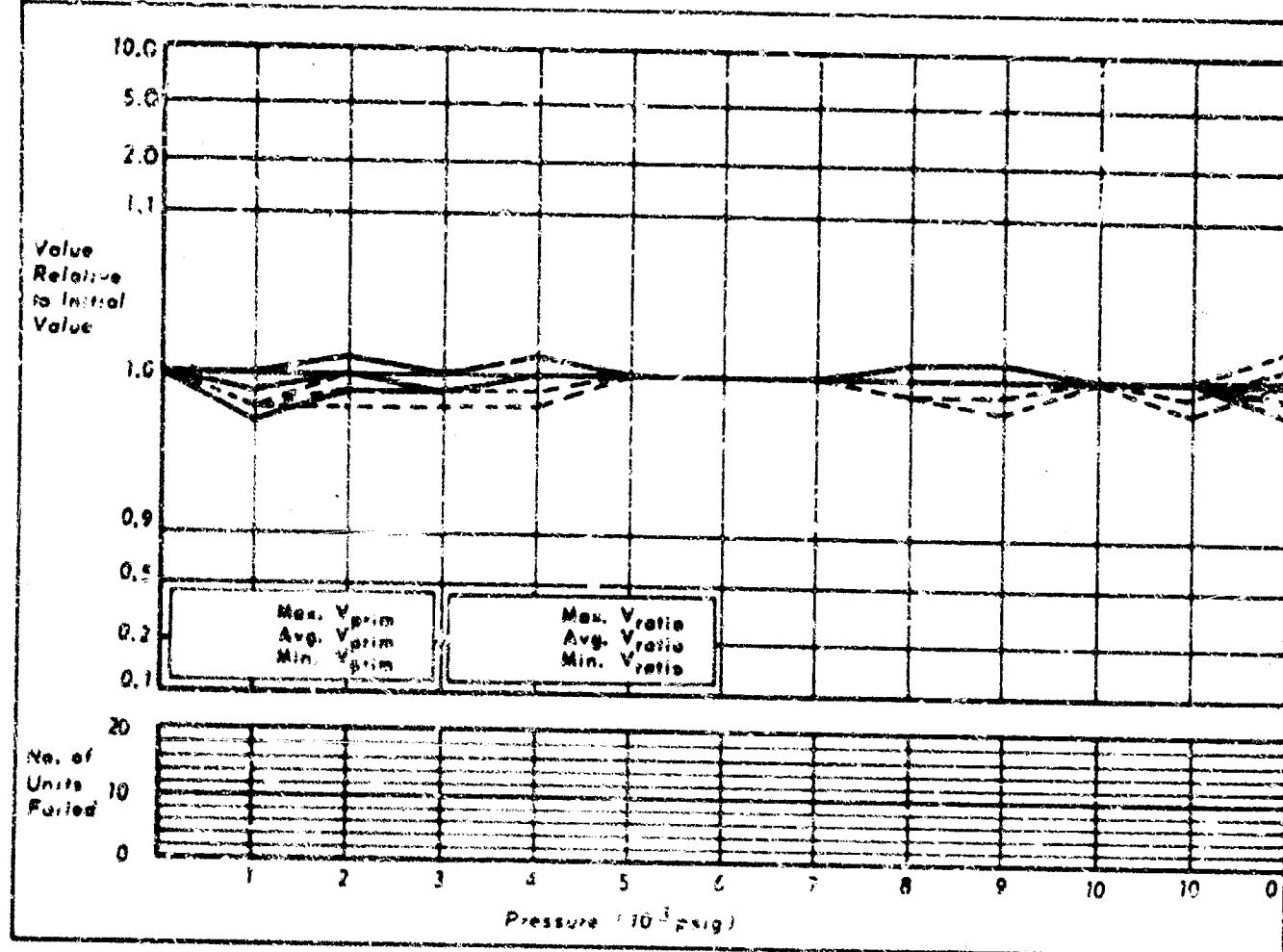
MFG. - MICROTRAN
TYPE - TRANSFORMER
DESCRIPTION - VM 6 - FPS

CHART NO. 136
NO. OF SAMPLES TESTED - 8



Microtron	Pri. Imp. 10,000	Open frame
VM 31-F	Sec. Imp. 1,200	Bracket mount
Transformer, inter-stage	UV level 5	$0.513 \times 0.469 \times 0.437"$
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated less than 10% change.		

Microtron	Pri. Imp. 100,000	Open frame
VM 4 FPP	Sec. Imp. 1,200	Bracket mount
Transformer	UV level 5	$0.513 \times 0.469 \times 0.437"$
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated less than 10% change.		

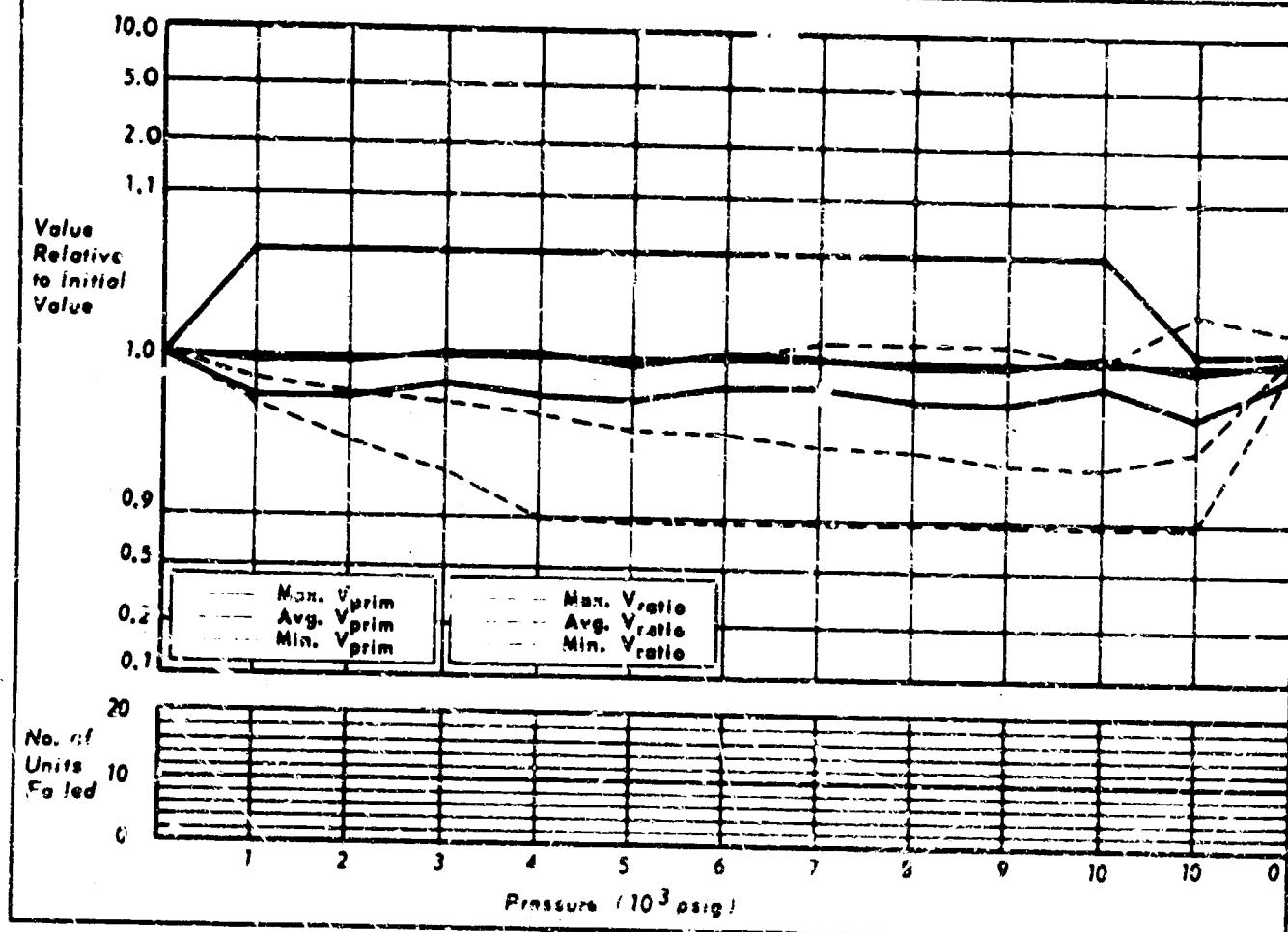


Microtron	Prl. Imp. 1,500 Ω	Open frame
PM33-F	Sec. Imp. 600 Ω	Bracket mount
Transformer, output	MW level 50	0.375 x 0.244 x 0.24"
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: All components indicated a change greater than 10% and less than 50%.		

United Transformer	Prl. Imp. 500	Epoxy Impreg
GH-727	Sec. Imp. 50	Free floating
Transformer	MW level 30	0.68 x 0.5 x 0.966"
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Fourteen components indicated less than 10% change. Five components indicated more than 10% and less than 50% change.		

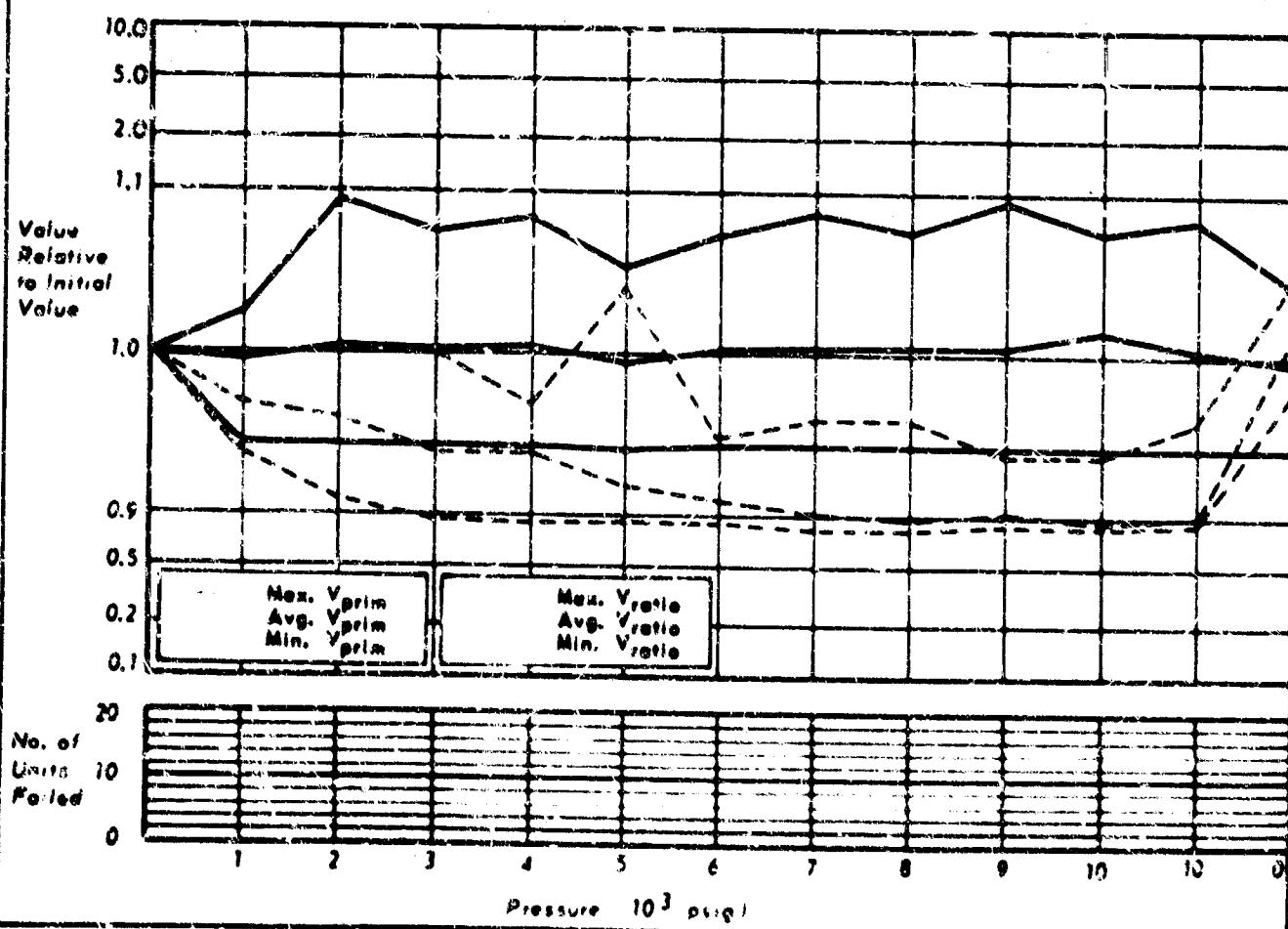
MFG.-UNITED TRANSFORMER
TYPE-TRANSFORMER
DESCRIPTION-CH-780

CHART NO. 139
NO. OF SAMPLES TESTED-20



MFG.-UNITED TRANSFORMER
TYPE-TRANSFORMER
DESCRIPTION-CH-780

CHART NO. 140
NO. OF SAMPLES TESTED-20

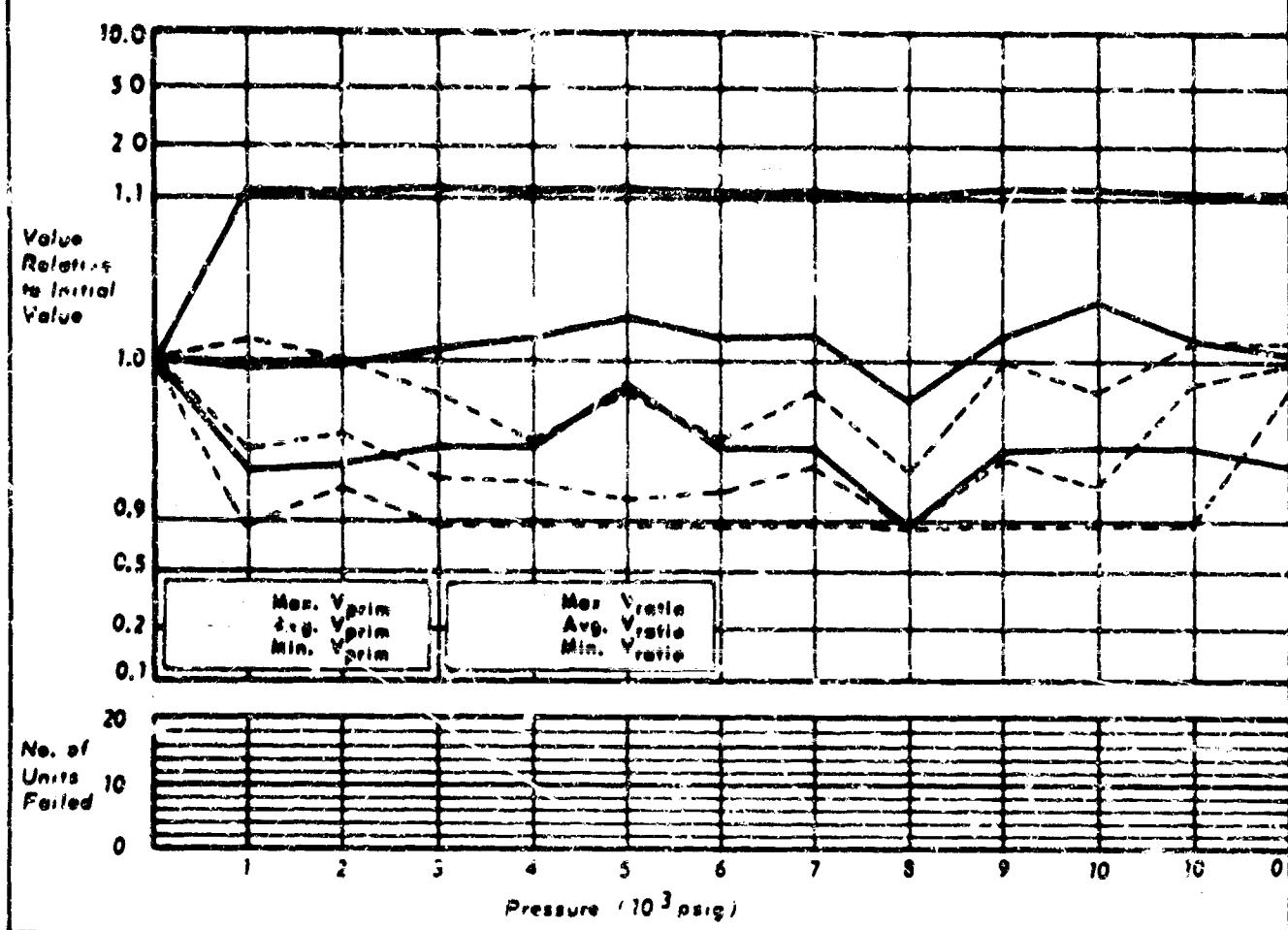


United transformer	Pri. Imp. 500Ω	Wax impreg.
GH-726	Sec. Imp. 50 Ω	Free flooding, metal case
Transformer	MW level 30	0.19 x 0.5 x 0.906"
SOAK PERIOD:	64 hours at 10,000 psig.	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	All components indicated less than 10% change.	

United transformer	Pri. Imp. 500/125 1) CT	Epoxy impreg.
GH-729	Sec. Imp. 150/37.5 Ω CT	Free flooding, metal case
Transformer	MW level 1 W at 200 cps	1.4 x 0.95 x 0.210"
SOAK PERIOD:	None	
MECHANICAL:	No apparent damage.	
ELECTRICAL:	Sixteen components indicated less than 10% change. Four components indicated + change greater than 10% and less than 50%.	

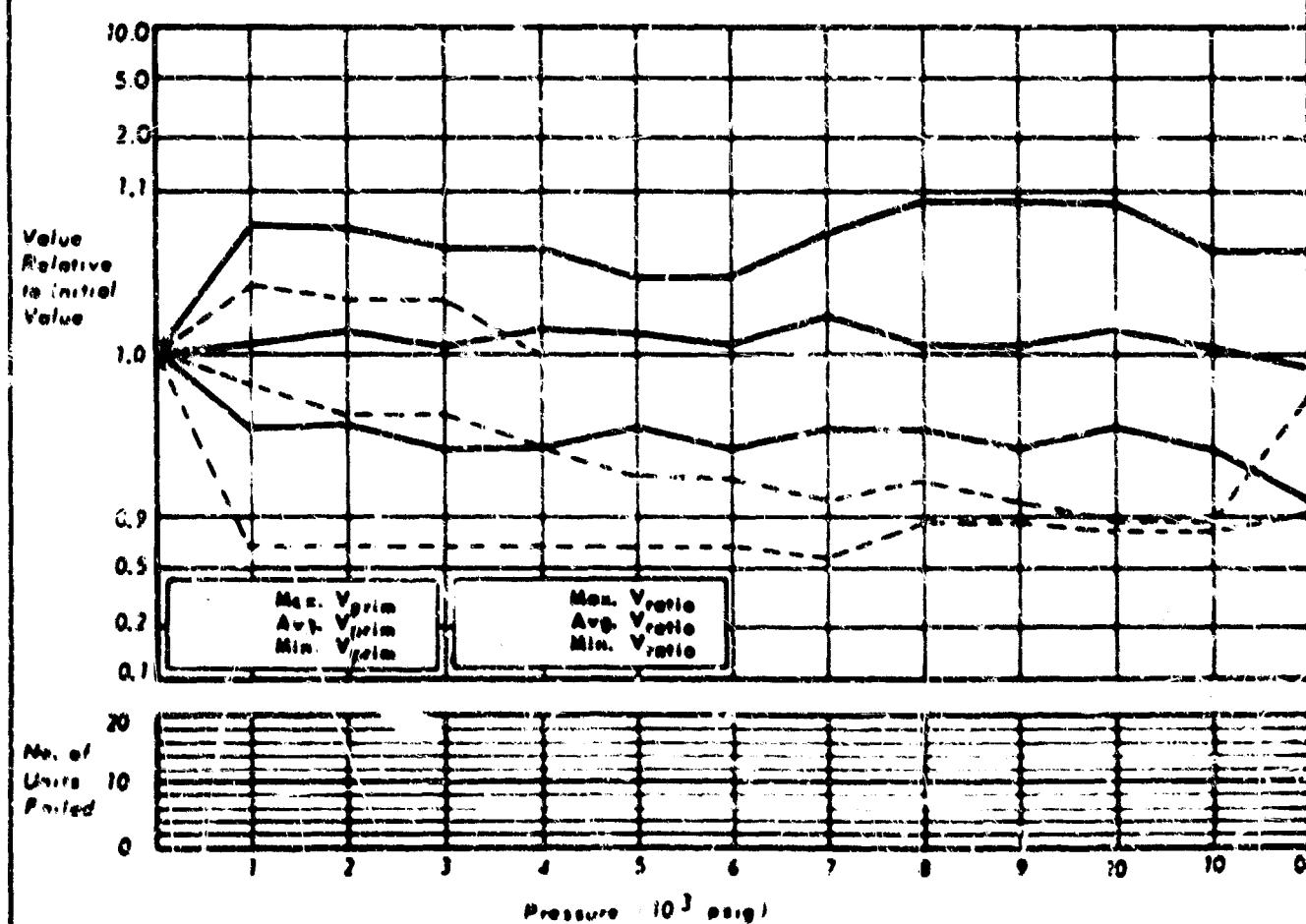
MFG. - UNITED TRANSFORMER
TYPE - TRANSFORMER
DESCRIPTION - SN - T20

CHART NO. 141
NO. OF SAMPLES TESTED - 20



MFG. - UNITED TRANSFORMER
TYPE - TRANSFORMER
DESCRIPTION - SN - T20

CHART NO. 142
NO. OF SAMPLES TESTED - 10

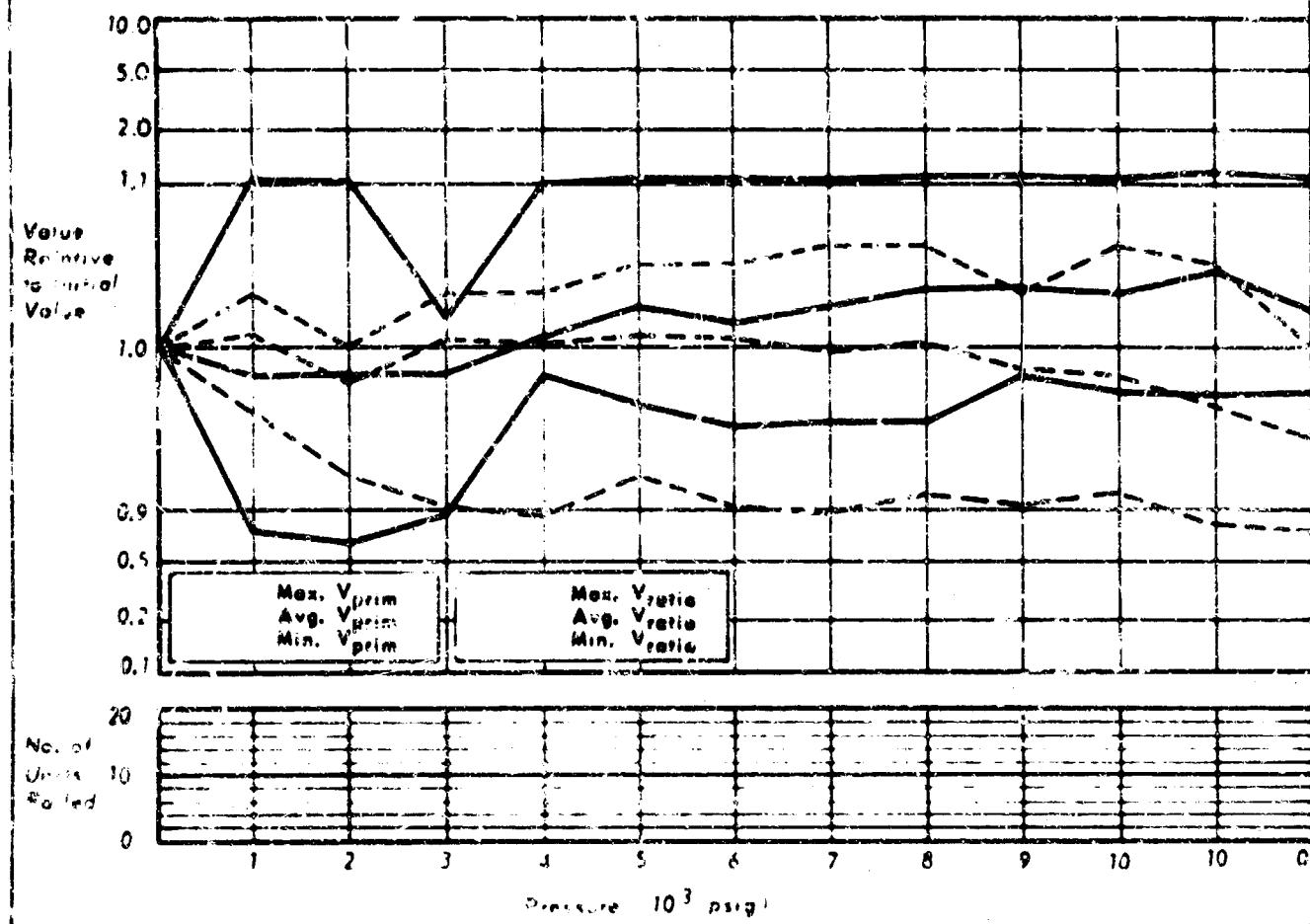


United transformer	500/125 Ω CT	Varnish impreg.
GH-728	150/37.5 Ω CT	Free floating, metal case
Transformer	MW level 1 W at 200 cps	$0.95 \times 1.68 \times 0.218"$
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Nineteen components indicated less than 10% change.		
	One component indicated a change greater than 10% and less than 50%.	

United Transformer	10/150 Ω CT	Epoxy sealed
DO-T29	3.2/4 Ω CT	Metal clad
Transformer	MW level 500	$0.4 \times 0.31"$ diam.
SOAK PERIOD: None		
MECHANICAL: No apparent damage.		
ELECTRICAL: Seventeen components indicated less than 10% change. Two components indicated a change greater than 10% and less than 50%.		

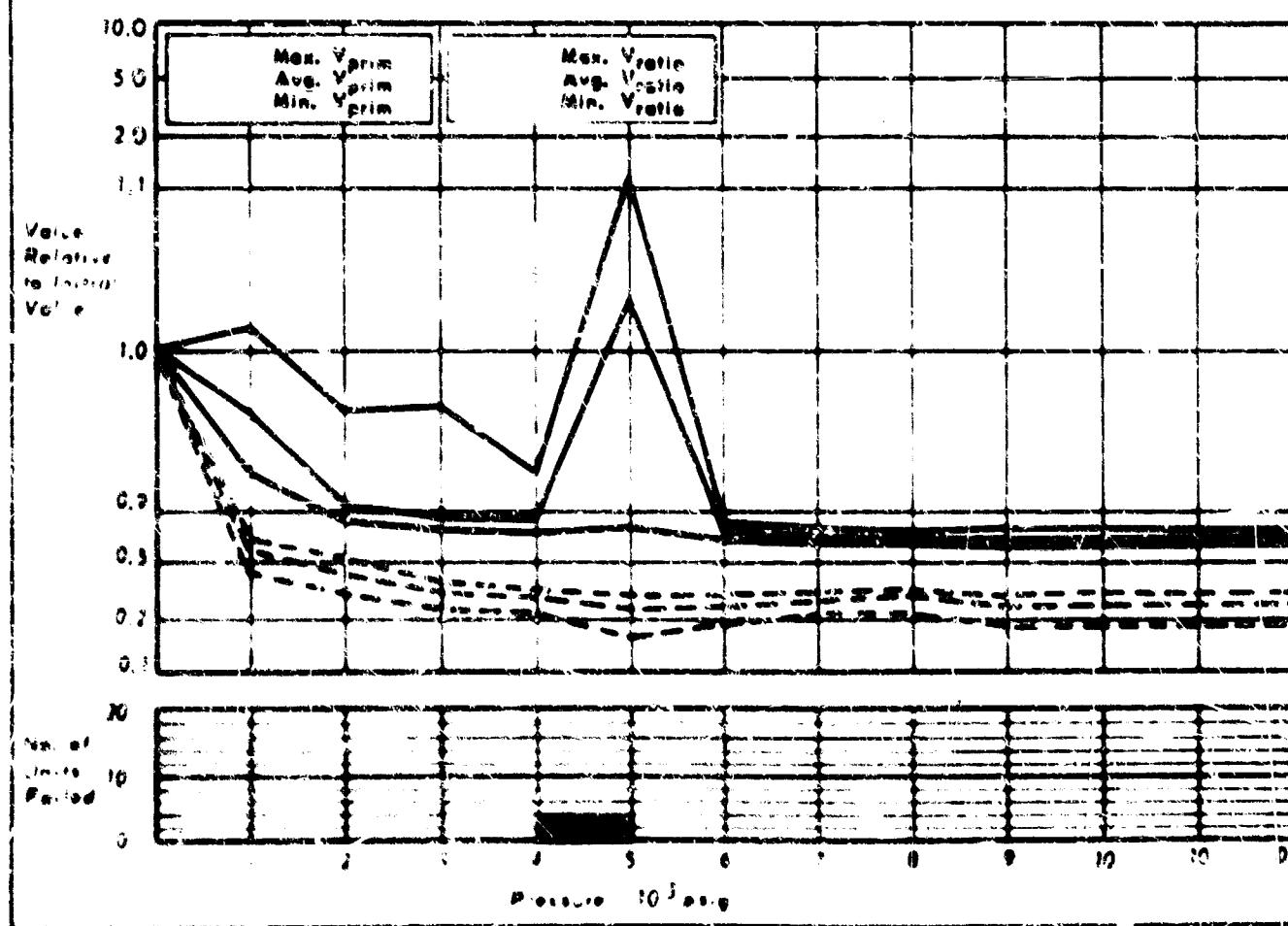
MFG. - UNITED TRANSFORMER
TYPE - TRANSFORMER
DESCRIPTION - DI-T44

CHART NO. 143
NO. OF SAMPLES TESTED - 12



MFG. - UNITED TRANSFORMER
TYPE - TRANSFORMER
DESCRIPTION - DI-T44

CHART NO. 144
NO. OF SAMPLES TESTED - 20

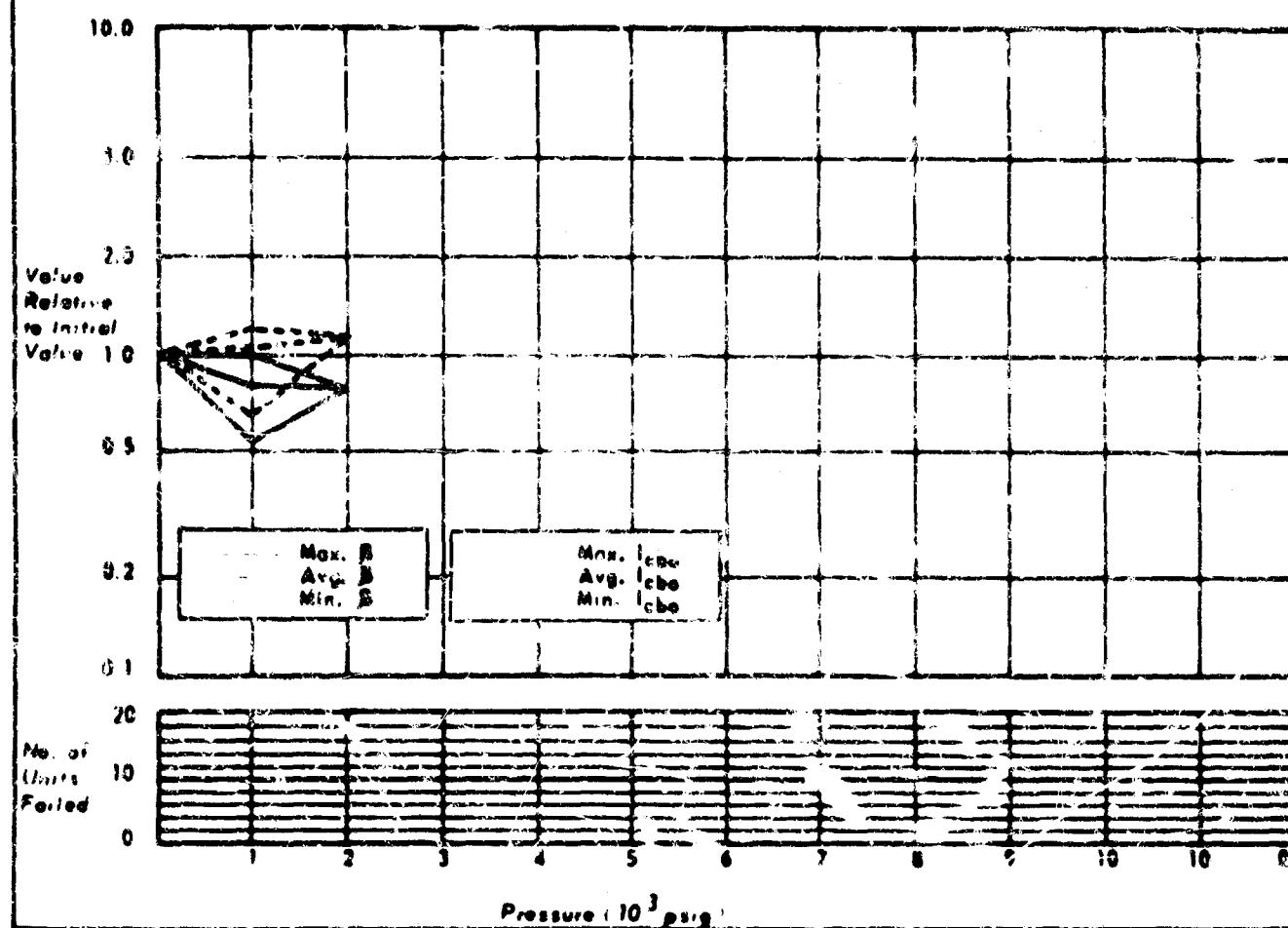


United transformer	89/100 Ω CT	Epoxy sealed
DI-T44	32/40 Ω split	Metal clad
Transformer	ΔW level 500	0.43 x 0.312" diam.
SOAK PERIOD:	None	
MECHANICAL:	Mr apparent damage.	
ELECTRICAL:	Eleven components indicated less than 10% change.	
	One component indicated a change greater than 10% and less than 50%.	

United transformer 80/100 Ω CT Molded unit
 SO-14P 32/48 Ω split Vacuum impreg.
 Transformer 0.75 x 1.0 x 0.718"
SOAK PERIOD: None
MECHANICAL: No apparent damage.
ELECTRICAL: All components indicated a change greater than 10% and less than 50%.

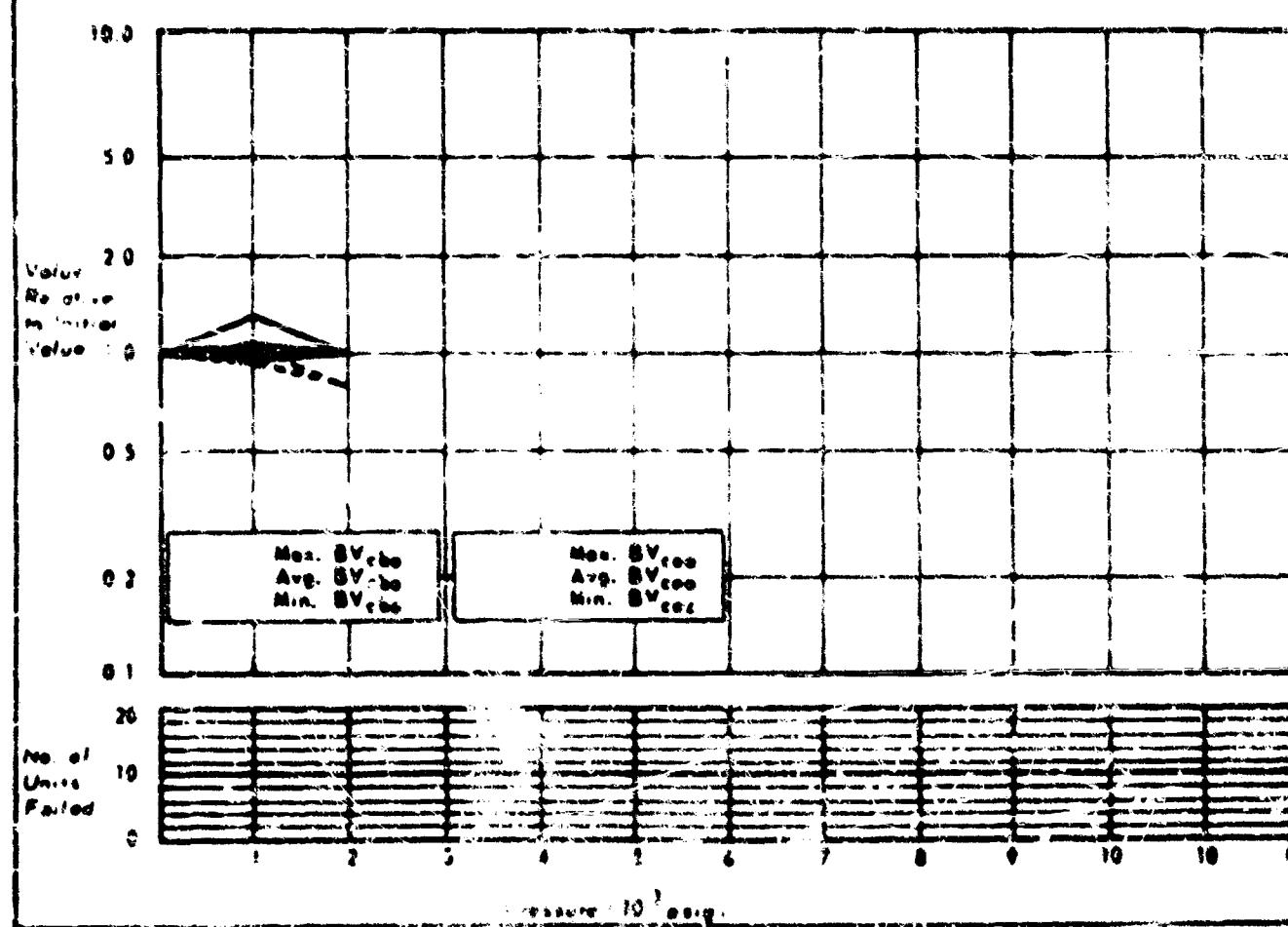
MFG. - GENERAL INSTRUMENT
TYPE - TRANSISTOR
DESCRIPTION - 2N509

CHART NO. 1453
NO. OF SAMPLES TESTED - 19



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 1454
NO. OF SAMPLES TESTED



General Instruments

2N 398

Translator

$I_{cbo} = 5 \mu A$
 $V_{cbo} = 45 V$

Germanium, PNP

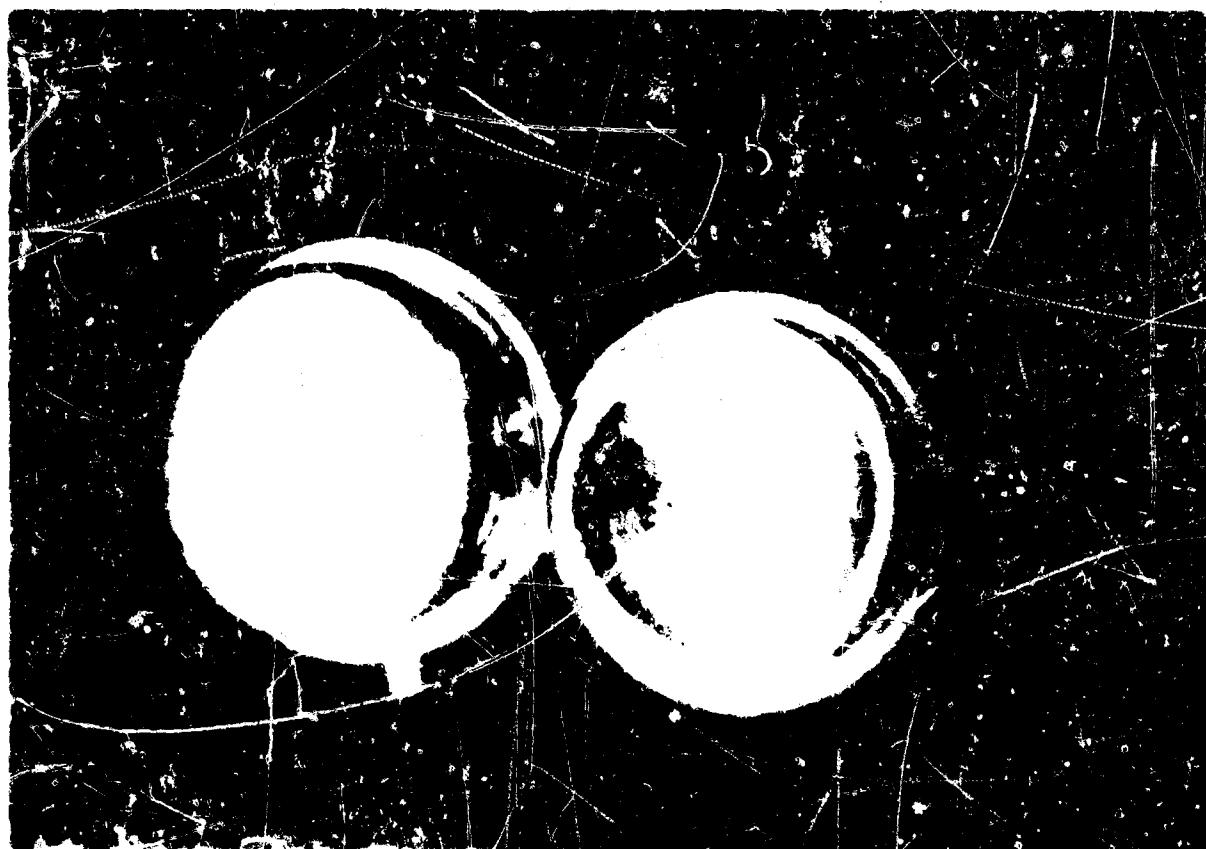
Altop Junction

0.15 x 0.36" diam

SOAK PERIOD: None

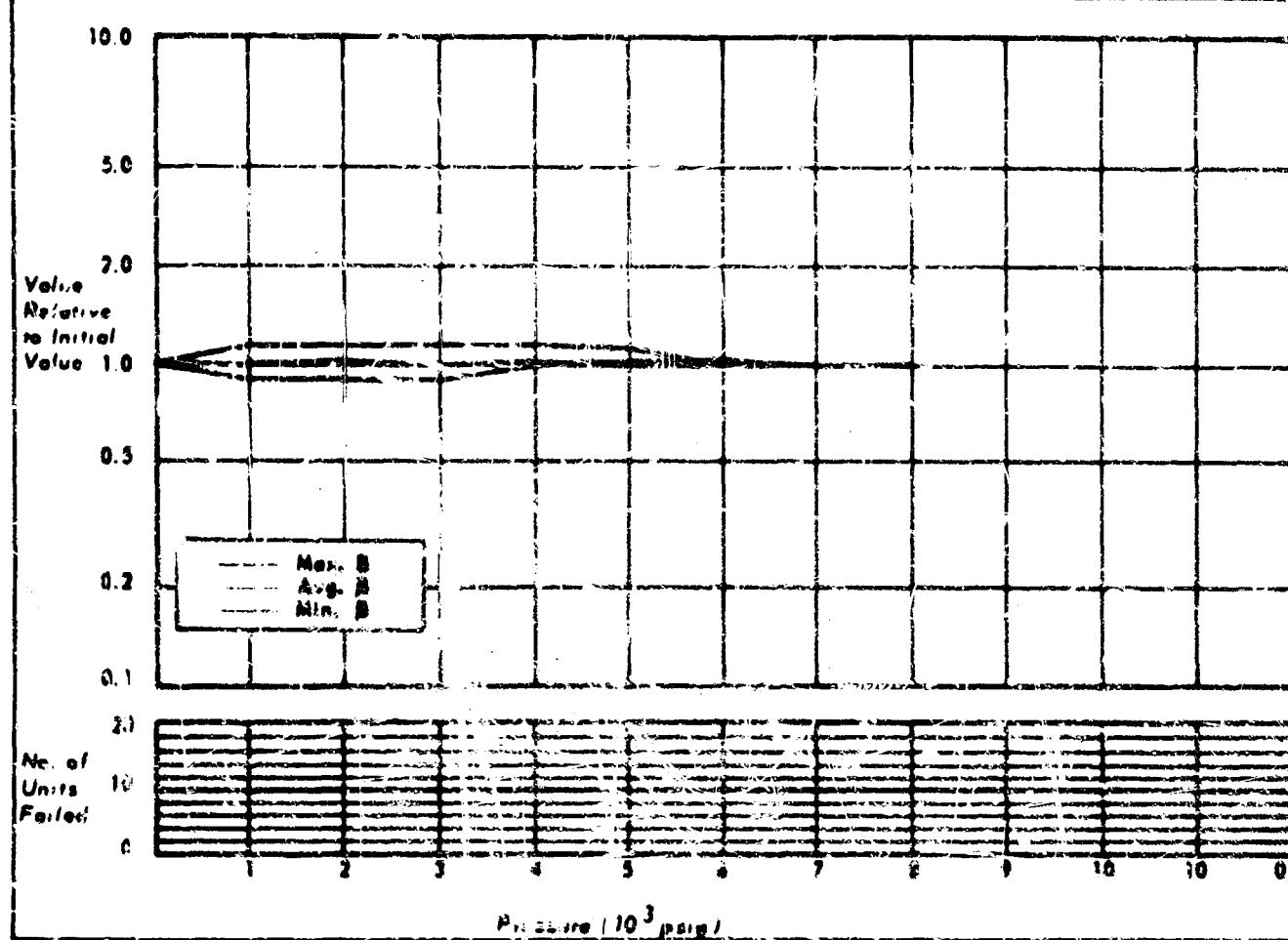
MECHANICAL: The metal cases of all components were deformed.

ELECTRICAL: All components operated with a change of more than 20% and less than 50% through 1,000 psig. One component operated through 2,000 psig. All samples failed above 2,000 psig. Failure in each case was catastrophic.



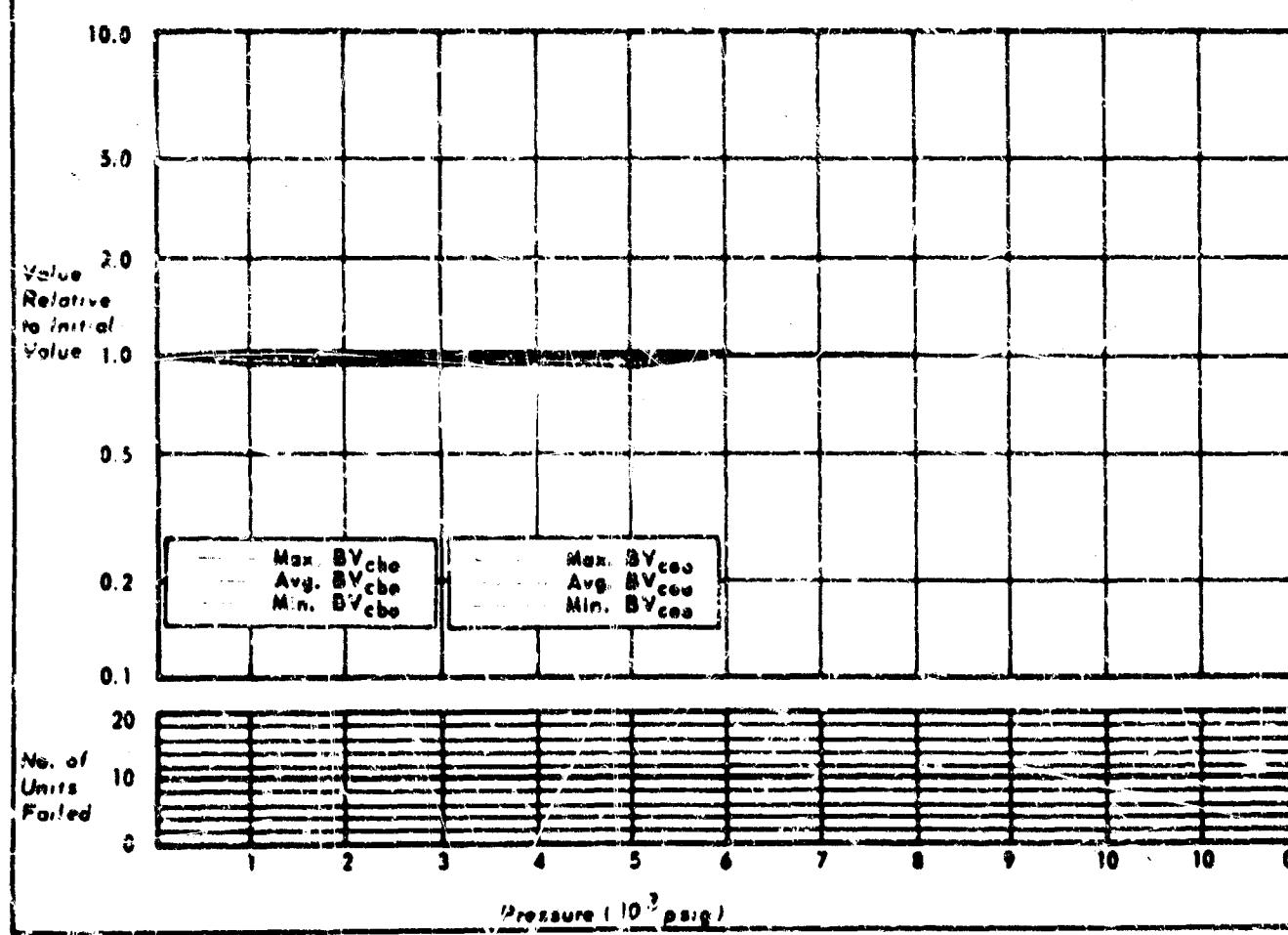
MFG. - GENERAL INSTRUMENTS
TYPE - TRANSISTOR
DESCRIPTION - 2N706

CHART NO. 146
NO. OF SAMPLES TESTED - 19



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 146A
NO. OF SAMPLES TESTED



General Instruments

2N 705

Transistor

$I_{CBO} = 0.01 \mu A$

$BV_{CBO} = 25 V$

Silicon, NPN

Planar, epitaxial

TO case

0.20 x 0.21" diam

SOAK PERIOD: None

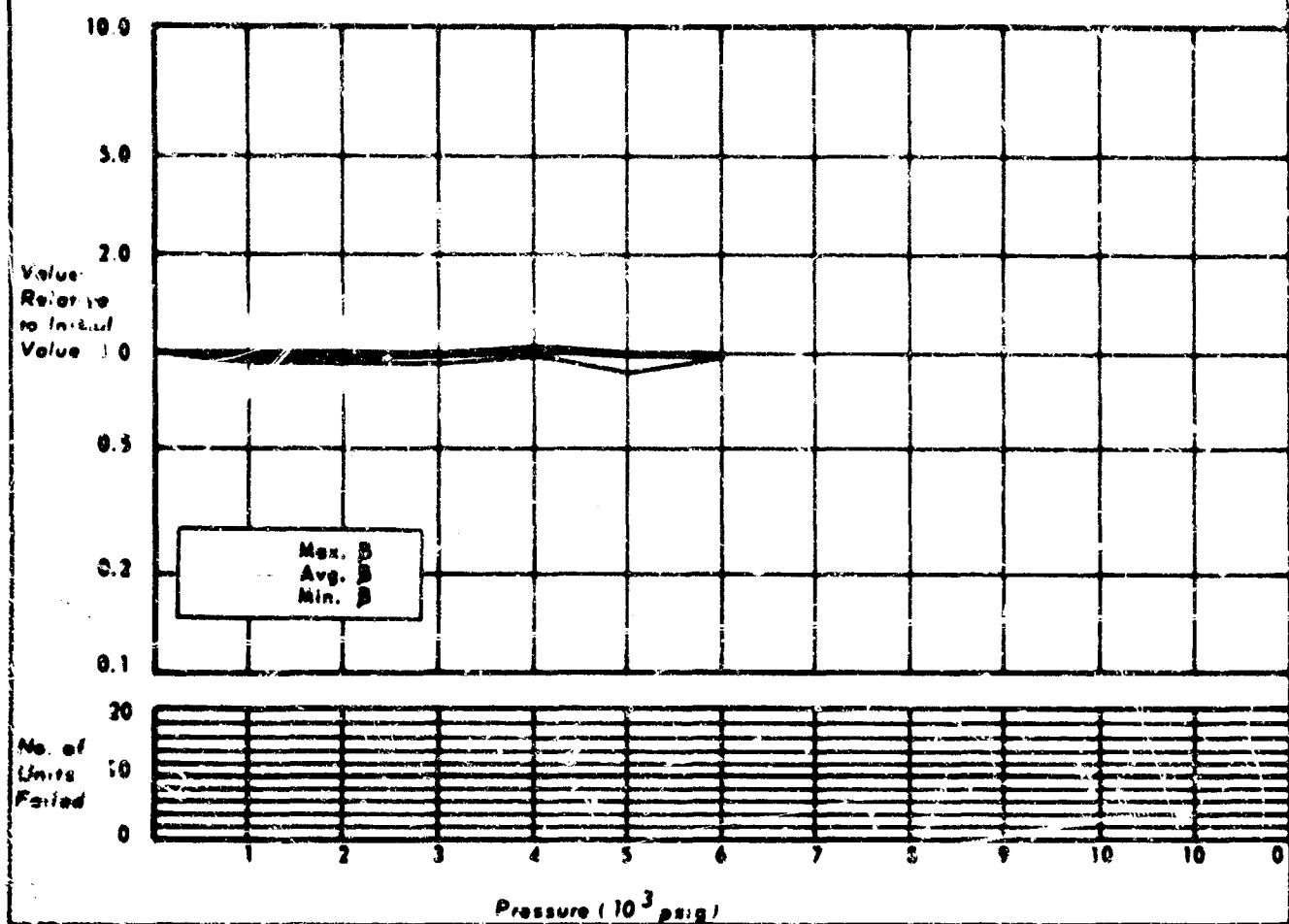
MECHANICAL: The metal cases of all components were deformed.

ELECTRICAL: All components functioned normally through 4,000 psig, eleven operated through 5,000 psig, eight through 6,000 psig and two through 7,000 psig. All components failed above 7,000 psig. Failure in each case was catastrophic.



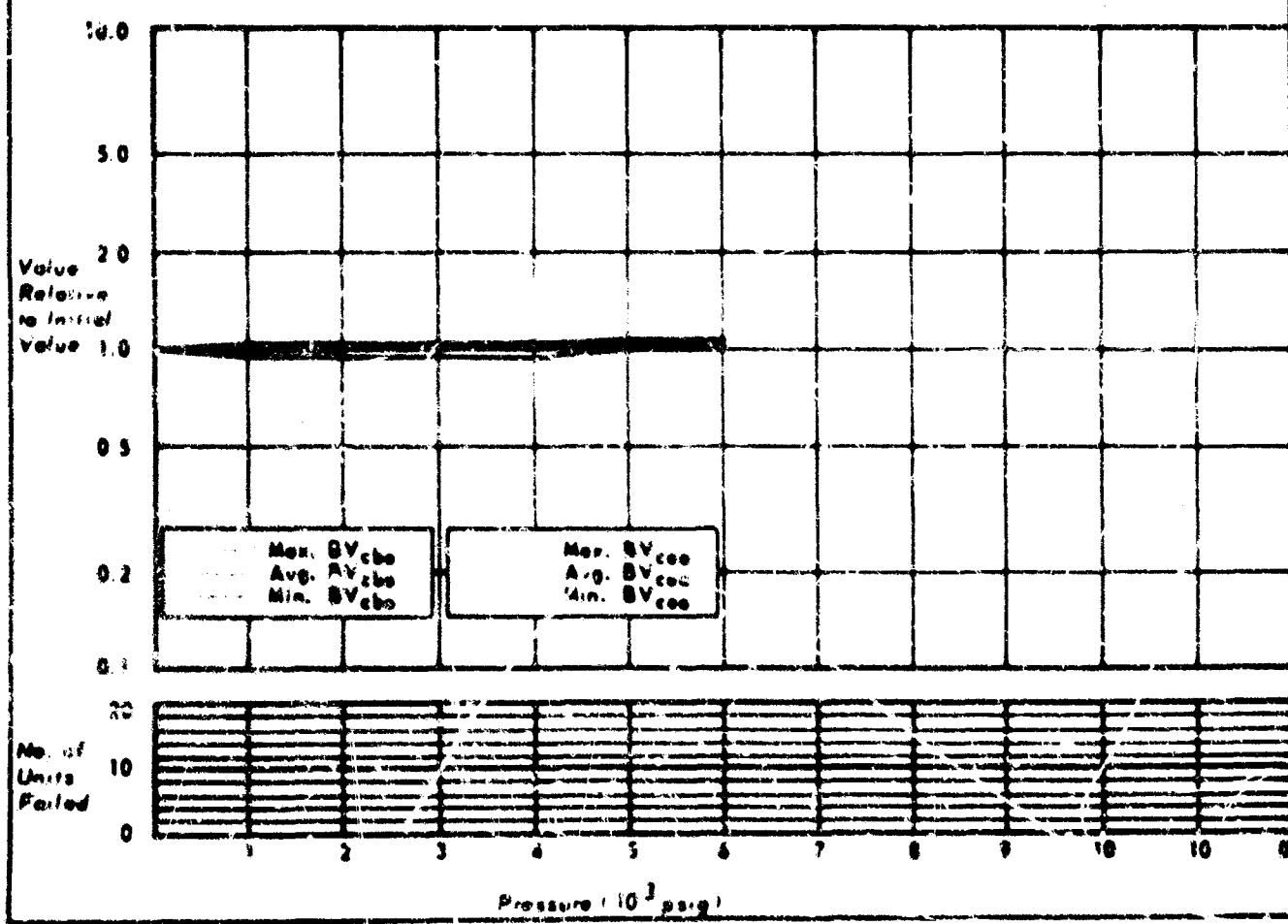
MFG. - MOTOROLA
TYPE - TRANSISTOR
DESCRIPTION - 2N834

CHART NO. 147
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 147A
NO. OF SAMPLES TESTED



Material
2N 834
Transistor

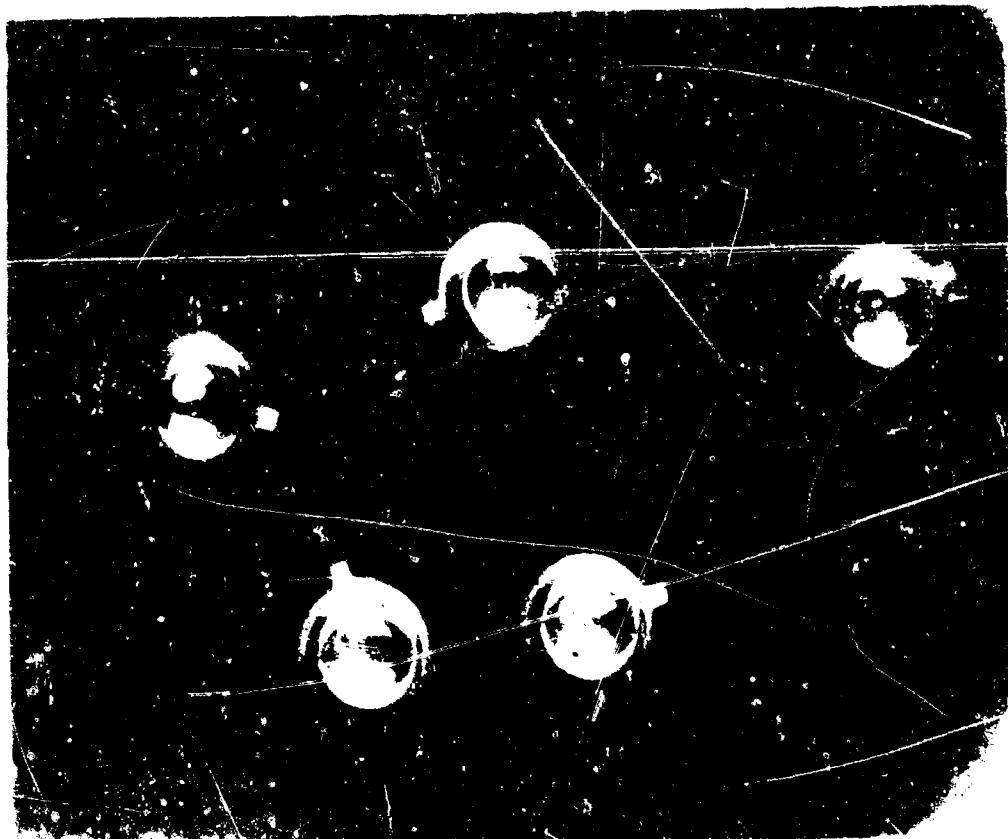
$I_{cbo} = 6 \mu A$
 $BV_{cbo} = 40 V$

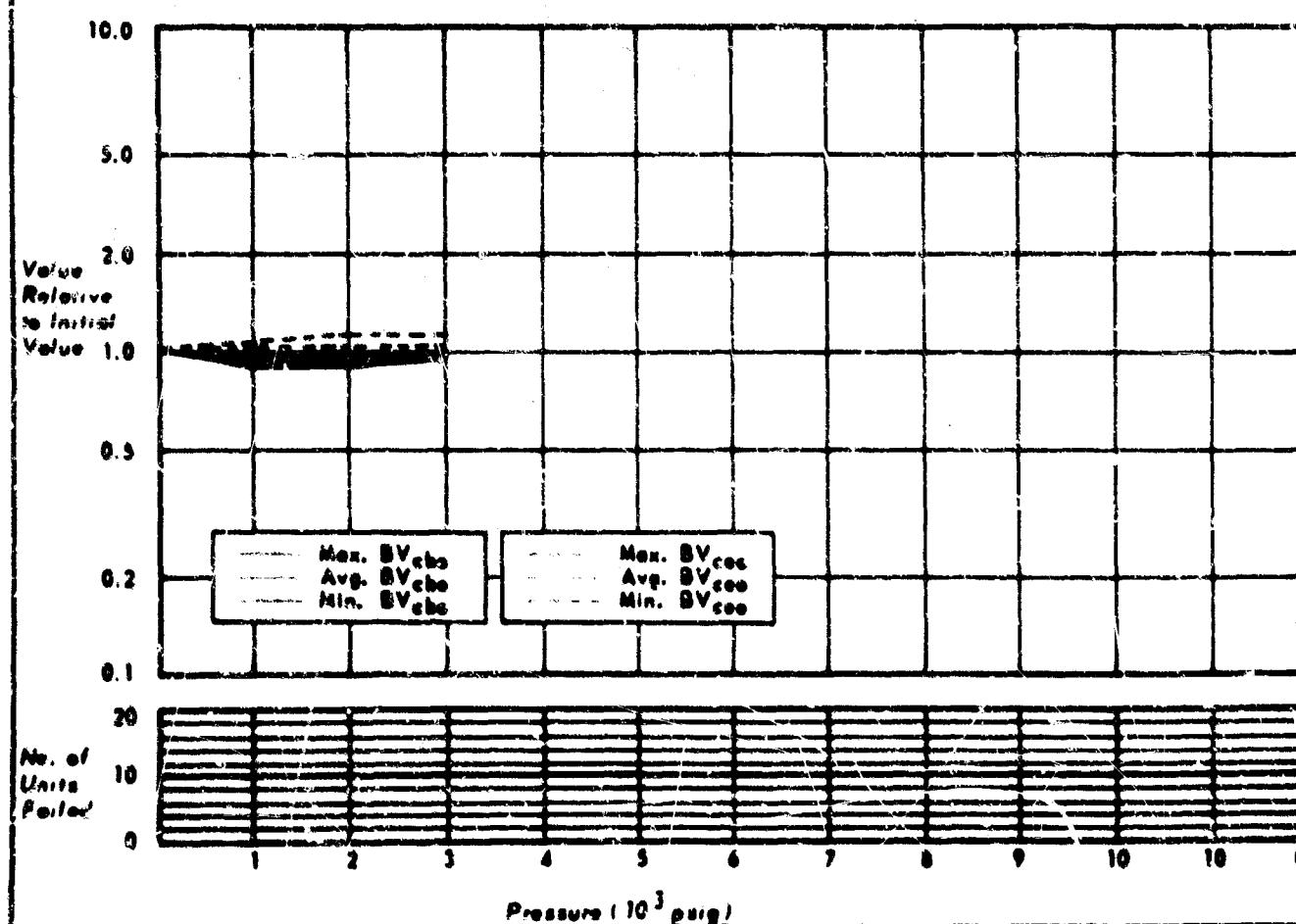
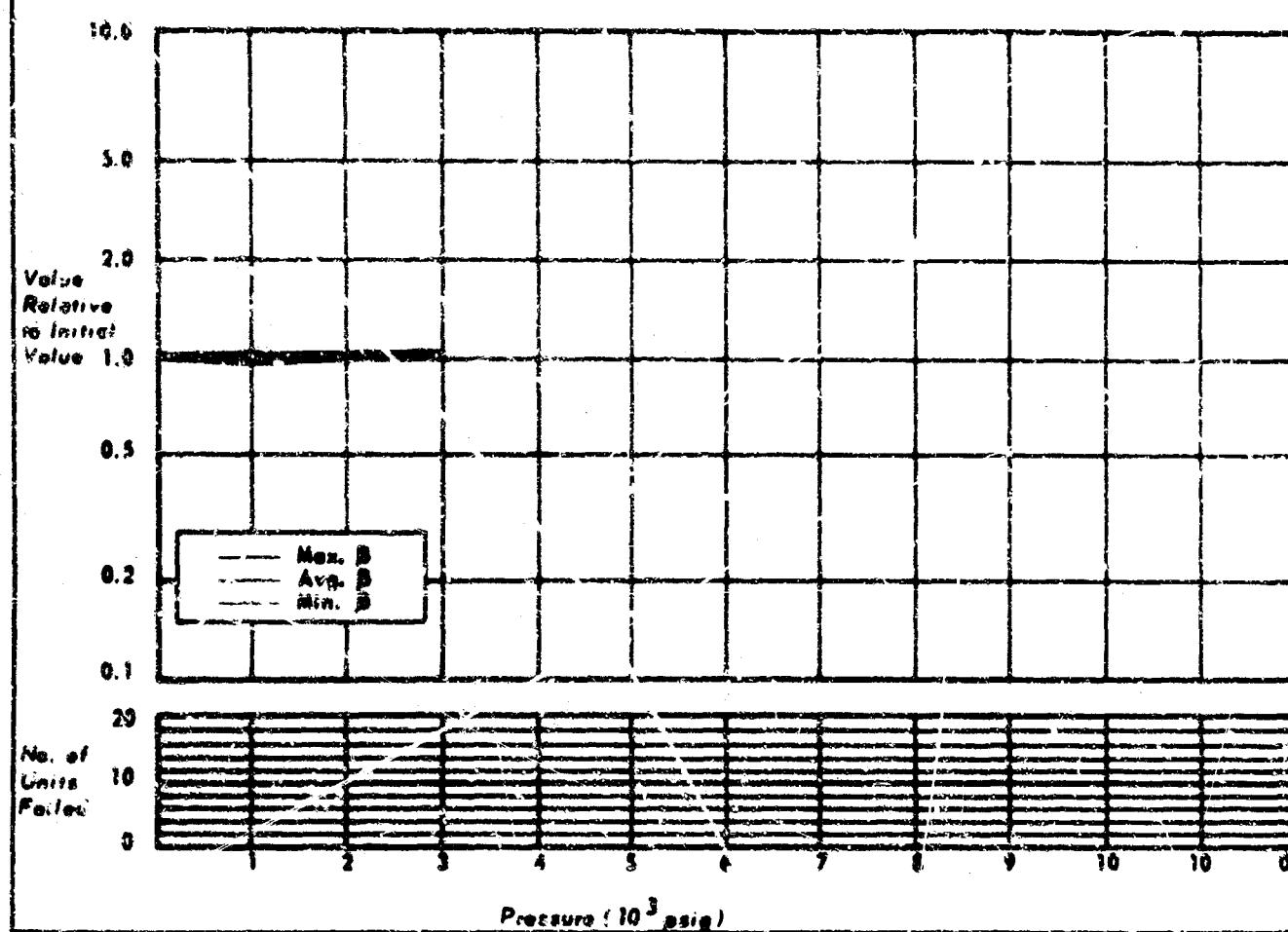
Silicon, NPN
Epitaxial mesa

SOAK PERIOD: None

MECHANICAL: All metal cases were deformed.

ELECTRICAL: All components operated with less than 10% change through 4,000 psig, thirteen operated through 5,000 psig and six operated with less than 25% change through 6,000 psig. All failures were catastrophic.





Materials
2N 2218
Transistor

$I_{cbo} = .01 \mu A$
 $BV_{cbo} = 40 V$

Silicon, NPN
Annular epitaxial

SOAK PERIOD: None

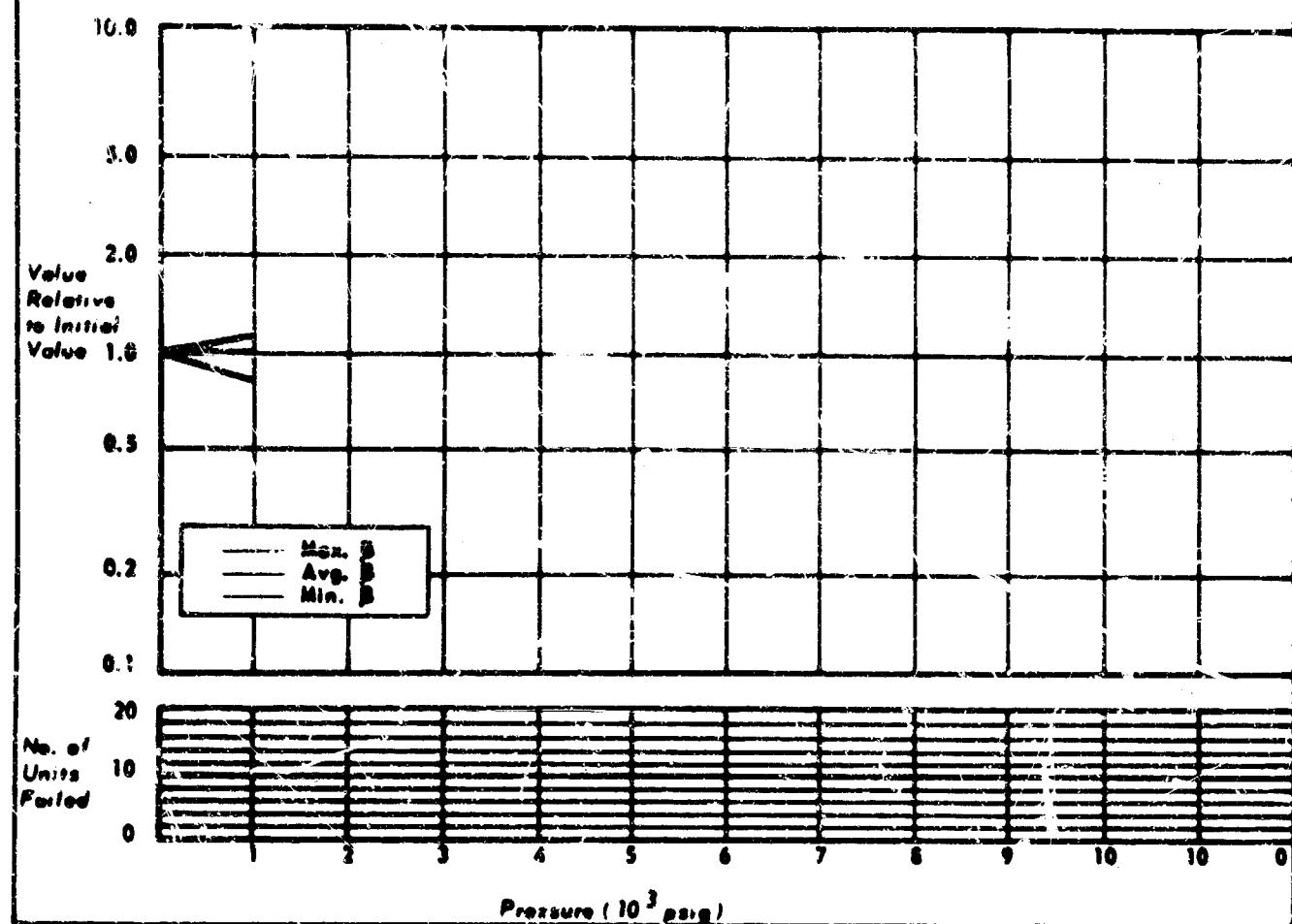
MECHANICAL: All metal cases were deformed.

ELECTRICAL: All components operated with less than 10% change through 2,000 psig and nine with less than 10% change through 3,000 psig. All failures were catastrophic.



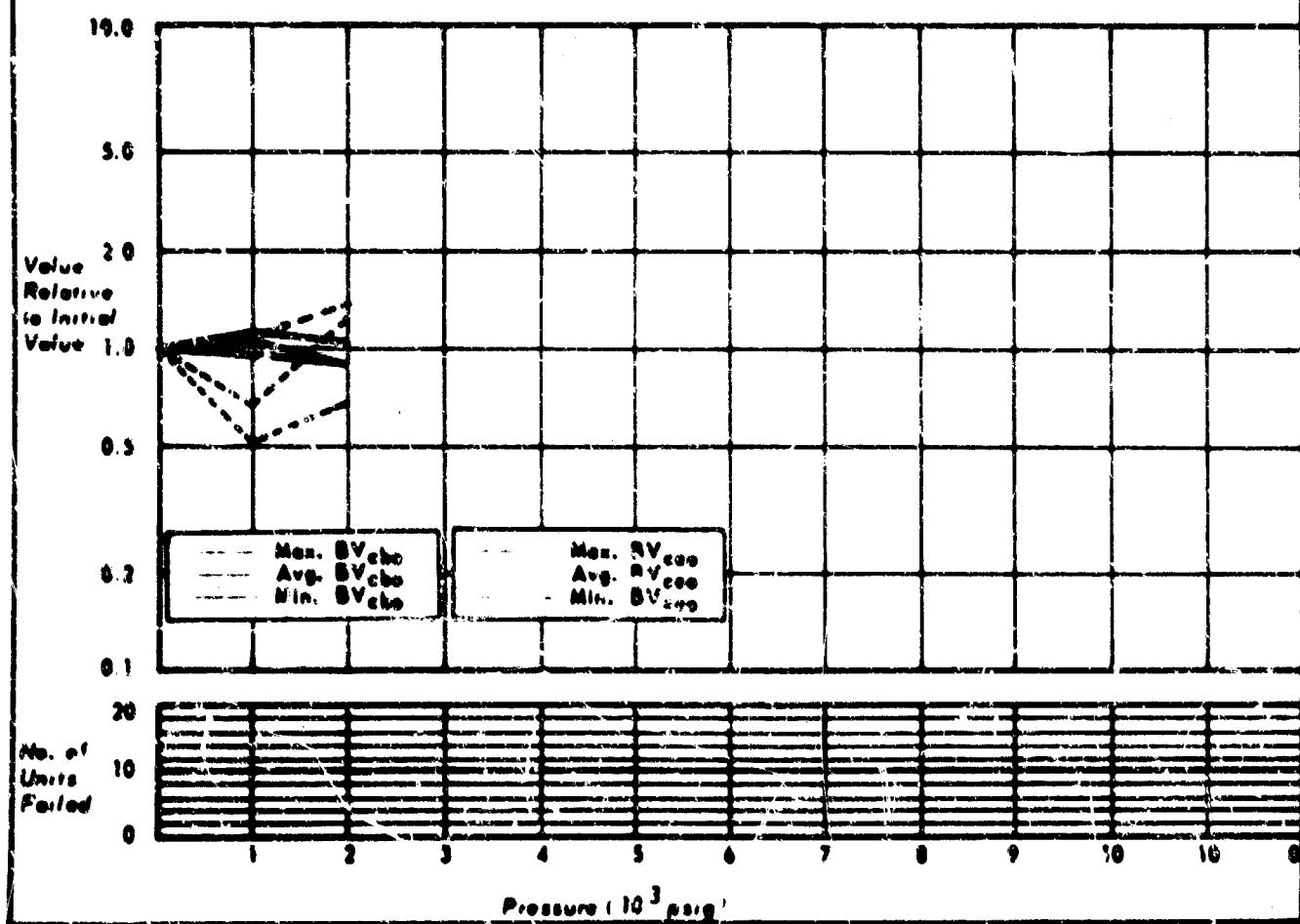
MFG. - SYLVANIA
TYPE - TRANSISTOR
DESCRIPTION - 2N7068

CHART NO. 149
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 149A
NO. OF SAMPLES TESTED



Sylvania
2N 7043
Transistor

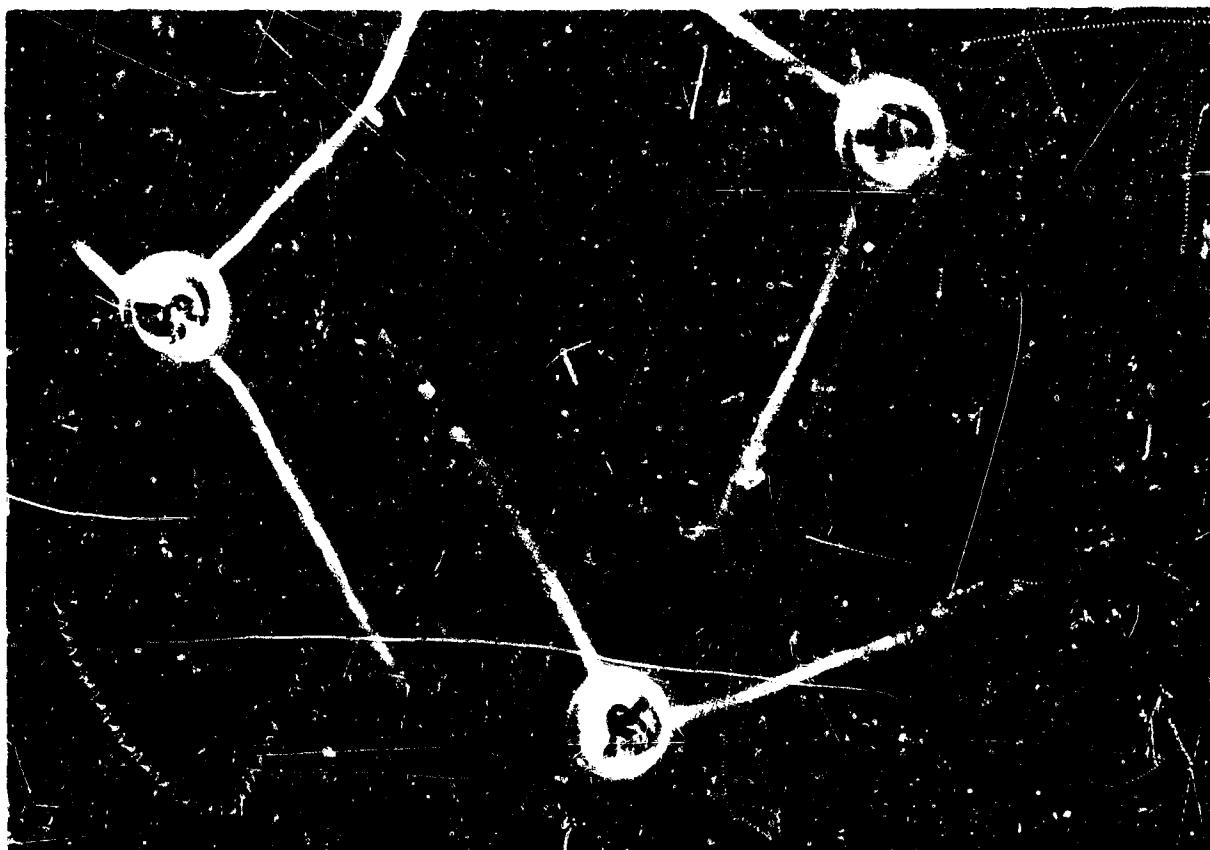
$I_C = 200 \text{ mA}$
 $V_{CEO} = 25 \text{ V}$

NPN Silicon
Epitaxial planar
Diffused, passivated
0.205 x 0.21" diam.

SOAK PERIOD: None

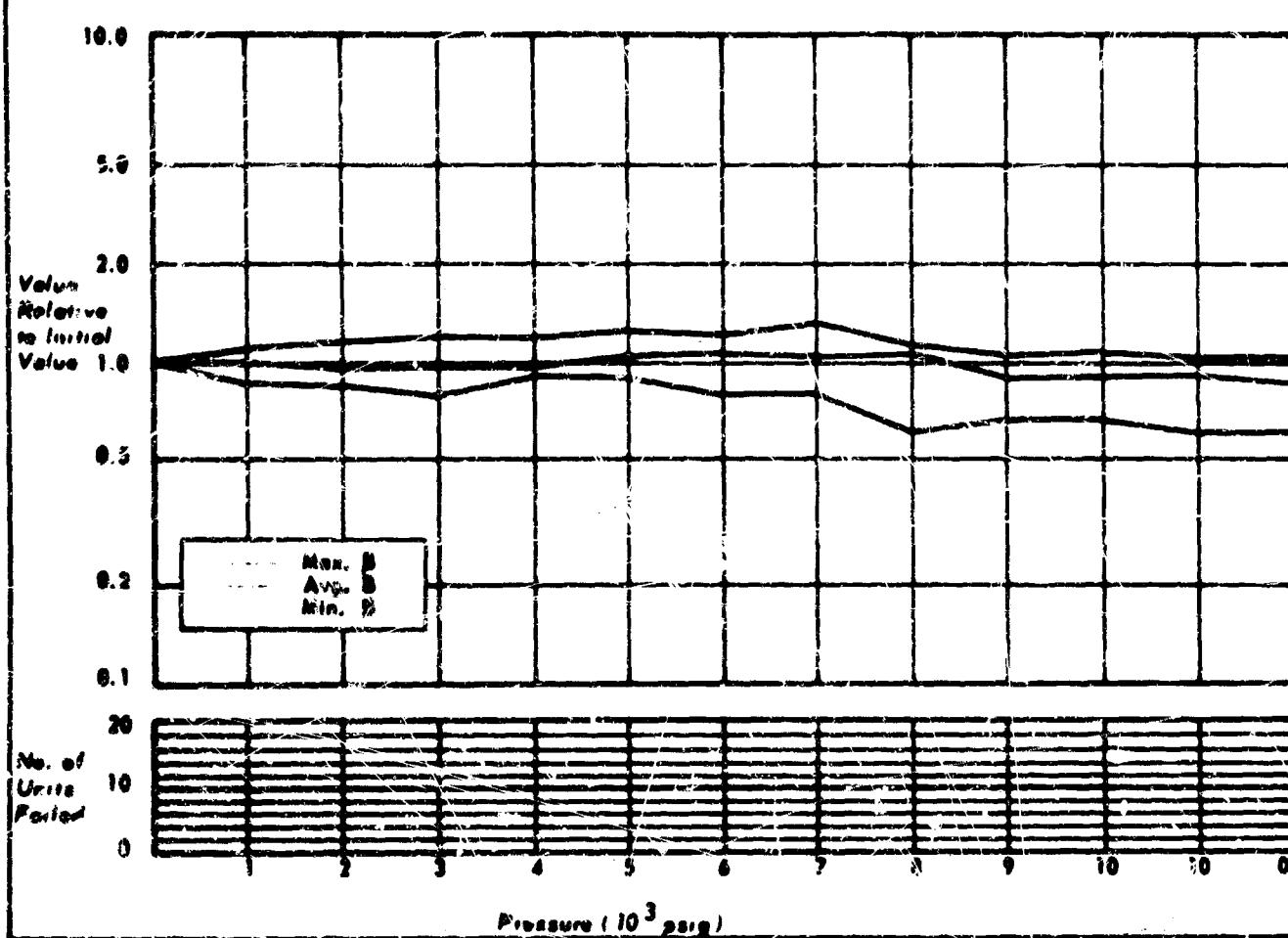
MECHANICAL: All metal cases were deformed.

ELECTRICAL: All components functioned normally through 2000 psig. Two components failed completely above 2000 psig and the remaining eighteen indicated incipient failure. All components failed above 3000 psig.



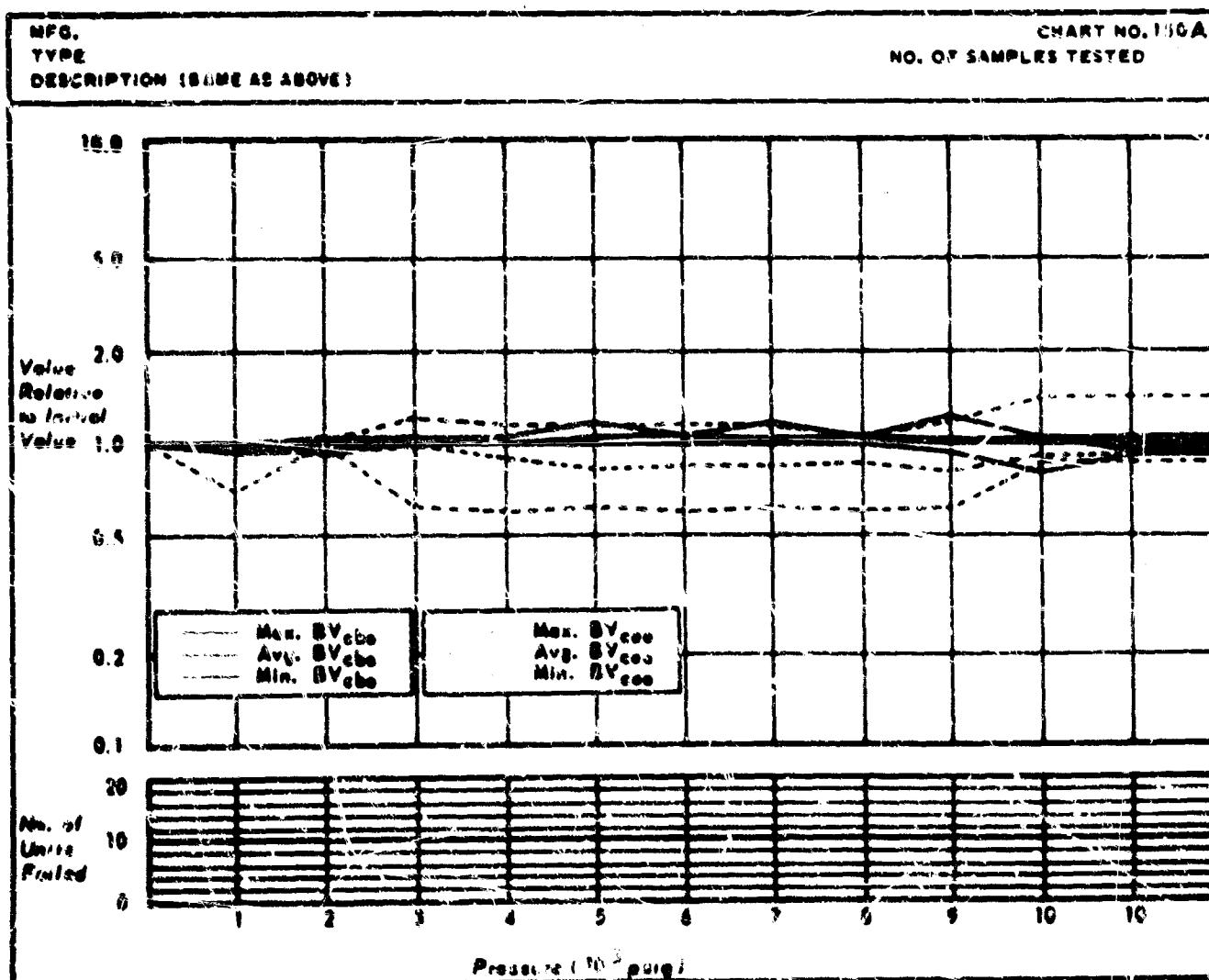
MFG. - SILVANIA
TYPE - TRANSISTOR
DESCRIPTION - 2N4151

CHART NO. 150
NO. OF SAMPLES TESTED - 8



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 150A
NO. OF SAMPLES TESTED



Sylvanie
2N 4131
Transistor

$I_{cbo} = 1 \mu A$
 $BV_{cbo} = 20 V$

Silicon, NPN
Planar epitaxial
Epoxy encaps.

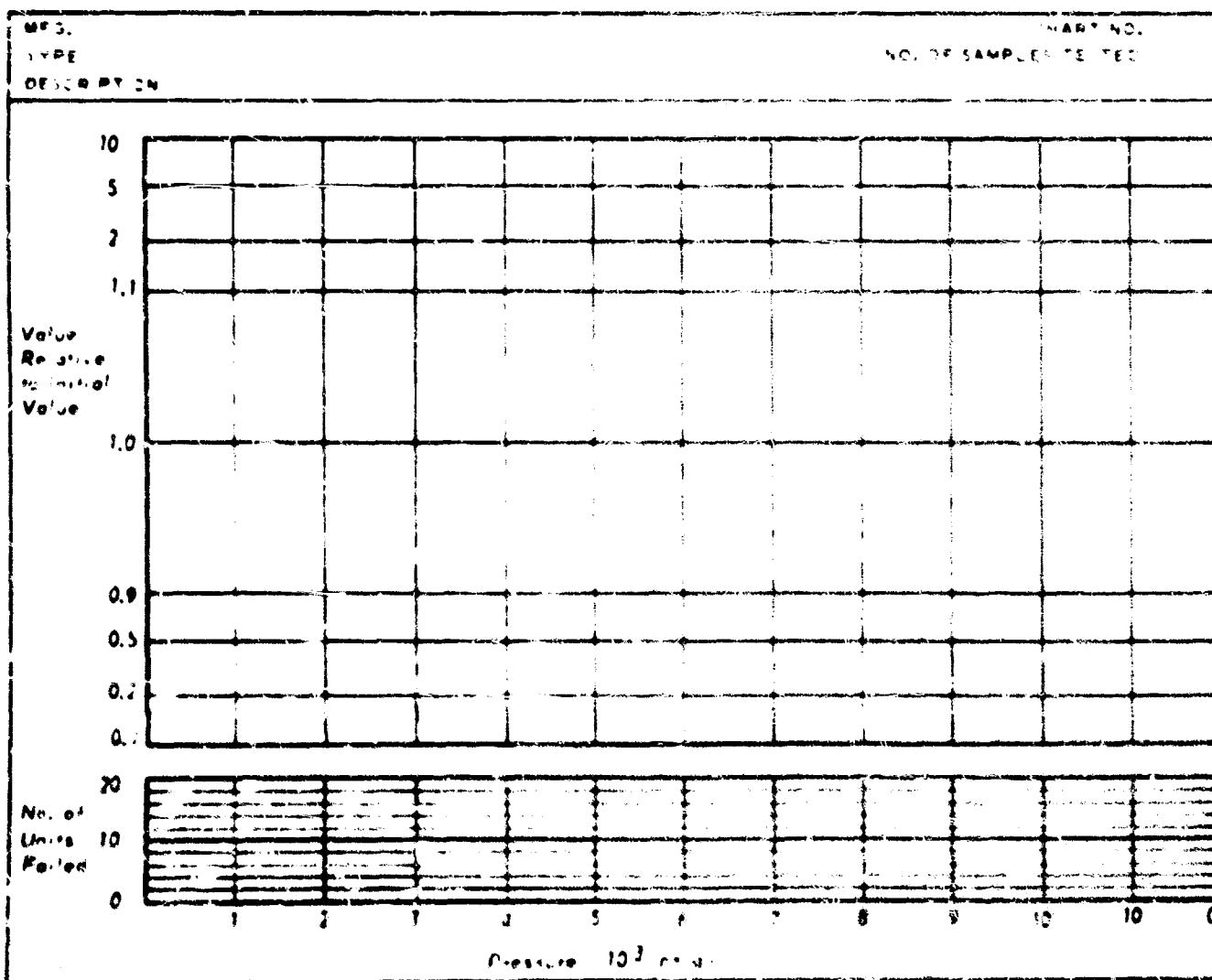
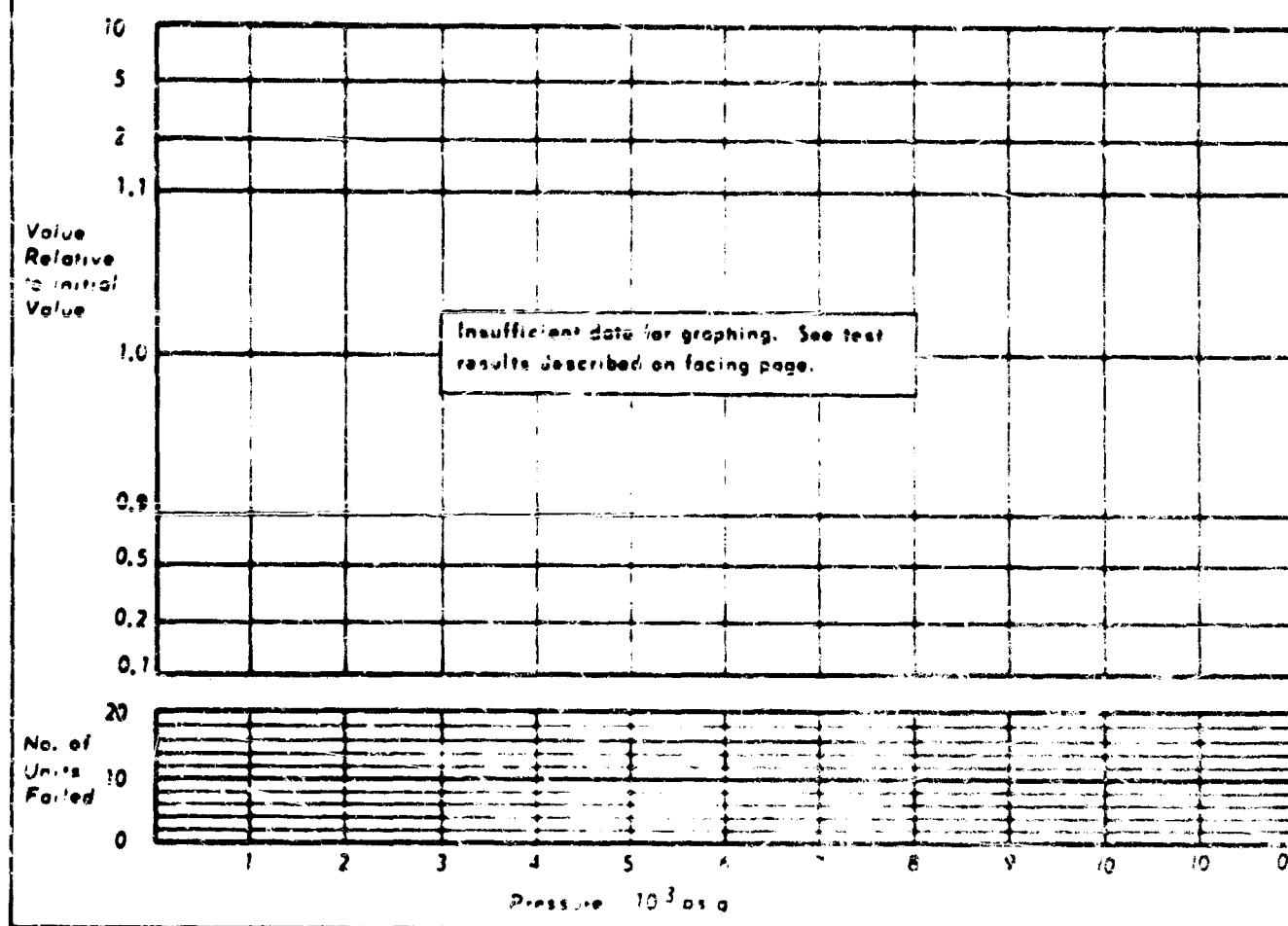
SOAK PERIOD: None

MECHANICAL: All metal cases were deformed.

ELECTRICAL: Six components functioned satisfactorily through the entire test program.
Two components failed above 7,000 psig.

MFG. - SYLVANIA
TYPE - TRANSISTOR
DESCRIPTION - SYL6942

CHART NO. 131
NO. OF SAMPLES TESTED



Sylvania
SYL4342
Transistor

$I_{CEO} = 5 \mu A$
 $BV_{CEO} = 15 V$

Silicon, epitaxial planar
Diffused, passivated
Kovar top mounting
 $0.04 \times 0.02 \times 0.003"$

SOAK PERIOD: 16 hours at 10,000 psig.

Due to the extremely small size of the components, functional operation was impossible during test. The laboratory facilities available were also considered inadequate for evaluation following test. The components were therefore subjected to the entire test program and subsequently returned to the vendor for operational check. The following information was received from Sylvania.

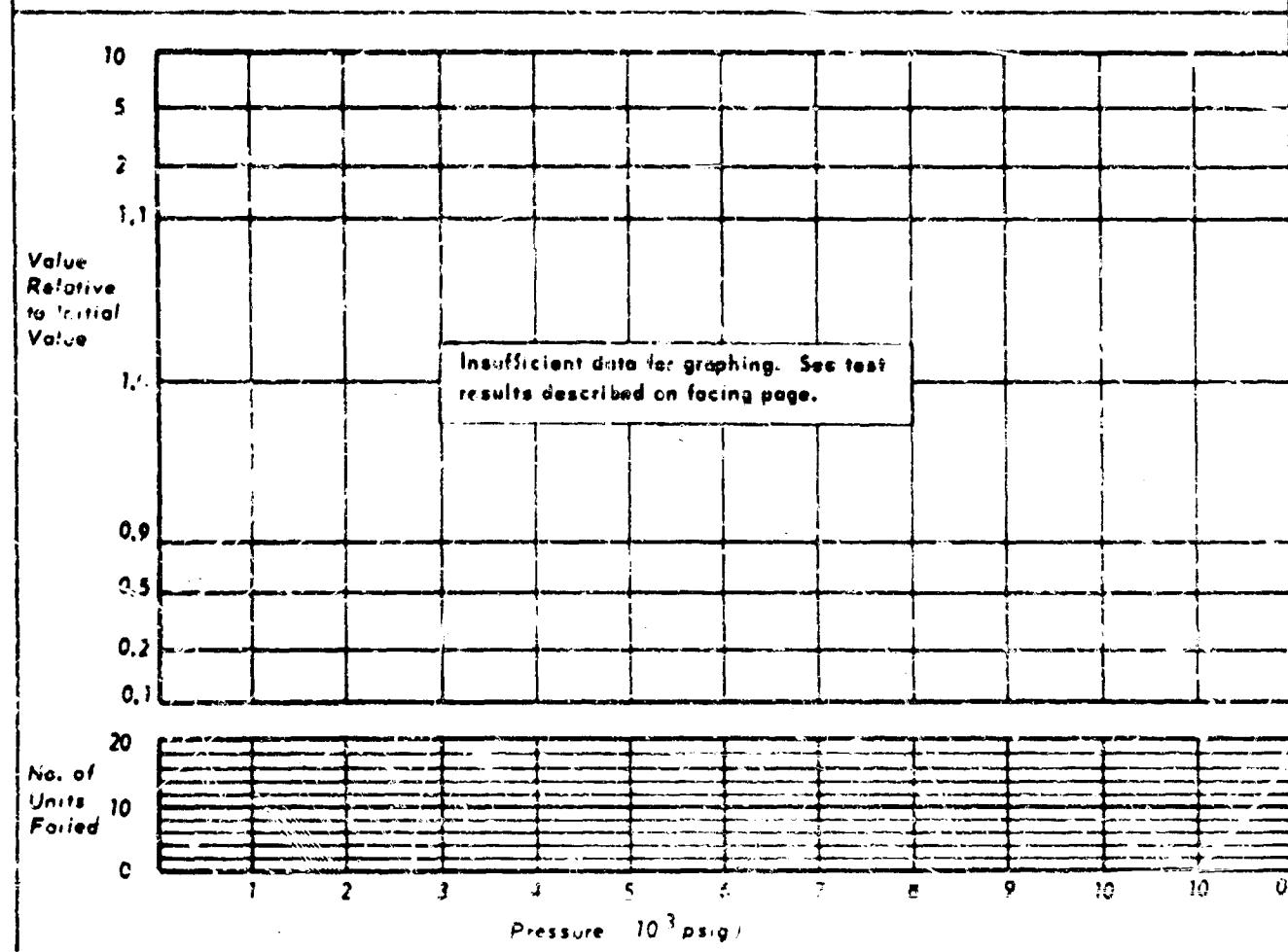
All units were examined microscopically. It was found that the aluminum metallization of all units displayed a black corrosion, which made electrical contact to some of the units impossible. However, electrical contact was successfully made to the large majority of the units without removal of the corrosion. The following electrical characteristics were measured by probing:

		Min.	Med.	Max.	Units
BV_{CEO}	0 10 μA	25	27.5	30	volts
BV_{CEO}	0 100 μA	26	28	30	volts
BV_{CEO}	0 10 μA	5.0	5.1	5.3	volts
BV_{CEO}	0 100 μA	5.1	5.1	7.0	volts
h _{FE}	0 0.5 V, 10 μA	51	63	83	

Thus, it appears from probe readings that all units are good electrically. Although the corrosion on the metallization does not appear to effect the devices' electrical characteristics, it could cause problems in making contacts to other components. This corrosion problem can probably be overcome, however, if after wire leads are bonded to the contact areas, a protective coating such as glass or epoxy is applied to the units.

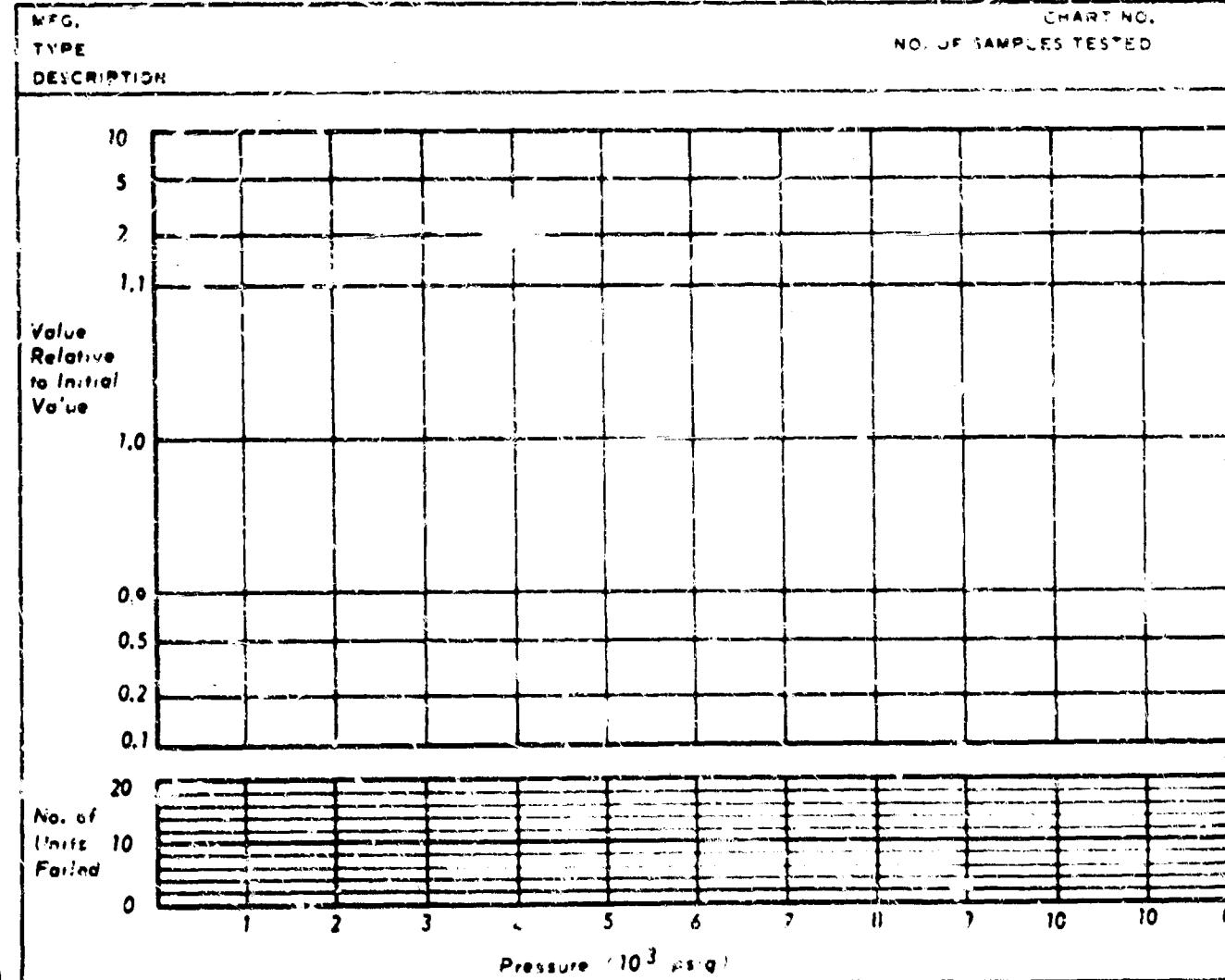
MFG. - TEXAS INSTRUMENTS
TYPE - TRANSISTOR
DESCRIPTION - 2N741

CHART NO. 152
NO. OF SAMPLES TESTED



MFG.
TYPE
DESCRIPTION

CHART NO.
NO. OF SAMPLES TESTED



Texas Instruments

2N 743

Transistor

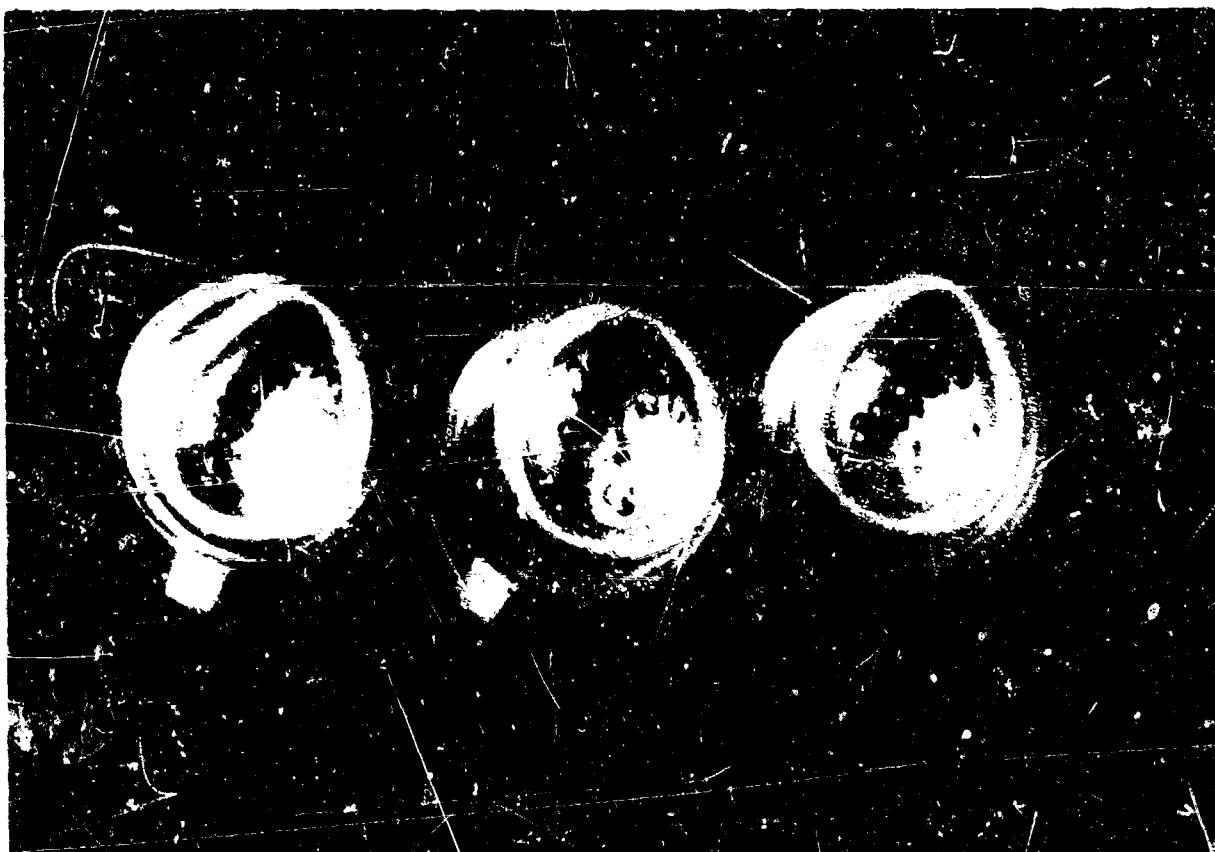
$I_{CBO} = 1 \mu\text{A}$
 $SV_{CBO} = 20 \text{ V}$

NPN epitaxial
Diffused mesa silicon

SOAK PERIOD: None

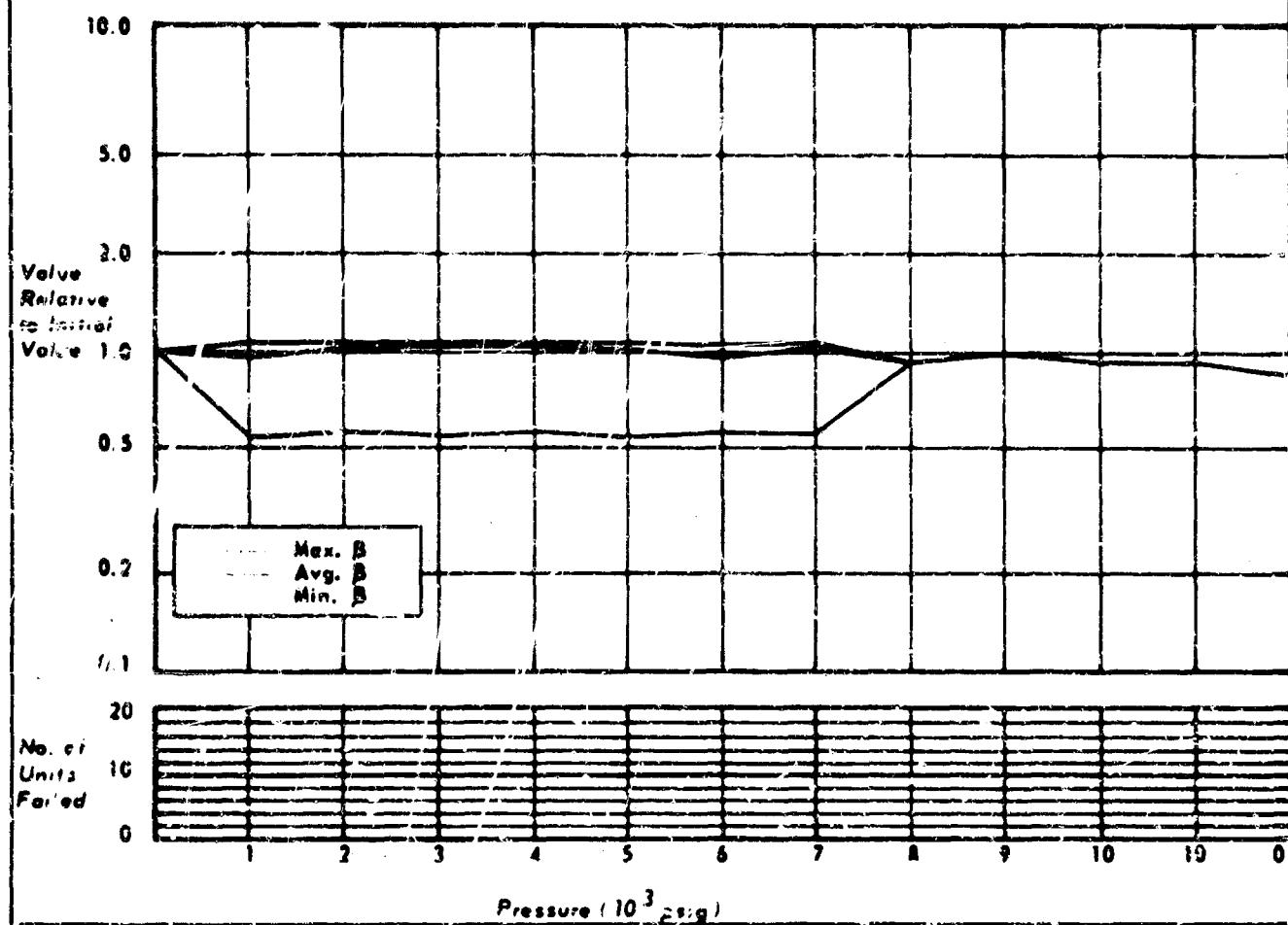
MECHANICAL: All metal cases were deformed.

ELECTRICAL: After completion of test it was noted that instrumentation problems had given invalid readings on all except one transistor. That component operated through 3,000 psig, failing between 3,000 and 4,000 psig.



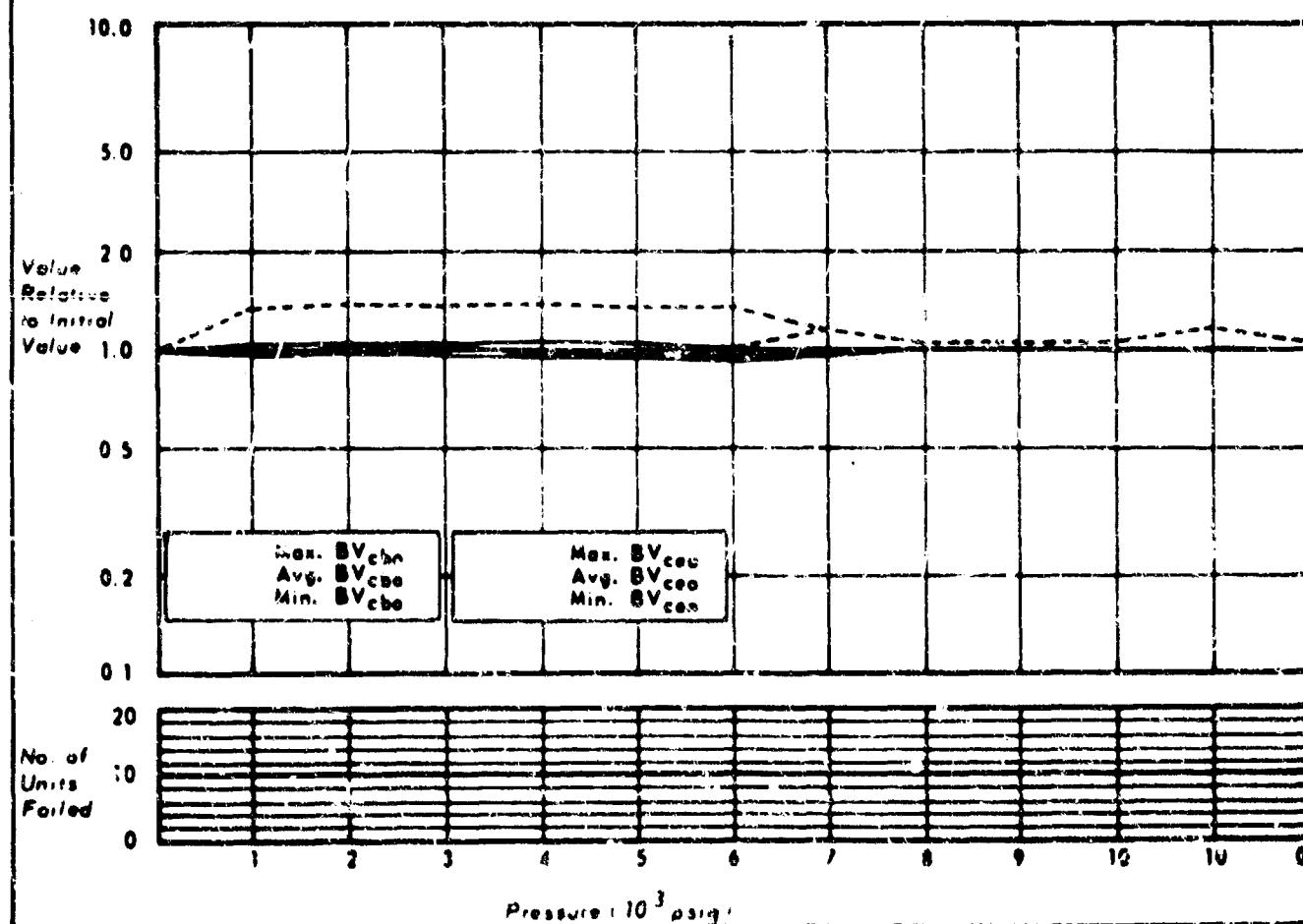
MFG. - TEXAS INSTRUMENT
TYPE - TRANSISTOR
DESCRIPTION - 2N2051

CHART NO. 153
NO. OF SAMPLES TESTED - 3



MFG.
TYPE
DESCRIPTION (SAME AS ABOVE)

CHART NO. 153A
NO. OF SAMPLES TESTED



Texas Instruments

SN 2861

Translator

IOAK PERIOD: None

MECHANICAL: The end caps of all components were deformed.

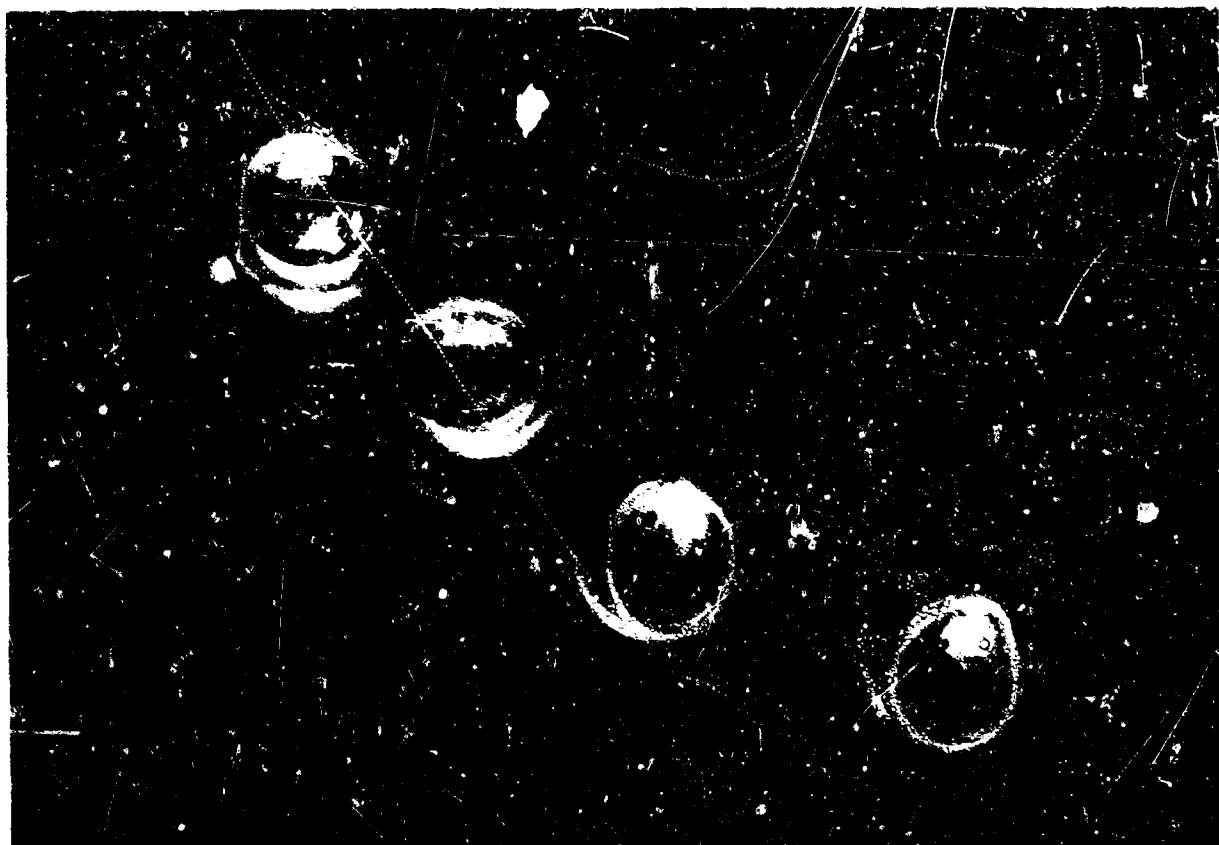
ELECTRICAL: All components functioned normally through 6000 psig. One component continued operational through the entire test program.

I_{ebo} 10 nA

$5V_{ebo}$ 25 V

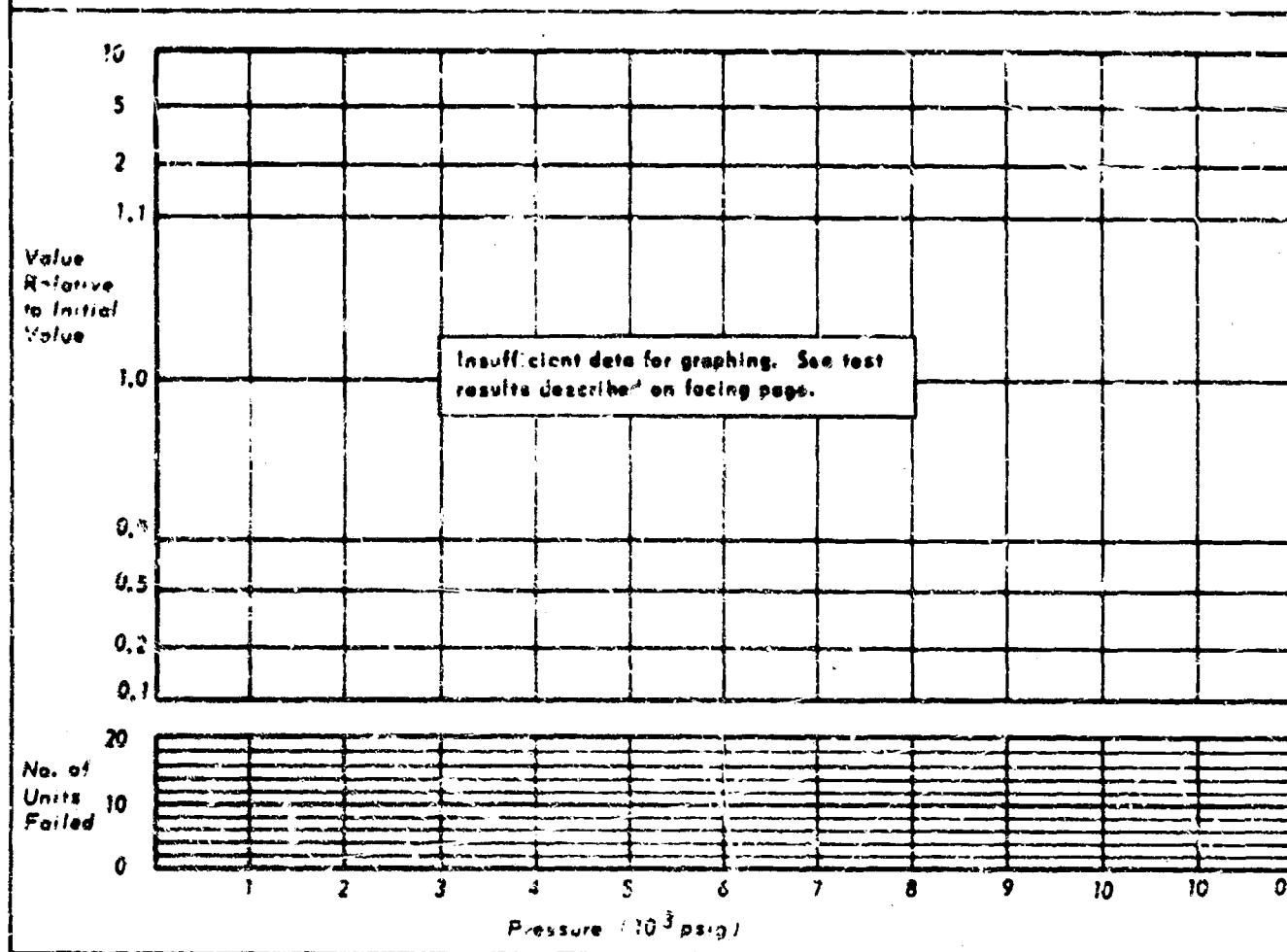
PNP epitaxial

Planar silicon



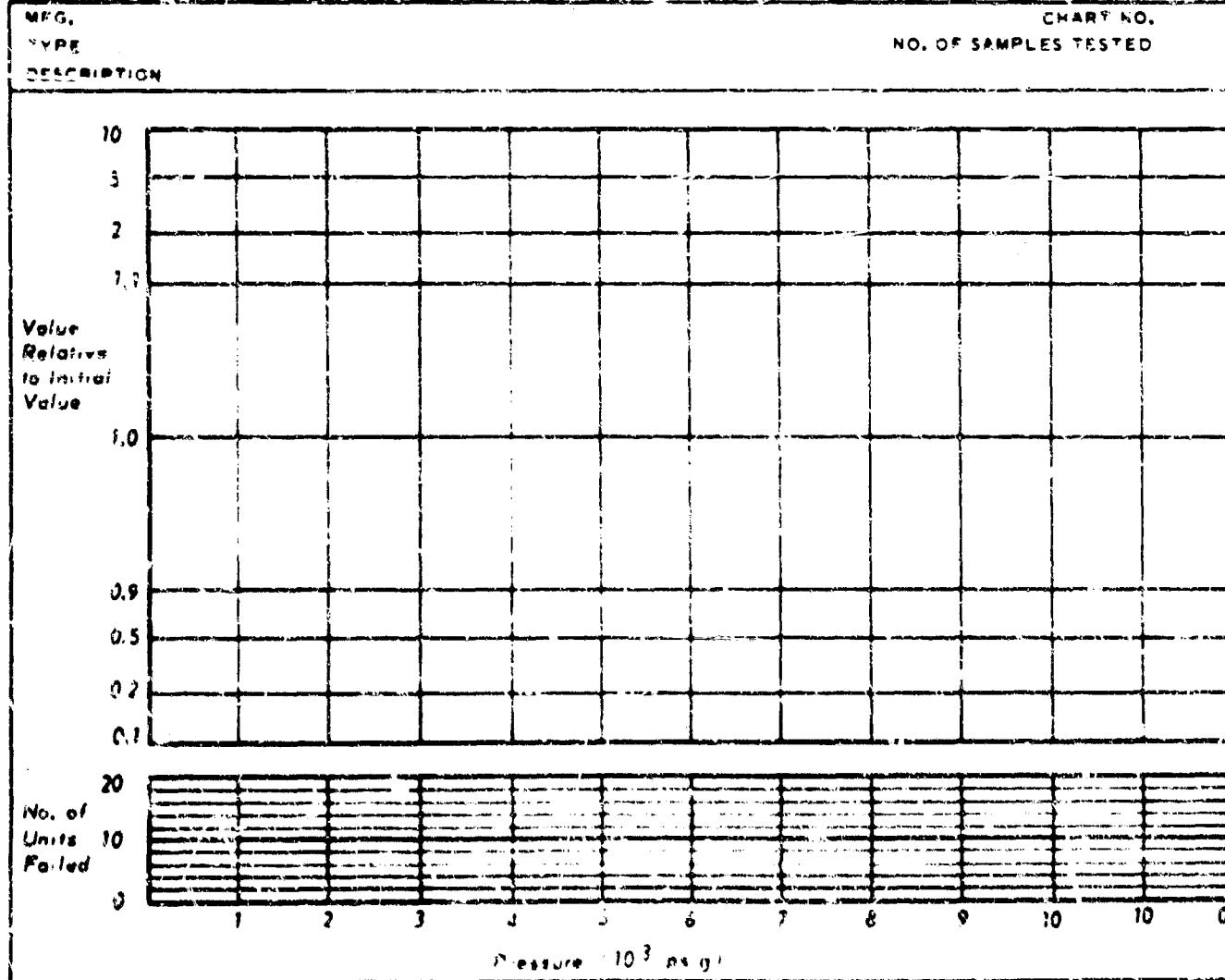
MFG. - MOTOROLA
TYPE - TRANSISTOR
DESCRIPTION - 2N2904

CHART NO. 154
NO. OF SAMPLES TESTED



MFG.
TYPE
DESCRIPTION

CHART NO.
NO. OF SAMPLES TESTED



Motorola
2N 2904
Transistor
Integrated network

Four PNP Transistors
Silicon, passivated

Ceramic flat package
6 lead
0.25 x 0.125"

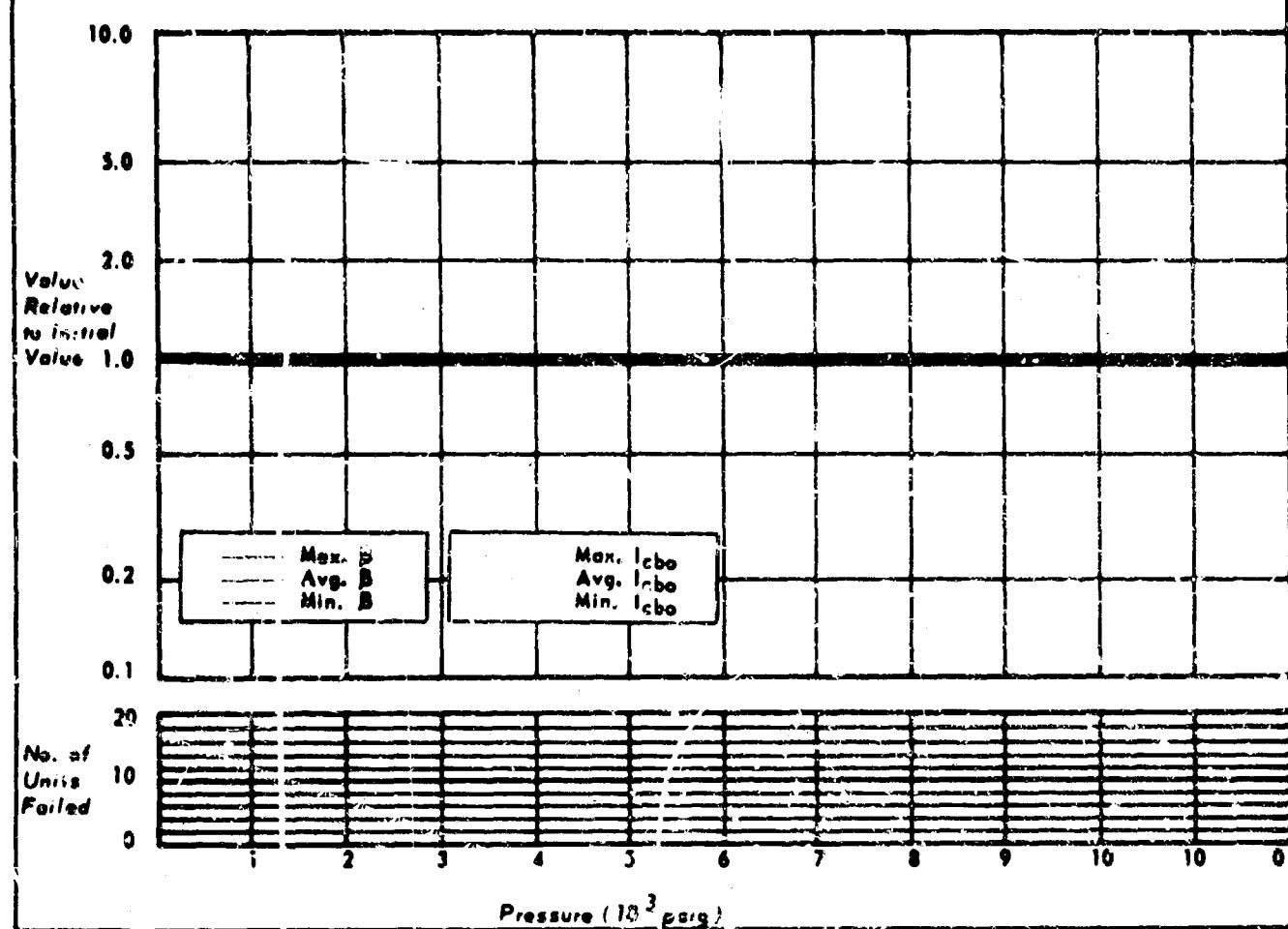
SOAK PERIOD: None

All packages were crushed before reading the 1,000 psig reading station. No electrical readings were possible other than at the initial 0 psig pressure.



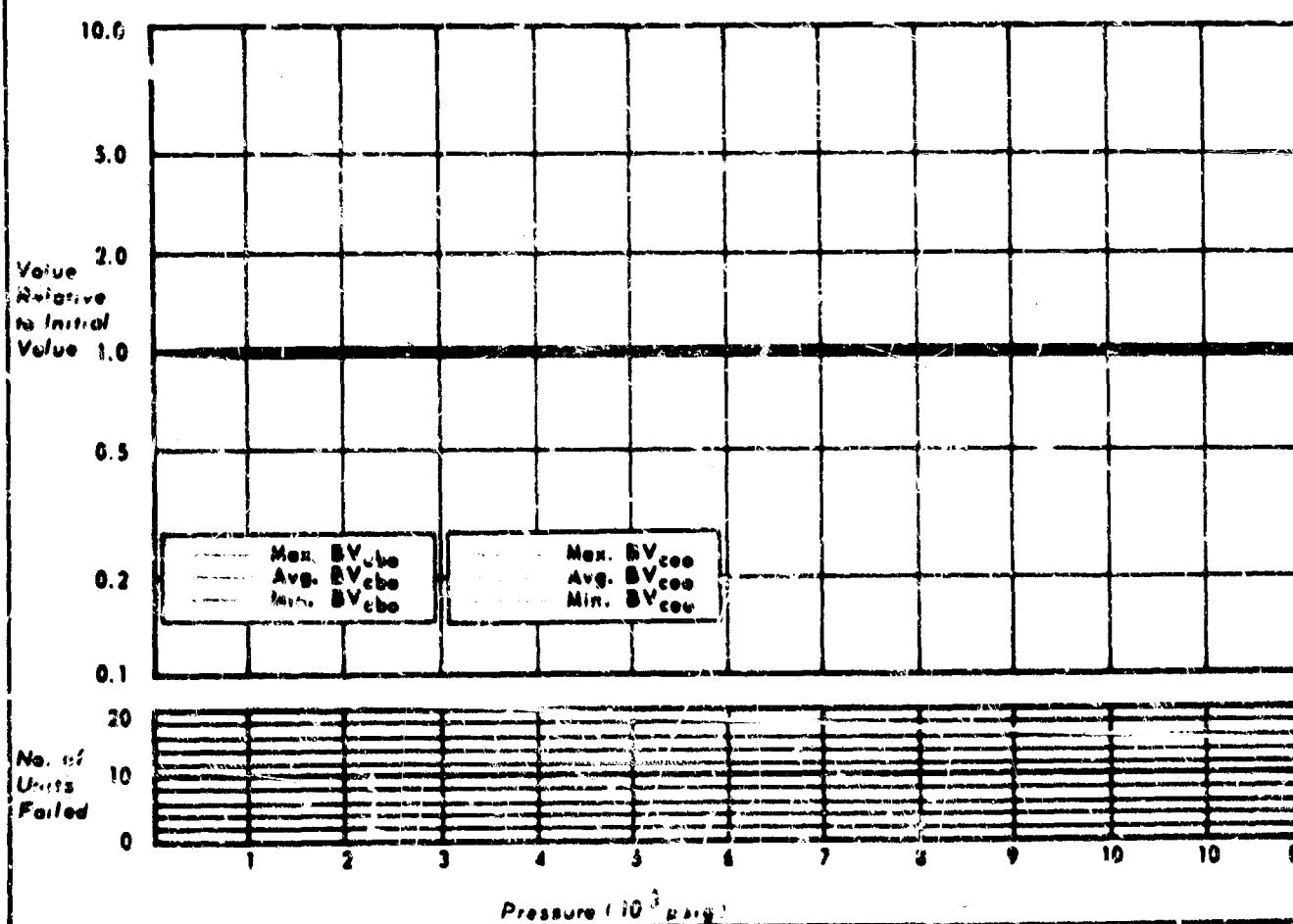
MFG. - MOTOROLA
TYPE - MICRO INTEGRATED NETWORK
DESCRIPTION - M3982

CHART NO. 155
NO. OF SAMPLES TESTED - 20



MFG.
TYPE
DESCRIPTION - (SAME AS ABOVE)

CHART NO. 155A
NO. OF SAMPLES TESTED



Motorola
MD982F

Transistor

Integrated network

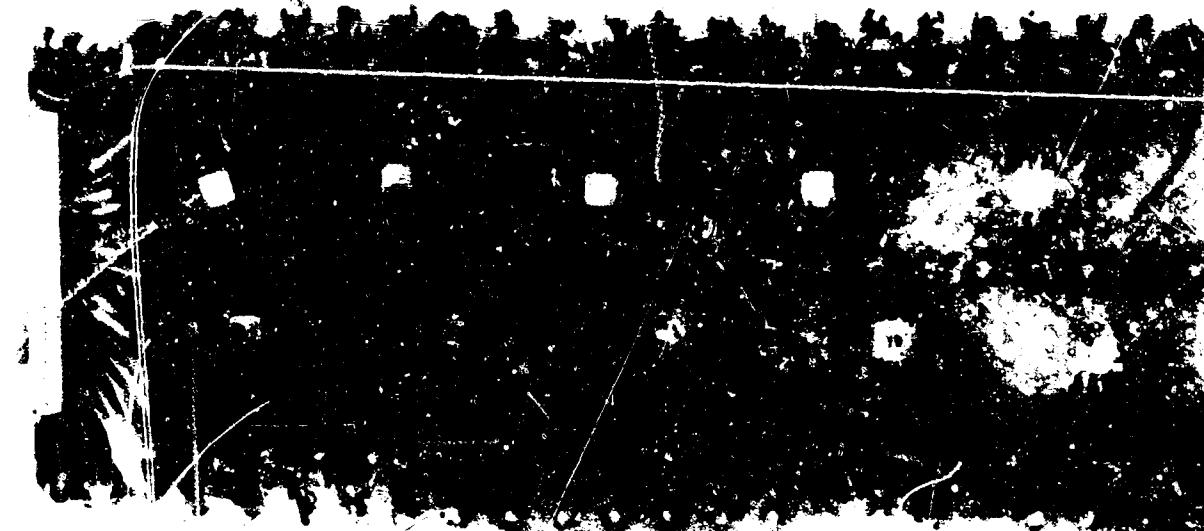
SOAK PERIOD: None

MECHANICAL: Sixteen packages were crushed between 1000 & 2000 psig. Four packages remained intact through the entire test program.

ELECTRICAL: Sixteen components functioned through 1000 psig. Four components functioned normally through the entire test program.

Two PNP transistor
Silicon, epitaxial

Ceramic flat package
14 lead



UNCLASSIFIED

Security Classification

14. KEY WORDS	LINK A		LINK B		LINK C	
	ROLE	WT	ROLE	WT	ROLE	WT
Component testing						

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1. **ORIGINATING ACTIVITY:** Enter the name and address of the contractor, subcontractor, grantee, Department of Defense activity or other organization (corporate author) issuing the report.

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1. ORIGINATING ACTIVITY (Corporate author)

University of California, Marine Physical Laboratory

2a. REPORT SECURITY CLASSIFICATION

UNCLASSIFIED

2b. GROUP

3. REPORT TITLE

ELECTRONIC COMPONENTS AT 10,000 PSI

4. DESCRIPTIVE NOTES (Type of report and inclusive dates)

Summary of component testing. 12 June 1964 to 1 May 1965.

5. AUTHOR(S) (Last name, first name, initial)

Anderson, Victor C.

Gibson, Daniel K.

Ramey, Roy E.

6. REPORT DATE

1 May 1965

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-610-Reference 54-6-

8c. PROJECT NO.

9. OTHER REPORT NO(S) (Any other numbers that may be assigned to report)

MPL-U-64/64

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11. SUPPLEMENTARY NOTES

12. SPONSORING MILITARY ACTIVITY

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Department of the Navy
Washington, D. C. 20360

13. ABSTRACT

This report presents the results of a component test program in which a series of commercial electronic components were immersed in oil and subjected to hydrostatic pressures ranging from 0 to 10,000 psig. Over 3000 components representing 163 manufacturer types were tested. Results are presented in graphic form for the readers' own interpretation. (U)

Marine Physical Laboratory
MPL-U-64/64

ELECTRONIC COMPONENTS AT 10,000 PSI by
Victor C. Anderson, Daniel K. Gibson and Roy E.
Raney, University of California, San Diego, Marine
Physical Laboratory of the Scripps Institution of
Oceanography, San Diego, California 92152.

This report presents the results of a composite
test program in which a series of commercial elec-
tronic components were immersed in oil and sub-
jected to hydrostatic pressures ranging from 0 to
10,000 psig. Over 3000 components representing
163 manufacturer types were tested. Results are
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interpretation.

V. Ocean engineering

Marine Physical Laboratory
MPL-U-64/64

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